

AECTP 500  
Edition 2

# **AECTP 500**

# **ELECTRICAL/ELECTROMAGNETIC**

# **ENVIRONMENTAL TESTS**

**JANUARY 2006**

AECTP 500  
Edition 2

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**NORTH ATLANTIC TREATY ORGANIZATION**  
**NATO STANDARDISATION AGENCY (NSA)**  
**NATO LETTER OF PROMULGATION**

18 May 2006

1. AECTP-500 (Edition 2) – ELECTRICAL/ELECTROMAGNETIC ENVIRONMENTAL TESTS is a NATO/PFP UNCLASSIFIED publication. The agreement of nations to use this publication is recorded in STANAG 4370.
2. AECTP-500 (Edition 2) is effective upon receipt. It supersedes AECTP-500 (Edition 1) which shall be destroyed in accordance with the local procedure for the destruction of documents.

J. MAJ  
Brigadier General, POL(A)  
Director, NSA

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### RECORD OF CHANGES

<b>Identification of Changes, Reg, No. (if any), and Date</b>	<b>Date Entered</b>	<b>NATO Effective Date</b>	<b>By whom Entered (Signature; Rank, Grade or Rate; Name of Command)</b>

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**ALLIED ENVIRONMENTAL CONDITIONS AND TEST PUBLICATION**

**AECTP 500**

**ELECTRICAL/ELECTROMAGNETIC ENVIRONMENTAL TESTS**

AECTP 500 is one of five documents included in STANAG 4370. Its most common application is for ensuring the resistance of materiel to electric and electromagnetic effects.

The documents in AECTP 500 contain generic test procedures that are to be tailored for the specific test program.

The enclosed list of test categories and methods reflects completed and currently developed methods. It is not comprehensive in that it will be revised as other categories and methods are developed. All methods listed are not to be applied indiscriminately, but rather selected for application as required.

In developing a test program, consideration must be given to the anticipated life cycle of the materiel. The cumulative damage caused by long-term exposure to the various electric and electromagnetic environments and the associated changes in resistance to electric and electromagnetic effects must be taken into account. The interface with the appropriate platforms must also be accounted for.

The tests herein are believed to provide a reasonable verification of the test item's performances and resistance to the effects of the elements involved. The tests are not necessarily intended to duplicate the environment and, where possible, guidance on the limitations or intended applications is provided.

The use of measured data is recommended whenever data are available.

Category 501 contains test procedures for use with equipments and sub-systems that can generally be tested in a screened room. Category 502 and later test categories will be added to future editions to cover system level tests.

**INDEX****CATEGORY 501 EQUIPMENT AND SUBSYSTEM TESTING**

<b>GENERAL REQUIREMENTS AND TEST APPLICABILITY GUIDE.....</b>	<b>501- 5</b>
<b>1 SCOPE .....</b>	<b>501- 5</b>
<b>2 GUIDANCE.....</b>	<b>501- 7</b>
<b>3 TESTING .....</b>	<b>501- 8</b>
<b>4 GENERAL REQUIREMENTS .....</b>	<b>501- 11</b>
<b>5. APPLICABILITY REQUIREMENTS .....</b>	<b>501- 49</b>
<b>6 DETAILED TEST METHOD REQUIREMENTS.....</b>	<b>501- 53</b>
<b>7. APPLICABLE DOCUMENTS .....</b>	<b>501- 99</b>
<b>8. DEFINITIONS .....</b>	<b>501- 102</b>

**TEST METHODS**

NCE01	Conducted emissions, power control and signal leads, 30 Hz to 150 MHz.....	NCE01-1
NCE02	Conducted emissions, power leads, 10 kHz to 10 MHz.....	NCE02-1
NCE03	Conducted emissions, antenna terminal, 10 kHz to 40 GHz.....	NCE03-1
NCE04	Conducted emissions, exported transients on power leads.....	NCE04-1
NCE05	Conducted emission, Power, Signal and Control Leads, 30 Hz to 150 MHz.....	NCE05-1
NCS01	Conducted susceptibility, power leads, 30 Hz to 150 kHz.....	NCS01-1
NCS02	Conducted susceptibility, control and signal leads, 20 Hz to 50 kHz.....	NCS02-1
NCS03	Conducted susceptibility, antenna port, intermodulation, 15 kHz to 10 GHz.....	NCS03-1
NCS04	Conducted susceptibility, antenna port, rejection of undesired signals, 30 Hz to 20 GHz.....	NCS04-1
NCS05	Conducted susceptibility, antenna port, cross modulation, 30 Hz to 20 GHz.....	NCS05-1
NCS06	Conducted susceptibility, structure current, 60 Hz to 100 kHz.....	NCS06-1
NCS07	Conducted susceptibility, bulk cable injection, 10 kHz to 400 MHz.....	NCS07-1
NCS08	Conducted susceptibility, bulk cable injection, impulse excitation.....	NCS08-1
NCS09	Conducted susceptibility, damped sinusoid transients, cables and power leads, 10 kHz to 100 MHz.....	NCS09-1
NCS10	Conducted susceptibility, imported lightning (aircraft).....	NCS10-1

NCS11	Conducted susceptibility, low frequency power leads (sea systems) .....	NCS11-1
NCS12	Conducted susceptibility electrostatic discharge .....	NCS12-1
NRE01	Radiated emissions, magnetic field, 30 Hz to 100 kHz .....	NRE01-1
NRE02	Radiated emissions, electric field, 10 kHz to 18 GHz.....	NRE02-1
NRE03	Radiated emissions, antenna spurious and harmonic outputs, 10 kHz to 40 GHz .....	NRE03-1
NRS01	Radiated susceptibility, magnetic fields, 30 Hz to 100 kHz, .....	NRS01-1
NRS02	Radiated susceptibility, electric field, 50 kHz to 40 GHz .....	NRS02-1
NRS03	Radiated susceptibility, transient, electromagnetic field.....	NRS03-1
NRS04	Radiated susceptibility, Magnetic Field Susceptibility (DC).....	NRS04-1

**CATEGORY 502 SYSTEM TESTING** (Not Yet Issued)

AECTP 500  
Edition 2

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# CATEGORY 501

## EQUIPMENT AND SUBSYSTEM TESTING

### TABLE OF CONTENTS

<b>GENERAL REQUIREMENTS AND TEST APPLICABILITY GUIDE</b> .....		<b>501- 5</b>
<b>1</b>	<b>SCOPE</b> .....	<b>501- 5</b>
1.1	Purpose .....	501- 5
1.2	Application.....	501- 5
1.3	Limitations .....	501- 6
<b>2</b>	<b>GUIDANCE</b> .....	<b>501- 7</b>
2.1	Objectives of the Test Program .....	501- 7
2.2	Management and Planning Procedures.....	501- 7
2.3	Environmental Considerations .....	501- 8
2.4	Electrical / Electromagnetic Parameter / Requirement Levels.....	501- 8
<b>3</b>	<b>TESTING</b> .....	<b>501- 8</b>
3.1	Test Item Configuration.....	501- 8
3.2	Test Conditions .....	501- 9
3.3	Information Required.....	501- 9
3.4	Failure Criteria.....	501- 10
<b>4</b>	<b>GENERAL REQUIREMENTS</b> .....	<b>501- 11</b>
4.1	General.....	501- 11
4.2	Interface Requirements.....	501- 11
4.3	Verification requirements .....	501- 14
<b>5.</b>	<b>APPLICABILITY REQUIREMENTS</b> .....	<b>501- 49</b>
5.1	General.....	501- 49
5.2	EMI control requirements versus intended installations .....	501- 49

<b>6</b>	<b>DETAILED TEST METHOD REQUIREMENTS .....</b>	<b>501- 53</b>
6.1	General.....	501- 53
6.2	Units of frequency domain measurements .....	501- 53
6.3	Emission and susceptibility requirements, limits, and test procedures.....	501- 53
6.4	NCE01, conducted emissions, power leads, 30 Hz to 10 kHz.....	501- 53
6.5	NCE02, conducted emissions, power leads, 10 kHz to 10 MHz.....	501- 54
6.6	NCE03, conducted emissions, antenna terminal, 10 kHz to 40 GHz .....	501- 57
6.7	NCE04, conducted emissions, exported transients on power leads .....	501- 59
6.8	NCE05, conducted emission, power, signal and control leads, 30 Hz to 150 MHz.....	501- 60
6.9	NCS01, conducted susceptibility, power leads, 30 Hz to 150 kHz .....	501- 61
6.10	NCS02, conducted susceptibility, control and signal leads, 30 Hz to 50 kHz.....	501- 63
6.11	NCS03, conducted susceptibility, antenna port, intermodulation, 15 kHz to 10 GHz....	501- 64
6.12	NCS04, conducted susceptibility, antenna port, rejection of undesired signals, 30 Hz to 20 GHz.....	501- 67
6.13	NCS05, conducted susceptibility, antenna port, cross modulation, 30 Hz to 20 GHz...	501- 69
6.14	NCS06, conducted susceptibility, structure current, 60 Hz to 100 kHz .....	501- 71
6.15	NCS07, conducted susceptibility, bulk cable injection, 10 kHz to 400 MHz. ....	501- 72
6.16	NCS08, conducted susceptibility, bulk cable injection, impulse excitation .....	501- 76
6.17	NCS09, conducted susceptibility, damped sinusoid transients, cables and power leads, 10 kHz to 100 MHz.....	501- 79
6.18	NCS10 conducted susceptibility, imported lightning (aircraft) .....	501- 81
6.19	NCS11 conducted susceptibility, low frequency power leads (sea systems).....	501- 83
6.20	NCS12 conducted susceptibility electrostatic discharge .....	501- 84
6.21	NRE01, radiated emissions, magnetic field, 30 Hz to 100 kHz .....	501- 85
6.22	NRE02, radiated emissions, electric field, 10 kHz to 18 GHz.....	501- 86
6.23	NRE03, radiated emissions, antenna spurious and harmonic outputs, 10 kHz to 40 GHz .....	501- 89
6.24	NRS01, radiated susceptibility, magnetic fields, 30 Hz to 100 kHz .....	501- 90
6.25	NRS02, radiated susceptibility, electric field, 50 kHz to 40 GHz .....	501- 92
6.26	NRS03, radiated susceptibility, transient, electromagnetic field .....	501- 96
6.27	NRS04, radiated susceptibility, magnetic field susceptibility (DC).....	501- 97

<b>7.</b>	<b>APPLICABLE DOCUMENTS .....</b>	<b>501- 99</b>
7.1	General.....	501- 99
7.2	Government documents.....	501- 99
7.3.	Non-Government publications .....	501- 101
<b>8.</b>	<b>DEFINITIONS .....</b>	<b>501- 102</b>
8.1	General.....	501- 102
8.2	Acronyms .....	501- 103
<b>FIGURES</b>		
FIGURE 1	Voltage probe for tests at user's installation.....	501- 16
FIGURE 2	RF Absorber loading diagram.....	501- 18
FIGURE 3	Test set-up for conductive surface mounted EUT .....	501- 21
FIGURE 4	Test set-up for non-conductive surface mounted EUT .....	501- 22
FIGURE 5	Test set-up for free standing EUT in shielded enclosure .....	501- 23
FIGURE 6	Test set-up for free standing EUT.....	501- 24
FIGURE 7	50 $\mu$ H LISN schematic.....	501- 26
FIGURE 8	5 $\mu$ H LISN schematic.....	501- 26
FIGURE 9	50 $\mu$ H LISN Impedance .....	501- 27
FIGURE 10	5 $\mu$ H LISN Impedance .....	501- 27
FIGURE 11	Peak detector response.....	501- 38
FIGURE 12	Example of data presentation resolution. ....	501- 42
FIGURE 13	Correction factor for LISN capacitor. ....	501- 56
FIGURE 14	Basic Circuit for NCE04 Probe/Filter/Oscilloscope Combination .....	501- 60
FIGURE 15	NCS01 Power amplifier protection.....	501- 63
FIGURE 16	NCS03 General test set-up.....	501- 66
FIGURE 17	NCS04 General test set-up.....	501- 69
FIGURE 18	NCS05 General test set-up.....	501- 71
FIGURE 19	Typical NCS07 calibration fixture.....	501- 74
FIGURE 20	Maximum VSWR of calibration fixture .....	501- 75
FIGURE 21	Insertion loss measurement.....	501- 76
FIGURE 22	Circuit diagram of NCS08 pulse generator.....	501- 78
FIGURE 23	Typical NCS08 calibration fixture waveform.....	501- 79

**TABLES**

TABLE 1	Absorption at normal incidence .....	501- 18
TABLE 2	Bandwidth and measurement time .....	501- 39
TABLE 3	Susceptibility scanning .....	501- 43
TABLE 4	Susceptibility testing times.....	501- 45
TABLE 5	Emission and susceptibility requirements.....	501- 50
TABLE 6	Requirement Matrix.....	501- 51
TABLE 7	Tests required by NATO Nations.....	501- 52

## CATEGORY 501

### General Requirements and Test Applicability Guide

#### 1 SCOPE

##### 1.1 Purpose

This document is intended to cover general and specific requirements relating to equipment and subsystems, guidance and requirements for development of a test program for all materiel characterised as electronic, electrical and electromechanical equipment, to be tested at the equipment and subsystems level.

General purpose is:

- a. To state the overall test objectives for the validation of materiel design, within the electromagnetic environment.
- b. To provide general guidance for management of a test program for the electrical/ electromagnetic environment and to provide guidance in the selection of tests
- c. To outline the necessary processes and products of the test program that includes test procedures, data collection and assessment to achieve acceptable assurance.

Specific purpose is:

To provide background information under the heading 'discussion' for general requirements and applicability for detailed test requirements. This information includes rationale for requirements, guidance in applying the requirements, and lessons learned from platform and laboratory experience. This information should help users understand the intent behind the requirements. In addition it should aid the procuring activity in tailoring emission and susceptibility requirements as necessary for particular applications and help users develop detailed test procedures in the EMITP based on the general test procedures in this document. This background information is provided for guidance purposes and, as such, should not be interpreted as providing contractual requirements.

##### 1.2 Application

This document includes information which shall be considered as follows when using the AECTP 500 series of Electrical /Electromagnetic Tests:

- a. Test program development.
- b. Applicability of each test
- c. Test Methodology
- d. Parameter levels for the tests.
- e. Characteristics of Test Facilities.
- f. Test Item configuration.
- g. Test Conditions.
- h. Pre and Post-test checks of the test item
- i. Test Products including Plans, Data and Reports
- j. Failure criteria.

### 1.2.1 Materiel containing Electro Explosive Devices (EEDs)

Test and assessment requirements for materiel containing EEDs are documented in STANAG 4239, 4324, 4327 and 4416. In general EMC tests in accordance with the AECTP 500 series tests will also be necessary for materiel that do not directly interface with the EEDs.

### 1.2.2 Combined Testing

The tailoring process (AECTP100) may identify a need to combine electrical/electromagnetic environmental testing with other environments in the 300 and 400 series. Such combinations may produce a more realistic representation of the effects of the overall environment than a series of single tests

### 1.2.3 Materiel (Whole System) Testing

This Edition of AECTP500 does not cover whole System Testing

## 1.3 Limitations

### 1.3.1 Test item

The test item may be of such size and complexity that it cannot be contained within available test facilities.

**Discussion:** *The test item should be equipment or a subsystem that may be used independently or as an integral part of other subsystems or systems. Successful completion of system or platform EMC testing may be hampered if appropriate test procedures have not been previously carried out on sub divisions of systems or platforms. Success in the equipment or subsystem testing would build confidence that, upon connecting the equipment or subsystems together to form the whole system, it would be likely that the materiel would pass whole system testing. An assessment may show that some test procedures for the whole system need not be conducted.*

Test methods suitable for component level testing are not given in the AECTP 500 series.

**Discussion:** *However components within equipment's or systems should be selected from those which are believed to be able to perform the design function over the whole life cycle including its environmental elements. Testing can provide evidence to support selection. Components likely to be exposed to abnormal environments need to be identified and special testing may need to be devised.*

*When it is demonstrated that a commercial item selected by the equipment developer is responsible for equipment or subsystems failing to meet the EMC requirements. Then either the commercial item shall be modified or replaced or interference suppression measures shall be employed, so that the equipment or subsystems meet the EMC requirements.*

### 1.3.2 Environment

The electromagnetic environment that materiel could encounter throughout their life cycle may be self-generated, be generated by other materiel, or be generated by natural phenomena. The total environment at any particular phase of the materiel life cycle may be composed of any combination of environments from these sources. In general, concurrent electrical/electromagnetic environmental testing is not performed, and the test procedures within AECTP 500 relate to separate environments or their effects.

**Discussion:** *The test parameters and their levels are chosen to provide repeatable simulation of the 'real' environments. For natural phenomena, levels are often adopted that correspond to those that the materiel could conceivably encounter, and not necessarily to the worst possible cases. For self-generated and externally generated environments, levels shall either be specified by the adoption of standards or shall be derived from the knowledge of the likely external environment. The latter option is preferable when the external environment is known to be severe.*

## 2 GUIDANCE

The AECTP 500 series contains generic test procedures that may be applied to any type of materiel. The test procedures to be used for a specific test program shall be selected on the basis of the operational use and environmental conditions that will be experienced during the lifetime of the materiel. The selection of some test procedures will be dependent on the procuring nation (see paragraph 5.2 and Applicability Tables 6 and 7).

### 2.1 Objectives of the Test Program

The objectives of the program shall be to demonstrate, where appropriate, that the materiel:

- a. Will not unacceptably interfere with, perturb or damage other materiel when operating as intended.
- b. Will not unacceptably interfere with, perturb or damage its own components or equipment when operating as intended.
- c. Will not be unacceptably perturbed or damaged by external environments, whether generated by other materiel, by humans or by natural phenomena.
- d. Will not unacceptably endanger personnel during those phases of the materiel life cycle in which either the materiel could produce discharges or emissions of an electrical or electromagnetic nature, or the materiel could be affected by external environments with adverse consequences.

### 2.2 Management and Planning Procedures

#### 2.2.1 EMC Specification

It is the program manager's responsibility to ensure that the test item requirement document for the materiel is used as the basis for the development of an electrical/electromagnetic compatibility specification for the materiel. The test requirement document will contain environmental statements, design requirements for the protection of equipment and subsystems and compliance criteria. For complex materiel, an EMC Control Plan is needed to identify management responsibilities to ensure EMC requirements in the specification are addressed, to ensure a cost effective program to demonstrate compliance is developed and to provide a consistent review procedure.

#### 2.2.2 Test Program and Plans

A test program shall be developed for the materiel including all components and subsystems, where appropriate. The program shall be sufficiently detailed to enable any test to be repeated with the same results. The program shall cover both development and acceptance testing up to and including system testing. The program/plans shall define:

- a. Contractor EMI/C Management Structure (as appropriate)
- b. The equipment, subsystem or system which will be tested and when the test should be completed.
- c. The nature or purpose of each test.
- d. The Mode(s) of Operation of the equipment under test
- e. The signal modulation to apply during susceptibility testing, as required
- f. The functional tests and inspections to be performed before, during and after each EMC test procedure.
- g. The facility to be used and the support equipment needed for the test.
- h. Data recording, test configuration description/photographs, analysis and reporting to be used.

Individual test plans for each procedure shall be prepared.

## 2.3 Environmental Considerations

The most realistic approach for testing materiel under simulated electrical/electromagnetic environments would be to expose the test item in a deployed and functional state under those conditions in which it would be operated by national and NATO forces. Some land-based materiel could be tested using such an approach. Air and ship-borne materiel are more difficult to deploy in realistic conditions since; for the most part land-based test facilities are used. Suspending or isolating the test item in free space may represent aircraft flight or ship's decks or by using a conducting ground plane upon which the test item stands. More difficult still are types of materiel, which form an interconnected part of an extensive system, or are installed on or within a building, or large mobile platform. Testing in the natural environment (open site) may not be possible for all materiel. It also may be precluded for reasons of intolerable, possibly illegal, interference with test site neighbours. Where the materiel is to be divided into its equipment or subsystems, environmentally protected test facilities are essential.

### 2.3.1 Program schedule

Subsystem EMC testing should be completed before integrated system testing is undertaken. Testing the integrated system may uncover deficiencies not revealed during subsystem testing.

## 2.4 Electrical / Electromagnetic Parameter / Requirement Levels

### 2.4.1 Parametric Considerations

In determining test parameters/requirements, consideration shall be given to:

- a. Anticipated external life cycle environments not modified by other materiel in or on which the materiel is placed.
- b. Induced environments where the external environment is modified by other materiel in or on which the considered materiel is placed.
- c. Internal environments that the materiel produces by its own operation within the life cycle.

### 2.4.2 Tailoring of Parameters/Requirements

Parameters/requirements should be tailored in accordance with the function of the materiel, its life cycle, its interaction with other materiel and the derived electrical/electromagnetic environment. The logic for the tailoring shall be included in either the EMC specification or the test program/plans. The selection of parameters preferably should be based on direct environmental measurements made under real life cycle situations. The alternative is to use derived levels, which can be obtained either by assessment or reference to data collected during test programs completed on similar types of materiel.

## 3 TESTING

### 3.1 Test Item Configuration

The test item configuration should be the actual materiel configuration at the appropriate phase of the life cycle. As a minimum, the following configurations shall be considered:

- a. The materiel by itself in an operating or active mode.
- b. Materiel contained in any shipping or transit casing where the casing should be assessed for electromagnetic shielding against the environment, including any grounding provisions.
- c. The materiel in a test mode where other equipment or materiel is connected to it. Conduct of the test procedures shall consider the potential safety hazards to test personnel. In particular, inadvertent initiation of energetic materials by electro-ignition

and other hazardous electrical/mechanical reactions that could be induced by the testing should not be possible.

### 3.2 Test Conditions

#### 3.2.1 Climatic Conditions for Testing

Tests made on equipment are usually made indoors in uncontrolled climatic conditions but, since most of the test facilities are within buildings, the range of the climatic conditions is limited. The procedure for conducting electrostatic charge/discharge testing must include a consideration of climatic parameters.

#### 3.2.2 Electrical/Electromagnetic Test Conditions

Test conditions are given in each of the appropriate test procedures of AECTP500.

#### 3.2.3 Tolerances, Data and Recording

Unless otherwise specified, the test equipment and auxiliary instrumentation shall be capable of maintaining the prescribed test parameters (both input and output) within prescribed tolerances. Data shall be recorded either manually or automatically during testing, including any observation as to upset, perturbation or damage to equipment. For emissions measurements, amplitude versus frequency profiles of emission data shall be recorded on an automatically generated continuous plot. The applicable parameter/requirement limit shall be displayed on the plot. Manually gathered emissions data is not acceptable except for plot verification.

### 3.3 Information Required

The following paragraphs list the minimum essential information on pre and post test status of the materiel.

#### 3.3.1 Pre Test Information

- a. Test item description (make, model, serial number etc.).
- b. Test item configuration.
- c. Appropriate test procedure to be applied.
- d. Objectives of the test and acceptance criteria.
- e. Test equipment to be used (make, model, serial number, calibration, etc.).
- f. Cable types if applicable
- g. Defect recording and rectification.
- h. Results of pre-test operational check.
- i. Date for Test
- j. Test Personnel
- k. Test Organisation or Test House

#### 3.3.2 Post Test Information

- a. Test item responses to procedures.
- b. Deviations from planned test procedures and their affect on test acceptability.
- c. Records of ambient test conditions other than those associated with the Methods used.
- d. Observations of defects, upsets, perturbation or damage and their location during the test, and an evaluation of the problem.
- e. Investigation of damage at the component level.
- f. Test equipment used (make, model, serial number, calibration, etc.).
- g. Date of Test

- h Test Personnel
- i Test Organisation or Test House

### 3.3.3 Test Report

The information shall be collated into a test report.

## 3.4 Failure Criteria

### 3.4.1 Failure

Any one of the following conditions shall normally constitute a test item failure:

- a. Deviation of the monitored output parameter beyond the requirement levels established in the EMC specification for the materiel or for equipment/ subsystems, which constitute the materiel.
- b. Observation of transient phenomena or damage likely to lead to the development of a safety hazard associated with the material.
- c. Observation of transient phenomena or damage likely to lead to preventing the materiel from meeting its specified performance at some phase in the life cycle.

### 3.4.2 Degraded Performance

Degraded performance may be acceptable at the extremes of the electrical/electromagnetic environments if identified in the specification. Restriction on the operability of the materiel can also be acceptable, e.g., for RF radiation hazards (RADHAZ). Degraded performance is a failure if:

- a. The degradation exceeds specification limits.
- b. The specified performance is not restored upon removal of the electrical/electromagnetic environment causing the degradation.

### 3.4.3 Retest

Retesting of the EUT will take place in the event that:

- a. The EUT has been repaired or redesigned as a result of a previous test failure. In such circumstances, where compliance can be assured, it is permissible to test only those parts of the EUT that failed under the test conditions that caused it. Where repairs or redesign of the EUT may have an impact on testing already performed, then those tests are to be repeated also.
- b. The test procedure is not followed correctly or the EUT has been configured incorrectly. This includes where the EUT is operated differently to that previously agreed with the procuring authority or to how it would operate in its normal installation. In such circumstances all testing undertaken will be repeated with the EUT in the correct configuration.

### 3.4.4 Comments

A commentary on all test failures observed shall be made within the test report. If further assessment is necessary, it shall be included in any overall EMC final report on the materiel.

## 4 GENERAL REQUIREMENTS

### 4.1 General

Electronic, electrical, and electromechanical equipment and subsystems shall comply with the applicable general interface requirements in paragraph 4.2. General requirements for verification shall be in accordance with paragraph 4.3. These general requirements are in addition to the applicable detailed emission and susceptibility requirements and associated test procedures defined in paragraph 5.0.

**Discussion:** *The requirements in this paragraph are universally applicable to all subsystems and equipment. Separate emission and susceptibility requirements that are structured to address specific concerns with various classes of subsystems and equipment are contained in other portions of this standard.*

*This document is concerned only with specifying technical requirements for controlling electromagnetic interference (EMI) emissions and susceptibility at the subsystem-level and equipment-level. The requirements in this document are not intended to be directly applied to subassemblies of equipment such as modules or circuit cards. The basic concepts can be implemented at the subassembly level; however, significant tailoring needs to be accomplished for the particular application. The requirements included herein are intended to be used as a baseline. Placement of the limits is based on demonstrated performance typically required for use on existing platforms in order to achieve electromagnetic compatibility (EMC). System-level requirements dealing with integration of subsystems and equipment are contained in documents such as MIL-STD-464A and MIL-STD-188-125 and Def Stan 59-41. MIL-STD-464A requirements include intra-system compatibility within the system, inter-system compatibility with external radio frequency environments, lightning protection, and hazards of electromagnetic radiation to ordnance, fuel and personnel. The procuring activity and system contractors should review the requirements contained herein for possible tailoring based on system design and expected operational environments. MIL-STD-469 provides additional requirements for radars for achieving electromagnetic compatibility. In addition national laws governing use of the radio frequency spectrum must be addressed.*

*Guidance and techniques, which are helpful in meeting the requirements of this standard, are contained in MIL-HDBK-241, MIL-HDBK-253, MIL-HDBK-423, AFSC DH 1-4, Def Stan 59-41 and AMC Pamphlet 706-410. MIL-HDBK-237 provides guidance for management of EMC efforts. ADS-37A-PRF provides additional guidance for Army equipment located or operated on fixed-wing aircraft and helicopters. MIL-HDBK-235 and Def Stan 08-46 provides information on land, air, and sea based RF emitters, both hostile and friendly, which contribute to the overall electromagnetic environment.*

*The qualification status of equipment and subsystems becomes uncertain when hardware or software changes are incorporated due to equipment updates or test failures, including failures from testing to requirements other than EMI. To maintain AECTP500 qualification after changes are implemented, either an analysis showing no substantive impact needs to be issued or continued compliance needs to be demonstrated by limited testing deemed to be appropriate to evaluate the changes. The approach used to maintain continued certification and the results of analysis and testing are normally subject to procuring activity approval.*

### 4.2 Interface Requirements

#### 4.2.1 Joint procurement

Equipment or subsystems procured by one user activity for multi-agency use shall comply with the requirements of the user agencies.

**Discussion:** *When a government procures equipment that will be used by more than one service or agency, a particular activity is assigned responsibility for overall procurement. The responsible activity must address the concerns of all the users. Conflicts may exist among the parties concerned. Also,*

*imposition of more severe design requirements by one party may adversely affect other performance characteristics required by the second party. For example, severe radiated susceptibility levels on an electro-optical sensor may require aperture protection measures which compromise sensitivity. It is important that these issues be resolved to the satisfaction of all parties and that all genuine requirements be included.*

#### 4.2.2 Filtering (Navy only)

The use of line-to-ground filters for EMI control shall be minimised. Such filters establish low impedance paths for structure (common-mode) currents through the ground plane and can be a major cause of interference in systems, platforms, or installations because the currents can couple into other equipment using the same ground plane. If such a filter must be employed, the line-to-ground capacitance for each line shall not exceed 0.1 microfarad ( $\mu\text{F}$ ) for 60 Hertz (Hz) equipment or 0.02  $\mu\text{F}$  for 400 Hz equipment. For submarine DC-powered equipment and aircraft DC-powered equipment, the filter capacitance from each line-to-ground at the user interface shall not exceed 0.075  $\mu\text{F}/\text{kW}$  of connected load. For DC loads less than 0.5 kW, the filter capacitance shall not exceed 0.03  $\mu\text{F}$ . The filtering employed shall be fully described in the equipment or subsystem technical manual and the Electromagnetic Interference Control Procedures (EMICP).

**Discussion:** *The power systems for Navy ships and submarines are ungrounded. The capacitance-to-ground of power line filters provides a path for conducting current into the hull structure. The Navy uses very sensitive low frequency radio and sonar receivers. At low frequencies, currents flowing through the installation structure and across surfaces of electronic enclosures will penetrate to the inside of the enclosure. The magnetic fields created by these currents can couple into critical circuits and degrade performance. At higher frequencies (greater than 100 kHz), the combination of power line filter capacitance-to-ground limitation, skin effect of equipment enclosures, and reduced harmonic currents tend to minimise the problems associated with structure currents.*

#### 4.2.3 Self-compatibility

The operational performance of an equipment or subsystem shall not be degraded, nor shall it malfunction, when all of the units or devices in the equipment or subsystem are operating together at their designed levels of efficiency or their design capability.

**Discussion:** *The EMI controls imposed by this standard apply to subsystem-level hardware with the purpose of insuring compatibility when various subsystems are integrated into a system platform. In a parallel sense, a subsystem can be considered to be an integration of various assemblies, circuit cards, and electronics boxes. While specific requirements could be imposed to control the interference characteristics of these individual items, this standard is concerned only with the overall performance characteristics of the subsystem after integration. Therefore, the subsystem itself must exhibit compatibility among its various component parts and assemblies.*

#### 4.2.4 Non-Developmental Items (NDI)

In accordance with the guidance provided by **the procuring Government**, the requirements of this standard shall be met when applicable and warranted by the intended installation and platform requirements.

**Discussion:** *NDI refers to any equipment that is already developed and ready for use including both commercial and military items. Acceptance in the commercial marketplace does not mean that EMC requirements are met and modifications to correct EMC problems can be costly and time consuming. EMC problems that arise from NDI equipment can be potentially hazardous. Quantitative EMC requirements should be developed and valid data needs to be gathered during a market investigation for performance of analysis to determine the suitability of the NDI. Testing may be required if there is insufficient data. An EMC advisory board is recommended to provide alternatives to the procuring authority.*

#### 4.2.4.1 Commercial items

**Discussion:** *The use of commercial off-the-shelf equipment presents a dilemma between the need for EMI control with appropriate design measures implemented and the desire to take advantage of existing designs, which may exhibit undesirable EMI characteristics. Paragraphs 4.2.4.1.1 and 4.2.4.1.2 address the specific requirements for the two separate cases of contractor selection versus procuring activity specification of commercial equipment.*

*For some applications of commercially developed products, such as commercial transport aircraft, EMI requirements similar to those in this standard are usually imposed on equipment. Most commercial aircraft equipment is required to meet the EMI requirements in RTCA DO-160 or an equivalent contractor in-house document. Recent revisions to RTCA DO-160 are making the document more compatible with this standard. Equipment qualified to revisions "C" or "D" of RTCA DO-160 is often suitable for military aircraft applications.*

*EMI requirements on most commercial equipment are more varied and sometimes non-existent. The minimum EMI requirements shall be those pertaining to the commercial regulations for the countries which the equipment shall be deployed in. These requirements are typically less stringent than military requirements of a similar type. Also, there is difficulty in comparing levels between commercial and military testing due to differences in measurement distances, different types of antennas, and near-field conditions.*

##### 4.2.4.1.1 Selected by contractor

When it is demonstrated that a commercial item selected by the contractor is responsible for equipment or subsystems failing to meet the contractual EMI requirements. Then either the commercial item shall be modified or replaced or interference suppression measures shall be employed, so that the equipment or subsystems meet the contractual EMI requirements.

**Discussion:** *The contractor retains responsibility for complying with EMI requirements regardless of the contractor's choice of commercial off-the-shelf items. The contractor can treat selected commercial items as necessary provided required performance is demonstrated.*

##### 4.2.4.1.2 Specified by procuring activity

When it is demonstrated by the contractor, that a commercial item specified by the procuring activity for use in an equipment or subsystem is responsible for failure of the equipment or subsystem to meet its contractual EMI requirements. The data indicating such failure shall be included in the Electromagnetic Interference Test Report (EMITR). No modification or replacement shall be made unless authorised by the procuring activity.

**Discussion:** *The procuring activity retains responsibility for EMI characteristics of commercial items that the procuring activity specifies to be used as part of a subsystem or equipment. The procuring activity will typically study trade-offs between the potential for system-level problems and the benefits of retaining unmodified commercial equipment. The procuring activity needs to provide specific contractual direction when modifications are considered to be necessary.*

#### 4.2.4.2 Procurement of equipment or subsystems having met other EMI requirements

Procurement of equipment and subsystems electrically and mechanically identical to those previously procured by activities of agencies, or their contractors, shall meet the EMI requirements and associated limits, as applicable in the earlier procurement, unless otherwise specified by the Command or agency concerned.

**Discussion:** *In general, the government expects configuration controls to be exercised in the manufacturing process of equipment and subsystems to ensure that produced items continue to meet the particular EMI requirements to which the design was qualified. This standard reflects the most up-to-date environments and concerns. Since the original EMI requirements may be substantially different than those in this standard, they may not be adequate to assess the suitability of the item in a*

*particular installation. This situation most often occurs for equipment susceptibility tests related to the radiated electromagnetic environment. Procuring activities need to consider imposing additional test requirements on the contractor to gather additional data to permit adequate evaluation.*

*Testing of production items has shown degraded performance of the equipment from that previously demonstrated during development. One problem area is engineering changes implemented for ease of manufacturing which are not adequately reviewed for potential effects on EMI control design measures. Specific problems have been related to treatment of cable and enclosure shields, electrical grounding and bonding, and substitution of new component parts due to obsolescence.*

#### 4.2.5 Government Furnished Equipment (GFE)

When the contractor demonstrates that a GFE is responsible for failure of an equipment or subsystem to meet its contractual EMI requirements, the data indicating such failure shall be included in the EMITR. No modification shall be made unless authorised by the procuring activity.

**Discussion:** *GFE is treated the same as commercial items specified by the procuring activity.*

#### 4.3 Verification requirements

The general requirements related to test procedures, test facilities, and equipment stated below, together with the detailed test procedures included in paragraph 5.0, shall be used to determine compliance with the applicable emission and susceptibility requirements of this standard. Any procuring activity approved exceptions or deviations from these general requirements shall be documented in the Electromagnetic Interference Test Procedures (EMITP). Equipment that are intended to be operated as a subsystem shall be tested as such to the applicable emission and susceptibility requirements whenever practical. Formal testing is not to commence without approval of the EMITP by the Command or agency concerned. Data that is gathered as a result of performing tests in one electromagnetic discipline might be sufficient to satisfy requirements in another. Therefore, to avoid unnecessary duplication, a single test program should be established with tests for similar requirements conducted concurrently whenever possible.

**Discussion:** *This portion of the document specifies general requirements that are applicable to a variety of test procedures applicable for individual emissions and susceptibility requirements. The detailed test procedures for each emissions and susceptibility requirement include procedures that are unique to that requirement. Other sources of information dealing with electromagnetic interference testing are available in industry documents such as RTCA DO-160 and SAE ARP 1972 etc.*

*Electromagnetic disciplines (EMC), electromagnetic pulse (EMP), lightning, RF compatibility, frequency allocation, etc. are integrated to differing levels in various government and contractor organisations. There is often a common base of requirements among the disciplines. It is more efficient to have unified requirements and complete and concise testing. For example, the EMC, EMP and lightning areas all pertain to electronic hardness to transients. The transient requirements in this standard should satisfy most concerns or should be adapted as necessary to do so.*

*Testing integrated equipment at the subsystem-level is advantageous because the actual electrical interfaces are in place rather than electrical load or test equipment simulations. When simulations are used, there is always doubt regarding the integrity of the simulation and questions arise whether emission and susceptibility problems are due to the equipment under test or the simulation.*

*"Contractor-generated" test procedures provide a mechanism to interpret and adapt AECTP500, as it is applicable to a particular subsystem or equipment and to detail the test agency's facilities and instrumentation and their use. It is important that the procedures are available to the procuring activity early so that the procuring activity can approve the test procedures prior to the start of testing. Agreement needs to exist between the procuring activity and the contractor on the interpretation of test requirements and procedures, thereby minimising the possible need for re-testing.*

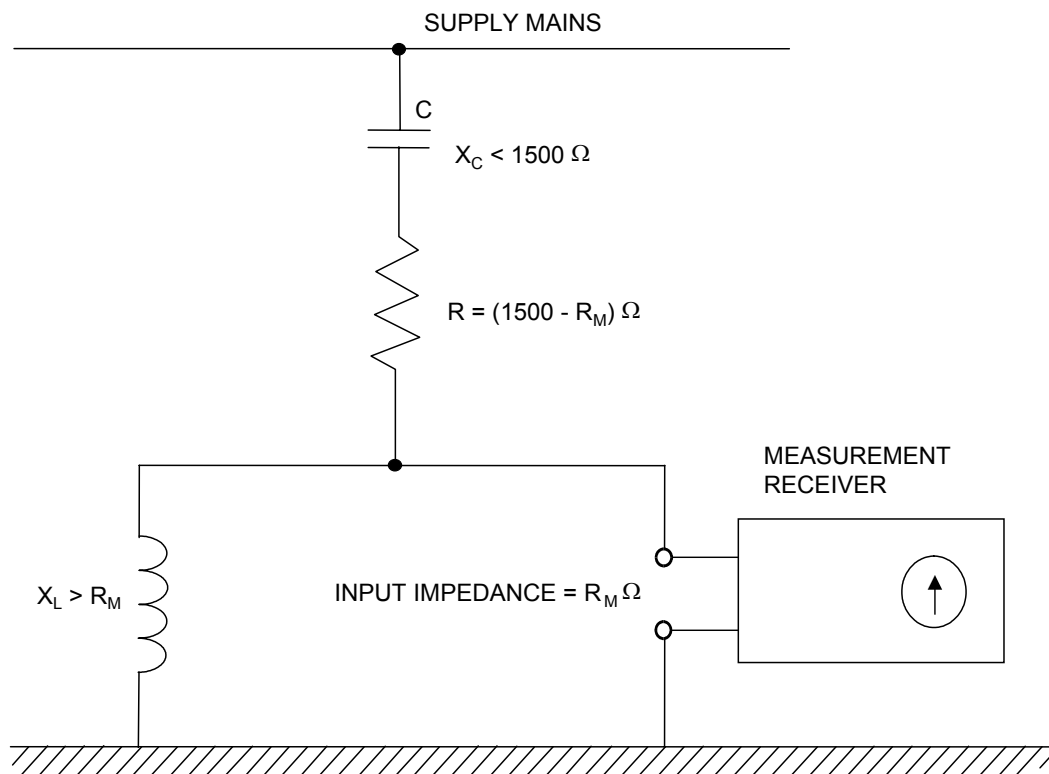
*When testing large equipment, equipment that requires special handling provision or high power equipment, deviations from the standard testing procedures may be required. Large equipment may not fit through the typical shielded room door or may be so heavy that it would crush the floor. Other equipment has large movable arms or turrets or equipment that requires special heating or cooling facilities. This equipment may have to be tested at the manufacturer's facilities or at the final installation. The following examples are for guidance. Sound engineering practices should be used and explained in detail in the EMITP when deviating from the standard test procedures due to EUT characteristics. The design of the tests is of primary importance and the data recorded during the testing must reflect the final installation characteristics as closely as possible.*

*For equipment which requires high input current (for example: > 200 A), commercial LISNs may not be available. For NCE02, the "voltage probe" called out in ANSI C63.4 may be substituted. The construction of the probe is shown in Figure 1. A direct connection to the power lines is required and care must be taken to establish a reference ground for the measurements. It may be necessary to perform repeated measurements over a suitable period of time to determine the variation in the power line impedance and the impact on the measured emissions from the EUT.*

*The measurements are made between each current-carrying conductor in the supply mains and the ground conductor with a blocking capacitor C and resistor R, as shown in Figure 1, so that the total resistance between the line under test and ground is 1500  $\Omega$ . The probe attenuates the voltage so calibration factors are required. The measurement point (probe's position on the cables) must be identified in all test set-ups.*

*When equipment is too large or requires special provisions (loads, drives, water, emission of toxic fumes and such), testing in a typical anechoic room may not be feasible. Temporary screen rooms consisting of RF absorbant cloth can be built around the test area to reduce the ambient for radiated emission testing and to contain the RF field during radiated susceptibility testing. Since the room may be highly reflective, care must be taken to identify any resonances. Several antenna positions may be required in order to reduce the effect of the resonances.*

*Equipment, which produces high power RF output, may be required to be tested on an open area test site. Additionally, equipment that needs to have a communication link to the outside world must be tested in the open. Government approval may be required in order to generate the RF fields for the NRS02 test requirement. If the communication link can be simulated, then the test can be performed in a shielded room. In this case, special dummy loads may be required, since the high power RF radiation could damage the anechoic material due to heating.*



**FIGURE 1 Voltage probe for tests at user's installation.**

Imposition of EMI requirements on large equipment has become essential to prevent EMI problems. Therefore, EMI requirements should not be waived simply because of special handling problems or equipment size. Typical equipment and subsystems for which these special provisions have been applied are as follows:

- Air handling units (heating, ventilating, and air conditioning)
- Large uninterruptible power supplies (UPS)
- Equipment vans/motorised vehicles
- Desalination units
- Large motors/generators/drives/power distribution systems
- Large radars
- Rail guns and their power sources
- Catapults and their power sources
- Multiple console subsystems

#### 4.3.1 Measurement tolerances

Unless otherwise stated for a particular measurement, the tolerance shall be as follows:

- a. Distance:  $\pm 5\%$
- b. Frequency:  $\pm 2\%$
- c. Amplitude, measurement receiver:  $\pm 2$  dB
- d. Amplitude, measurement system (includes measurement receivers, transducers, cables, and so forth):  $\pm 3$  dB
- e. Time (waveforms):  $\pm 5\%$
- f. Resistors:  $\pm 5\%$
- e. Capacitors:  $\pm 20\%$

**Discussion:** *Tolerances are necessary to maintain controls for obtaining consistent measurements.*

#### 4.3.2 Shielded enclosures

To prevent interaction between the EUT and the outside environment, shielded enclosures will usually be required for testing. These enclosures prevent external environment signals from contaminating emission measurements and susceptibility test signals from interfering with electrical and electronic items in the vicinity of the test facility. Shielded enclosures must have adequate attenuation such that the ambient requirements of paragraph 4.3.4 are satisfied. The enclosures must be sufficiently large such that the EUT arrangement requirements of paragraph 4.3.8 and antenna positioning requirements described in the individual test procedures are satisfied.

**Discussion:** *Potential accuracy problems introduced by shielded enclosure resonances are well documented and recognised; however, shielded enclosures are usually a necessity for testing of military equipment to the requirements of this standard. Most test agencies are at locations where ambient levels outside of the enclosures are significantly above the limits in this standard and would interfere with the ability to obtain meaningful data.*

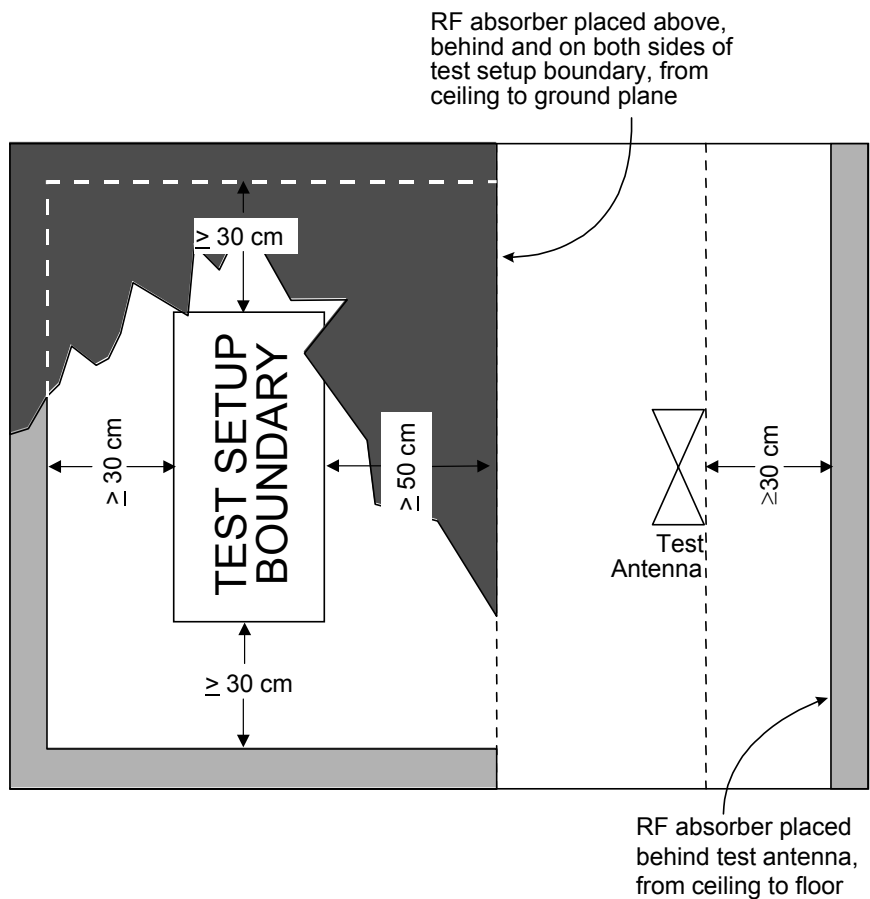
*Electrical interfaces with military equipment are often complex and require sophisticated test equipment to simulate and evaluate the interface. This equipment usually must be located outside of the shielded enclosure to achieve sufficient isolation and prevent it from contaminating the ambient and responding to susceptibility signals.*

*The shielded enclosure also prevents radiation of applied susceptibility signals from interfering with local antenna-connected receivers. The most obvious potential offender is the NRS02 test. However, other susceptibility tests can result in substantial radiated energy that may violate Government rules.*

##### 4.3.2.1 Radio Frequency (RF) absorber material

RF absorber material (carbon impregnated foam pyramids, ferrite tiles, and so forth) shall be used when performing electric field radiated emissions or radiated susceptibility testing inside a shielded enclosure (except for mode stir testing) to reduce reflections of electromagnetic energy and to improve accuracy and repeatability. The RF absorber shall be placed above, behind, and on both sides of the EUT, and behind the radiating or receiving antenna as shown in Figure 2. Minimum performance of the material shall be as specified in Table 1. The manufacturer's certification of their RF absorber material (basic material only, not installed) is acceptable.

**DISCUSSION:** *Accuracy problems with making measurements in untreated shielded enclosures due to reflections of electromagnetic energy have been widely recognised and documented. The values of RF absorption required by Table 1 are considered to be sufficient to substantially improve the integrity of the measurements without unduly impacting test facilities. The minimum placement provisions for the material are specified to handle the predominant reflections. The use of additional material is desirable, where possible. It is intended that the values in Table 1 can be met with available ferrite tile material or standard 0.6 metres (24 inch) pyramidal absorber material.*



**FIGURE 2 RF Absorber loading diagram**

Frequency	Minimum absorption
80 MHz - 250 MHz	6 dB
Above 250 MHz up to highest frequency of test	10 dB

**TABLE 1 Absorption at normal incidence**

#### 4.3.3 Other test sites

If other test sites are used, the ambient requirements of paragraph 4.3.4 shall be met.

**Discussion:** *For certain types of EUTs, testing in a shielded enclosure may not be practical. Examples are EUTs which are extremely large, require high electrical power levels or motor drives to function, emit toxic fumes, or are too heavy for normal floor loading (see the discussion section of paragraph 4.3 for additional information). There is a serious concern with ambient levels contaminating data when testing is performed outside of a shielded enclosure. Therefore, special attention is given to this testing under paragraph 4.3.4, "Ambient electromagnetic level." All cases where testing is performed outside a shielded enclosure shall be justified in detail in the EMITP, including typical profiles of expected ambient levels.*

*If it is necessary to operate EUTs that include RF transmitters outside of a shielded enclosure, spectrum certification and a frequency assignment must first be obtained through the spectrum management process.*

*An option in emission testing is the use of an open area test site (OATS) in accordance with ANSI C63.4. These sites are specifically designed to enhance accuracy and repeatability. Due to differences between ANSI C63.4 and this standard in areas such as antenna selection, measurement distances, and specified frequency ranges, the EMITP shall detail the techniques for using the OATS and relating the test results to the requirements of this standard.*

#### 4.3.4 Ambient electromagnetic level

During testing, the ambient electromagnetic level measured with the EUT de-energised and all auxiliary equipment turned on shall be at least 6 dB below the allowable specified limits when the tests are performed in a shielded enclosure. Ambient conducted levels on power leads shall be measured with the leads disconnected from the EUT and connected to a resistive load, which draws the same rated current as the EUT. When tests are performed in a shielded enclosure and the EUT is in at least 6dB below required limits, the ambient profile need not be recorded in the Electromagnetic Interference Test Report (EMITR). When measurements are made outside a shielded enclosure, the tests shall be performed during times and conditions when the ambient is at its lowest level. The ambient shall be recorded in the EMITR and shall not compromise the test results.

**Discussion:** *Controlling ambient levels are critical to maintaining the integrity of the gathered data. High ambients present difficulties distinguishing between EUT emissions and ambient levels. Even when specific signals are known to be ambient related, they may mask EUT emissions that are above the limits of this standard.*

*The requirement that the ambient be at least 6 dB below the limit ensures that the combination of the EUT emissions and ambient does not unduly affect the indicated magnitude of the emission. If a sinusoidal noise signal is at the limit and the ambient is 6 dB below the limit, the indicated level should be approximately 3 dB above the limit. Similarly, if the ambient were allowed to be equal to the limit for the same true emission level, the indicated level would be approximately 5 dB above the limit.*

*A resistive load is specified to be used for conducted ambients on power leads. However, under certain conditions actual ambient levels may be higher than indicated with a resistive load. The most likely reason is the presence of capacitance at the power interface of the EUT that will lower the input impedance at higher frequencies and increase the current. This capacitance should be determined and ambient measurements repeated with the capacitance in place. There is also the possibility of resonance conditions with shielded room filtering, EUT filtering, and powerline inductance. These types of conditions may need to be investigated if unexpected emission levels are observed.*

*Testing outside of a shielded enclosure often must be performed at night to minimise influences of the ambient. A prevalent problem with the ambient is that it continuously changes with time as various emitters are turned on and off and as amplitudes fluctuate. A useful tool for improving the flow of testing is to thoroughly analyse the EUT circuitry prior to testing and identify frequencies where emissions may be expected to be present.*

*An option to improve overall measurement accuracy is to make preliminary measurements inside a shielded enclosure and accurately determine frequencies where emissions are present. Testing can be continued outside the shielded enclosure with measurements being repeated at the selected frequencies. The 6 dB margin between the ambient and limits must then be observed only at the selected frequencies.*

#### 4.3.5 Ground plane

The EUT shall be installed on a ground plane that simulates the actual installation. If the actual installation is unknown or multiple installations are expected, then a metallic ground plane shall be used. Unless otherwise specified below, ground planes shall be 2.25 square metres or larger in area with the smaller side no less than 76 centimetres. When a ground plane is not present in the EUT installation, the EUT shall be placed on a non-conductive table.

**Discussion:** *Generally, the radiated emissions and radiated susceptibilities of equipment are due to coupling from and to the interconnecting cables and not via the case of the EUT. Emissions and susceptibility levels are directly related to the placement of the cable with respect to the ground plane and to the electrical conductivity of the ground plane. Thus, the ground plane plays an important role in obtaining the most realistic test results.*

*When the EUT is too large to be installed on a conventional ground plane on a bench, the actual installation should be duplicated. For example, a large radar antenna may need to be installed on a test stand and the test stand bonded to the floor of the shielded enclosure. Ground planes need to be placed on the floor of shielded rooms with floor surfaces such as tiles that are not electrically conductive.*

*The use of ground planes is also applicable for testing outside of a shielded enclosure. These ground planes will need to be referenced to earth as necessary to meet the electrical safety requirements of the National Electrical Code. Where possible, these ground planes should be electrically bonded to other accessible grounded reference surfaces such as the outside structure of a shielded enclosure.*

*The minimum dimensions for a ground plane of 2.25 square metre with 76 centimetres on the smallest side will be adequate only for set-ups involving a limited number of EUT enclosures with few electrical interfaces. The ground plane must be large enough to allow for the requirements included in paragraph 4.3.8 on positioning and arrangement of the EUT and associated cables to be met.*

##### 4.3.5.1 Metallic ground plane

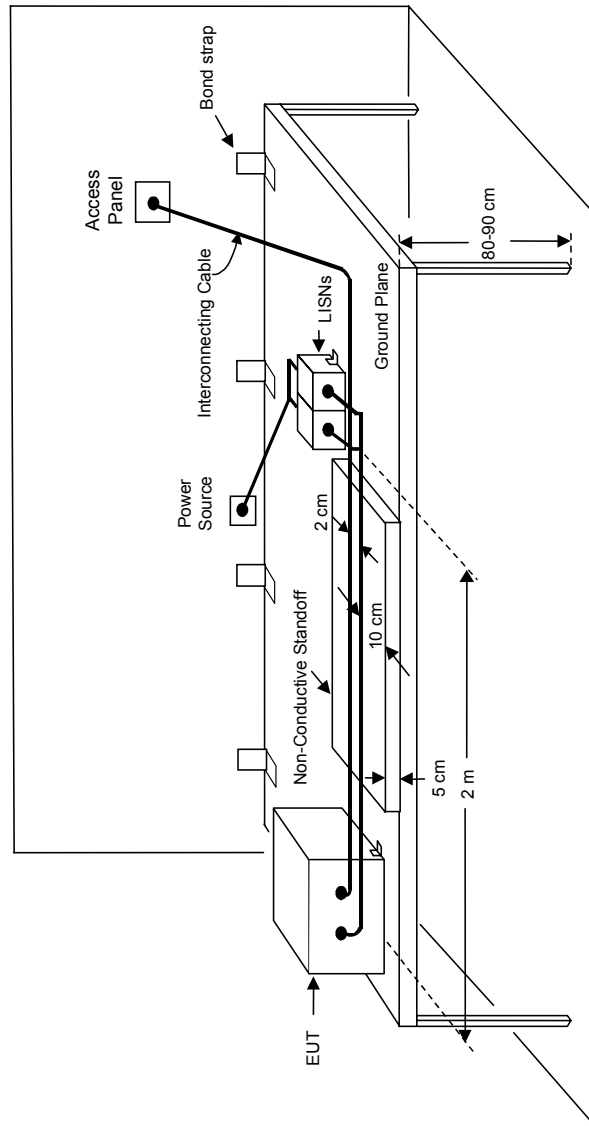
When the EUT is installed on a metallic ground plane, the ground plane shall have a surface resistivity no greater than 0.1 m $\Omega$  per square. The DC resistance between metallic ground planes and the shielded enclosure shall be 2.5 m $\Omega$  or less. The metallic ground planes shown in Figures 3 through to 6 shall be electrically bonded to the floor or wall of the basic shielded room structure at least once every 1 metre. The metallic bond straps shall be solid and maintain a five-to-one ratio or less in length to width. Metallic ground planes used outside a shielded enclosure shall extend at least 1.5 metres beyond the test set-up boundary in each direction.

**Discussion:** *For the metallic ground plane, a copper ground plane with a thickness of 0.25 millimetres has been commonly used and satisfies the surface resistance requirements. Other metallic materials of the proper size and thickness needed to achieve the resistivity can be substituted.*

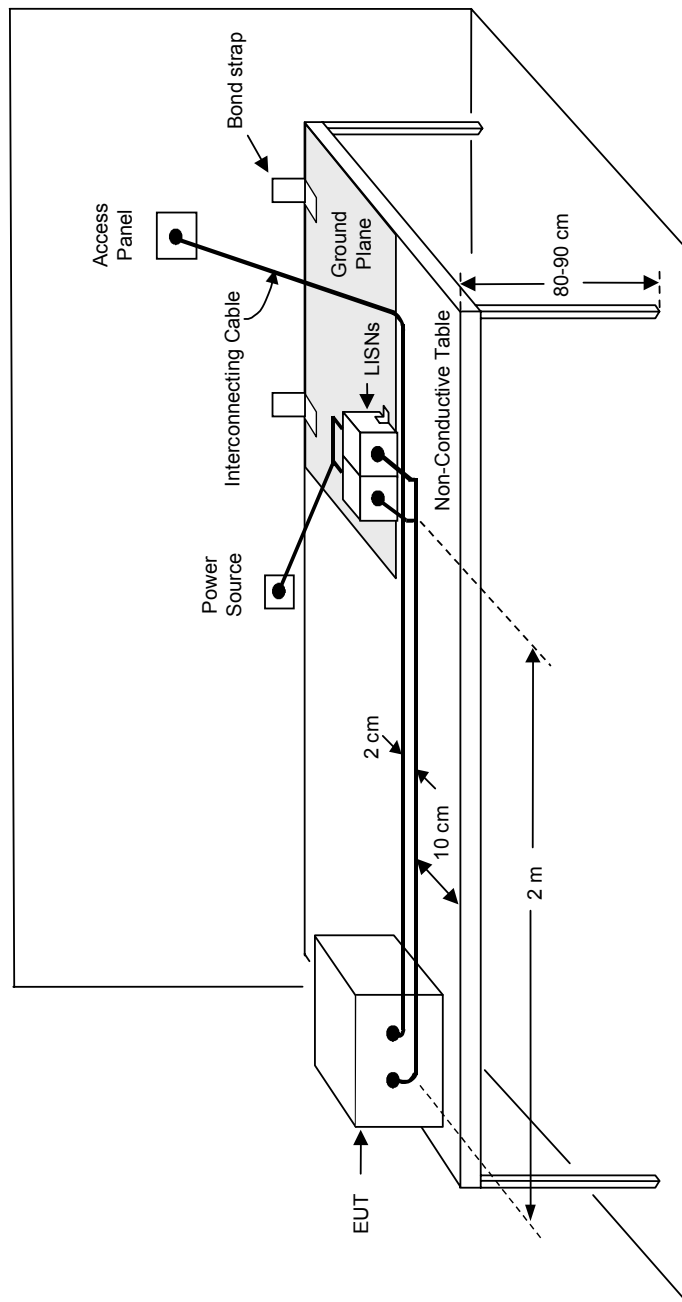
*For metallic ground planes, the surface resistivity can be calculated by dividing the bulk resistivity by the thickness. For example, copper has a bulk resistivity of  $1.75 \times 10^{-8}$   $\Omega$ -metres. For a ground plane 0.25 millimetre thick as noted above, the surface resistance is:*

$$\begin{aligned} 1.7 \times 10^{-8} / 2.5 \times 10^{-4} &= 6.8 \times 10^{-5} \text{ } \Omega\text{s per square} \\ &= 0.068 \text{ m}\Omega\text{s per square} \end{aligned}$$

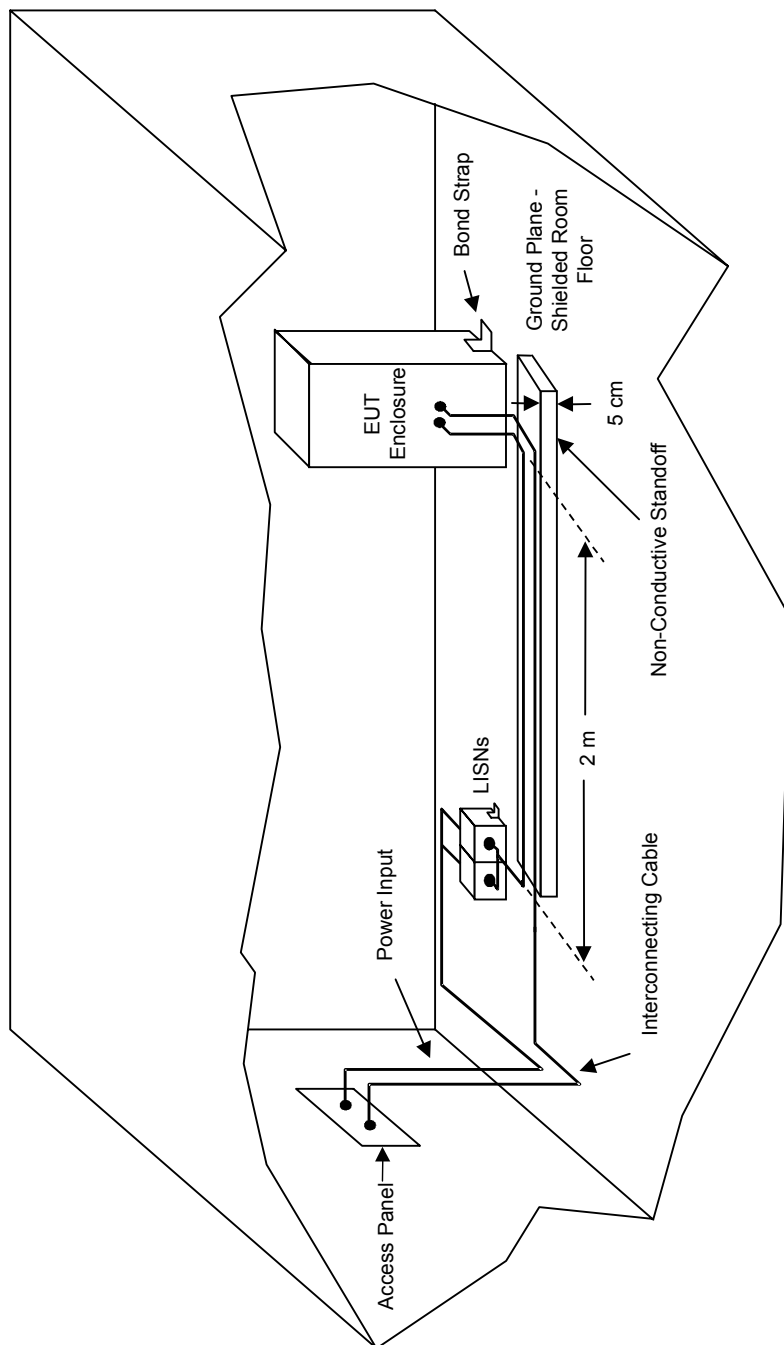
*The requirement is 0.1 m $\Omega$ s per square*



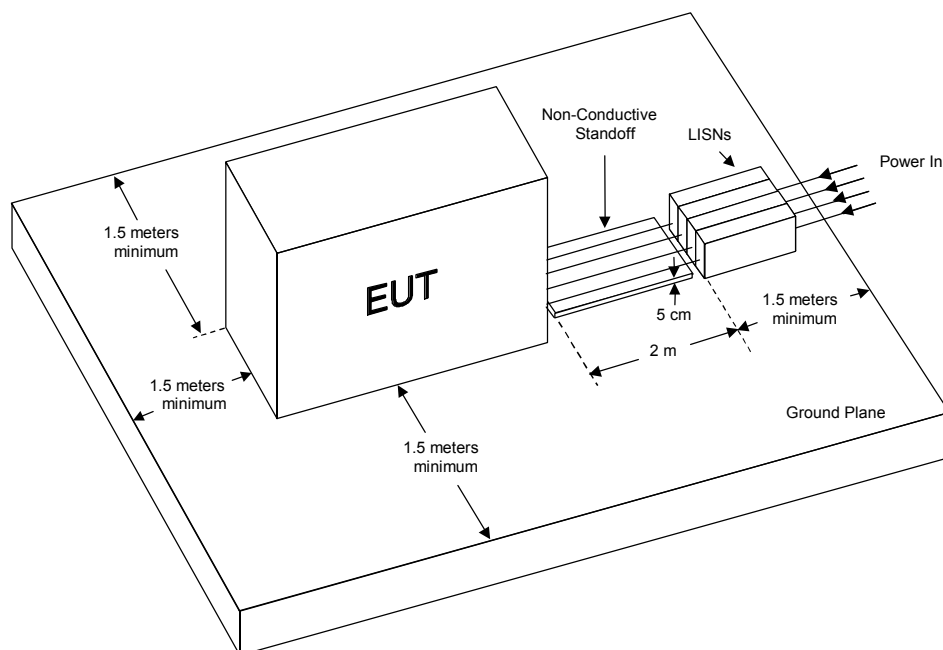
**FIGURE 3** Test set-up for conductive surface mounted EUT



**FIGURE 4** Test set-up for non-conductive surface mounted EUT



**FIGURE 5** Test set-up for free standing EUT in shielded enclosure



**FIGURE 6 Test set-up for free standing EUT**

#### 4.3.5.2 Composite ground plane.

When the EUT is installed on a conductive composite ground plane, the surface resistivity of the typical installation shall be used. Composite ground planes shall be electrically bonded to the enclosure with means suitable to the material.

**Discussion:** A copper ground plane has typically been used for all testing in the past. For most instances, this has been adequate. However, with the increasing use of composites, the appropriate ground plane will play a bigger role in the test results. Limited testing on both copper and conductive composite ground planes has shown some differences in electromagnetic coupling test results, thus the need exists to duplicate the actual installation, if possible. In some cases, it may be necessary to include several ground planes in the same test set-up if different units of the same EUT are installed on different materials in the installation.

With the numerous different composite materials being used in installations, it is not possible to specify a general resistivity value. The typical resistivity of carbon composite is about 2000 times that of aluminium. The actual resistivity needs to be obtained from the installation contractor and used for testing.

#### 4.3.6 Power source impedance

The impedance of power sources providing input power to the EUT shall be controlled by Line Impedance Stabilisation Networks (LISNs) for all measurement procedures of this document unless otherwise stated in a particular test procedure. LISNs shall not be used on output power leads. The LISNs shall be located at the power source end of the exposed length of power leads specified in paragraph 4.3.8.6.2. The LISN circuits shall be in accordance with the schematic shown in Figures 7 and 8. The LISN impedance characteristics shall be in accordance with Figures 9 and 10. The LISN impedance shall be measured at least annually under the following conditions:

- a. The impedance shall be measured between the power output lead on the load side of the LISN and the metal enclosure of the LISN.

- b. The signal output port of the LISN shall be terminated in 50  $\Omega$ .
- c. The power input terminal on the power source side of the LISN shall be unterminated.

The impedance measurement results shall be provided in the EMITR.

**Discussion:** *The impedance is standardised to represent expected impedances in actual installations and to ensure consistent results between different test agencies. The intent of these devices was to determine the current generator portion of a Norton current source model. If the impedance of the interference source was also known, the interference potential of the source could be analytically determined for particular circumstances in the installation. A requirement was never established for measuring the impedance portion of the source model. More importantly, concerns arose over the test configuration influencing the design of powerline filtering. Optimised filters are designed based on knowledge of both source and load impedances. Significantly different filter designs will result for the 10  $\mu\text{F}$  capacitor loading versus the impedance loading shown in Figure 9.*

*LISNs are not used on output power leads. Emission measurements using LISNs are performed on input power leads because the EUT is using a power source common to many other equipment items and the EUT must not degrade the quality of the power. When the EUT is the source of power, the issue is completely different since the electrical characteristics of the power required are controlled by the defined power quality requirements. Output power leads should be terminated with appropriate electrical loading that produces potentially worst-case emission and susceptibility characteristics.*

*The particular configuration of the LISN is specified for several reasons. A number of experiments were performed to evaluate typical power line impedances present in a shielded room on various power input types both with and without power line filters and to assess the possible methods of controlling the impedance. An approach was considered for the standard to simply specify an impedance curve from 30 Hz to 100 MHz. This would have allowed the test agency to meet the impedance using whatever means the agency found suitable. The experiments showed that there were no straightforward techniques to maintain desired controls over the entire frequency range.*

*A specific 50  $\mu\text{H}$  LISN (see ANSI C63.4) was selected to maintain a standardised control on the impedance as low as 10 kHz. 5  $\mu\text{H}$  LISNs used commonly in the past provide little control below 100 kHz, however where extended frequency range testing is required above 10 MHz these will still be used due to the instability of the 50  $\mu\text{H}$  LISN at higher frequencies see Figures 8 and 10. Impedance control below 10 kHz is difficult. From evaluations of several 50  $\mu\text{H}$  LISN configurations, the one specified demonstrated the best overall performance for various shielded rooms filtering variations. Near 10 kHz, the reactance's of the 50  $\mu\text{H}$  inductor and 8  $\mu\text{F}$  capacitor cancel and the LISN is effectively a 5  $\Omega$  resistive load across the power line.*

*Using a common LISN is important for standardisation reasons. However, the use of alternative LISNs may be desirable in certain application where the characteristics of the LISN may not be representative of the actual installation and the design of EUT circuitry is being adversely affected. For example, there are issues with switching power supply stability and the power source impedance seen by the power supply. The 50  $\mu\text{H}$  inductor in the LISN represents the inductance of power distribution wiring running for approximately 50 metres. For a large platform, such as a ship or cargo aircraft, this value is quite representative of the actual installation. However, for smaller platforms such as fighter aircraft, inductance values may be substantially lower than 50  $\mu\text{H}$ s and hence the 5  $\mu\text{H}$  LISN may be more appropriate*

*Caution needs to be exercised in using the 50  $\mu\text{H}$  LISN for 400 Hz power systems. Some existing LISNs may not have components sufficient to handle the power dissipation requirements. At 115 volts, 400 Hz, the 8  $\mu\text{F}$  capacitor and 5  $\Omega$  resistor will pass approximately 2.3 amperes, which results in 26.5 watts being dissipated in the resistor.*

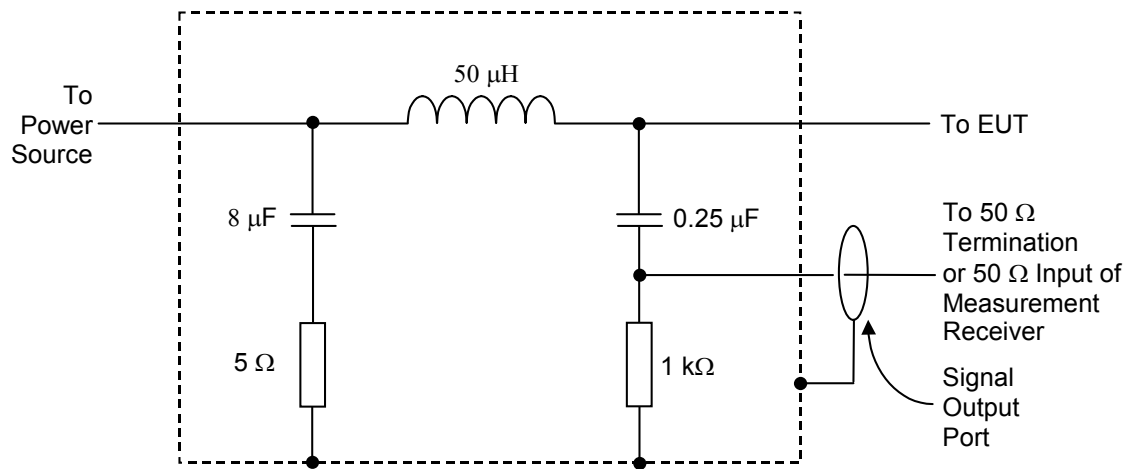
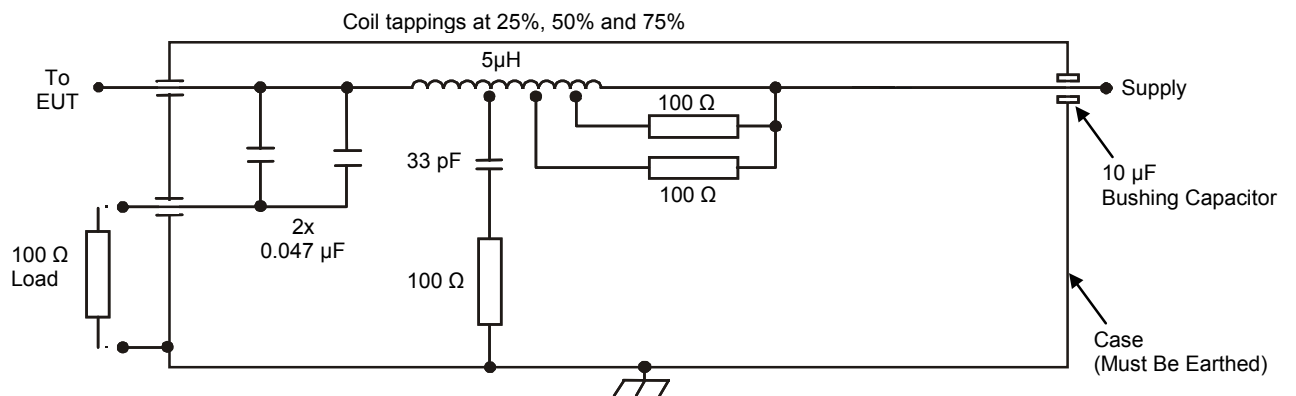
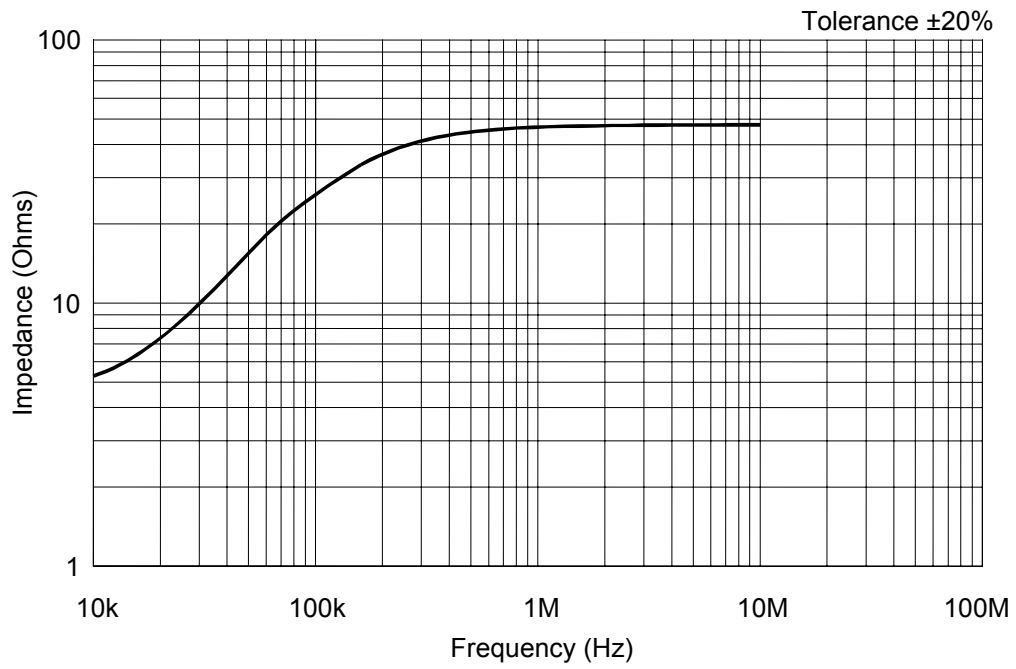


FIGURE 7 50 μH LISN schematic

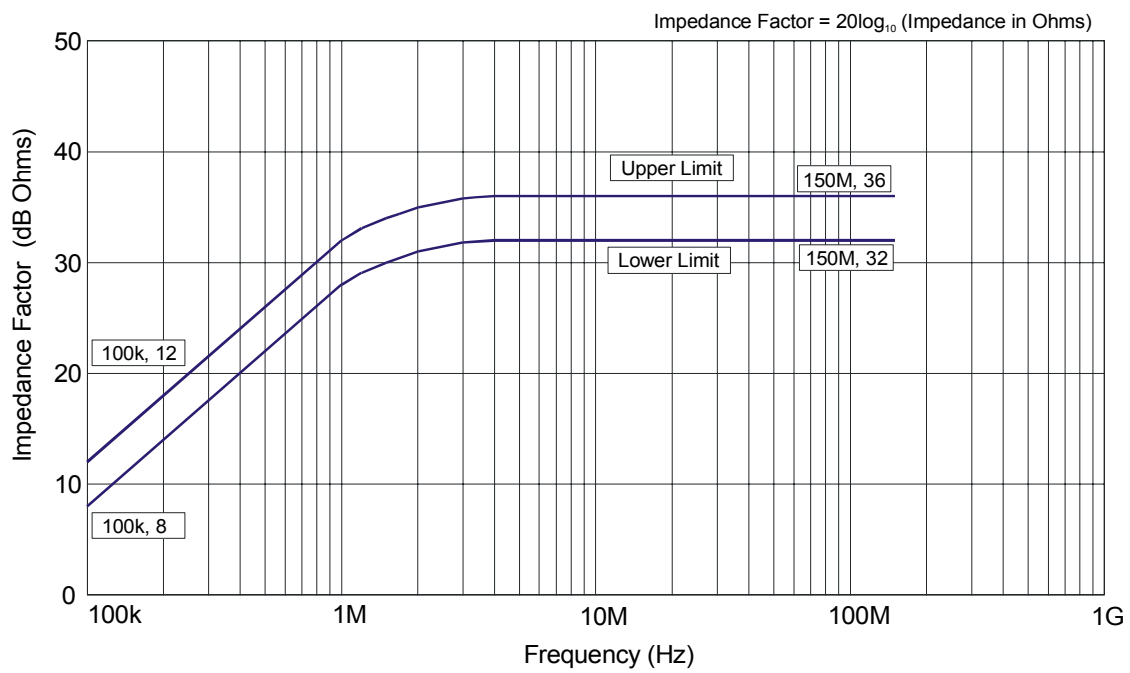


Note: Rating for 100 Ω resistors is 2 Watt.

FIGURE 8 5 μH LISN schematic



**FIGURE 9 50 μH LISN Impedance**



**FIGURE 10 5 μH LISN Impedance**

#### 4.3.7 General test precautions

**Discussion:** *The requirements included here cover important areas related to improving test integrity and safety that need special attention. There are many other areas where test difficulties may develop. Some are described below.*

*It is common for shields to become loose or broken at connectors on coaxial cables resulting in incorrect readings. There also are cases where centre conductors of coaxial cables break or separate. Periodic tests should be performed to ensure cable integrity. Special low loss cables may be required when testing at higher frequencies. Cables should also be verified for correct operation over the required frequency range of measurement. The resulting attenuation of those cables should be taken into account.*

*Caution needs to be exercised when performing emission testing at frequencies below approximately 10 kHz to avoid ground loops in the instrumentation, which may introduce faulty readings. A single-point ground often needs to be maintained. It is usually necessary to use isolation transformers at the measurement receiver and accessory equipment. The single-point ground is normally established at the access (feedthrough) panel for the shielded enclosure. However, if a transducer is being used which requires an electrical bond to the enclosure (such as the rod antenna counterpoise), the coaxial cable will need to be routed through the enclosure access panel without being grounded. Since the shielded room integrity will then be compromised, a normal multiple point grounded set-up needs to be re-established as low in frequency as possible.*

*Rather than routing the coaxial cable through the enclosure access panel without grounding it to the enclosure, a 50  $\Omega$  video isolation transformer may be connected to the grounded RF connector at the access panel inside the room. Normal connection of the measuring receiver is made to the grounded connector at the panel outside the room. This technique effectively breaks the ground loop without sacrificing the room's shielding integrity. The losses of the video isolation transformer must be accounted for in the measurement data. These devices are typically useful up to approximately 10 MHz.*

*If isolation transformers are found to be necessary in certain set-ups, problems may exist with items powered by switching power supplies. A solution is to use transformers that are rated at approximately five times the current rating of the item.*

*Solid-state instrumentation power sources have been found to be susceptible to radiated fields even to the extent of being shut down. It is best to keep these items outside of the shielded enclosure.*

##### 4.3.7.1 Accessory equipment

Accessory equipment used in conjunction with measurement receivers shall not degrade measurement integrity.

**Discussion:** *Measurement receivers are generally designed to meet the limits of this standard so they do not contaminate the ambient for emission testing when they are used inside the shielded enclosure. However, accessory equipment such as computers, oscilloscopes, plotters, or other instruments used to control the receiver or monitor its outputs can cause problems. They may compromise the integrity of the receiver by radiating signals conducted out of the receiver from improperly treated electrical interfaces or may produce interference themselves and raise the ambient. Even passive devices such as headsets have been known to impact the test results.*

*It is best to locate all of the test equipment outside of the shielded enclosure with the obvious exception of the transducer (antenna or current probe). Proper equipment location will ensure that the emissions being measured are being generated in the EUT only and will help ensure that the ambient requirements of paragraph 4.3.4 are met. If the equipment must be used inside the enclosure or if testing is being conducted outside of an enclosure, the measurement receiver and accessory equipment should be located as far away from the transducers as practical to minimise any impact.*

#### 4.3.7.2 Excess personnel and equipment

The test area shall be kept free of unnecessary personnel, equipment, cable racks, and desks. Only the equipment essential to the test being performed shall be in the test area or enclosure. Only personnel actively involved in the test shall be permitted in the enclosure.

**Discussion:** *Excess personnel and both electronic and mechanical equipment such as desks or cable racks in the enclosure can affect the test results. During radiated emission testing in particular, all nonessential personnel and equipment need to be removed from the test site. Any object in the enclosure can significantly influence or introduce standing waves in the enclosure and thus alter the test results. The requirement to use RF absorber material will help to mitigate these effects. However, material performance is not defined below 80 MHz for practical reasons and standing waves continue to be a concern.*

#### 4.3.7.3 Overload precautions

Measurement receivers and transducers are subject to overload, especially receivers without preselectors and active transducers. Periodic checks shall be performed to assure that an overload condition does not exist. Instrumentation changes shall be implemented to correct any overload condition.

**Discussion:** *Overloads can easily go unnoticed if there is not an awareness of the possibility of an overload or active monitoring for the condition. The usual result is a levelling of the output indication of the receiver.*

*Two types of overloads are possible. A narrowband signal such as a sinusoid can saturate any receiver or active transducer. Typical procedures for selecting attenuation settings for measurement receivers place detected voltages corresponding to emission limits well within the dynamic range of the receiver. Saturation problems for narrowband type signals will normally only appear for a properly configured receiver if emissions are significantly above the limits. Saturation can occur more readily when receivers are used to monitor susceptibility signals due to the larger voltages involved.*

*Overload from impulsive type signals with broad frequency content can be much more deceptive. This condition is most likely to occur with devices without a tuneable bandpass feature in the first stage of the signal input. Examples are preamplified rod antennas and spectrum analysers without preselectors. The input circuitry is exposed to energy over a large portion of the frequency spectrum. Preselectors include a tuneable tracking filter which bandwidth limits the energy applied to the receiver front-end circuitry.*

*Measurement receiver overload to both narrowband and impulsive type signals can be evaluated by applying 10 dB additional attenuation in the first stage of the receiver (before mixer circuitry) or external to the receiver. If overload is not present, the observed output will uniformly decrease by 10 dB.*

*Overload conditions for active antennas are normally published as part of the literature supplied with the antenna. For narrowband signals, the indicated level in the data can be reviewed with respect to the literature to evaluate overload. Levels are also published for impulsive type signals; however, these levels are not very useful since they usually assume that a flat field exists across the useable range of the antenna. In reality, the impulsive field will vary significantly with frequency and the antenna circuitry sees the integration of the spectral content of this field over its bandpass. The primary active antenna used is an active rod antenna. Overload can be evaluated by collapsing the rod and observing the change in indication. If overload is not present, the indicated level should drop approximately 8 dB (rod at 30% of its original height). The actual change for any particular manufacturer's product will depend on the telescoping design and can be determined by radiating a signal to the antenna that is within its linear range.*

#### 4.3.7.4 RF hazards

Some tests in this standard will result in electromagnetic fields that are potentially dangerous to personnel. The permissible exposure levels shall not be exceeded in areas where personnel are present. Safety procedures and devices shall be used to prevent accidental exposure of personnel to RF hazards.

**Discussion:** *During some radiated susceptibility and radiated emission testing, NRS02, NRS03 and NRE03 in particular, fields may exceed the permissible exposure levels. During these tests, precautions must be implemented to avoid inadvertent exposure of personnel. Monitoring of the EUT during testing may require special techniques such as remotely connected displays external to the enclosure or closed circuit television to adequately protect personnel.*

#### 4.3.7.5 Shock hazard

Some of the tests require potentially hazardous voltages to be present. Extreme caution must be taken by all personnel to assure that all safety precautions are observed.

**Discussion:** *A safety plan and training of test personnel are normally required to assure that accidents are minimised. Test equipment manufacturers' precautions need to be followed, if specified. If these are not available, the test laboratory should establish adequate safety precautions and train all test personnel. Special attention should be observed for NCS06 since electronic enclosures are intentionally isolated from the ground plane for test purposes.*

#### 4.3.7.6 Transmission restrictions

Some of the tests require high level signals to be generated that could interfere with normal transmission approved frequency assignments. All such testing should be conducted in a shielded enclosure. Some open site testing may be feasible if prior co-ordination is accomplished with the appropriate authorities.

**Discussion:** *Radiated susceptibility NRS02 testing and possibly other tests will produce signals above authorisations. This situation is one of the reasons that shielded enclosures are normally required.*

#### 4.3.8 EUT test configurations

The EUT shall be configured as shown in the general test set-ups of Figures 2 through to 6 as applicable. These set-ups shall be maintained during all testing unless other direction is given for a particular test procedure.

**Discussion:** *Emphasis is placed on "maintaining" the specified set-up for all testing unless a particular test procedure directs otherwise.*

##### 4.3.8.1 EUT design status

EUT hardware and software shall be representative of production. Software may be supplemented with additional code that provides diagnostic capability to assess performance.

**Discussion:** *It is important that the hardware and software being tested is the same as the equipment that is being fielded. Sometimes equipment is tested which is pre-production and contains circuit boards that do not include the final layout or software that is not the final version. Questions inevitably arise concerning the effects of the differences between the tested equipment and production configurations on the qualification status of the equipment. Analytically determining the impact is usually difficult.*

##### 4.3.8.2 Bonding of EUT

Only the provisions included in the design of the EUT shall be used to bond units such as equipment case and mounting bases together, or to the ground plane. When bonding straps are required, they shall be identical to those specified in the installation drawings.

**Discussion:** *Electrical bonding provisions for equipment are an important aspect of platform installation design. Adequacy of bonding is usually one of the first areas reviewed when platform problems develop. Electrical bonding controls common mode voltages that develop between the equipment enclosures and the ground plane. Voltages potentially affecting the equipment will appear across the bonding interface when RF stresses are applied during susceptibility testing. Voltages will also develop due to internal circuit operation and will contribute to radiated emission profiles. Therefore, it is important that the test set-up use actual bonding provisions so that test results are representative of the intended installation.*

#### 4.3.8.3 Shock and vibration isolators

EUTs shall be secured to mounting bases having shock or vibration isolators if such mounting bases are used in the installation. The bonding straps furnished with the mounting base shall be connected to the ground plane. When mounting bases do not have bonding straps, bonding straps shall not be used in the test set-up.

**Discussion:** *Including shock and vibration isolators in the set-up when they represent the platform installation is important. The discussion above for paragraph 4.3.8.2 is also applicable to shock and vibration isolators; however, the potential effect on test results is even greater. Hard mounting of the equipment enclosures to the ground plane can produce a low impedance path across the bonding interface over most of the frequency range of interest. The bonding straps associated with isolators will typically represent significant impedances at frequencies as low as tens of kilohertz. The common mode voltages associated with these impedances will generally be greater than the hard mounted situation. Therefore, the influence on test results can be substantial.*

#### 4.3.8.4 Safety grounds

When external terminals, connector pins, or equipment grounding conductors are available for safety ground connections and are used in the actual installation, they shall be connected to the ground plane. Arrangement and length shall be in accordance with paragraph 4.3.8.6.1. Shorter lengths shall be used if they are specified in the installation instructions.

**Discussion:** *Safety grounds used in equipment enclosures have been the source of problems during EMI testing. Since they are connected to the equipment enclosure, they would be expected to be at a very low potential with respect to the ground plane and a non-contributor to test results. However, the wire lengths within enclosures are often sufficiently long that coupling to them results from noisy circuits. Also, safety grounds can conduct induced signals from external sources and reradiate within the equipment enclosure. Therefore, they must be treated similarly to other wiring.*

#### 4.3.8.5 Orientation of EUTs

EUTs shall be oriented such that surfaces, which produce maximum radiated emissions and respond most readily to radiated signals face the measurement antennas. Bench mounted EUTs shall be located  $10 \pm 2$  centimetres from the front edge of the ground plane subject to allowances for providing adequate room for cable arrangement as specified below.

**Discussion:** *Determination of appropriate surfaces is usually straightforward. Seams on enclosures that have metal-to-metal contact or contain EMI gaskets rarely contribute and should be considered low priority items. Prime candidates are displays such as video screens, ventilation openings, and cable penetrations. In some cases, it may be necessary to probe the surfaces with a sensor and measurement receiver to decide on EUT orientation.*

*Previous national military standards specifically required probing with a loop antenna to determine localised areas producing maximum emissions or susceptibility for radiated electric field testing. The test antennas were to be placed 1 metre from the identified areas. The requirement was not included in this standard due to difficulties in applying the requirement and the result that probing was often not performed. Probing implies both scanning in frequency and physical movement of the probe. These two actions cannot be performed in a manner to cover all physical locations at all frequencies. A*

*complete frequency scan can be performed at particular probe locations and movement of the probe over the entire test set-up can be performed at particular frequencies. The detailed requirements on the use of multiple antenna positions and specific requirements on the placement of the antennas in test procedures for NRE02 and NRS02 minimise concerns with the need to probe.*

#### 4.3.8.6 Construction and arrangement of EUT cables

Electrical cable assemblies shall simulate actual installation and usage. Shielded cables or shielded leads (including power leads and wire grounds) within cables shall be used only if they have been specified in installation requirements. Cables shall be checked against installation requirements to verify proper construction techniques such as use of twisted pairs, shielding, and shield terminations. Details on the cable construction used for testing shall be included in the EMITP.

**Discussion:** *For most EUTs, electrical interface requirements are covered in interface control or similar documents. Co-ordination between equipment manufacturers and system integration organisations is necessary to ensure a compatible installation from both functional and electromagnetic interference standpoints. For general purpose EUTs, which may be used in many different installations, either the equipment specifications cover the interface requirements or the manufacturers publish recommendations in the documentation associated with the equipment.*

*Equipment manufacturers sometimes contend that failures during EMI testing are not due to their equipment and can be cured simply by placing overall shields on the interface cabling. High-level emissions are often caused by electronic circuits within EUT enclosures coupling onto cables simulating the installation, which interface, with the EUT. Overall shielding of the cabling is certainly permissible if it is present in the installation. However, the use of overall shielding that is not representative of the installation would result in test data that is useless. Also, overall shielding of cabling in some installations is not a feasible option due to weight and maintenance penalties. The presence of platform structure between cabling and antennas on a platform is not an acceptable reason for using overall shields on cables for testing in accordance with this standard. The presence of some platform shielding is a basic assumption.*

*An issue that arises with power leads concerns the use of shielding. It is unusual for power leads to be shielded in the actual installation. If they come directly off a prime power bus, shielding can only be effective if the entire bus is shielded end-to-end. Since buses normally distribute power to many locations, it is not practical to shield them. An exception to this situation is when power is derived from an intermediate source that contains filtering. Shielding between the intermediate source and the EUT will then be effective. When it is proposed that shielded power leads be used in the test set-up, the configuration needs to be researched to ensure that it is correct. There may be instances when published interface information is not available. In this case, overall shielding is not to be used. Individual circuits are to be treated as they typically would for that type of interface with shielding not used in questionable cases.*

*For some testing performed in the past using bulk cable drive techniques, overall cable shields were routinely removed and the injected signal was applied to the core wiring within the shield. The intent of this standard is to test cables as they are configured in the installation. If the cable uses an overall shield, the test signal is applied to the overall shielded cable. If the procuring agency desires that the test be performed on the core wiring, specific wording needs to be included in contractual documentation.*

##### 4.3.8.6.1 Interconnecting leads and cables

Individual leads shall be grouped into cables in the same manner as in the actual installation. Total interconnecting cable lengths in the set-up shall be the same as in the actual platform installation. If a cable is longer than 10 metres, at least 10 metres shall be included. When cable lengths are not specified for the installation, cables shall be sufficiently long to satisfy the conditions specified below. At least the first 2 metres (except for cables which are shorter in the actual installation) of each interconnecting cable associated with each enclosure of the EUT shall be run parallel to the front

boundary of the set-up. Remaining cable lengths shall be routed to the back of the set-up and shall be placed in a zigzagged arrangement. When the set-up includes more than one cable, individual cables shall be separated wherever possible by 2 centimetres measured from their outer circumference. For bench top set-ups using ground planes, the cable closest to the front boundary shall be placed 10 centimetres from the front edge of the ground plane. All cables shall be supported 5 centimetres above the ground plane.

**Discussion:** *Actual lengths of cables used in installations are necessary for several reasons. At frequencies below resonance, coupling is generally proportional to cable length. Resonance conditions will be representative of the actual installation. Also, distortion and attenuation of intentional signals due strictly to cable characteristics will be present and potential susceptibility of interface circuits to induced signals will therefore be similar to the actual installation.*

*Zigzagging of long cables is accomplished by first placing a length of cable in an open area and then reversing the direction of the cable run by 180 degrees each time a change of direction is required. Each subsequent segment is farther from the first. Individual segments of the cable are parallel and should be kept 2 centimetres apart. The zigzagging of long cables rather than coiling is to control excess inductance. A 2 centimetre spacing between cables is required to expose all cabling to the test antennas and limit coupling of signals between cables. The 10 centimetre dimension for cables from the front edge of the ground plane ensures that there is sufficient ground plane surface below the first cable to be effective. The 5 centimetre stand-offs standardise loop areas available for coupling and capacitance to the ground plane. The standoffs represent routing and clamping of cables in actual installations a fixed distance from structure.*

*The requirement that the first 2 metres of each interconnecting cable associated with each enclosure of the EUT be routed parallel to the front boundary of the set-up is intended to ensure that radiated emissions and susceptibility testing properly assesses the performance of the EUT. Noise signals developed within the EUT and conducted outside on electrical interfaces will tend to be attenuated as they travel along interconnecting cables, particularly at frequencies where the associated wavelength is becoming short compared with the cable length. Similarly, induced signals on interconnecting cables from radiated susceptibility fields will be attenuated as they travel along the cable. Requiring that the first 2 metres of the cabling be exposed therefore maximises the effects of potential radiated coupling.*

*In some military applications, there can be over 2000 cables associated with a subsystem. In most cases where large numbers of cables are involved, there will be many identical cable interfaces connected to identical circuitry. Testing of every cable interface is not necessary in this situation. The EMITP should document instances where these circumstances exist and should propose which cables are to be included in the set-up and to be tested.*

#### 4.3.8.6.2 Input power leads

Two metres of input power leads (including neutrals and returns) shall be routed parallel to the front edge of the set-up in the same manner as the interconnecting leads. Each input power lead, including neutrals and returns, shall be connected to a LISN (see paragraph 4.3.6). Power leads that are bundled, as part of an interconnecting cable in the actual installation shall be configured in the same fashion for the 2 metre exposed length and then shall be separated from the bundle and routed to the LISNs. After the 2 metre exposed length, the power leads shall be terminated at the LISNs in as short a distance as possible. The total length of power lead from the EUT electrical connector to the LISNs shall not exceed 2.5 metres. All power leads shall be supported 5 centimetres above the ground plane. If the power leads are twisted in the actual installation, they shall be twisted up to the LISNs.

**Discussion:** *Appropriate power lead length is a trade-off between ensuring sufficient length for efficient coupling of radiated signals and maintaining the impedance of the LISNs. To keep a constant set-up, it is undesirable to change the power lead length for different test procedures. Requiring a 2 metre exposed length is consistent with treatment of interconnecting leads for radiated concerns.*

*Wiring inductance 5 centimetres from a ground plane is approximately 1  $\mu\text{H}/\text{metre}$ . At 1 MHz this inductance has an impedance of approximately 13  $\Omega$ , which is significant with respect to the LISN requirement.*

*While it is common to require that neutrals and returns be isolated from equipment chassis within equipment enclosures, there are some cases where the neutral or return is tied directly to chassis. If the equipment is electrically bonded to metallic system structure in the installation and the system power source neutral or return is also tied to system structure, power return currents will flow primarily through system structure rather than through wiring. For this case, a LISN should normally be used only on the high side of the power. There are other installations, such as many types of aircraft, where returns and neutrals are isolated within the equipment, but they are often connected to system structure outside of the equipment enclosure. This practice allows for the flexibility of using a wired return, if necessary. For this situation, LISNs should normally be used on neutrals and returns to test for the wired return configuration.*

*The LISN requirement standardises impedance for power leads. While signal and control circuits are usually terminated in specified impedances, power circuit impedances are not usually well defined. The LISN requirement applies to all input prime power leads. The LISN requirement does not apply to output power leads. These leads should be terminated after the 2 metre exposed length in a load representing worst-case conditions. This load would normally draw the maximum current allowed for the power source.*

*The construction of the power cable between the EUT and the LISNs must be in accordance with the requirements of paragraph 4.3.8.6. For example, if a twisted triplet is used to distribute three phase ungrounded power in the actual installation, the same construction should be used in the test set-up. The normal construction must be interrupted over a sufficient length to permit connection to the LISNs.*

#### 4.3.8.7 Electrical and mechanical interfaces

All electrical input and output interfaces shall be terminated with either the actual equipment from the platform installation or loads which simulate the electrical properties (impedance, grounding, balance, and so forth) present in the actual installation. Signal inputs shall be applied to all applicable electrical interfaces to exercise EUT circuitry. EUTs with mechanical outputs shall be suitably loaded. When variable electrical or mechanical loading is present in the actual installation, testing shall be performed under expected worst-case conditions. When active electrical loading (such as a test set) is used, precautions shall be taken to insure the active load meets the ambient requirements of paragraph 4.3.4 when connected to the set-up, and that the active load does not respond to susceptibility signals. Antenna ports on the EUT shall be terminated with shielded, matched loads.

**Discussion:** *The application of signals to exercise the electrical interface is necessary to effectively evaluate performance. Most electronic subsystems on platforms are highly integrated with large amounts of digital and analog data being transferred between equipment. The use of actual platform equipment for the interfacing eliminates concerns regarding proper simulation of the interface. The interfaces must function properly in the presence of induced levels from susceptibility signals. Required isolation may be obtained by filtering the interface leads at the active load and either shielding the load or placing it outside of the shielded enclosure. The filtering should be selected to minimise the influence on the interface electrical properties specified above. For proper simulation, filtering at the loads should be outside the necessary bandwidth of the interface circuitry.*

*Antenna ports are terminated in loads for general set-up conditions. Specific test procedures address electromagnetic characteristics of antenna ports and required modifications to the test set-up.*

#### 4.3.9 Operation of EUT

During emission measurements, the EUT shall be placed in an operating mode, which produces maximum emissions. During susceptibility testing, the EUT shall be placed in its most susceptible operating mode. For EUTs with several available modes (including software controlled operational

modes), a sufficient number of modes shall be tested for emissions and susceptibility such that all circuitry is evaluated. The rationale for modes selected shall be included in the EMITP.

**Discussion:** *The particular modes selected may vary for different test procedures. Considerations for maximum emissions include conditions which cause the EUT to draw maximum prime power current, result in greatest activity in interface circuit operation, and generate the largest current drain on internal digital clock signals. Settings for a radar could be adjusted such that an output waveform results which has the highest available average power. Data bus interfaces could be queried frequently to cause constant bus traffic flow. Any modes of the EUT that are considered mission critical in the installation should be evaluated during susceptibility testing.*

*A primary consideration for maximum susceptibility is placing the EUT in its most sensitive state for reception of intentional signals (maximum gain). An imaging sensor would normally be evaluated with a scene meeting the most stringent specifications for the sensor. RF receivers are normally evaluated using an input signal at the minimum signal to noise specification of the receiver. An additional consideration is ensuring that all electrical interfaces that intentionally receive data are exercised frequently to monitor for potential responses.*

#### 4.3.9.1 Operating frequencies for tuneable RF equipment.

Measurements shall be performed with the EUT tuned to not less than three frequencies within each tuning band, tuning unit, or range of fixed channels, consisting of one mid-band frequency and a frequency within  $\pm 5\%$  from each end of each band or range of channels.

**Discussion:** *Tuned circuits and frequency synthesis circuitry inside RF equipment typically vary in characteristics such as response, rejection, and spectral content of emissions as they are set to different frequencies. Several test frequencies are required simply to obtain a sampling of the performance of the EUT across its operating range.*

*RF equipment that operates in several frequency bands or performs multiple functions is becoming more common. One example is a radio transceiver with VHF-FM, VHF-AM, and UHF-AM capability. Other devices are adaptive over large frequency ranges and can be programmed to perform different functions as the need arises. To meet the intent of the requirement to perform measurements at three frequencies within each tuning band, tuning unit, or range of fixed channels, each of the three functions of the radio in the example should be treated as separate bands, even if they are adjacent in frequency. Similarly, each function of adaptive RF equipment needs to be separately assessed.*

*The “value added” of performing all required tests at three frequencies within each band needs to be weighed against the added cost and schedule. The specific equipment design and intended function needs to be evaluated for each case.*

*For example, performing NCS01 on a VHF-FM, VHF-AM, and UHF-AM combined receiver–transmitter would require that the test be performed a minimum of 18 times (3 frequencies \* 3 bands \* 2 modes). Since NCS01 performance generally is related to the power supply design and load rather than the specific tuned frequency, doing the test for more than a few conditions may not add much value. If there is a problem, a typical result is “hum” on the secondary power outputs that is transmitted with the RF or that appears on the output audio of the receiver portion of the equipment. An appropriate approach for this particular requirement might be to test at one mid-band frequency for each of the three functions for both transmit and receive (6 tests – 3 frequencies \* 2 modes).*

*Other requirements need to be evaluated similarly. Since NCE02 emissions are mainly caused by power supply characteristics, testing at a mid-band frequency for each band just in the transmit mode might be adequate. For requirements with frequency coverage that extends into the operating frequency range of the equipment, such as NRE02, NCE03, and NRS02, testing at three frequencies per band may be necessary.*

#### 4.3.9.2 Operating frequencies for spread spectrum equipment

Operating frequency requirements for two major types of spread spectrum equipment shall be as follows:

- a. Frequency hopping. Measurements shall be performed with the EUT utilising a hop set which contains a minimum of 30% of the total possible frequencies. This hop set shall be divided equally into three segments at the low, mid and high end of the EUT's operational frequency range.
- b. Direct sequence. Measurements shall be performed with the EUT processing data at the highest possible data transfer rate.

**Discussion:** *During testing it is necessary to operate equipment at levels that they will experience during normal field operations. This is to allow for a realistic representation of the emission profile of the EUT during radiated and conducted testing and to provide realistic loading and simulation of the EUT during radiated and conducted susceptibility testing.*

**Frequency hopping:** *Utilisation of a hopset that is distributed across the entire operational spectrum of the EUT will help assure that internal circuitry dependent on the exact EUT transmit frequency being used is active intermittently during processing of the entire pseudo random stream. The fast operating times of hopping receivers/transmitters versus the allowable measurement times of the measurement receivers being used (see paragraph 4.3.10.3) will allow a representative EUT emission signature to be captured.*

**Direct sequence:** *Requiring the utilisation of the highest data transfer rate used in actual operation of the EUT should provide a representative worst-case radiated and conducted emission profile. Internal circuitry will operate at its highest processing rate when integrating the data entering the transmitter, and then resolving (disintegrating) the data back once again on the receiver end. Additionally, the data rate will need to be an area of concentration during all susceptibility testing.*

#### 4.3.9.3 Susceptibility monitoring

The EUT shall be monitored during susceptibility testing for indications of degradation or malfunction. This monitoring is normally accomplished through the use of built-in-test (BIT), visual displays, aural outputs, and other measurements of signal outputs and interfaces. Monitoring of EUT performance through installation of special circuitry in the EUT is permissible; however, these modifications shall not influence test results.

**Discussion:** *Most EUTs can be adequately monitored through normal visual and aural outputs, self-diagnostics, and electrical interfaces. The addition of special circuitry for monitoring can present questions related to its influence on the validity of the test results and may serve as an entry or exit point for electromagnetic energy.*

*The monitoring procedure needs to be specified in the EMITP and needs to include allowances for possible weaknesses in the monitoring process to assure the highest probability of finding regions of susceptibility.*

#### 4.3.10 Use of measurement equipment

Measurement equipment shall be as specified in the individual test procedures of this standard. Any frequency selective measurement receiver may be used for performing the testing described in this standard. Provided that the receiver characteristics (that is, sensitivity, selection of bandwidths, detector functions, dynamic range, and frequency of operation) meet the constraints specified in this standard and are sufficient to demonstrate compliance with the applicable limits. Typical instrumentation characteristics may be found in ANSI C63.2.

**Discussion:** *Questions frequently arise concerning the acceptability for use of measurement receivers other than instruments that are specifically designated "field intensity meters" or "EMI receivers." Most questions are directed toward the use of spectrum analysers. These instruments are*

generally acceptable for use. However, depending on the type, they can present difficulties that are not usually encountered with the other receivers. Sensitivity may not be adequate in some frequency bands requiring that a low noise preamplifier be inserted before the analyser input. Impulse type signals from the EUT with broad spectral content may overload the basic receiver or preamplifier. The precautions of paragraph 4.3.7.3 must be observed. Both of these concerns can usually be adequately addressed by the use of a preselector with the analyser. These devices typically consist of a tuneable filter which tracks the analyser followed by a preamplifier.

ANSI C63.2 represents a co-ordinated position from industry on required characteristics of instrumentation receivers. This document can be used when assessing the performance of a receiver.

Many of the test procedures require non-specialised instrumentation that is used for many other purposes. The test facility is responsible for selecting instrumentation that has characteristics capable of satisfying the requirements of a particular test procedure.

Current probes used for EMI testing are more specialised instrumentation. These devices are current transformers with the circuit under test forming a single turn primary. They are designed to be terminated in  $50 \Omega$ . Current probes are calibrated using transfer impedance that is the ratio of the voltage output of the probe across  $50 \Omega$  to the current through the probe. Probes with higher transfer impedance provide better sensitivity. However, these probes also result in more series impedance added to the circuit with a greater potential to affect the electrical current level. The series impedance added by the probe is the transfer impedance divided by the number of turns in the secondary winding on the probe. Typical transfer impedances are  $5 \Omega$  or less. Typical added series impedance is  $1 \Omega$  or less.

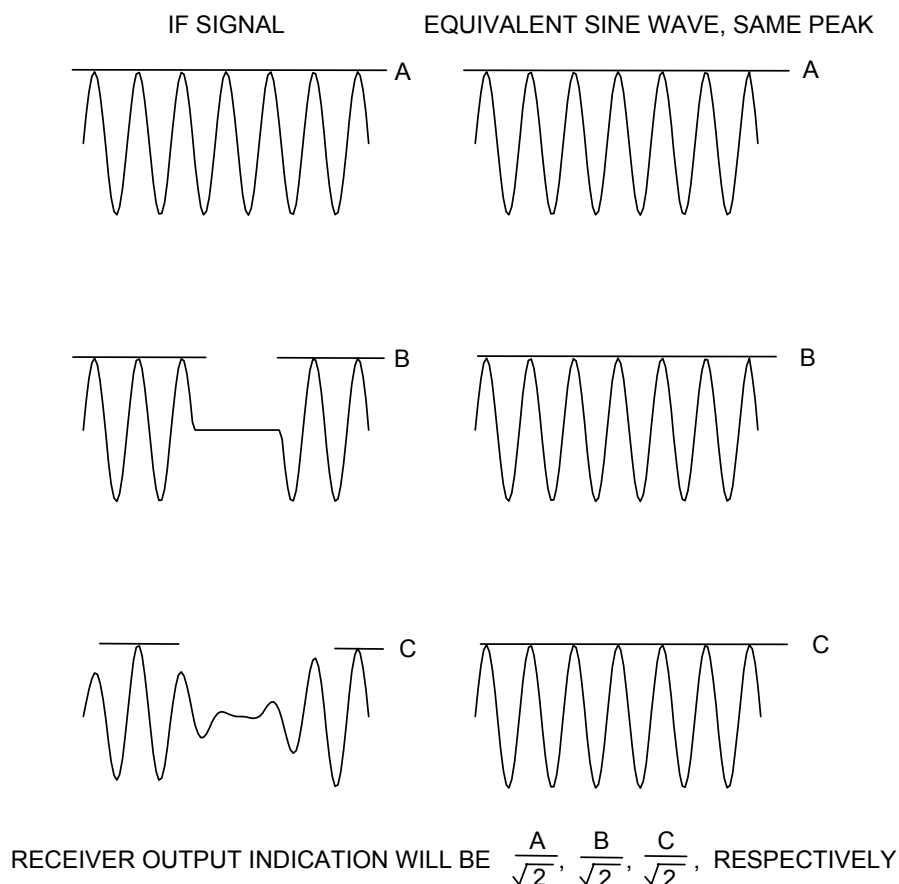
#### 4.3.10.1 Detector

A peak detector shall be used for all frequency domain emission and susceptibility measurements. This device detects the peak value of the modulation envelope in the receiver bandpass. Measurement receivers are calibrated in terms of an equivalent Root Mean Square (RMS) value of a sine wave that produces the same peak value. When other measurement devices such as oscilloscopes, non-selective voltmeters, or broadband field strength sensors are used for susceptibility testing, correction factors shall be applied for test signals to adjust the reading to equivalent RMS values under the peak of the modulation envelope.

**Discussion:** *The function of the peak detector and the meaning of the output indication on the measurement receiver are often confusing. Although there may appear to be an inherent discrepancy in the use of the terms "peak" and "RMS" together, there is no contradiction. All detector functions (that is peak, carrier, field intensity, and quasi-peak) process the envelope of the signal present in the receiver intermediate frequency (IF) section. All outputs are calibrated in terms of an equivalent RMS value. For a sine wave input to the receiver, the signal envelope in the IF section is a DC level and all detectors produce the same indicated RMS output. Calibration in terms of RMS is necessary for consistency. Signal sources are calibrated in terms of RMS. If a 0 dBm (107 dB $\mu$ V) unmodulated signal is applied to the receiver, the receiver must indicate 0 dBm (107 dB $\mu$ V).*

*If there is modulation present on the signal applied to the receiver, the detectors respond differently. The IF section of the receiver sees the portion of the applied signal within the bandwidth limits of the IF. The peak detector senses the largest level of the signal envelope in the IF and displays an output equal to the RMS value of a sine wave with the same peak. The specification of a peak detector ensures that the worst-case condition for emission data is obtained. A carrier detector averages the modulation envelope based on selected charge and discharge time constants.*

*Figure 11 shows the peak detector output for several modulation waveforms. An item of interest is that for a square wave modulated signal, which can be considered a pulse type modulation, the receiver can be considered to be displaying the RMS value of the pulse when it is on. Pulsed signals are often specified in terms of peak power. The RMS value of a signal is derived from the concept of power, and a receiver using a peak detector correctly displays the peak power.*



**FIGURE 11 Peak detector response.**

All frequency domain measurements are standardised with respect to the response that a measurement receiver using a peak detector would provide. Therefore, when instrumentation is used which does not use peak detection; correction factors must be applied for certain signals. For an oscilloscope, the maximum amplitude of the modulated sine wave measured from the DC level is divided by 1.414 (square root of 2) to determine the RMS value at the peak of the modulation envelope.

Correction factors for other devices are determined by evaluating the response of the instrumentation to signals with the same peak level with and without modulation. For example, a correction factor for a broadband field sensor can be determined as follows. Place the sensor in an unmodulated field and note the reading. Apply the required modulation to the field ensuring that the peak value of the field is the same as the unmodulated field. For pulse type modulation, most signal sources will output the same peak value when modulation is applied. Amplitude modulation increases the peak amplitude of the signal and caution must be observed. Note the new reading. The correction factor is simply the reading with the unmodulated field divided by the reading with the modulated field. If the meter read 10 volts/metre without modulation and 5 volts/metre with modulation, the correction factor is 2. The evaluation should be tried at several frequencies and levels to ensure that a consistent value is obtained. When subsequently using the sensor for measurements with the evaluated modulation, the indicated reading is multiplied by the correction factor to obtain the correct reading for peak detection.

## 4.3.10.2 Computer-controlled receivers

A description of the operations being directed by software for computer-controlled receivers shall be included in the EMITP. Verification techniques used to demonstrate proper performance of the software shall also be included.

**Discussion:** *Computer software obviously provides excellent opportunities for automating testing. However, it also can lead to errors in testing if not properly used or if incorrect code is present. It is essential that users of the software understand the functions it is executing, know how to modify parameters (such as transducer or sweep variables) as necessary, and perform sanity checks to ensure that the overall system performs as expected.*

## 4.3.10.3 Emission testing

## 4.3.10.3.1 Bandwidths

The measurement receiver bandwidths listed in Table 2 shall be used for emission testing. These bandwidths are specified at the 6 dB down points for the overall selectivity curve of the receivers. Video filtering shall not be used to bandwidth limit the receiver response. If a controlled video bandwidth is available on the measurement receiver, it shall be set to its greatest value. Larger receiver bandwidths may be used; however, they may result in higher measured emission levels. NO BANDWIDTH CORRECTION FACTORS SHALL BE APPLIED TO TEST DATA DUE TO THE USE OF LARGER BANDWIDTHS.

Frequency Range	6 dB Bandwidth	Minimum Dwell Time	Minimum Measurement Time Analog Measurement Receiver
30 Hz - 1 kHz	10 Hz	0.15 sec	0.015 sec/Hz
1 kHz - 10 kHz	100 Hz	0.015 sec	0.15 sec/kHz
10 kHz - 150 kHz	1 kHz	0.015 sec	0.015 sec/kHz
150 kHz - 30 MHz	10 kHz	0.015 sec	1.5 sec/MHz
30 MHz - 1 GHz	100 kHz	0.015 sec	0.15 sec/MHz
Above 1 GHz	1 MHz	0.015 sec	15 sec/GHz

**TABLE 2 Bandwidth and measurement time**

**Discussion:** *The bandwidths specified in Table 2 are consistent with the recommended available bandwidths and the bandwidth specification technique for receivers contained in ANSI C63.2. Existing receivers have bandwidths specified in a number of different ways. Some are given in terms of 3 dB down points. The 6 dB bandwidths are usually about 40% greater than the 3 dB values. Impulse bandwidths are usually very similar to the 6 dB bandwidths. For gaussian shaped bandpasses, the actual value is 6.8 dB.*

*The frequency break point between using a 1 kHz and 10 kHz bandwidth was modified from 250 kHz to 150 kHz in this version of the standard to harmonise with commercial EMI standards.*

*In order not to restrict the use of presently available receivers that do not have the specified bandwidths, larger bandwidths are permitted. The use of larger bandwidths can produce higher detected levels for wide bandwidth signals. The prohibition against the use of correction factors is included to avoid any attempts to classify signals.*

*The sensitivity of a particular receiver is an important factor in its suitability for use in making measurements for a particular requirement. NRE02 is usually the most demanding requirement. The sensitivity of a receiver at room temperature can be calculated as follows:*

$$\text{Sensitivity in dBm} = -114 \text{ dBm/MHz} + \text{bandwidth (dBMHz)} + \text{noise figure (dB)}$$

As noted in the equation, reducing the noise figure is the only way (cryogenic cooling is not practical) to improve sensitivity for a specified bandwidth. The noise figure of receivers can vary substantially depending on the front-end design. System noise figure can be improved through the use of low noise preamplifiers. The resulting noise figure of a preamplifier/receiver combination can be calculated from the following. All numbers are real numbers. Conversion to decibels (10 log) is necessary to determine the resulting sensitivity in the above formula:

$$\text{System noise figure} = \text{preamp noise figure} + (\text{receiver noise figure})/(\text{preamp gain})$$

Since preamplifiers are broadband devices, issues of potential overload need to be addressed. Separate preselectors, which are available for some spectrum analysers, usually combine a tracking filter with a low noise preamplifier to eliminate overload. Preselection is an integral part of many receivers.

Dwell times may need to be extended dependant upon the operation of the EUT. There should be a dwell at each frequency consistent with the EUT cyclic time.

#### 4.3.10.3.2 Emission identification

All emissions regardless of characteristics shall be measured with the measurement receiver bandwidths specified in Table 2 and compared against the applicable limits. Identification of emissions with regard to narrowband or broadband categorisation is not applicable.

**Discussion:** Requirements for specific bandwidths and the use of single limits are intended to resolve a number of problems. The significance of the particular bandwidths chosen for use by a test facility were addressed by classification of the appearance of the emissions with respect to the chosen bandwidths. Emissions considered to be broadband had to be normalised to equivalent levels in a 1 MHz bandwidth. The bandwidths and classification techniques used by various facilities were very inconsistent and resulted in a lack of standardisation. The basic issue of emission classification was often poorly understood and implemented. Requiring specific bandwidths with a single limit eliminates any need to classify emissions.

An additional problem is that emission profiles from modern electronics are often quite complex. Some emission signatures have frequency ranges where the emissions exhibit white noise characteristics. Normalisation to a 1 MHz bandwidth using spectral amplitude assumptions based on impulse noise characteristics is not technically correct. Requiring specific bandwidths eliminates normalisation and this discrepancy.

#### 4.3.10.3.3 Frequency scanning

For emission measurements, the entire frequency range for each applicable test shall be scanned. Minimum measurement time for analog measurement receivers during emission testing shall be as specified in Table 2. Synthesized measurement receivers shall step in one-half bandwidth increments or less, and the measurement dwell time shall be as specified in Table 2. For equipment that operates such that potential emissions are produced at only infrequent intervals, times for frequency scanning shall be increased as necessary to capture any emissions.

**Discussion:** For each emission test, the entire frequency range as specified for the applicable requirement must be scanned to ensure that all emissions are measured.

Continuous frequency coverage is required for emission testing. Testing at discrete frequencies is not acceptable unless otherwise stated in a particular test procedure. The minimum scan times listed in Table 2 are based on two considerations. The first consideration is the response time of a particular bandwidth to an applied signal. This time is  $1/(\text{filter bandwidth})$ . The second consideration is the potential rates (that is modulation, cycling, and processing) at which electronics operate and the need to detect the worst-case emission amplitude. Emission profiles usually vary with time. Some signals are present only at certain intervals and others vary in amplitude. For example, signals commonly present in emission profiles are harmonics of microprocessor clocks. These harmonics are very stable

*in frequency; however, their amplitude tends to change, as various circuitries are exercised and current distribution changes.*

*The first entry in the table for analog measurement receivers of 0.015 sec/Hz for a bandwidth of 10 Hz is the only one limited by the response time of the measurement receiver bandpass. The response time is  $1/\text{bandwidth} = 1/10 \text{ Hz} = 0.1 \text{ seconds}$ . Therefore, as the receiver tunes, the receiver bandpass must include any particular frequency for 0.1 seconds implying that the minimum scan time =  $0.1 \text{ seconds}/10 \text{ Hz} = 0.01 \text{ seconds/Hz}$ . The value in the table has been increased to 0.015 seconds/Hz to ensure adequate time. This increase by a multiplication factor of 1.5 results in the analog receiver having a frequency in its bandpass for 0.15 seconds as it scans. This value is the dwell time specified in the table for synthesised receivers for 10 Hz bandwidths. Since synthesised receivers are required to step in one-half bandwidth increments or less and dwell for 0.15 seconds, test time for synthesised receivers will be greater than analog receivers.*

*The measurement times for other table entries are controlled by the requirement that the receiver bandpass include any specific frequency for a minimum of 15 milliseconds (dwell time in table), which is associated with a potential rate of variation of approximately 60 Hz. As the receiver tunes, the receiver bandpass is required to include any particular frequency for the 15 milliseconds. For the fourth entry in the table of 1.5 seconds/MHz for a 10 kHz bandwidth, the minimum measurement time is  $0.015 \text{ seconds}/0.01 \text{ MHz} = 1.5 \text{ seconds/MHz}$ . A calculation based on the response time of the receiver would yield a response time of  $1/\text{bandwidth} = 1/10 \text{ kHz} = 0.0001 \text{ seconds}$  and a minimum measurement time of  $0.0001 \text{ seconds}/0.01 \text{ MHz} = 0.01 \text{ seconds/MHz}$ . The longer measurement time of 1.5 seconds/MHz is specified in the table. If the specified measurement times are not adequate to capture the maximum amplitude of the EUT emissions, longer measurement times should be implemented.*

*Caution must be observed in applying the measurement times. The specified parameters are not directly available on measurement receiver controls and must be interpreted for each particular receiver. Also, the specified measurement times may be too fast for some data gathering devices such as real-time X-Y recording. Measurement receiver peak hold times must be sufficiently long for the mechanical pen drive on X-Y recorders to reach the detected peak value. In addition, the scan speed must be sufficiently slow to allow the detector to discharge after the signal is detuned so that the frequency resolution requirements of paragraph 4.3.10.3.4 are satisfied.*

*For measurement receivers with a "maximum hold" feature that retains maximum detected levels after multiple scans over a particular frequency range, multiple faster sweeps that produce the same minimum test times as implied by Table 2 are acceptable. For the situation noted in the requirement concerning equipment that produces emissions at only infrequent intervals, using the multiple scan technique will usually provide a higher probability of capturing intermittent data than using one slower scan.*

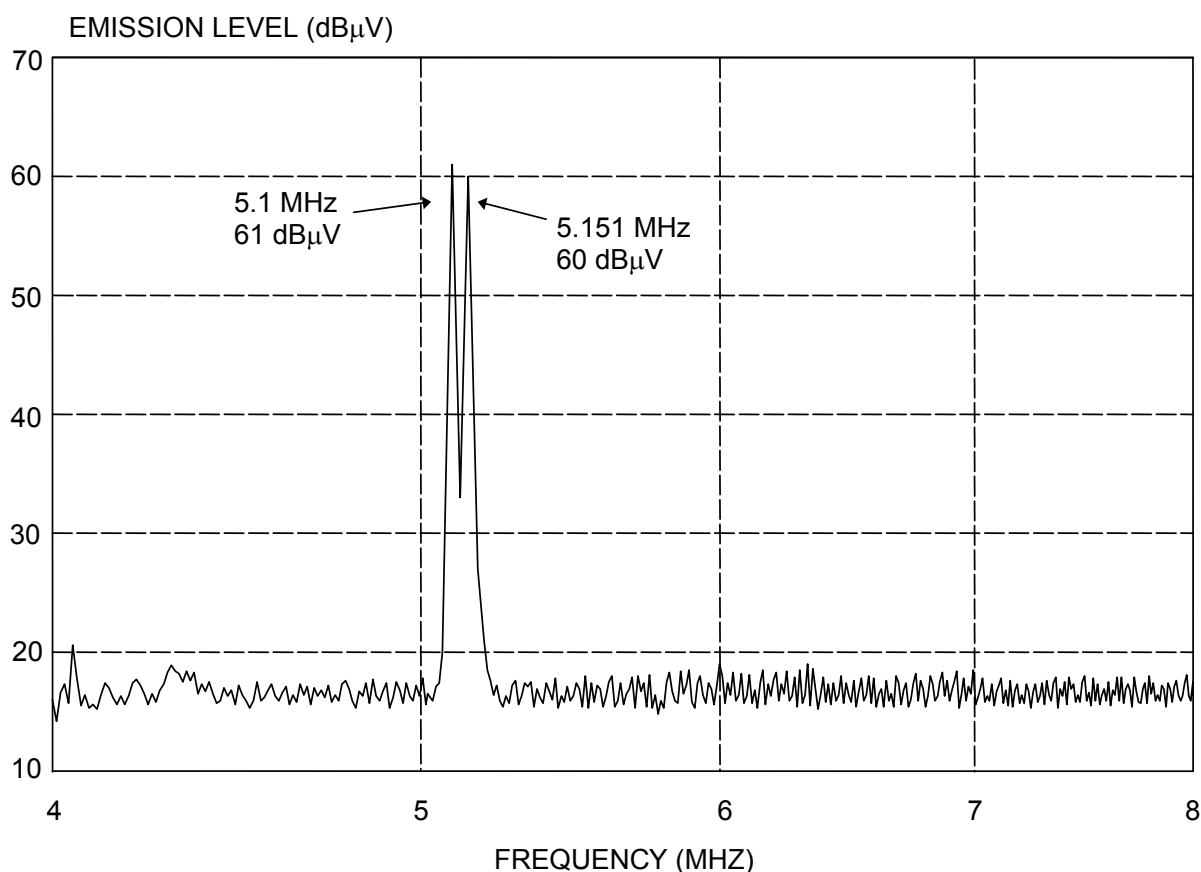
#### 4.3.10.3.4 Emission data presentation.

Amplitude versus frequency profiles of emission data shall be automatically generated and displayed at the time of test and shall be continuous. The displayed information shall account for all applicable correction factors (transducers, attenuators, cable loss, and the like) and shall include the applicable limit. Manually gathered data is not acceptable except for verification of the validity of the output. Plots of the displayed data shall provide a minimum frequency resolution of 1% or twice the measurement receiver bandwidth, whichever is less stringent, and minimum amplitude resolution of 1 dB. The above resolution requirements shall be maintained in the reported results of the EMITR.

**Discussion:** *Continuous displays of amplitude versus frequency are required. This information can be generated in a number of ways. The data can be plotted real-time as the receiver scans. The data can be stored in computer memory and later dumped to a plotter. Photographs of video displays are acceptable; however, it is generally more difficult to meet resolution requirements and to reproduce data in this form for submittal in an EMITR.*

Placement of limits can be done in several ways. Data may be displayed with respect to actual limit dimensions (such as  $\text{dB}\mu\text{V}/\text{m}$ ) with transducer, attenuation, and cable loss corrections made to the data. An alternative is to plot the raw data in  $\text{dB}\mu\text{V}$  (or  $\text{dBm}$ ) and convert the limit to equivalent  $\text{dB}\mu\text{V}$  (or  $\text{dBm}$ ) dimensions using the correction factors. This second technique has the advantage of displaying the proper use of the correction factors. Since both the emission level and the required limit are known, a second party can verify proper placement. Since the actual level of the raw data is not available for the first case, this verification is not possible.

An example of adequate frequency and amplitude resolution is shown in Figure 12. 1% frequency resolution means that two sinusoidal signals of the same amplitude separated by 1% of the tuned frequency are resolved in the output display so that they both can be seen. As shown in the figure, 1% of the measurement frequency of 5.1 MHz is 0.051 MHz and a second signal at 5.151 MHz (1 dB different in amplitude on the graph) is easily resolved in the display. The "2 times the measurement receiver bandwidth" criteria means that two sinusoidal signals of the same amplitude separated by twice the measurement receiver bandwidth are resolved. For the example shown in Figure 12, the bandwidth is 0.01 MHz and 2 times this value is 0.02 MHz. Therefore, the 1% criterion is less stringent and is applicable. 1 dB amplitude resolution means that the amplitude of the displayed signal can be read within 1 dB. As shown in the figure, the reviewer can determine whether the signal amplitude is 60  $\text{dB}\mu\text{V}$  or 61  $\text{dB}\mu\text{V}$ .



**FIGURE 12** Example of data presentation resolution.

The difference between resolution and accuracy is sometimes confusing. Paragraph 4.3.1 requires 3 dB measurement system accuracy for amplitude while paragraph 4.3.10.3.4 requires 1 dB amplitude resolution. Accuracy is an indication how precisely a value needs to be known while resolution is an indication of the ability to discriminate between two values. A useful analogy is reading time from a watch. A watch typically indicates the time within one second (resolution) but may be 30 seconds different than the absolute correct time (accuracy).

#### 4.3.10.4 Susceptibility testing.

##### 4.3.10.4.1 Frequency scanning.

For susceptibility measurements, the entire frequency range for each applicable test shall be scanned. For swept frequency susceptibility testing, frequency scan rates and frequency step sizes of signal sources shall not exceed the values listed in Table 3. The rates and step sizes are specified in terms of a multiplier of the tuned frequency ( $f_0$ ) of the signal source. Analog scans refer to signal sources, which are continuously tuned. Stepped scans refer to signal sources, which are sequentially tuned to discrete frequencies. Stepped scans shall dwell at each tuned frequency for the greater of 3 seconds or EUT response time. Scan rates and step sizes shall be decreased when necessary to permit observation of a response.

Frequency Range	Analog Scans Maximum Scan Rates	Stepped Scans Maximum Step Size
30 Hz - 1 MHz	$0.0333f_0/\text{sec}$	$0.05 f_0$
1 MHz - 30 MHz	$0.00667 f_0/\text{sec}$	$0.01 f_0$
30 MHz - 1 GHz	$0.00333 f_0/\text{sec}$	$0.005 f_0$
1 GHz - 8 GHz	$0.000667 f_0/\text{sec}$	$0.001 f_0$
8 GHz - 40 GHz	$0.000333 f_0/\text{sec}$	$0.0005 f_0$

**TABLE 3 Susceptibility scanning**

**Discussion:** For any susceptibility test performed in the frequency domain, the entire frequency range as specified in the applicable requirement must be scanned to ensure that all potentially susceptible frequencies are evaluated.

The scan rates and step sizes in Table 3 are structured to allow for a continuous change in value with frequency for flexibility. Computerised test systems could be programmed to change values very frequently. A more likely application is to block off selected bands for scanning and to base selections of scan rate or step size on the lowest frequency. For example, if 1 - 2 GHz were selected, the maximum scan rate would be  $(0.000667 \times 1 \text{ GHz})/\text{sec}$  which equals 0.667 MHz/sec and the maximum step size would be  $0.001 \times 1 \text{ GHz}$ , which equals 1 MHz. Both automatic and manual scanning are permitted.

The two primary areas of concern for frequency scanning for susceptibility testing are response times for EUTs to react to stimuli and how sharply the responses tune with frequency, normally expressed as quality factor (Q). Both of these items have been considered in the determination of the scan rates and step sizes in Table 3. The table entries are generally based on the assumption of a maximum EUT response time of three seconds and Q values of 10, 50, 100, 500, and 1000 (increasing values as frequency increases in Table 3). Since EUT responses are more likely to occur in approximately the 1 to 200 MHz range due to efficient cable coupling based on wavelength considerations, Q values

have been increased somewhat to slow the scan and allow additional time for observation of EUT responses. More detailed discussions on these items follow.

The assumption of a maximum response time of three seconds is considered to be appropriate for a large percentage of possible cases. There are several considerations. While the electronics processing the interfering signal may respond quickly, the output display may take some time to react. Outputs that require mechanical motion such as metre movements or servo driven devices will generally take longer to show degradation effects than electronic displays such as video screens. Another concern is that some EUTs will only be in particularly susceptible states periodically. For example, sensors feeding information to a microprocessor are typically sampled at specific time intervals. It is important that the susceptibility stimuli be located at any critical frequencies when the sensor is sampled. The time intervals between steps and sweep rates in Table 3 may need to be modified for EUTs with unusually long response times.

Some concern has been expressed on the susceptibility scan rates and the impact that they would have on the length of time required to conduct a susceptibility test. The criteria of Table 3 allow the susceptibility scan rate to be adjusted continually as the frequency is increased; however, as a practical matter, the rate would most likely only be changed once every octave or decade. As an example, Table 4 splits the frequency spectrum up into ranges varying from octaves to decades and lists the minimum time required to conduct a susceptibility test for an analog scan. The scan rate for each range is calculated based on the start frequency for the range. The total test time to run NRS02 from 1 MHz to 18 GHz is 177 minutes. A similar calculation for a stepped scan results in a total test time which is 2 times this value or 353 minutes. It must be emphasised that the scan speeds should be slowed down if the EUT response time or Q are more critical than those used to establish the values in Table 3.

Q is expressed as  $f_0/BW$  where  $f_0$  is the tuned frequency and BW is the width in frequency of the response at the 3 dB down points. For example, if a response occurred at 1 MHz at a susceptibility level of 1 volt and the same response required 1.414 volts (3 dB higher in required drive) at 0.95 and 1.05 MHz, the Q would be  $1 \text{ MHz}/(1.05 - 0.95 \text{ MHz})$  or 10. Q is primarily influenced by resonances in filters, interconnecting cabling, physical structure, and cavities. The assumed Q values are based on observations from various types of testing. The step sizes in Table 3 are one half of the 3 dB bandwidths of the assumed value of Q ensuring that test frequencies will lie within the resonant responses.

Below approximately 200 MHz, the predominant contributors are cable and interface filter resonances. There is loading associated with these resonances, which dampens the responses and limits most values of Q to less than 50. Above 200 MHz, structural resonances of enclosures and housings start playing a role and have higher values of Q due to less dampening. Above approximately 1 GHz, aperture coupling with excitation of cavities will become dominant. Values of Q are dependent on frequency and on the amount of material contained in the cavity. Larger values of Q result when there is less material in the volume. A densely packaged electronics enclosure will exhibit significantly lower values of Q than an enclosure with a higher percentage of empty volume. Q is proportional to  $\text{Volume}/(\text{Surface Area} \times \text{Skin Depth})$ . The value of Q also tends to increase with frequency, as the associated wavelength becomes smaller. EUT designs with unusual configurations that result in high Q characteristics may require that the scan rates and step sizes in Table 3 be decreased for valid testing.

RF processing equipment presents a special case requiring unique treatment. Intentionally tuned circuits for processing RF can have very high values of Q. For example, a circuit operating at 1 GHz with a bandwidth of 100 kHz has a Q of  $1 \text{ GHz}/100 \text{ kHz}$  or 10,000.

Automatic levelling used to stabilise the amplitude of a test signal for stepped scans may require longer dwell times than one second at discrete frequencies. The signal will take time to settle and any EUT responses during the levelling process should be ignored.

Frequency Range	Maximum Scan Rate	Actual Scan Time
30 Hz - 100 Hz	1.0 Hz/sec	1.2 min
100 Hz - 1 kHz	3.33 Hz/sec	4.5 min
1 kHz - 10 kHz	33.3 Hz/sec	4.5 min
10 kHz - 100 kHz	333 Hz/sec	4.5 min
100 kHz - 1 MHz	3.33 kHz/sec	4.5 min
1 MHz - 5 MHz	6.67 kHz/sec	10 min
5 MHz - 30 MHz	33.3 kHz/sec	12.5 min
30 MHz - 100 MHz	100 kHz/sec	11.7 min
100 MHz - 200 MHz	333 kHz/sec	5.0 min
200 MHz - 400 MHz	667 kHz/sec	5.0 min
400 MHz - 1 GHz	1.33 MHz/sec	7.5 min
1 GHz - 2 GHz	0.667 MHz/sec	25.0 min
2 GHz - 4 GHz	1.33 MHz/sec	25.0 min
4 GHz - 8 GHz	2.67 MHz/sec	25.0 min
8 GHz - 12 GHz	2.67 MHz/sec	25.0 min
12 GHz - 18 GHz	4 MHz/sec	25.0 min
18 GHz - 30 GHz	6 MHz/sec	33.3 min
30 GHz - 40 GHz	10 MHz/sec	16.7 min

**TABLE 4 Susceptibility testing times.**

## 4.3.10.4.2 Modulation of susceptibility signals.

Susceptibility test signals for NCS07 and NRS02 shall be pulse modulated (on/off ratio of 40 dB minimum) at a 1 kHz rate with a 50% duty cycle.

**Discussion:** Modulation is usually the effect that degrades EUT performance. The wavelengths of the RF signal cause efficient coupling to electrical cables and through apertures (at higher frequencies). Non-linearities in the circuit elements detect the modulation on the carrier. The circuits may then respond to the modulation depending upon detected levels, circuit bandpass characteristics, and processing features.

Pulse modulation at a 1 kHz rate, 50% duty cycle, (alternately termed 1 kHz square wave modulation) is specified for several reasons. One kHz is within the bandpass of most analog circuits such as audio or video. The fast rise and fall times of the pulse causes the signal to have significant harmonic

*content high in frequency and can be detrimental to digital circuits. Response of electronics has been associated with energy present and a square wave results in high average power. The modulation encompasses many signal modulations encountered in actual use. The square wave is a severe form of amplitude modulation used in communications and broadcasting. It also is a high duty cycle form of pulse modulation representative of radars.*

*Care needs to be taken in implementing 1 kHz, 50% duty cycle, pulse modulation (on/off ratio of 40 dB) using some signal sources. Most higher frequency signal sources have either internal pulse modulation or an external port for pulse modulation. This function switches the output on and off without affecting the amplitude of the unmodulated signal, provided that the strength of the modulation signal is adequate. For other signal sources, particularly at lower frequencies, the external amplitude modulation (AM) port needs to be driven to a minimum of 99 % depth of modulation (equivalent to 40 dB on/off ratio) to simulate pulse modulation. The output signal will essentially double in amplitude compared to an unmodulated signal for this type of input. Depending on the type of testing being performed and the technique of monitoring applied signals; this effect may or may not influence the results. Use of an AM port can be substantially more involved than using a pulse modulation port. The amplitude of the input signal directly influences the depth of modulation. There is a potential of exceeding 100% depth of modulation, which will result in signal distortion. Since the on/off ratio requirement is stringent, it is necessary to view the output signal on an oscilloscope to set the appropriate depth of modulation. Another complication is that the bandwidth of AM ports is usually less than pulse ports. Driving the port with a pulse shape may result in difficulty in setting the source for a minimum of 99%.*

*Worst-case modulation may not be related to modulations seen in actual use or may be very specialised. The most typical modulations used below approximately 400 MHz have been amplitude modulation at either 400 or 1000 Hz (30 to 80%) or pulse modulation, 50% duty cycle, at 400 or 1000 Hz. These same modulations have been used above 400 MHz together with pulse modulation at various pulse widths and pulse repetition frequencies. Continuous wave (CW - no modulation) has also occasionally been used. CW typically produces a detected DC level in the circuitry and affects certain types of circuits. In general, experience has shown that modulation is more likely to cause degradation. CW should be included as an additional requirement when assessing circuits that respond only to heat such as electro explosive devices. CW should not normally be used as the only condition.*

*Consideration should be given to applying a secondary 1 Hz modulation (where the normal 1 kHz square wave modulated waveform is completely turned on and off every 500 milliseconds) for certain subsystems with low frequency response characteristics, such as aircraft flight control subsystems. This modulation simulates characteristics of some transmitters such as HF radios in single sideband operation (no carrier), where a transmitted voice signal will cause the RF to be present only when a word is spoken. The dilemma with using this modulation is that the potential response of some subsystems may be enhanced, while others may be less responsive. In the latter case, the 500 millisecond off period allows the subsystem to recover from effects introduced during the "on" period.*

#### 4.3.10.4.3 Thresholds of susceptibility.

When susceptibility indications are noted in EUT operation, a threshold level shall be determined where the susceptible condition is no longer present. Thresholds of susceptibility shall be determined as follows and described in the EMITR:

- a. When a susceptibility condition is detected, reduce the interference signal until the EUT recovers.
- b. Reduce the interference signal by an additional 6 dB.
- c. Gradually increase the interference signal until the susceptibility condition reoccurs. The resulting level is the threshold of susceptibility.

- d. Record this level, frequency range of occurrence, frequency and level of greatest susceptibility, and other test parameters, as applicable.

**Discussion:** *It is usually necessary to test at levels above the limits to ensure that the test signal is at least at the required level. Determination of a threshold of susceptibility is necessary when degradation is present to assess whether requirements are met. This information should be included in the EMITR. Threshold levels below limits are unacceptable.*

*The specified steps to determine thresholds of susceptibility standardise a particular technique. An alternative procedure sometimes utilised in the past was to use the value of the applied signal where the EUT recovers (step a above) as the threshold. Hysteresis type effects are often present where different values are obtained for the two procedures.*

*Distortion of sinusoidal susceptibility signals caused by non-linear effects in power amplifiers can lead to erroneous interpretation of results. When distortion is present, the EUT may actually respond to a harmonic of the intended susceptibility frequency, where the required limit may be lower. When frequency selective receivers are used to monitor the injected level, distortion itself does not prevent a valid susceptibility signal level from being verified at the intended frequency. However, harmonic levels should be checked when susceptibility is present to determine if they are influencing the results. When broadband sensors are being used, such as in portions of NRS02, distortion can result in the sensor incorrectly displaying the required signal level at the intended frequency. In this case, distortion needs to be controlled such that correct levels are measured.*

#### 4.3.10.4.4 Susceptibility of EUT input power filters.

Conducted emission test NCE01 or NCE05 must be performed prior to performing transient tests NCS10 and NCS11 to obtain a baseline measurement. On completion of transient tests NCS10 and NCS11 conducted emission test NCE01 or NCE05 shall be repeated. This is to confirm no damaged has been sustained by the EUT power line filters.

**Discussion:** *Comparison of emission profiles before and after transient testing shall be performed. This shall determine whether any damage to the EUT occurred during application of the transients, i.e. Filtering or other component damage. Should any significant changes in emission profile be evident then a FAIL result shall be recorded for this test even if the emission profile has been reduced due to the application of the transient.*

*The conducted emission assessment is not intended to show compliance against the NCE01 or NCE05 limits but is used solely to compare the 'before' and 'after' emission profiles.*

*If test NCE01 or NCE05 has been performed as part of the trial prior to the transient tests then these results are acceptable to use as a baseline.*

#### 4.3.11 Calibration of measuring equipment.

Test equipment and accessories required for measurement in accordance with this standard shall be calibrated in accordance with National Standards (e.g. ANSI/NCSL Z540-1 or ISO 10012-1 etc). In particular, measurement antennas, current probes, field sensors, and other devices used in the measurement loop shall be calibrated at least every 2 years unless otherwise specified by the procuring activity, or when damage is apparent.

**Discussion:** *Calibration is typically required for any measurement device whose characteristics are not verified through use of another calibrated item during testing. For example, it is not possible during testing to determine whether an antenna used to measure radiated emissions is exhibiting correct gain characteristics. Therefore, these antennas require periodic calibration. Conversely, a power amplifier used during radiated susceptibility testing often will not require calibration since application of the proper signal level is verified through the use of a separate calibrated field sensing device. Other amplifier applications such as the use of a signal pre-amplifier in front of a*

*measurement receiver would require calibration of the amplifier characteristics since the specific gain versus frequency response is critical and is not separately verified.*

#### 4.3.11.1 Measurement system test.

At the start of each emission test, the complete test system (including measurement receivers, cables, attenuators, couplers, and so forth) shall be verified by injecting a known signal, as stated in the individual test procedure, while monitoring system output for the proper indication. When the emission test involves an uninterrupted set of repeated measurements (such as evaluating different operating modes of the EUT) using the same measurement equipment, the measurement system test needs to be accomplished only one time.

**Discussion:** *The end-to-end system check prior to emission testing is valuable in demonstrating that the overall measurement system is working properly. It evaluates many factors including proper implementation of transducer factors and cable attenuation, general condition and setting of the measurement receiver, damaged RF cables or attenuators, and proper operation of software. Details on implementation are included in the individual test procedures.*

#### 4.3.11.2 Antenna factors.

Factors for test antennas shall be determined in accordance with SAE ARP-958 or other acceptable test methods.

**Discussion:** *SAE ARP-958 provides a standard basis for determining antenna factors emission testing. A caution needs to be observed in trying to apply these factors in applications other than EMI testing. The two antenna technique for antennas such as the biconical and double ridge horns is based on far field assumptions, which are not met over much of the frequency range. Although the factors produce standardised results, the true value of the electric field is not necessarily being provided through the use of the factor. Different measuring sensors need to be used when the true electric field must be known.*

## 5. APPLICABILITY REQUIREMENTS

### 5.1 General

This section specifies details the test applicability requirements. Table 5 is a list of the specific requirements established by this standard identified by requirement number and title. Specific test procedures are implemented by approved EMITP as detailed in Section 6. All results of tests performed to demonstrate compliance with the requirements are to be documented in the EMITR and forwarded to the Command or agency concerned for evaluation prior to acceptance of the equipment or subsystem. Design procedures and techniques for the control of EMI shall be described in the EMICP. Approval of design procedures and techniques described in the EMICP does not relieve the supplier of the responsibility of meeting the contractual emission, susceptibility, and design requirements.

**Discussion:** *The applicability of individual requirements in Table 5 for a particular equipment or subsystem is dependent upon the platforms where the item will be used. The electromagnetic environments present on a platform together with potential degradation modes of electronic equipment items play a major role regarding which requirements are critical to an application. For example, emissions requirements are tied to protecting antenna-connected receivers on platforms. The operating frequency ranges and sensitivities of the particular receivers on-board a platform, therefore, influence the need for certain requirements.*

*The EMICP, EMITP, and EMITR are important elements in documenting design efforts for meeting the requirements of this standard, testing approaches, which interpret the generalised test procedures in this standard, and reporting of the results of testing. The EMICP is a mechanism instituted to help ensure that contractors analyse equipment design for EMI implications and include necessary measures in the design for compliance with requirements. Approval of the document does not indicate that the procuring activity agrees that all the necessary effort is stated in the document. It is simply a recognition that the design effort is addressing the correct issues.*

*The susceptibility limits are the upper bound on the range of values for which compliance is required. The EUT must also provide required performance at any stress level below the limit. For example, if the limit for radiated susceptibility to electric fields is 10 volts/metre, the EUT must also meet its performance requirements at 5 volts/metre or any other field less than or equal to 10 volts/metre. There have been cases documented where equipment (such as equipment with automatic gain control circuitry) was not susceptible to radiated electric fields at given frequencies at the limit level but was susceptible to the environment at the same frequencies when exposed to fields below the limit level.*

### 5.2 EMI control requirements versus intended installations

Table 6 shows the applicability of the test methods to each of the Land, Sea and Air service environments and should be read in conjunction with the more detailed discussion of applicability of each individual test method listed in section 6. In addition there are differences between Nations on where/whether a particular test should be applied. Table 7 shows each NATO Nation's individual testing requirement.

Where an equipment or subsystem is to be installed in more than one type of platform or installation, it shall comply with the most stringent of the applicable requirements and limits. Also where procurement is for more than one nation the requirements of each nation shall be addressed.

**Discussion:** *Discussion on each requirement as it relates to different platforms is contained with in later paragraphs of Section 6. These discussions explain where each test may be specifically required according to the type of platform/service or the types of sensor system fitted.*

Requirement	Description
NCE01	Conducted Emissions, Power Leads, 30 Hz to 10 kHz
NCE02	Conducted Emissions, Power Leads, 10 kHz to 10 MHz
NCE03	Conducted Emissions, Antenna Terminal, 10 kHz to 40 GHz
NCE04	Conducted Emissions, Exported Transients on Power Leads
NCE05	Conducted Emissions, Power, Control & Signal Leads, 30 Hz to 150 MHz
NCS01	Conducted Susceptibility, Power Leads, 30 Hz to 150 kHz
NCS02	Conducted Susceptibility, Control & Signal Leads, 20 Hz to 50 kHz
NCS03	Conducted Susceptibility, Antenna Port, Intermodulation, 15 kHz to 10 GHz
NCS04	Conducted Susceptibility, Antenna Port, Rejection of Undesired Signals, 30 Hz to 20 GHz
NCS05	Conducted Susceptibility, Antenna Port, Cross-Modulation, 30 Hz to 20 GHz
NCS06	Conducted Susceptibility, Structure Current, 60 Hz to 100 kHz
NCS07	Conducted Susceptibility, Bulk Cable Injection, 10 kHz to 200 MHz
NCS08	Conducted Susceptibility, Bulk Cable Injection, Impulse Excitation
NCS09	Conducted Susceptibility, Damped Sinusoidal Transients, Cables and Power Leads, 10 kHz to 100 MHz
NCS10	Conducted Susceptibility, Imported Lightning (Aircraft)
NCS11	Conducted Susceptibility, Imported Low Frequency on Power Leads (Ships)
NCS12	Conducted Susceptibility, Electrostatic Discharge
NRE01	Radiated Emissions, Magnetic Field, 30 Hz to 100 kHz
NRE02	Radiated Emissions, Electric Field, 10 kHz to 18 GHz
NRE03	Radiated Emissions, Antenna Spurious and Harmonic Outputs, 10 kHz to 40 GHz
NRS01	Radiated Susceptibility, Magnetic Field, 30 Hz to 100 kHz
NRS02	Radiated Susceptibility, Electric Field, 50 kHz to 40 GHz
NRS03	Radiated Susceptibility, Transient Electromagnetic Field
NRS04	Radiated Susceptibility, Magnetic Field, Susceptibility (DC)

**TABLE 5 Emission and susceptibility requirements.**

Equipment and Subsystems installed in, on, or launched from the following Platforms	Requirement Applicability																							
	NCE01	NCE02	NCE03	NCE04	NCE05	NCS01	NCS02	NCS03	NCS04	NCS05	NCS06	NCS07	NCS08	NCS09	NCS10	NCS11	NCS12	NRE01	NRE02	NRE03	NRS01	NRS02	NRS03	NRS04
Land	-	Y	P	Y	Y	Y	Y	P	P	P	-	Y	Y	Y	-	-	Y	Y	Y	P	Y	Y	P	-
Ships	P	Y	P	Y	Y	Y	Y	P	P	P	-	Y	P	Y	-	Y	P	Y	Y	P	Y	Y	P	Y
Submarines	Y	Y	P	Y	Y	Y	Y	P	P	P	P	Y	P	Y	-	Y	P	Y	Y	P	Y	Y	P	Y
Air	Y	Y	P	Y	Y	Y	Y	P	P	P	-	Y	Y	Y	Y	-	Y	Y	Y	P	Y	Y	P	-
Space Systems, Including Launch Vehicles	-	Y	P	-	-	Y		P	P	P	-	Y	Y	Y	-	-	-	-	Y	P	-	Y	-	-

**TABLE 6 Requirement Matrix.**

Key: Y Test is required for all equipment on this platform type.

P Test is partially applicable. Selection of the test should be based on knowledge of the installation and other co-located equipment's based on guidance for each test method given later in this section. These tests may also be specified/selected by the procurement authority.

No entry in the table means the test is not applicable to equipment on/in that service/platform.

- Notes:
- Where NCE05 Test is performed, it is not necessary to also undertake test NCE01.
  - NRS04 is only applicable where equipment/subsystem is installed on a platform fitted with a degaussing system or which may be subject to deperming.

Definitions:

- Land covers military applications that are primarily land based. It includes all military vehicles including armoured and transport vehicles that will be used in or close to front line systems. In addition it includes equipment in ground facilities, which are operated in proximity or directly connected to sensitive receiving equipment or weapon systems. Where such facilities are largely in a commercial setting or only a limited use of military equipment is required the procuring authority shall specify which of these tests or other commercial tests are required.
- Aircraft operated by all 3 services should be treated in the same manner. However, as explained in the discussion on individual test methods in Section 6, some tests may not be required if sensors of a particular type are not installed.
- Ship / Submarine application include all EUTs fitted on metallic and non-metallic military platforms which operate in open and littoral waters.

NATO NATION	Test Method and Applicability																								
	NCE01	NCE02	NCE03	NCE04	NCE05	NCS01	NCS02	NCS03	NCS04	NCS05	NCS06	NCS07	NCS08	NCS09	NCS10	NCS11	NCS12	NRE01	NRE02	NRE03	NRS01	NRS02	NRS03	NRS04	
Belgium																									
Bulgaria																									
Canada	Y	Y	Y	-	-	Y	-	-	-	Y	Y	Y	Y	Y	-	-	Y	Y	Y	Y	Y	Y	Y	Y	-
Czech Republic																									
Denmark																									
Estonia																									
France	Y	Y	Y	Y	Y	Y	Y	-	Y	-	Y	Y	Y	Y	Y	-	Y	Y	Y	-	Y	Y	Y	Y	
Germany																									
Greece																									
Hungary																									
Iceland																									
Italy																									
Latvia																									
Lithuania																									
Luxembourg																									
Netherlands(navy only)	Y	Y	-	-	-	Y	-	-	-	-	Y	Y	Y	Y	-	-	Y	Y	Y	-	Y	Y	Y	Y	-
Norway																									
Poland																									
Portugal																									
Romania																									
Slovakia																									
Slovenia																									
Spain																									
Turkey																									
United Kingdom	-	Y	-	Y	Y	Y	Y	-	-	-	-	Y	-	Y	Y	Y	Y	Y	Y	-	Y	Y	-	Y	
United States	Y	Y	Y	-	-	Y	-	Y	Y	Y	Y	Y	Y	Y	-	-	-	Y	Y	Y	Y	Y	Y	Y	-

TABLE 7 Tests required by NATO Nations.

Key: Y Test will be applied by that Nation

- Test will only be applied by that Nation if called up in procurement specification

Where no entries are made for a Nation the relevant authority/project office for that Nation should be consulted to determine the requirements for individual tests.

## 6 DETAILED TEST METHODS REQUIREMENTS

### 6.1 General

This section specifies detailed emissions and susceptibility requirements and the associated test procedures. General test procedures are included in this section.

### 6.2 Units of frequency domain measurements

All frequency domain limits are expressed in terms of equivalent Root Mean Square (RMS) value of a sine wave as would be indicated by the output of a measurement receiver using peak envelope detection (see paragraph 4.3.10.1).

**Discussion:** *A detailed discussion is provided on peak envelope detection in paragraph 4.3.10.1. A summary of output of the detector for several input waveforms is as follows. For an unmodulated sine wave, the output simply corresponds to the RMS value of the sine wave. For a modulated sine wave, the output is the RMS value of an unmodulated sine wave with the same absolute peak value. For a signal with a bandwidth greater than the bandwidth of the measurement receiver, the output is the RMS value of an unmodulated sine wave with the same absolute peak value as the waveform developed in the receiver bandpass.*

### 6.3 Emission and susceptibility requirements, limits, and test procedures

Individual emission or susceptibility requirements and their associated limits and test procedures are grouped together in the following sections. The applicable frequency range and limit of many emission and susceptibility requirements varies depending on the particular platform or installation. The test procedures included in this section are valid for the entire frequency range specified in the procedure; however, testing only needs to be performed over the frequency range specified for the particular platform or installation.

**Discussion:** *In this version of AECTP500, the test procedures for individual requirements follow directly after the applicability and limit statements. The discussion for the individual requirements is separated into these two areas.*

### 6.4 NCE01, conducted emissions, power leads, 30 Hz to 10 kHz

**Applicability and limits:** The requirements are applicable to leads that obtain power from sources that are not part of the EUT. There is no requirement on output leads from power sources.

This test need not be performed if test method NCE05 is being performed. See paragraph 5.2 and Applicability Tables 6 and 7.

The limits are in terms of current because of the difficulty in controlling the power source impedance in test facilities at lower frequencies. This type of control would be necessary to specify the limits in terms of voltage. Emission current levels will be somewhat independent of power source impedance variations as long as the impedance of the emission source is large relative to the power source impedance.

For submarines, the intent of this requirement is to control the effects of conducted emissions peculiar to the shipboard power distribution system. Harmonic line currents are limited for each electrical load connected to the power distribution system.

The submarine service power distribution system (ship's primary power) supplied by the submarine's alternators is 440 VAC, 60 Hz, 3-phase, 3-wire, ungrounded. Although ship's primary power is ungrounded, there exists a virtual alternating current (AC) ground at each electrical load due to capacitance to chassis. The unbalance between the virtual grounds at each electrical load causes AC currents to flow in the hull of the submarine. These hull currents can degrade the performance of electronic equipment, upset ground detectors, and counteract degaussing.

Hull currents are controlled by limiting the amplitude of harmonic currents conducted on the power distribution system wiring for each electrical load. The limit is based on maintaining total harmonic voltage distortion of the ship power distribution system within 5% of the supply voltage with the contribution from any single harmonic being less than 3%. In addition to the hull current concern, total harmonic distortion of the supply voltage waveform greater than 5% is above the tolerance of most electronic equipment, induction motors, magnetic devices, and measuring devices.

For air the primary concern is to ensure that the EUT does not corrupt the power quality (allowable voltage distortion) on the power buses present on the platform. In the case of aircraft using anti-submarine warfare (ASW) equipment it is the unacceptable levels of emission currents in the frequency range of this test that would limit the detection and processing capabilities of the Magnetic Anomaly Detection (MAD) and Acoustic Sensor systems.

The MAD systems must be able to isolate a magnetic disturbance in the earth's magnetic field of less than one part in 50,000. In present aircraft, the full sensitivity of the MAD systems is not available due to interference produced by onboard equipment. Low frequency interference effects in the 30 Hz to 10 kHz can be a problem for Acoustic Sensor systems.

Tailoring of the requirements by the procuring activity is to impose the requirement if sensitive receivers operating in the frequency range of the requirement are to be installed on a platform or to modify the limit based on the particular characteristics of the power system onboard the platform.

**Test procedures:** Emission levels are determined by measuring the current present on each power lead. The LISNs will have little influence on the results of this testing. The circuit characteristics of the LISN will help stabilise measurements near 10 kHz; however, the LISN parameters will not be significant over most of the frequency range of the test.

Current is measured because of the low impedances present over most of the frequency range of the test. Current levels will be somewhat independent of power source impedance variations as long as the impedance of the emission source is significant in relation to the power source impedance. However, at frequencies where the shielded room filters in the test facility resonate (generally between 1 and 10 kHz), influences on measured currents can be expected.

During the measurement system check, the signal generator may need to be supplemented with a power amplifier to obtain the necessary current 6 dB below the applicable limit.

The value of the resistor "R" in Figure NCE01-5 of Method NCE01 is not specified because a particular value is not critical. Whatever value is convenient for measurement and possible matching of the signal generator can be used.

A possible alternative measurement tool in this frequency range is a wave analyser using a Fast Fourier Transform algorithm. Use of this type of instrumentation requires specific approval by the procuring activity.

#### 6.5 NCE02, conducted emissions, power leads, 10 kHz to 10 MHz

**Applicability and limits:** The requirements are applicable to leads that obtain power from sources that are not part of the EUT. There is no requirement on output leads from power sources.

The basic concept in the lower frequency portion of the requirement is to ensure that the EUT does not corrupt the power quality (allowable voltage distortion) on the power buses present on the platform.

Since power quality standards govern allowable distortion on output power, there is no need for separate EMI requirements on output leads. The output power leads are treated no differently than any other electrical interface. This standard does not directly control the spectral content of signals present on electrical interfaces. Waveform definitions and distortion limits are specified in documents such as interface control documents. In the case of output power, the quality of the power must be specified over an appropriate frequency range so that the user of the power can properly design for its

characteristics. This situation is true whether the power source is a primary source such as 115 volts, 400 Hz, or a  $\pm 15$  VDC low current supply. A significant indirect control on spectral content exists in the NRE02 limits which essentially require that appropriate waveform control and signal transmission techniques be used to prevent unacceptable radiation (see discussion on NCE02 limit placement and NRE02 relationship below).

Since voltage distortion is the basis for establishing power quality requirements, the NCE02 limit is in terms of voltage. The use of a standardised line impedance over the frequency range of this test provides for the convenient measurement of the voltage as developed across this impedance.

At higher frequencies, the NCE02 limit serves as a separate control from NRE02 on potential radiation from power leads that may couple into sensitive antenna-connected receivers. The NCE02 limits have been placed to ensure that there is no conflict with the NRE02 limit. Emissions at the NCE02 limit should not radiate above the NRE02 limit. Laboratory experiments on coupling from a 2.5 metre power lead connected to a line impedance stabilisation network have shown that the electric field detected by the NRE02 rod antenna is flat with frequency up to approximately 10 MHz and is approximately equal to  $(x-40)$  dB $\mu$ V/m, where "x" is the voltage expressed in dB $\mu$ V. For example, if there is a signal level of 60 dB $\mu$ V on the lead, the detected electric field level is approximately 20 dB $\mu$ V/m.

Tailoring of the requirements in contractual documents may be desirable by the procuring activity. Adjusting the limit line to more closely emulate a spectral curve for a particular power quality standard is one possibility. Contributions from multiple interference sources need to be considered as noted above. If antenna-connected receivers are not present on the platform at the higher frequencies, tailoring of the upper frequency of the requirement is another possibility. The requirement is limited to an upper frequency of 10 MHz due to the allowable 2.5 metre length of power lead in the test set-up approaching resonance. Any conducted measurements become less meaningful above this frequency. If tailoring is done to impose the requirement at higher frequencies, the test set-up should be modified for NCE02 to shorten the allowable length of the power leads.

**Test procedures:** Emission levels are determined by measuring the voltage present at the output port on the 50  $\mu$ H LISN.

The power source impedance control provided by the LISN is a critical element of this test. This control is imposed due to wide variances in characteristics of shielded room filters and power line impedances among various test agencies and to provide repeatability through standardisation. The LISN standardises this impedance. The impedance present at the EUT electrical interface is influenced by the circuit characteristics of the power lead wires to the LISNs. The predominant characteristic is inductance. The impedance starts to deviate noticeably at approximately 1 MHz where the lead inductance is about 13  $\Omega$ .

A correction factor must be included in the data reduction to account for the 20 dB attenuator and for voltage drops across the coupling capacitor. This capacitor is in series with a parallel combination of the 50  $\Omega$  measurement receiver and the 1 k $\Omega$  resistor in the 50  $\mu$ H LISN. The two parallel resistances are equivalent to 47.6  $\Omega$ . The correction factor equals:

$$20 \log_{10} (1 + 5.60 \times 10^{-9} f^2)^{1/2} / (7.48 \times 10^{-5} f)$$

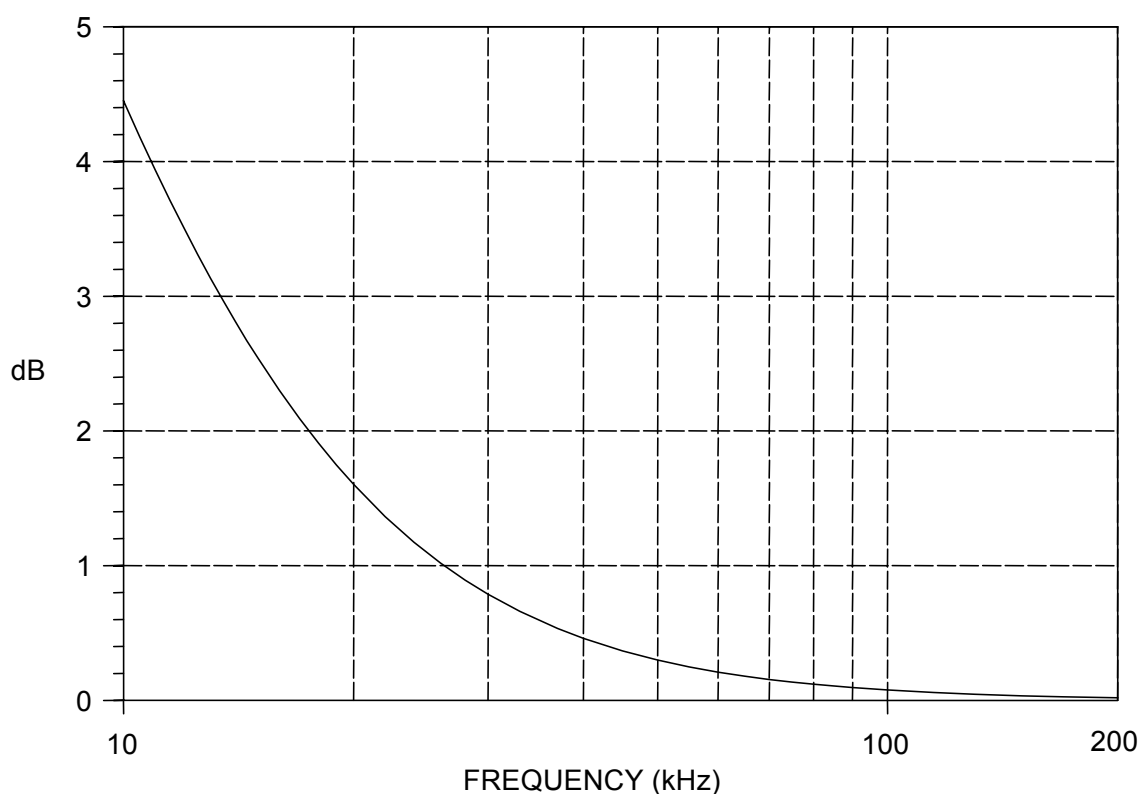
Where f is the frequency of interest expressed in Hz. This equation is plotted in Figure 13. The correction factor is 4.45 dB at 10 kHz and drops rapidly with frequency.

The upper measurement frequency is limited to 10 MHz because of resonance conditions with respect to the length of the power leads between the EUT and 50  $\mu$ H LISN. As noted in paragraph 4.3.8.6.2, these leads are between 2.0 and 2.5 metres long. Laboratory experimentation and theory show a quarter-wave resonance close to 25 MHz for a 2.5 metre lead. In the laboratory experiment, the impedance of the power lead starts to rise significantly at 10 MHz and peaks at several thousand  $\Omega$  at

approximately 25 MHz. Voltage measurements at the 50  $\mu$ H LISN become largely irrelevant above 10 MHz.

The 0.25  $\mu$ F coupling capacitor in the 50  $\mu$ H LISN allows approximately 3.6 volts to be developed across the 50  $\Omega$  termination on the signal port for 115 volt, 400 Hz, power sources. The 20 dB attenuator is specified in the test procedure to protect the measurement receiver and to prevent overload. Sources of 60 Hz pose less of a concern.

An oscilloscope is necessary for the measurement system check in Figure NCE02-1 to ensure that the actual applied voltage is measured accurately at 10 kHz and 100 kHz and maintains a sinusoidal shape. The 50  $\mu$ H LISN presents a 50  $\Omega$  load impedance to a 50  $\Omega$  signal generator only for frequencies of approximately 300 kHz or higher (see Figures 9 & 10). Since a 50  $\Omega$  signal generator is essentially an ideal voltage source in series with 50  $\Omega$ , the amplitude display setting of the generator is correct only when it is terminated in a matched impedance of 50  $\Omega$ . Under this condition the voltage splits between the two 50  $\Omega$  resistances. If the output is measured directly with a high impedance instrument, such as an oscilloscope, the indicated voltage is twice the amplitude setting. The load seen by the signal generator varies with frequency and the voltage at the 50  $\mu$ H LISN will also vary.



**FIGURE 13** Correction factor for LISN capacitor.

An area of concern for this test procedure is the potential to overload the measurement receiver due to the line voltage at the power frequency. Overload precautions are discussed in paragraph 4.3.7.3. When an overload condition is predicted or encountered, a rejection filter can be used to attenuate the power frequency. A correction factor must be then included in the emission data to account for the filter loss with respect to frequency.

## 6.6 NCE03, conducted emissions, antenna terminal, 10 kHz to 40 GHz

**Applicability and limits:** The requirement is applicable for transmitters, receivers and amplifiers. The basic concern is to protect antenna-connected receivers both on and off the platform from being degraded due to radiated interference from the antenna associated with the EUT. The limit for transmitters in the transmit mode is placed primarily at levels which are considered to be reasonably obtainable for most types of equipment. Suppression levels that are required to eliminate all potential electromagnetic compatibility situations are often much more severe and could result in significant design penalties. The limit for receivers and transmitters in standby is placed at a level that provides reasonable assurance of compatibility with other equipment. Common requirements are specified for all applications since the concerns are the same for all platforms.

As an example of an antenna coupling situation, consider a 10 watt VHF-AM transmitter operating at 150 MHz and a UHF-AM receiver with a sensitivity of -100 dBm tuned to 300 MHz with isotropic antennas located 10 metres apart. The requirement is that the transmitter second harmonic at 300 MHz must be down  $50 + 10 \log 10 = 60$  dB.

The free space loss equation.

$$P_R/P_T = (\lambda^2 G_T G_R)/(4\pi R)^2$$

indicates an isolation of 42 dB between the two antennas for the following conditions.

$P_R$	=	Received Power	$G_R$	=	Receive Antenna Gain	=	1
$P_T$	=	Transmitted Power	$G_T$	=	Transmitter Antenna Gain	=	1
$\lambda$	=	Wavelength	=	1 metre	$R$	=	Distance between Antennas = 10 metres

A second harmonic at the limit would be  $60 + 42 = 102$  dB down at the receiver. 102 dB below 10 Watts (40 dBm) is -62 dBm, which is still 38 dB above the receiver sensitivity. The level that is actually required not to cause any degradation in the receiver is -123 dBm. This value results because the worst-case situation occurs when the interfering signal is competing with the sidebands of the intentional signal with a signal amplitude at the receiver sensitivity. For a standard tone of 30% AM used to verify sensitivity, the sidebands are 13 dB down from the carrier and a 10 dB signal-to-noise ratio is normally specified. To avoid problems, the interfering signal must, therefore, be  $13 + 10 = 23$  dB below -100 dBm or -123 dBm. This criterion would require the second harmonic to be 121 dB down from the transmitter carrier that could be a difficult task. Harmonic relationships can sometimes be addressed through frequency management actions to avoid problems.

Assessing the  $34 \text{ dB}\mu\text{V}$  (-73 dBm) requirement for standby, the level at the receiver would be -115 dBm, which could cause some minimal degradation in the presence of a marginal intentional signal.

Greater antenna separation or antenna placement not involving direct line of sight would improve the situation. Also, the VHF antenna may be poorer than isotropic in the UHF band. NCE106 does not take into account any suppression associated with frequency response characteristics of antennas; however, the results of the case cited are not unusual. NRE03, which is a radiated emission control on spurious and harmonic outputs, includes assessment of antenna characteristics.

Since the free space loss equation indicates that isolation is proportional to the wavelength squared, isolation values improve rapidly as frequency increases. Also, antennas are generally more directional in the GHz region and receivers tend to be less sensitive due to larger bandwidths.

The procuring activity may consider tailoring contractual documents by establishing suppression levels based on antenna-to-antenna coupling studies on the particular platform where the equipment will be used. Another area could be relaxation of requirements for high power transmitters. The standard suppression levels may result in significant design penalties. For example, filtering for a 10,000 watt

HF transmitter may be excessively heavy and substantially attenuate the fundamental frequency. Engineering trade-offs may be necessary.

**Test procedures:** Since the test procedures measure emissions present on a controlled impedance, shielded, transmission line, the measurement results should be largely independent of the test set-up configuration. Therefore, it is not necessary to maintain the basic test set-up described in the main body of this standard.

The NCE03 procedure uses a direct coupled technique and does not consider the effect that the antenna system characteristics will have on actual radiated levels.

The selection of modulation for transmitters and frequency, input power levels, and modulation for amplifiers can influence the results. The procedure requires that parameters that produce the worst-case emission spectrum be used. The most complicated modulation will typically produce the worst-case spectrum. The highest allowable drive level for amplifiers usually produces the worst harmonics and spurious outputs. However, some amplifiers with automatic gain controls may produce higher distortion with drive signals set to the lowest allowable input due to the amplifier producing the highest gain levels. The details of the analysis on the selection of test parameters shall be included in the EMITP.

Figure NCE03-3 of Method NCE03 is used for receivers and transmitters in the stand-by mode. The purpose of the attenuator pad in Figure NCE03-3 of Method NCE03 is to establish a low VSWR for more accurate measurements. Its nominal value is 10 dB, but it can be smaller, if necessary, to maintain measurement sensitivity.

The set-up in Figure NCE03-1 of Method NCE03 is used for low power transmitters in which the highest intentionally generated frequency does not exceed 40 GHz. The attenuator pad should be approximately 20 dB or large enough to reduce the output level of the transmitter sufficiently so that it does not damage or overload the measurement receiver. The rejection network in the figure is tuned to the fundamental frequency of the EUT and is intended to reduce the transmitter power to a level that will not desensitize or induce spurious responses in the measurement receiver. Both the rejection network and RF pad losses must be adjusted to maintain adequate measurement system sensitivity. The total power reaching the measurement receiver input should not exceed the maximum allowable level specified by the manufacturer. All rejection and filter networks must be calibrated over the frequency range of measurement.

The set-up of Figure NCE03-2 of Method NCE03 is for transmitters with high average power. For transmitters with an integral antenna, it is usually necessary to measure the spurious emissions by the radiated procedures of NRE03.

Some caution needs to be exercised in applying Table 2. For spurious and harmonic emissions of equipment in the transmit mode, it is generally desirable for the measurement receiver bandwidth to be sufficiently large to include at least 90% of the power of the signal present at a tuned frequency. This condition is required if a comparison is being made to a power requirement in a specification. Spurious and harmonic outputs generally have the same modulation characteristics as the fundamental. Since this procedure measures relative levels of spurious and harmonic signal with respect to the fundamental, it is not necessary for the measurement receiver to meet the above receiver bandwidth to signal bandwidth criterion. However, if the measurement receiver bandwidth does not meet the criterion and spurious and harmonic outputs are located in frequency ranges where this standard specifies a bandwidth different than that used for the fundamental. Then the measurement receiver bandwidth should be changed to that used at the fundamental to obtain a proper measurement.

For EUTs having waveguide transmission lines, the measurement receiver needs to be coupled to the waveguide by a waveguide to coaxial transition. Since the waveguide acts as a high-pass filter, measurements are not necessary at frequencies less than  $0.8 f_{co}$ , where  $f_{co}$  is the waveguide cut-off frequency.

## 6.7 NCE04, conducted emissions, exported transients on power leads

**Applicability and limits:** Where specified by the procuring authority NCE04 shall be performed on AC & DC primary power cables, which interface with the platform power supply.

Contacting switching transients are generated by switching the EUT on and off using an external supply contactor of the type to be used in its final installation. If the contactor type is not known or unavailable, then an alternative of suitable type and current rating may be used.

Functional switching transients are generated by switching the EUT on and off using the power switch on the EUT, if fitted. Additionally, functional switching transients may be generated by operation of the EUT, i.e. while operating the EUT over its normal operating sequence and exercising the EUT through its full range of functions.

**Test procedures:** The purpose of this test is to measure the amplitude and duration of transients appearing on primary power lines caused by the normal operation of the EUT and also as a result of switching on and off the power supply to the EUT. These transient emissions may couple via conduction and radiation from the power lines to other potentially susceptible equipment in the actual installation.

For AC supplies, a twin 'T' notch filter may be used to filter the power supply frequency. With the power frequency filtered, any transients shown on the oscilloscope are relative to the AC waveform when measured between the transients peak and the oscilloscope's reference level.

The accurate measurement of transient amplitude in conducting this test may sometimes be prejudiced by the high amplitude response at the power supply frequency. The following describes the design of a twin-T filter, tuned to the supply frequency, which is connected at the oscilloscope input, in tandem with a voltage probe, which attenuates the power supply frequency response by at least 30 dB.

Figure 14 shows a typical x10 voltage probe connected via a twin-T filter to an oscilloscope. For simplicity, the additional components necessary to ensure broad-band performance are not shown. Typical component values for the probe and oscilloscope are  $Z_1 = 9 \text{ M}\Omega$  and  $Z_0 = 1 \text{ M}\Omega$ , giving a x10 attenuation. For probes with both series and shunt resistances  $Z_1$  should be calculated as the output impedance of the probe.

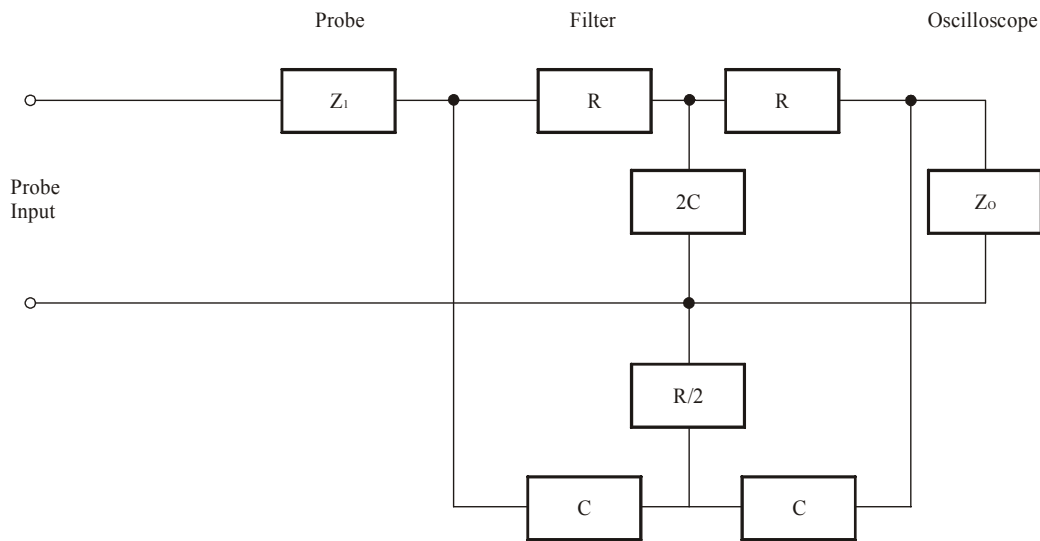
Given the impedances of the probe and oscilloscope combination to be used, the component values of the twin-T network may now be calculated for the chosen power frequency  $f_0$ . To ensure symmetry of the twin-T response at frequencies well above and below  $f_0$ .

$$\text{Let } R = \sqrt{(2Z_1Z_0)} \text{ and } 2R = 2\sqrt{(2Z_1Z_0)}$$

To locate the notch frequency at  $f_0$  let  $\omega_0 = 2\pi f_0$  then  $C = 1/R\omega_0$  and  $2C = 2/R\omega_0$

The use of 1% tolerance components, in series and parallel combinations to achieve the calculated values, is usually satisfactory. The filter components should be installed in a screened box with short connections between them. Note that the overall attenuation from probe input to oscilloscope input, at frequencies well above the notch frequency is  $A = Z_0/(Z_1+2R+Z_0)$  rather than  $Z_0/(Z_1+Z_0)$  without the filter. For a x10 probe and a notch frequency of 50 Hz the probe attenuation without the filter is 20 dB while with the filter it is 25.3 dB at all frequencies except in the vicinity of the notch frequency. The attenuation exceeds 35 dB between 30 Hz and 82 Hz and exceeds 55 dB within  $\pm 5\%$  of the notch frequency.

It will be necessary to calibrate the attenuation of the probe/filter/oscilloscope combination over the required frequency range to check that the notch frequency has been sufficiently centred on the power frequency and the attenuation away from the notch frequency is constant near the design value. This attenuation value will be used to determine the true transient amplitude. At this stage it may be necessary to optimise the broad-band performance of the probe using the adjustments provided in the probe and then re-calibrate.



**FIGURE 14 Basic Circuit for NCE04 Probe/Filter/Oscilloscope Combination.**

Alternatively, a fast acquisition digital oscilloscope may be used to store the data. Although the power supply frequency is not filtered, measurement of all transient types can be made with reference to the AC waveform. This is achieved by reducing the timebase, effectively zooming in on the transient using the data stored within the oscilloscope.

It should be noted that different limits may apply for systems operating at power line frequencies or voltages other than those specified in this section. In these cases the Procuring Authority may adjust the limits accordingly.

Prior to performing the test the contactor shall be validated. To ascertain that transient levels consistent with contact bounce do not mask those caused by the EUT, the test house shall ensure that the contactor meets the following validation. The set up shall be based on that given in Figures NCE04-2 and NCE04-3 of test NCE04. The difference being resistive load substitutes the EUT with a 10 $\mu$ F capacitor on each lead to the ground plane and the oscilloscope probes connected directly onto either side of the contactor. The value of the load shall be such that the same current is drawn from the power source as when the EUT is connected.

6.8 NCE05, conducted emission, power, signal and control leads, 30 Hz to 150 MHz

**Applicability and limits:** This requirement is applicable to all power, signal and control leads connected to a EUT that are greater than 1 m in length. Particular attention should be given to leads that are installed in the same conduit, trunking or cable bundles as those of other systems fitted to the same platform where cross coupling can readily occur. Where internal EUT cables interface between different component parts of the EUT only and no part of the installation is closer than 15 cm to external cabling then these may be excluded from this test.

Where fibre optic cables that have a protective conducting sheaf, are used within an installation, they may also be subject to this test if run in close proximity to other cable harnesses or interference sources.

This requirement is also applicable for power leads, including returns that obtain power from other sources not part of the EUT for Land, Sea and Air applications.

For AC applications, this requirement is applicable starting at the second harmonic of the EUT power frequency.

This requirement is performed to control the levels of conducted interference appearing on EUT cabling which could couple to adjacent cabling from other systems installed on the same platform.

Reference shall be made to the Applicability Tables 6 and 7 in Category 501 before subjecting the EUT to this test method. Where some procuring authorities require testing to a higher frequency than normally covered by NCE02 then NCE05 should be used. If NCE05 is performed on the input power leads of a EUT then it is permissible to omit NCE01 and NCE02 testing.

**Test procedures:** During application of this test the 5  $\mu$ H LISN must be used throughout as its impedance characteristic remains more stable at higher frequencies than that of the 50  $\mu$ H LISN used in other test procedures.

When using current probes care should be taken to make sure that the cable under test passes through the centre of the internal aperture so that measurements are more repeatable. This can most easily be achieved with the use of a former of some kind that holds the cable in place. When placing current probes on cabling minimise the effect of neighbouring cable harnesses on the measurement by maintaining the maximum separation distance to them.

Current probes should be positioned at a point 5 cm from each LISN terminal stud on each power lead tested. Supplies and their returns should be tested separately (common mode) and not as pairs (differential mode). Current probes should be positioned 5 cm from the EUT connector back shell of each signal and control lead being tested. Where signal or control leads are longer than 2 m then testing is required at both ends of the cable at frequencies above 30 MHz.

Ambient measurements are made on power leads prior to EUT testing with the EUT replaced by a resistive load drawing the same steady state current. Ambient measurements on signal and control lines are performed at the same location as the EUT measurement but with the EUT switched off. All EUT exercising equipment must be fully functional and connected in circuit during all ambient measurements, although it is understood that in some circumstances full functionality may not be achievable due to required interaction with the EUT. Care should be taken not to introduce additional interference from exercising equipment and wherever possible this should be of a passive nature or filtered to minimise interference levels.

For the purpose of the test the EUT should be powered and in its normal mode of operation throughout and some means of indication should be present to establish its correct operation.

6.9 NCS01, conducted susceptibility, power leads, 30 Hz to 150 kHz

**Applicability and limits:** The requirement is applicable to power input leads that obtain power from other sources that are not part of the EUT. There is no requirement on power output leads. The basic concern is to ensure that equipment performance is not degraded from ripple voltages associated with allowable distortion of power source voltage waveforms.

The required signal is applicable only to the high sides on the basis that the concern is developing a differential voltage across the power input leads to the EUT. The series injection technique in the test procedure results in the voltage dropping across the impedance of the EUT power input circuitry. The impedance of the power return wiring is normally insignificant with respect to the power input over most of the required frequency range. Common mode voltages evaluations are addressed by other susceptibility tests such as NCS07 and NRS02. Injection on a power return will result in the same differential voltage across the power input; however, it will result in a large voltage at the return connection to the EUT with respect to the ground plane, which is considered unrealistic.

Similar to NCE02, the limits are based on a review of the power quality standards with emphasis toward the spectral content curves present in MIL-STD-704. Rather than having a separate curve for each possible power source voltage, only two curves are specified. The voltage amplitude specified is

approximately 6 dB above typical power quality limits, although the limit has been somewhat generalised to avoid complex curves. The margin between the limit and the power quality standard is necessary to allow for variations in performance between manufactured items.

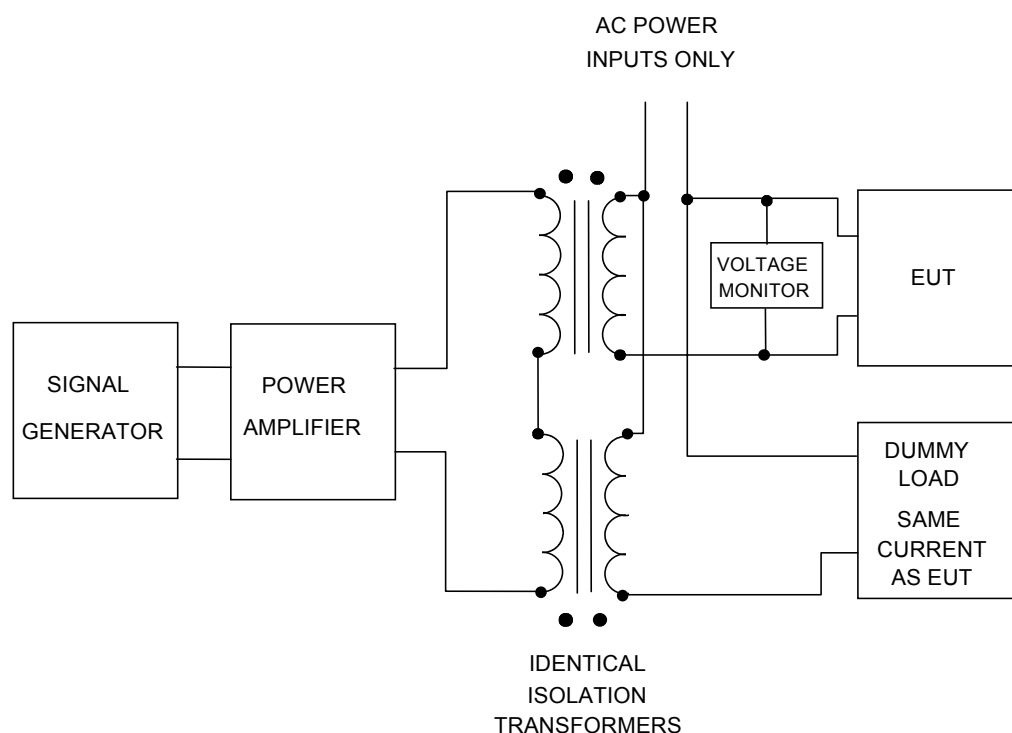
The difference between the limits for NCE02 and NCS01 of approximately 26 dB should not be viewed as a margin. The NCE02 limit is placed so that ripple voltages do not exceed that allowed by the power quality standards due to interference contributions from multiple EUTs. Therefore, the power quality standard is the only valid basis of comparison.

The primary tailoring consideration for the procuring activity for contractual documents is adjustment of the limit to follow more closely a particular power quality standard.

**Test procedures:** Since the applied voltage is coupled in series using a transformer, Kirchoff's voltage law requires that the voltage appearing across the transformer output terminals must drop around the circuit loop formed by the EUT input and the power source impedance. The voltage level specified in the limit is measured across the EUT input because part of the transformer induced voltage can be expected to drop across the source impedance.

Earlier EMI standards introduced a circuit for a phase shift network, which was intended to cancel out AC power waveforms and allow direct measurement of the ripple present across the EUT. While these devices very effectively cancel the power waveform, they return the incorrect value of the ripple and are not acceptable for use. The networks use the principle of inverting the phase of the input power waveform, adding it to the waveform (input power plus ripple) across the EUT, and presumably producing only the ripple as an output. For a clean power waveform, the network would perform properly. However, the portion of the ripple that drops across the power source impedance contaminates the waveform and gets recombined with the ripple across the EUT resulting in an incorrect value.

Voltages will appear across the primary side of the injection transformer due to the EUT current load at the power frequency. Larger current loads will result in larger voltages and are the predominant concern. These voltages can cause potential problems with the power amplifier. The circuit arrangement in Figure 15 will substantially reduce this voltage and provide protection for the amplifier. This effect is accomplished by using a dummy load equal to the EUT and wiring the additional transformer so that its induced voltage is equal to and 180 degrees out of phase with the induced voltage in the injection transformer. If possible, the dummy load should have the same power factor as the EUT.



**FIGURE 15 NCS01 Power amplifier protection.**

On initial turn on, DC-to-DC power switching converters can create large voltages on the primary side of the injection transformer that can damage the power amplifier. A precaution is to place a  $5 \Omega$  resistor across the primary and to disconnect the transformer during initial turn on.

The injected signal should be maintained as a sinusoid. Saturation of the power amplifier or coupling transformer may result in a distorted waveform.

If the return side of power is not connected to the shielded room ground, the oscilloscope may need to be electrically "floated" using an isolation transformer to correctly measure the injected voltage resulting in a potential shock hazard. Differential probe amplifiers are available which will convert a differential measurement between the high side and an isolated ground to a single-ended measurement where the measurement device can be grounded. These probes have an output that is suitable for measurement with either an oscilloscope or a high impedance, frequency selective, receiver (provided the receiver can tolerate the high input voltage).

6.10 NCS02, conducted susceptibility, control and signal leads, 30 Hz to 50 kHz.

**Applicability and limits:** This test is applicable to all control and signals leads connected to the EUT. Cables, which include power supply leads together with control and signal leads are also subject to this test and shall be tested as a bundle.

This test is only applicable to cables in excess of 1 metre in length. The effective coupling between cables is dependent upon length and separation. Electromagnetic radiation is produced by conductors in which currents or voltages are changing. In the near field (i.e. at distances less than  $\lambda/2\pi$  at the relevant frequency) the induction components are dominant but these components

decrease rapidly with distance (proportional to  $1/d^2$  or  $1/d^3$  at a distance  $d$ ). In the far field (i.e. at distances greater than  $\lambda/2\pi$ ) the radiation field, which varies as  $1/d$ , is dominant.

The purpose of this test is to ensure that EUTs are not susceptible to low frequency induced ripple from adjacent cabling.

The limits for this test are representative of those typically found in most military installations and have been derived by empirical measurements. The procuring authority should give consideration to tailoring the limits at frequencies where high-level ripple is expected.

**Test procedures:** The test wire shall be of suitable current rating and flexible enough to enable close coupling to the cable bundle under test. It shall consist of 3 turns evenly distributed over a straight 1 metre length of the cable bundle under test.

The test wire shall be fixed as described above to ensure that the test set up is maintained both between individual test set-ups and throughout the duration of each test. The cable bundle under test shall be mounted on 50 millimetre non-conducting spacers with respect to the ground plane.

The test signal shall consist of an unmodulated carrier wave and shall be maintained at the test limit current across the test frequency range. Measurement of the current in the test wire can be made using a suitable measurement instrument in peak mode, but calibrated in RMS.

#### 6.11 NCS03, conducted susceptibility, antenna port, intermodulation, 15 kHz to 10 GHz

**Applicability and limits:** The intent of this requirement is to control the response of antenna-connected receiving subsystems to in-band signals resulting from potential intermodulation products of two signals outside of the intentional passband of the subsystem produced by non-linearities in the subsystem. The requirement can be applied to receivers, transceivers, amplifiers, and the like. Due to the wide diversity of subsystem designs being developed, the applicability of this type of requirement and appropriate limits need to be determined for each procurement. Also, requirements need to be specified that are consistent with the signal processing characteristics of the subsystem and the particular test procedures to be used to verify the requirement.

One approach for determining levels required for the out-of-band signals is from an analysis of the electromagnetic environments present and characteristics of receiving antennas. However, levels calculated by this means will often place unreasonable design penalties on the receiver. For example, if an external environment of 200 volts/metre is imposed on a system, an isotropic antenna at 300 MHz will deliver 39 dBm to the receiver. This level represents a severe design requirement to many receivers. An alternative approach is to simply specify levels that are within the state-of-the-art for the particular receiver design.

This requirement is most applicable to fixed frequency, tuneable, superheterodyne receivers. Previous versions of this standard required normal system performance with the two out-of-band signals to be 66 dB above the level required to obtain the standard reference output for the receiver. One signal was raised to 80 dB above the reference in the 2 to 25 MHz and 200 to 400 MHz bands to account for transmissions from HF and UHF communication equipment. Maximum levels for both signals were limited to 10 dBm. As an example, conventional communication receivers commonly have sensitivities on the order of -100 dBm. For this case, the 66 dB above reference signal is at -34 dBm and the 80 dB above reference signal is at -20 dBm. Both are substantially below the 10 dBm maximum used in the past.

For other types of receivers, application of this requirement is often less straightforward and care must be taken to ensure that any applied requirements are properly specified. Many receivers are designed to be interference or jam resistant and this feature may make application of this requirement difficult or inappropriate.

One complicating factor is that one of the out-of-band signals typically is modulated with a waveform normally used by the receiver. For receivers that process a very specific modulation, the issue exists

whether an out-of-band signal can reasonably be expected to contain that modulation. Another complicating factor is related to the potential intermodulation products resulting from two signals. Responses from intermodulation products can be predicted to occur when  $f_o = mf_1 \pm nf_2$  where  $f_o$  is the operating frequency of the receiver,  $m$  and  $n$  are integers, and  $f_1$  and  $f_2$  are the out-of-band signals. For receivers, which continuously change frequency (such as frequency agile or frequency hopping), the relationship will be true only for a portion of the operating time of the receiver, unless the out-of-band signals are also continuously tuned or the receiver operating characteristics are modified for the purpose of evaluation.

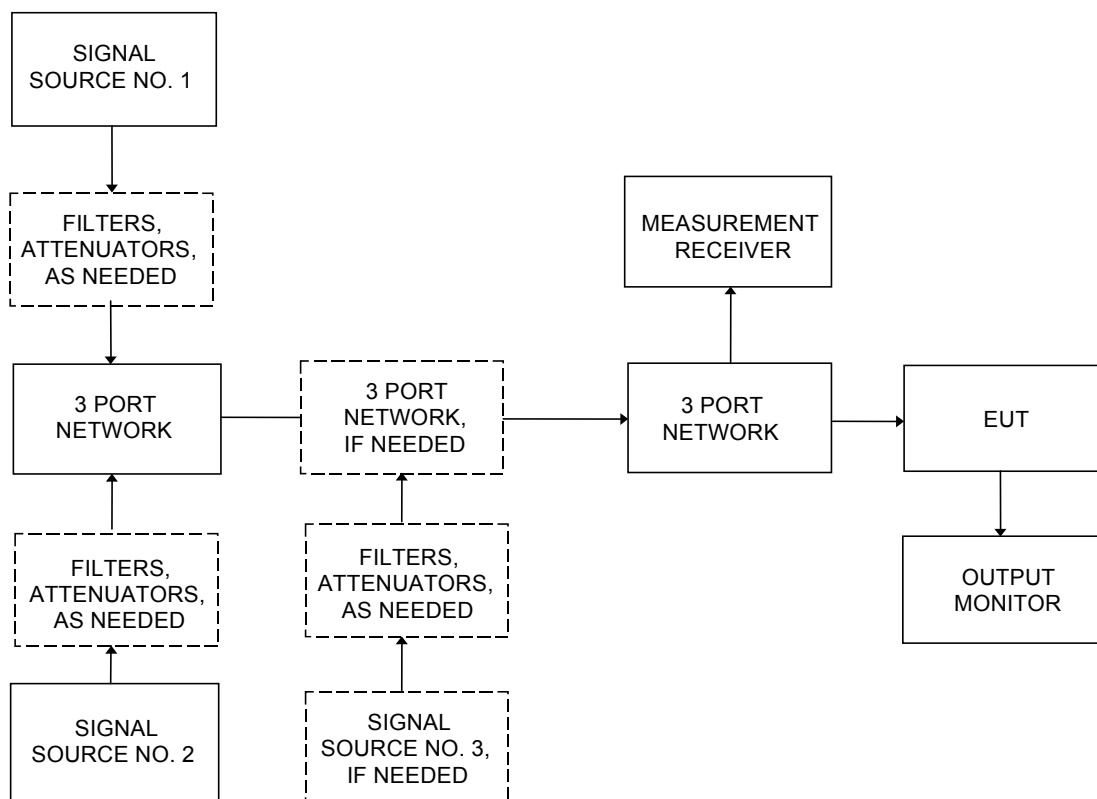
**Test procedures:** No test procedures are provided in the main body of this standard for this requirement. Because of the large variety of receiver designs being developed, the requirements for the specific operational characteristics of a receiver must be established before meaningful test procedures can be developed. Only general testing techniques are discussed in this appendix.

Intermodulation testing can be applied to a variety of receiving subsystems such as receivers, RF amplifiers, transceivers and transponders.

Several receiver front-end characteristics must be known for proper testing for intermodulation responses. These characteristics generally should be determined by test. The maximum signal input that the receiver can tolerate without overload needs to be known to ensure that the test levels are reasonable and that the test truly is evaluating intermodulation effects. The bandpass characteristics of the receiver are important for determining frequencies near the receiver fundamental  $f_o$  that will be excluded from test. Requirements for this test are generally expressed in terms of a relative degree of rejection by specifying the difference in level between potentially interfering signals and the established sensitivity of the receiver under test. Therefore, determination of the sensitivity of the receiver is a key portion of the test.

The basic concept with this test is to combine two out-of-band signals and apply them to the antenna port of the receiver while monitoring the receiver for an undesired response. One of the out-of-band signals is normally modulated with the modulation expected by the receiver. The second signal is normally continuous wave (CW). Figure 16 shows a general set-up for this test. For applications where the receiver would not provide an indication of interference without a receive signal being present, a third signal can be used at the fundamental. This arrangement may also be suitable for some receivers that process a very specialised type of modulation, which would never be expected on an out-of-band signal. An option is for the two out-of-band signals to be CW for this application.

The frequency of the two out-of-band signals should be set such that  $f_o = 2f_1 - f_2$  where  $f_o$  is the tuned frequency of the receiver and  $f_1$  and  $f_2$  are the frequencies of the signal sources. This equation represents a third order intermodulation product, which is the most common response observed in receivers.  $f_1$  and  $f_2$  should be swept or stepped over the desired frequency range while maintaining the relationship in the equation. It is important to verify that any responses noted during this test are due to intermodulation responses. Responses can result from simply lack of rejection to one of the applied signals or from harmonics of one of the signal sources. Turning off each signal source in turn and noting whether the response remains can demonstrate the source of the response.



**FIGURE 16 NCS03 General test set-up.**

For receivers with front-end mixing and filtering in an antenna module, the test may need to be designed to be performed on a radiated basis. All signals would need to be radiated and assurances provided that any observed intermodulation products are due to the receiver and not caused by items in the test area. The EMITP would need to address antenna types, antenna locations, antenna polarisation and field measurement techniques. This test would probably need to be performed in an anechoic chamber.

For frequency hopping receivers, one possible approach is choose an  $f_0$  within the hop set and set up the signals sources as described above. The performance of the receiver could then be evaluated as the receiver hops. If the frequency hopping receiver has a mode of operation using just one fixed frequency, this mode should also be tested.

A common error made in performing this test procedure is attributing failures to the EUT, which are actually harmonics of the signal source or intermodulation products generated in the test set-up. Therefore, it is important to verify that the signals appearing at the EUT antenna port are only the intended signals through the use of a measurement receiver as shown in Figure 16. Damaged, corroded, and faulty components can cause signal distortion resulting in misleading results. Monitoring will also identify path losses caused by filters, attenuators, couplers, and cables.

Typical data for this test procedure for the EMITR are the sensitivity of the receiver, the levels of the signal sources, frequency ranges swept, operating frequencies of the receivers, and frequencies and threshold levels associated with any responses.

- 6.12 NCS04, conducted susceptibility, antenna port, rejection of undesired signals, 30 Hz to 20 GHz

**Applicability and limits:** The intent of this requirement is to control the response of antenna-connected receiving subsystems to signals outside of the intentional passband of the subsystem. The requirement can be applied to receivers, transceivers, amplifiers, and the like. Due to the wide diversity of subsystem designs being developed, the applicability of this type of requirement and appropriate limits need to be determined for each procurement. Also, requirements need to be specified that are consistent with the signal processing characteristics of the subsystem and the particular test procedures to be used to verify the requirement.

One approach for determining levels required for the out-of-band signal can be determined from an analysis of the electromagnetic environments present and characteristics of receiving antennas. However, levels calculated by this means will often place unreasonable design penalties on the receiver. For example, if an external environment of 200 volts/metre is imposed on a system, an isotropic antenna at 300 MHz will deliver 39 dBm to the receiver. This level represents a severe design requirement to many receivers. An alternative approach is to simply specify levels that are within the state-of-the-art for the particular receiver design.

This requirement is most applicable to fixed frequency, tuneable, superheterodyne receivers.

For other types of receivers, application of this requirement is often less straightforward and care must be taken to ensure that any applied requirements are properly specified. Many receivers are designed to be interference or jam resistant and this feature may make application of this requirement difficult or inappropriate.

This requirement is usually specified using either one or two signals. With the one signal requirement, the signal is out-of-band to the receiver and is modulated with a waveform normally used by the receiver. No in-band signal is used. For receivers that process a very specific modulation, the issue exists whether an out-of-band signal can reasonably be expected to contain that modulation. An alternative is to specify the requirement for two signals. An in-band signal can be specified which contains the normal receiver modulation. The out-of-band signal can be modulated or unmodulated with the criterion being that no degradation in reception of the intentional signal is allowed.

**Test procedures:** No test procedures are provided in the main body of this standard for this requirement. Because of the large variety of receiver designs being developed, the requirements for the specific operational characteristics of a receiver must be established before meaningful test procedures can be developed. Only general testing techniques are discussed here.

Front-end rejection testing can be applied to a variety of receiving subsystems such as receivers, RF amplifiers, transceivers, and transponders.

Several receiver front-end characteristics must be known for proper testing. These characteristics generally should be determined by test. The maximum signal input that the receiver can tolerate without overload needs to be known to ensure that the test levels are reasonable. The bandpass characteristics of the receiver are important for determining frequencies near the receiver fundamental that will be excluded from testing. Requirements for this test are often expressed in terms of a relative degree of rejection by specifying the difference in level between a potentially interfering signal and the established sensitivity of the receiver under test. Therefore, determination of the sensitivity of the receiver is a key portion of the test.

The basic concept with this test procedure is to apply out-of-band signals to the antenna port of the receiver while monitoring the receiver for degradation. Figure 17 shows a general test set-up for this test. There are two common techniques used for performing this test using either one or two signal sources. For the one signal source procedure, the signal source is modulated with the modulation expected by the receiver. It is then swept over the appropriate frequency ranges while the receiver is monitored for unintended responses. With the two signal source procedure, a signal appropriately modulated for the receiver is applied at the tuned frequency of the receiver. The level of this signal is

normally specified to be close to the sensitivity of the receiver. The second signal is unmodulated and is swept over the appropriate frequency ranges while the receiver is monitored for any change in its response to the intentional signal.

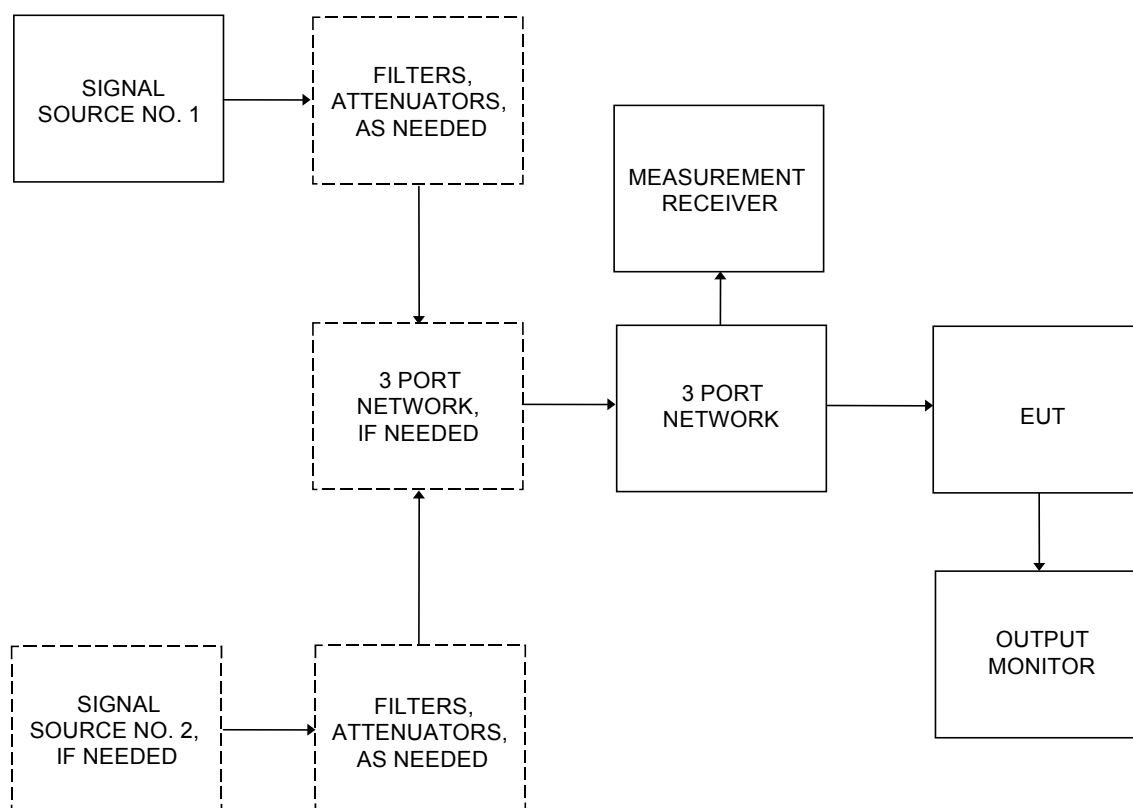
The two signal source procedure is more appropriate for most receivers. The one signal source procedure may be more appropriate for receivers that search for a signal to capture since they may respond differently once a signal has been captured. Some receivers may need to be evaluated using both procedures to be completely characterised.

For frequency hopping receivers, one possible approach is to use a one signal procedure as if the EUT did not have a tuned frequency (include frequency scanning across the hop set) to evaluate the jamming/interference resistance of the receiver. If a frequency hopping receiver has a mode of operation using just one fixed frequency, this mode should also be tested.

For receivers with front-end mixing and filtering in an antenna module, the test may need to be designed to be performed on a radiated basis. All signals would need to be radiated and assurances provided that any observed responses are due to the receiver and not caused by items in the test area. The EMITP would need to address antenna types, antenna locations, antenna polarisation, and field measurement techniques. This test would probably need to be performed in an anechoic chamber.

A common error made in performing this test procedure is attributing failures to the EUT, which are actually harmonics or spurious outputs of the signal source. Therefore, it is important to verify that the signals appearing at the EUT antenna port are only the intended signals through the use of a measurement receiver as shown in Figure 17. Damaged, corroded, and faulty components can cause signal distortion resulting in misleading results. Monitoring will also identify path losses caused by filters, attenuators, couplers, and cables.

Typical data for this test procedure for the EMITR are the sensitivity of the receiver, the levels of the signal sources, frequency ranges swept, operating frequencies of the receivers, degree of rejection (dB), and frequencies and threshold levels associated with any responses.



**FIGURE 17 NCS04 General test set-up.**

6.13 NCS05, conducted susceptibility, antenna port, cross modulation, 30 Hz to 20 GHz.

**Applicability and limits:** The intent of this requirement is to control the response of antenna-connected receiving subsystems to modulation being transferred from an out-of-band signal to an in-band signal. This effect results from a strong, out-of-band signal near the operating frequency of the receiver that modulates the gain in the front-end of the receiver and adds amplitude varying information to the desired signal. The requirement should be considered only for receivers, transceivers, amplifiers, and the like, which extract information from the amplitude modulation of a carrier. Due to the wide diversity of subsystem designs being developed, the applicability of this type of requirement and appropriate limits need to be determined for each procurement. Also, requirements need to be specified that are consistent with the signal processing characteristics of the subsystem and the particular test procedure to be used to verify the requirement.

One approach for determining levels required for the out-of-band signal can be determined from an analysis of the electromagnetic environments present and characteristics of receiving antennas. However, levels calculated by this means will often place unreasonable design penalties on the receiver. For example, if an external environment of 200 volts/metre is imposed on a system, an isotropic antenna at 300 MHz will deliver 39 dBm to the receiver. This level represents a severe design requirement to many receivers. An alternative approach is to simply specify levels that are within the state-of-the-art for the particular receiver design.

This requirement is most applicable to fixed frequency, tuneable, superheterodyne receivers

For other types of receivers, application of this requirement is often less straightforward and care must be taken to ensure that any applied requirements are properly specified. Many receivers are designed to be interference or jam resistant and this feature may make application of this requirement difficult or inappropriate.

One complicating factor is that one of the out-of-band signals typically is modulated with a waveform normally used by the receiver. For receivers that process a very specific modulation, the issue exists whether an out-of-band signal can reasonably be expected to contain that modulation. Another factor is that the out-of-band signal is normally specified to be close to the receiver operating frequency. For receivers that continuously change frequency (such as frequency agile or frequency hopping), an appropriate relationship may exist for only short periods for a fixed frequency out-of-band signal.

**Test procedures:** No test procedures are provided in the main body of this standard for this requirement. Because of the large variety of receiver designs being developed, the requirements for the specific operational characteristics of a receiver must be established before meaningful test procedures can be developed. Only general testing techniques are discussed in this appendix.

Cross modulation testing should be applied only to receiving subsystems such as receivers, RF amplifiers, transceivers and transponders which extract information from the amplitude modulation of a carrier.

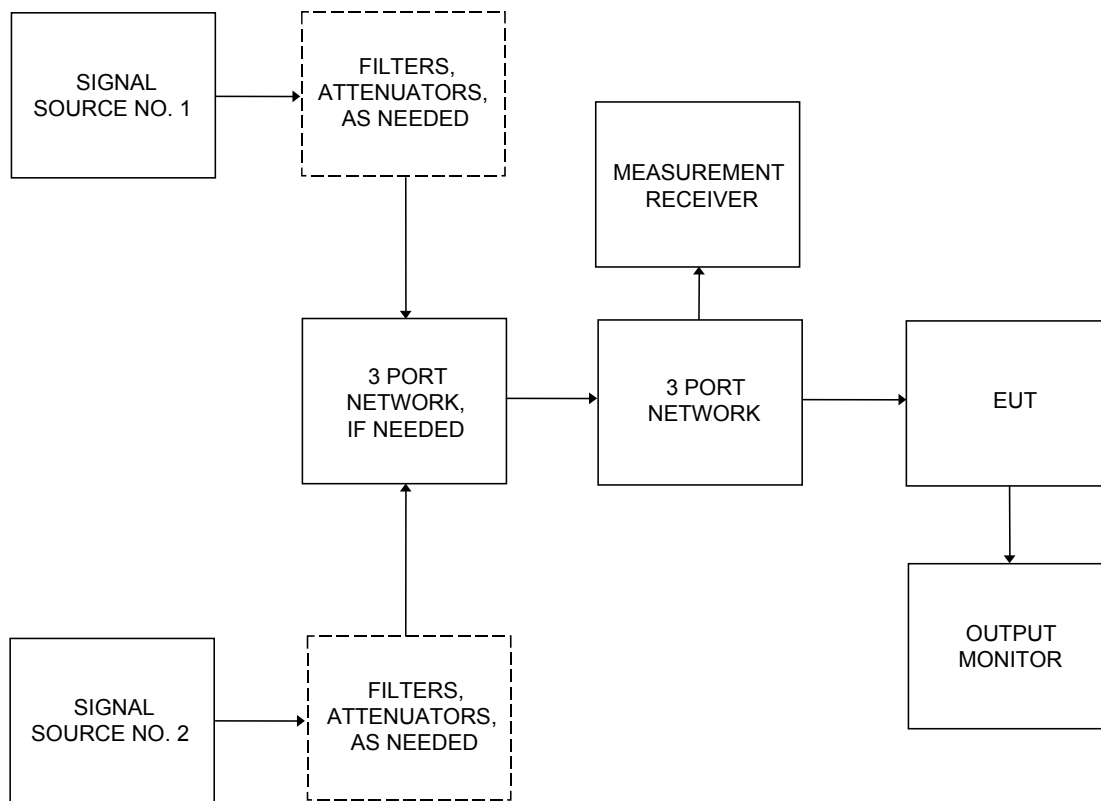
Several receiver front-end characteristics must be known for proper testing for cross modulation responses. These characteristics generally should be determined by test. The maximum signal input that the receiver can tolerate without overload needs to be known to ensure that the test levels are reasonable. The bandpass characteristics of the receiver are important for determining frequencies near the receiver fundamental that will be excluded from test. Requirements for this test are generally expressed in terms of a relative degree of rejection by specifying the difference in level between potentially interfering signals and the established sensitivity of the receiver under test. Therefore, determination of the sensitivity of the receiver is a key portion of the test.

The basic concept with this test is to apply a modulated signal out-of-band to the receiver and to determine whether the modulation is transferred to an unmodulated signal at the receiver's tuned frequency resulting in an undesired response. There may be cases where the in-band signal needs to be modulated if the receiver characteristics so dictate. The level of the in-band signal is normally adjusted to be close to the receiver's sensitivity. The out-of-band signal is modulated with the modulation expected by the receiver. It is then swept over the appropriate frequency ranges while the receiver is monitored for unintended responses. Testing has typically been performed over a frequency range  $\pm$  the receiver intermediate frequency (IF) centred on the receiver's tuned frequency. Figure 18 shows a general set-up for this test.

For receivers with front-end mixing and filtering in an antenna module, the test may need to be designed to be performed on a radiated basis. All signals would need to be radiated and assurances provided that any responses are due to the receiver and not caused by items in the test area. The EMITP would need to address antenna types, antenna locations, antenna polarisation and field measurement techniques. This test would probably need to be performed in an anechoic chamber.

For frequency hopping receivers, one possible approach is choose an  $f_0$  within the hop set and set up the signals sources as described above. The performance of the receiver could then be evaluated as the receiver hops. If the frequency hopping receiver has a mode of operation using just one fixed frequency, this mode should also be tested.

It is important to verify that the signals appearing at the EUT antenna port are only the intended signals through the use of a measurement receiver as shown in Figure 18. Damaged, corroded, and faulty components can cause signal distortion resulting in misleading results. Monitoring will also identify path losses caused by filters, attenuators, couplers, and cables.



**FIGURE 18 NCS05 General test set-up.**

Typical data for this test procedure for the EMITR are the sensitivity of the receiver, the levels of the signal sources, frequency ranges swept, operating frequencies of the receivers, and frequencies and threshold levels associated with any responses.

6.14 NCS06, conducted susceptibility, structure current, 60 Hz to 100 kHz

**Applicability and limits:** This requirement is specialised and is intended to be applied only for very sensitive equipment (1  $\mu\text{V}$  or better) such as tuned receivers operating over the frequency range of the test. The basic concern of the requirement is to ensure that equipment does not respond to magnetic fields caused by currents flowing in platform structure and through EUT housing materials. The magnetic fields are sufficiently low that there is no concern with most circuitry.

An estimate can be made of induced voltages that may result from the required NCS06 currents. Magnetic fields act by inducing voltages into loop areas in accordance with Faraday's law:

$$(V = -d\phi/dt)$$

For a constant magnetic field perpendicular to a given loop area, Faraday's law reduces to;

$$V = -2\pi fBA$$

Where  $f$  = Frequency of Interest  $B$  = Magnetic Flux Density  $A$  = Loop Area

Since Faraday's law indicates that these voltages are proportional to frequency, the maximum voltage from the NCS06 currents will result at the 20 kHz knee of the curve for a given loop area. A drop of 20 dB/decade would result in a constant voltage. Since the curve is dropping at only 10 dB/decade below

20 kHz, the induced voltage will rise as frequency increases. The sharp drop off above 20 kHz results in decreasing voltages with increasing frequency.

If the 103 dB $\mu$ A current at 20 kHz specified in the requirement is assumed to spread uniformly over a cross-sectional dimension of 10 centimetres, the surface current density and the resulting magnetic field intensity at the surface would be 1.41 amperes/metre. In air, this value corresponds to magnetic flux density of  $1.77 \times 10^{-6}$  Tesla. If it is further assumed that this magnetic field is uniform over a circuit loop area of 0.001 square metres (such as 20 centimetres by 0.5 centimetres) within the enclosure, Faraday's Law predicts an induced voltage of 222  $\mu$ V.

Similar calculations at 400 Hz and 100 kHz yield values of 31  $\mu$ V and 8  $\mu$ V, respectively.

It is apparent that design considerations such as proper grounding techniques, minimising of loop areas, and common mode rejection concepts need to be implemented to prevent potential problems with very sensitive circuits used in submarines such as low frequency tuned receivers. However, these levels are well below the sensitivity of typical circuits used in other equipment.

The limit is derived from operational problems due to current conducted on equipment cabinets and laboratory measurements of response characteristics of selected receivers.

No tailoring is recommended.

**Test procedures:** Electrical connection needs to be made to the external structure of the EUT and damage to the external finish should be minimised. Screws or protuberances at ground potential near the diagonal corners of the EUT should normally be used as test points. Connections should be made with clip or clamp type leads. If convenient test points are not available at the diagonal corners, a sharply pointed test probe should be used to penetrate the finish in place of the clip or clamp type lead.

The requirement to maintain the leads perpendicular to the surface for at least 50 centimetres is to minimise effects on the path of current flow along the surface from the magnetic fields caused by the current in the leads.

Coupling transformers used to perform NCS01 testing are normally suitable for this test. The electrical isolation that is provided by the coupling transformer eliminates the need to electrically "float" the amplifier and signal source that could result in a potential shock hazard.

6.15 NCS07, conducted susceptibility, bulk cable injection, 10 kHz to 400 MHz.

**Applicability and limits:** The requirements are applicable to all electrical cables interfacing with the EUT enclosures. The basic concept is to simulate currents that will be developed on platform cabling from electromagnetic fields generated by antenna transmissions both on and off the platform.

An advantage of this type of requirement is that it provides data that can be directly related to induced current levels measured during platform-level evaluations. An increasingly popular technique is to illuminate the platform with a low level, relatively uniform field while monitoring induced levels on cables. Then, either laboratory data can be reviewed or current injection done at the platform with the measured currents scaled to the full threat level. This same philosophy has been applied to lightning and electromagnetic pulse testing.

Due to size constraints and available field patterns during radiated susceptibility testing (such as NRS02), it has long been recognised that cabling cannot be properly excited to simulate platform effects at lower frequencies. The most notable example of this situation is experience with HF (2 to 30 MHz) radio transmissions. HF fields have caused numerous problems in platforms through cable coupling. However, equipment items rarely exhibit problems in this frequency range during laboratory testing.

The limits are primarily derived from testing on aircraft that were not designed to have intentionally shielded volumes. The basic structure is electrically conductive; however, there was no attempt to

ensure continuous electrical bonding between structure members or to close all apertures. The shape of the limit reflects the physics of the coupling with regard to resonant conditions, and the cable length with respect to the interfering frequency wavelength. At frequencies below resonance, coupling is proportional to frequency (20 dB/decade slope). Above resonance, coupled levels are cyclic with frequency with a flat maximum value. The 10 dB/decade decrease in the limit level at the upper frequency portion is based on actual induced levels in the aircraft testing data base when worst-case measurements for the various aircraft are plotted together. From coupling theory for a specific cable, the decrease would be expected to be cyclic with frequency with an envelope slope of 40 dB/decade.

The basic relationship for the limit level in the resonance (flat) portion of the curve is 1.5 milliamperes per volt/metre that is derived from worst-case measurements on aircraft. For example, 110 dB $\mu$ A corresponds to 200 volts/metre. At resonance, the effective shielding effectiveness of the aircraft can be zero. Application of these results to other platforms is reasonable.

The frequency range of 10 kHz to 200 MHz is now standardised for all applications. The optional frequency range of 200 MHz to 400 MHz is deleted because of the questionable validity of performing bulk cable measurements at higher frequencies.

For submarines, the NCS07 limit now distinguishes between equipment located internal versus external to the pressure hull. For equipment installed internal to the pressure hull, the curve 2 limit is now specified above 30 MHz to account for portable transmitters used with the submarine. For equipment located external to the pressure hull, stricter limits are imposed to more closely reflect the electromagnetic environment. The external NCS07 limits should be applied only to equipment that is required to be fully operational when located above the waterline. Separate limits are specified, which are less severe, for equipment that is "external" to the pressure hull but located with the submarine superstructure (metallic boundary).

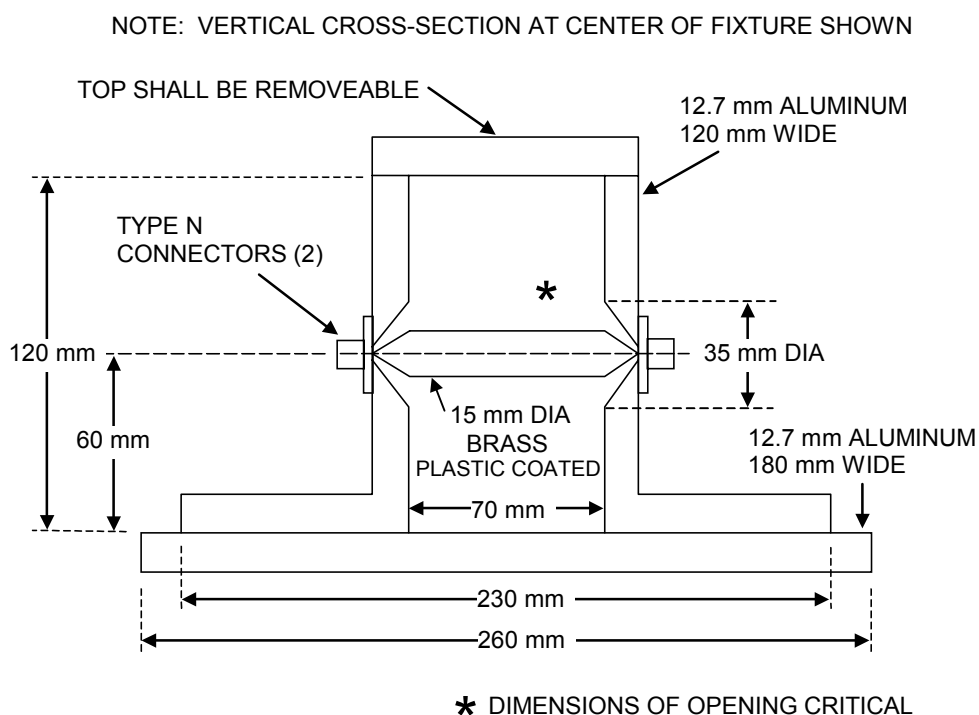
Possible tailoring by the procuring activity for contractual documents is a curve amplitude based on the expected field intensity for the installation and a breakpoint for the curve based on the lowest resonance associated with the platform. Tailoring of the frequency of application can be done based on the operating frequencies of antenna-radiating equipment. Tailoring should also include transmitters that are not part of the platform. For equipment used in benign environments, the requirement may not be necessary.

**Test procedures:** This type of test is often considered as a bulk current test since current is the parameter measured. However, it is important to note that the test signal is inductively coupled and that Faraday's law predicts an induced voltage in a circuit loop with the resultant current flow and voltage distribution dependent on the various impedances present.

The calibration fixture with terminations is a 50  $\Omega$  transmission line. Since the injection probe is around the centre conductor within the fixture, a signal is being induced in the loop formed by the centre conductor, the two 50  $\Omega$  loads, and the structure of the fixture to which the 50  $\Omega$  loads are terminated. From a loop circuit standpoint, the two 50  $\Omega$  loads are in series, providing a total loop impedance of 100  $\Omega$ . Because of the transmission line configuration, inductance effects are minimised. Measurement of induced current levels is performed by measuring a corresponding voltage across one of the 50  $\Omega$  loads. Since the 50  $\Omega$  loads are in series for the induced signal, the total drive voltage is actually two times that being measured.

The actual current that appears on a tested cable from the pre-calibrated drive signal depends on the loop impedance associated with the cable and the source impedance characteristics of the drive probe and amplifier. If the loop impedance is low, such as would often result with an overall shielded cable, currents greater than those the calibration fixture will result. The maximum required current is limited to 6 dB above the pre-calibration level.

This test procedure is applicable to all EUT cabling.



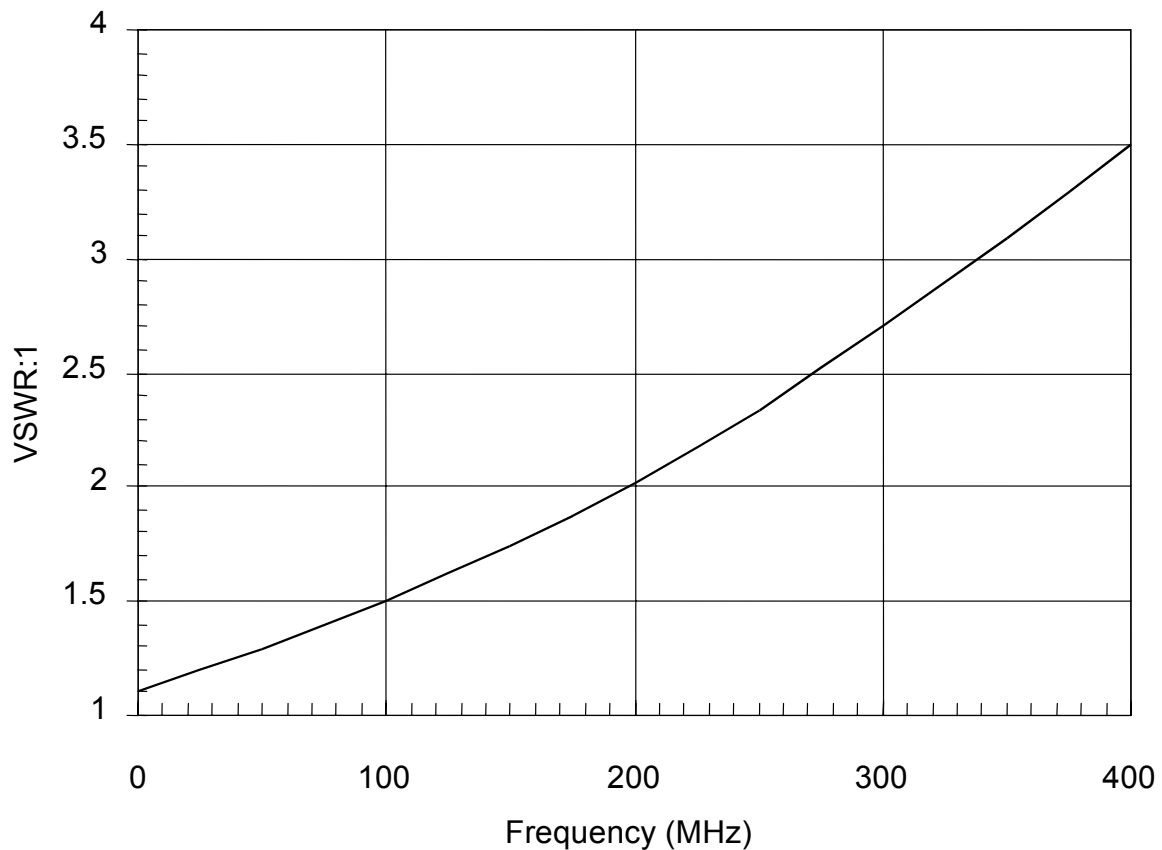
**FIGURE 19** Typical NCS07 calibration fixture.

A commonly used calibration fixture is shown in Figure 19. Other designs are available. The top is removable to permit the lower frequency probes to physically fit. The calibration fixture can be scaled to accommodate larger injection probes. Figure 20 displays the maximum VSWR that this calibration fixture should exhibit when measured without a current probe installed in the fixture. The presence of a probe will usually improve the VSWR of the fixture.

An advantage of this type of conducted testing as compared to radiated susceptibility testing is that voltage and current levels can be more easily induced on the interfaces that are comparable to those present in installations. The physical dimensions of the EUT cabling in a test set-up are often not large enough compared to the installation for efficient coupling at lower frequencies.

In the past, some platform-level problems on Navy aircraft could not be duplicated in the laboratory using the standard test procedures in other test standard. It was determined that differences between the aircraft installation and laboratory set-ups regarding the laboratory ground plane and avionics (aircraft electronics) mounting and electrical bonding practices were responsible. Most avionics are mounted in racks and on mounting brackets. At RF, the impedances to general aircraft structure for the various mounting schemes can be significantly different than they are with the avionics mounted on a laboratory ground plane. In the laboratory, it is not always possible to produce a reasonable simulation of the installation. A ground plane interference (GPI) test was developed to detect potential failures due to the higher impedance. In the GPI test, each enclosure of the EUT, in turn, is electrically isolated above the ground plane and a voltage is applied between the enclosure and the ground plane to simulate potential differences that may exist in the installation. Since NCS07 provides similar common mode stresses at electrical interfaces as the GPI, the GPI is not included in this standard. However, the Navy may prefer to perform an additional susceptibility scan for aircraft applications with an inductor placed between the EUT enclosure and ground plane to more closely

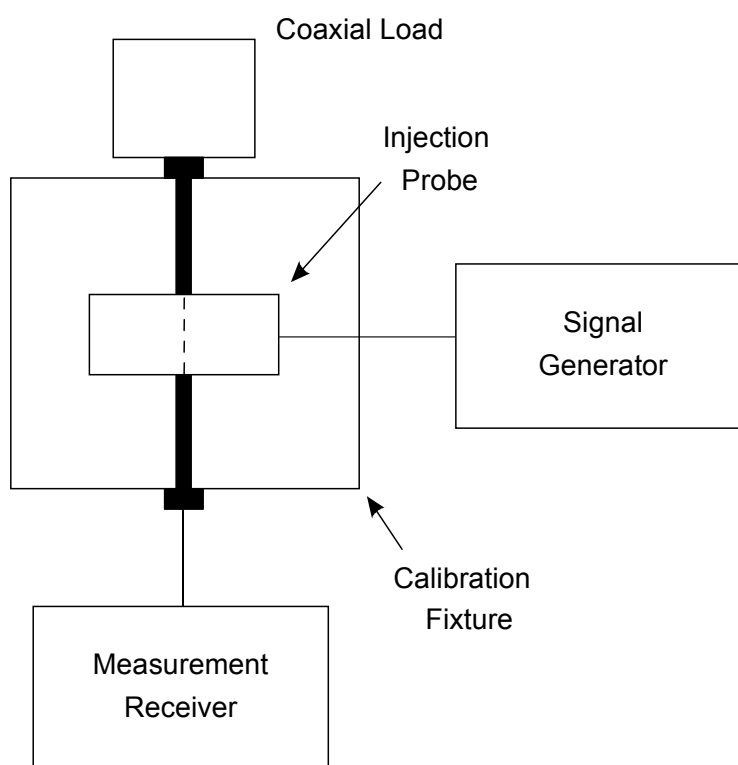
emulate the results of a GPI set-up. The primary side of a typical NCS01 injection transformer is considered to be an appropriate inductor.



**FIGURE 20 Maximum VSWR of calibration fixture.**

NCS07 has several advantages over the GPI as a general evaluation procedure. The GPI often results in significant current flow with little voltage developed at lower frequencies. NCS07 is a controlled current test. A concern with the GPI test, which is not associated with NCS07, is that the performance of interface filtering can be altered due to isolation of the enclosure from the ground plane. The results of NCS07 are more useful since the controlled current can be compared with current levels present in the actual installation induced from fields. This technique has commonly been used in the past for certification of aircraft as safe to fly.

Testing is required on both entire power cables and power cables with the returns removed to evaluate common mode coupling to configurations that may be present in different installations. In some installations, the power returns are routed with the high side wiring. In other installations, power returns are tied to system structure near the utilisation equipment with system structure being used as the power return path.



**FIGURE 21** Insertion loss measurement.

Insertion loss characteristics of injection probes are specified in Figure NCS07-2 of Method NCS07. A control on insertion loss has been found to be necessary to obtain consistency in test results. Insertion loss is measured as shown in Figure 21. It is the difference in dB of the power applied to the probe installed in the calibration fixture and the power level detected by the measurement receiver. Lower insertion loss indicates more efficient coupling. Since the signal level that is induced in the calibration fixture is equally divided between the  $50\ \Omega$  coaxial load and the measurement receiver, the lowest possible loss is 3 dB. The use of a network analyser or measurement receiver that includes a tracking generator can simplify the measurement.

Techniques using network analysers or spectrum analysers with tracking generators can simplify the measurements for both paragraphs 3.4.b calibration and paragraph 3.4.c EUT testing of Method NCS07. For example, the output signal can first be set to a predetermined value such as one milliwatt and the flatness of the signal with frequency can be separately verified through a direct connection to the receiver. With this same signal then applied to the directional coupler, the induced level in the calibration fixture can be directly plotted.

6.16 NCS08, conducted susceptibility, bulk cable injection, impulse excitation

**Applicability and limits:** The requirements are applicable to all electrical cables interfacing with EUT enclosures. The basic concern is to protect equipment from fast rise and fall time transients that may be present due to platform switching operations and external transient environments such as lightning and electromagnetic pulse. The requirement is intended to replace "chattering relay" type requirements commonly used in procurements of equipment for aircraft applications in the past. The

chattering relay has been criticised as unscientific and non-repeatable. The NCS08 requirement has a defined waveform and a repeatable coupling mechanism.

The 2 nanosecond rise time is consistent with rise times possible for the waveforms created by inductive devices interrupted by switching actions. The 30 nanosecond pulse width standardises the energy in individual pulses. In addition, it separates the rising and falling portions of the pulse so that each may act independently. Also, each portion may affect different circuits. The 5 ampere amplitude (500 volts across 100  $\Omega$  loop impedance calibration fixture) covers most induced levels that have been observed during system-level testing of aircraft to transient environments. The 30 Hz pulse rate is specified to ensure that a sufficient number of pulses are applied to provide confidence that the equipment will not be upset.

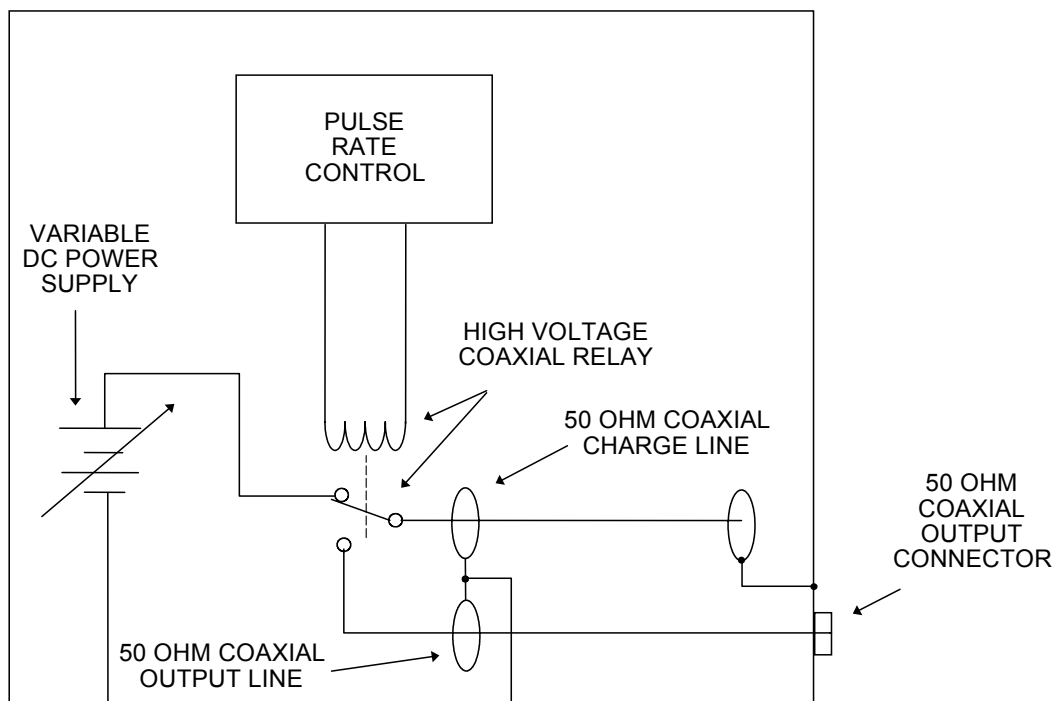
Many circuit interfaces are configured such that potential upset is possible for only a small percentage of the total equipment operating time. For example, a microprocessor may sequentially poll various ports for input information. A particular port may continuously update information between polling intervals. If the transient occurs at the time the port is accessed, an upset condition may result. At other times, no effect may occur.

Possible tailoring by the procuring activity for contractual documents is lowering or raising the required amplitude based on the expected transient environments in the platform. Another option is to adjust the pulse width based on a particular environment onboard a platform or for control of the energy content of the pulse.

**Test procedures:** The excitation waveform from the generator is a trapezoidal pulse. The actual waveform on the interconnecting cable will be dependent on natural resonance conditions associated with the cable and EUT interface circuit parameters.

A circuit diagram of the 50  $\Omega$ , charged line, pulse generator required by NCS08 is shown in Figure 22. Its operation is essentially the same as impulse generators used to calibrate measurement receivers except that the pulse width is much longer. A direct current power supply is used to charge the capacitance of an open-circuited 50  $\Omega$  coaxial line. The high voltage relay is then switched to the output coaxial line to produce the pulse. The pulse width is dependent upon the length of the charge line. The relay needs to have bounce-free contact operation.

The calibration fixture with terminations is a 50  $\Omega$  transmission line. Since the injection probe is around the centre conductor within the fixture, a signal is being induced in the loop formed by the centre conductor, the two 50  $\Omega$  loads, and the structure of the fixture to which the 50  $\Omega$  loads are terminated. From a loop circuit standpoint, the two 50  $\Omega$  loads are in series, providing a total loop impedance of 100  $\Omega$ . Because of the transmission line configuration, inductance effects are minimised. Measurement of induced current levels is performed by measuring a corresponding voltage across one of the 50  $\Omega$  loads. Since the 50  $\Omega$  loads are in series for the induced signal, the total drive voltage is actually two times that being measured.



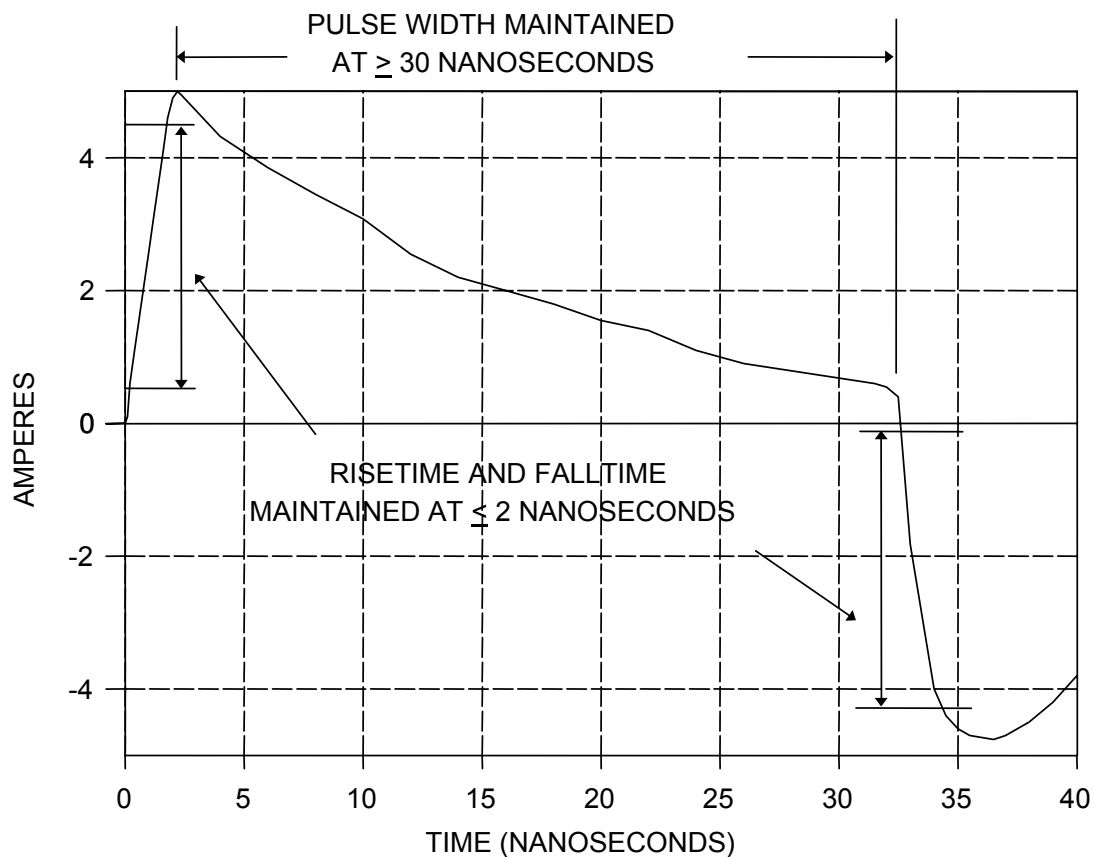
**FIGURE 22** Circuit diagram of NCS08 pulse generator.

Paragraph 3.4b(3) of NCS08 requires verification that the rise time, fall time, and pulse width portions of the applied waveform are present in the observed waveform induced in the calibration fixture. Figure 23 shows a typical waveform that will be present. Since the frequency response of injection probes falls off at lower frequencies, the trapezoidal pulse supplied to the probe sags in the middle portion of the pulse that is associated with the lower frequency content of the applied signal. The relevant parameters of the waveform are noted. It is critical that an injection probe be used with adequate response at higher frequencies to produce the required rise time and fall time characteristics.

As also specified in NCS08, testing is required on both entire power cables and power cables with the returns removed to evaluate common mode coupling to configurations, which may be present in different installations. In some installations, the power returns are routed with the high side wiring. In other installations, power returns are tied to system structure near the utilisation equipment with system structure being used as the power return path.

The chattering relay has been found to be effective for determining upset conditions of equipment. The basic concept was to electrically connect the relay coil in series with a normally closed contact and allow the relay to continuously interrupt itself. The wire between the coil and contact was used to couple the transient onto EUT cables. The greatest concern with the chattering relay is that it does not produce a repeatable waveform since an arcing process is involved. The particular relay being used and the condition of its contact and coil mechanics play a large role. NCS08 retains the most

important characteristic of the chattering relay, which is the fast rise time waveform and also has the important advantage of a consistent excitation waveform.



**FIGURE 23** Typical NCS08 calibration fixture waveform.

The same calibration fixture used for NCS07 can be used for this test procedure. An available design is shown in Figure 19.

6.17 NCS09, conducted susceptibility, damped sinusoid transients, cables and power leads, 10 kHz to 100 MHz.

**Applicability and limits:** The requirements are applicable to all electrical cables interfacing with each EUT enclosure and also individually on each power lead. The basic concept is to simulate electrical current and voltage waveforms occurring in platforms from excitation of natural resonances.

In contrast to the NCS08 procedure that excites natural resonances, the intent of this requirement is to control the waveform as a damped sine. Damped sine waveforms (sometimes complex combinations) are a common occurrence on platforms from both external stimuli such as lightning and electromagnetic pulse and from platform electrical switching phenomena. Waveforms appearing on cables can be due to the cable itself resonating or to voltage and current drives resulting from other resonances on the platform. Wide frequency coverage is included to account for a wide range of conditions. Transients caused from switching actions within the platform can also result in similar waveforms.

A consideration for the requirement is whether momentary upsets are allowable if the EUT is capable of self-recovery to normal operation. Some upsets may occur that are not even noticed by an operator due to self-correcting mechanisms in the equipment. There may be cases where longer term upset is acceptable which may possibly require action by an operator to reset the equipment. The EMITP shall address any instances where the contractor proposes that observable upsets be accepted.

A limited set of damped sine waves is specified to address a sampling of the various ringing frequencies that may be present in the platform. An advantage of using a set of damped sine waves is that different circuit types are evaluated for various waveform attributes that may cause worst-case effects. Some circuits may respond to peak amplitude while others may respond to total energy or rate of rise.

The current limits are set at levels that cover most induced levels found in platforms during system-level testing to external transient environments. The level for aircraft also typically allows for designs that do not require the use of terminal protection devices. These items are generally undesirable due to concerns with hardness maintenance/hardness surveillance and the ability to assess whether protection remains effective. The lower frequency breakpoints are at worst-case platform resonant frequencies below, which the response will fall off at 20 dB/decade. The upper frequency breakpoint is located where the spectral content of the transient environments falls off.

Possible tailoring of the requirements by the procuring activity in contractual documents is adjustment of the curve amplitude either higher or lower based on the degree of protection provided in the area of the platform where the equipment and interconnecting cabling will be located. A caution with this particular requirement based on past experiences is that the platform designer should be required to share in the burden of the hardening process by providing stress reduction measures in the platform. The equipment should not be expected to provide the total protection. Protection against transients generated internal to the platform needs to remain a consideration. Another potential tailoring area is adjusting the lower frequency breakpoint to be more consistent with the lowest resonance of a particular platform.

**Test procedures:** The calibration fixture with terminations is a 50  $\Omega$  transmission line. Since the injection probe is around the centre conductor within the fixture, a signal is being induced in the loop formed by the centre conductor, the two 50  $\Omega$  loads, and the structure of the fixture to which the 50  $\Omega$  loads are terminated. From a loop circuit standpoint, the two 50  $\Omega$  loads are in series, providing a total loop impedance of 100  $\Omega$ . Because of the transmission line configuration, inductance effects are minimised. Measurement of induced current levels is performed by measuring a corresponding voltage across one of the 50  $\Omega$  loads. Since the 50  $\Omega$  loads are in series for the induced signal, the total drive voltage is actually two times that being measured.

NCS09 addresses testing of cables (interconnecting including power) and individual power leads. The common mode cable portion of the test is the best simulation of the type of condition present on platforms from electromagnetic field excitation. The individual power lead test addresses differential type signals present on platforms from switching functions occurring in the power system.

As necessary, the test can be applied in a straightforward manner to wires on individual pins on an EUT connector or to individual circuits (twisted pairs, coaxial cables, and so forth).

Since the quality factor (Q) of the damped sine signal results in both positive and negative peaks of significant value regardless of the polarity of the first peak, there is no requirement to switch the polarity of the injected signal.

The common mode injection technique used in this procedure and other procedures such as NCS07 is a partial simulation of the actual coupling mechanism on platforms. The magnetic field in the injection device is present at the physical location of the core of the injection device. In the platform, the electromagnetic field will be distributed in space. The injection probe induces a voltage in the circuit loops present with the voltage dropping and current flowing based on impedances present in the loop. There is a complex coupling relationship among the various individual circuits within the cable bundle.

The injection probe is required to be close to the EUT connector for standardisation reasons to minimise variations particularly for higher frequencies where the shorter wavelengths could affect current distribution.

Caution needs to be exercised to ensure that attenuators and current injection probes are rated such that they will not be damaged or have their characteristics altered by the injected signals. Attenuators are generally rated in terms of their ability to handle average power. The peak power and associated voltages with the injected can damage attenuators. For example, the 10 ampere current limit for NCS09 exposes the attenuator to 500 volt (10 amperes x 50  $\Omega$ ) levels, which corresponds to a peak power of 5 kilowatts ((500 volts)<sup>2</sup>/50  $\Omega$ ). Similarly, current injection probes can have their magnetic properties altered by the pulsed signals.

For measurement of Q of the injected waveform, Figure NCS09-1 in Method NCS09 specifies the use of the peak of the first half-sine wave and the associated peak closest to being 50% down in amplitude. Some facilities use a damped cosine waveform rather than a damped sine. Since this waveform is more severe than the damped sine because of the fast rise time on the leading edge, there is no prohibition from using it. Because of potential distortion caused by leading edge effects, the first peak should not be used to determine Q for damped cosine waveforms. The next half peak (negative going) should be used together with the associated negative peak closest to 50% down. Equipment may exhibit failures with this waveform that would not be present with the damped sine.

#### 6.18 NCS10 conducted susceptibility, imported lightning (aircraft)

**Applicability and limits:** This test is applicable to aircraft equipment, which may be considered flight safety critical for aircraft operation. A direct lightning strike to an aircraft will result in electrical transients induced on equipment wiring, including equipment ground bonding straps. Other types of equipment shall be considered with regard to their function and vulnerability.

This test method requires the application of idealised waveforms to verify that the equipment is capable of withstanding the effects of lightning induced transients. The criteria for equipment performance while being subjected to lightning transients shall be defined in terms of equipment function and criticality. Flight safety critical systems are required to continue to function without manual intervention after the application of a lightning transient.

This test may not cover all aspects of lightning induced transients and interaction effects on equipment, particularly when incorporated into a system. Additional tests such as simultaneous cable bundle injection, multiple stroke/multiple burst and/or multiple frequency may be required to achieve equipment qualification. Because there is a close connection between the design requirements for protection against lightning Group Indirect Effects (GIE) and those covering EMC and Nuclear Electromagnetic Pulse (NEMP) considerations, the Lightning Protection Plan shall take account of EMC Requirements, and also of NEMP requirements if applicable. Lightning requirements shall be co-ordinated with these other requirements and any conflict of requirements in particular instances shall be noted in the Risk Assessment and proposals included for resolving the conflict.

There are various coupling modes between the lightning current or fields and the internal wiring, each of which tends to produce a transient of a particular waveform. Thus the total transient may be a complex composite of several waveforms, and transient testing of equipment needs to include a variety of voltage and current waveforms selected to cover the principal coupling modes. The purpose of such tests is to determine whether the equipment can experience a given level of transient (of representative waveform) without damage or functional upset.

The test levels applied to equipment are derived from the locations and positions of the installed equipment. The maximum amplitudes for the test waveforms are chosen according to equipment categories A-D (electromagnetic (EM) environments of the equipment) and E (criticality of equipment).

- CAT A Equipment and cabling installed in a protected EM environment such as a completely enclosed compartment in metallic material.
- CAT B Equipment and cabling installed in a partially exposed EM environment such as below a dielectric cover in a largely metallic structure.
- CAT C Equipment and cabling bonded to the same part of the material structure and installed in an exposed EM environment where large portions of the structure are constructed from poorly conducting or carbon fibre composite (CFC) materials.
- CAT D Equipment and cabling bonded on different parts of the material structure and installed in an exposed EM environment where large portions of the structure are constructed from poorly conducting materials or CFC.

Where equipment and cables can be defined in more than one of the above categories, the test levels associated with the more severe environment shall be applied.

For test purposes, four waveform shapes have been selected as representative of the range of waveforms that occurs in practice. Different cable bundles will experience different amplitudes of transients depending on their location and construction (for example, with or without shielding) so a range of test amplitudes (levels) will also be required together with Equipment Installation Categories.

When Computed Transient Levels (CTLs) are not known the limits given in NCS10 shall be used,

i.e. A current limit of 30 A from 0.5 to 30 MHz decreasing to 15 A at 50 MHz.

A voltage limit of 3 kV between 0.5 and 30 MHz decreasing to 1.5 kV at 50 MHz.

A kVA limit of 30 kVA between 0.5 and 30 MHz decreasing to 7.5 kVA at 50 MHz.

**Test procedures:** Equipment test methods are based on the Damped Sinewave testing (NCS09)

Two main types of waveform are employed, as follows: -

- a) Unidirectional pulses, having decay times considerably longer than their rise times, and whose shape is related to that of the lightning current waveform. These are sometimes known as forced transients because they are 'driven' by the lightning waveform.
- b) Bursts of damped sinusoidal oscillations. These are shock-excited oscillations corresponding to the natural electrical resonances of the aircraft and its electrical systems. They are free or natural oscillations, whose frequency and degree of damping are independent of the lightning current waveform, although their amplitude will depend on the shape and amplitude of the shock (the lightning waveform) that triggers them off.

The following is a general guide with respect to the test procedures that shall be followed:

The EUT shall be switched on and exercised to ensure that it is operating in accordance with the EMITP. The pulse generator output would be increased from zero up to the test limit in steps not exceeding 10% of the required test limit or greater if the EMITP stipulates. Application of at least 3 transients at each incremental step, with a delay of at least 8 seconds between each to allow protection components time to recover.

If a malfunction occurs, record the applied peak current and voltage levels.

If no malfunction occurs, increase the generator output until the peak current or peak voltage test limits is reached and then apply 10 transients at this level, separated by at least 8 seconds, over a period of not more than 2 minutes. Record a typical set of the current and voltage waveforms that appear between the equipment case and ground.

Repeat the above procedure for both positive and negative polarity pulses.

Application of Test Waveforms

The Short waveform shall be applied to all EUTs. If it is known that a particular equipment is intended to be installed in an aircraft with a well bonded, low impedance, largely metallic structure then the Intermediate pulse waveform shall be applied in addition to the Short pulse. For equipment that is intended to be installed in largely CFC airframes or equipment whose interconnecting wiring is run in areas covered by CFC panels then the Long pulse waveform shall be applied in place of the Intermediate waveform. If it is not known where the equipment is to be installed then guidance should be sought from the relevant procuring agencies.

#### Selection of Transient Test Frequencies

During injection tests, transients shall be injected at frequencies according to the following criteria.

- a. The most susceptible frequencies in the range 0.5 to 50 MHz found from any previous continuous wave (CW) bulk current injection EMC testing; or
- b. The frequencies at which maxima and minima cable impedances occurs.

Over the frequency range 0.5 to 50 MHz inclusive not less than 50 frequencies such that any resonance's in the EUT internal circuitry are excited, so subjecting any active or passive devices to maximum voltage or current threat. These frequencies shall be spaced evenly with a logarithmic increment. The approximate frequency of each injection is obtained by the use of the following equation: -

$$\text{Test frequency (MHz)} = 10(0.3 + 0.028k)$$

Where k = 0, 1, 2, 3 to 50 for 50 frequencies

#### 6.19 NCS11 conducted susceptibility, low frequency power leads (sea systems)

**Applicability and limits:** The purpose of this test is to confirm that the EUT will withstand imported low frequency transients imposed upon its power supply lines, This test simulates the effect of voltage transients observed due to switching of machines and other loads on ship and submarine power supply systems.

This test is applicable to all equipment in use in the Sea Systems environment connected to ship and submarine power supplies. The test subjects the EUT to high-energy transients, typically 6 Joules for the 750V limit and 18 Joules for the 2500V limit. In common with other transient tests the test relies on the attenuation effect of the power input filter to protect the EUT but it also exercises transient suppressors (if present) by applying levels above their clamping voltage. In addition determining EUT susceptibility the test assesses the robustness of the input filter, which if damaged by high-energy transients could lead to higher emission levels and reduced protection against all forms of susceptibility. Typical occurrences of filter damage are capacitor dielectric breakdown or damage to transient suppressors of insufficient rating. Positive-going and negative-going, damped sinewave transients between 10 to 16 kHz, are to be applied to individual supply leads of an EUT, for both AC and DC incoming supplies. Battery operated equipment which may be connected to a platform supply, for example, during battery charging, shall also be subjected to this test.

The limits for this test have been derived from empirical measurements made of typical transients on DC and AC supplies.

**Test procedures:** The transient generator shall be connected in series with the supply lead under test. The EUT shall be checked for correct function and operation prior to the application of the test transients.

Each supply lead in turn shall then be subjected to twelve positive-going applications of the transient using the generator output settings appropriate to the EUT supply voltage followed by twelve negative-going transients. These transients shall be applied at a rate of one every 2 to 5 seconds.

The generator output waveform shall be monitored on the oscilloscope. The voltage induced into the cable under test and oscillograms of the induced transient waveform may be recorded for inclusion in the test report.

During each transient application, the EUT shall be monitored for degradation of performance, damage or malfunction as defined in the EMITP. When testing digital systems it may be necessary to apply a greater number of transients to ensure detection of any malfunction. In this case, the EMITP shall include some guidance to ensure capture of a malfunction during test.

#### 6.20 NCS12 conducted susceptibility electrostatic discharge

**Applicability and limits:** The purpose of this test is to establish a common and reproducible basis for evaluating the performance of electrical and electronic equipment when subjected to electrostatic discharges. In addition, it includes electrostatic discharges, which may occur from personnel to objects near vital equipment.

It is not intended to specify the tests to be applied to a particular apparatus or system. The main aim is to give a general basic reference. The procuring agency, or users of the equipment, remain responsible for the appropriate choice of test and the severity level to be applied to the EUT.

In service, electrostatic discharges result from charges built up by friction between materials, such as clothing, and inadvertently transferred to equipment by personnel, either directly or indirectly

This test applies to all Air equipment fitted with electronic and active components, particularly non-linear items such as transistors or integrated circuits etc, and Land and Sea Systems equipment if operated in an air-conditioned or protected environment.

The test method is similar to that described in BS EN 61000-4-2: 1995 but the following differences should be noted:

- a. The applied levels and equipment classifications from this document should be used instead of those given in BS EN61000-4-2: 1995.
- b. The contact discharge method shall be used wherever possible but the rounded discharge tip described within the test method shall be substituted for that shown in BS EN61000-4-2: 1995.
- c. When the air discharge method is used on non-conducting surfaces an additional test level of 15 kV shall be applied to all test points.

Discharges are normally directed to points on the front panel of the EUT, e.g. keyboards, knobs, switches, buttons and indicators, LEDs, slots, grilles, connectors and any metallic parts on the outside of the EUT electrically isolated from ground, specific points shall be detailed in the EMITP. Equipment shall withstand discharges as specified above at charging voltages appropriate to the Category of the equipment, without malfunction or disturbance.

For Air service the tests shall be applied at one of two severity levels, depending on the category of the equipment:

- a. **Category A** Safety Critical in that the safety of personnel or third parties is placed at risk either directly or indirectly from malfunctioning of the equipment (and hence subsequently the materiel).
- b. **Category B** Mission Critical in that malfunctioning or upset of the equipment functions either reduces, damages or prevents the materiel from performing its mission.

ESD testing of Air service equipment not in either of these categories is not normally required but is at the discretion of the Procuring Agencies.

NOTE 1: Calibration of the ESD generator would normally be performed by an external calibration laboratory, however the test laboratory is responsible for verifying the ESD waveform prior to application of the test.

NOTE 2: For Munitions testing the test levels and methods in STANAGs 4235 and 4239 shall be applied.

**Test procedures:** The ESD generator is intended to simulate the current pulse, which arises when a person carrying an electric charge dissipates that charge on contact with the EUT. The characteristics of the ESD generator used are shown in Method NCS12. BS EN 61000-4-2:1995 should be consulted for the constructional details of the test target used during verification of the ESD waveform.

6.21 NRE01, radiated emissions, magnetic field, 30 Hz to 100 kHz

**Applicability and limits:** This requirement is specialised and is intended primarily to control magnetic fields for applications where equipment is present in the installation, which is potentially sensitive to magnetic induction at lower frequencies. The most common example is a tuned receiver that operates within the frequency range of the test.

NRS01 is a complimentary requirement imposed on equipment to ensure compatibility with the anticipated magnetic fields. The NRS01 limits are higher to allow for variations in performance between manufactured items and to account for the possibility that the emissions from the EUT may couple into a larger physical area than that evaluated under the NRS01 test procedures.

The Sea NRE01 limit is based on preventing induction of more than 0.5 microvolts (nominal) in an RG-264A/U transmission line (loop area, A, of 16 square mm), with a maximum induced level of 4 microvolts at 60 Hz. The need to limit the low frequency magnetic field emissions from equipment is due to the close proximity of electronic and electrical systems and associated cables installed on the Navy platforms, and the essentiality of low frequency sensors and systems. The primary concerns are potential effects to low frequency acoustic systems and sensors, and ELF and VLF/LF communications systems and sensors that have sensitivities in the nanovolt range.

Note that the limit does not take into account magnetic effects from equipment such as magnetic launchers, magnetic guns and the like.

An estimate can be made of the types of induced levels that will result in circuitry from the limits. Magnetic fields act by inducing voltages into loop areas in accordance with Faraday's law ( $V = -d\phi/dt$ ). For a uniform magnetic field perpendicular to the loop area, the induced voltage from Faraday's law reduces to  $V = -2\pi fBA$ .

f = Frequency of Interest      B = Magnetic Flux Density      A = Loop Area

The Land NRE01 limit is based on preventing induction of more than 2.5 millivolts (5 millivolts for NRS01) in a 12.7 centimetre diameter loop. Since magnetic induction is proportional to frequency and the limit falls off at 20 dB/decade, the induced voltage in a given loop area is constant. Since the Land limit is greater than or equal to the Sea limit at all frequencies, this induced level represents the worst-case. The primary concerns are potential effects to engine, flight and weapon turret control systems and sensors that have sensitivities in the millivolt range.

There are certain limited applications for Air where an NRE01 requirement needs to be considered. These applications are primarily when a subsystem will be installed in an aircraft in close proximity to an antenna connected to a VLF/LF receiver. An appropriate limit needs to be chosen based upon distances between the equipment and the antenna.

For Land applications, possible tailoring is increasing the limit for single-use equipment that will be located a sufficient distance from any potentially susceptible systems or waiving of the requirement.

**Test procedures:** A 13.3 centimetre loop is specified for the test.

If the maximum level is always observed on one face or on one cable at all frequencies, then data only needs to be recorded for that face or cable.

Typical points of magnetic field emissions leakage from EUT enclosures are CRT yokes, transformers and switching power supplies.

A possible alternative measurement tool in this frequency range is wave analyser using a Fast Fourier Transform algorithm. Use of this type of instrumentation requires specific approval by the procuring activity.

A correction factor curve to convert from the voltage indicated by the measurement receiver to the magnetic field in dBpT is required. Manufacturers use different construction techniques that cause the actual factor to vary somewhat. Where traceable calibration figures are not available it is necessary to use the manufacturers' supplied data.

6.22 NRE02, radiated emissions, electric field, 10 kHz to 18 GHz

**Applicability and limits:** The requirements are applicable to electric field emissions from the EUT and associated cables. The basic intent of the requirement is to protect sensitive receivers from interference coupled through the antennas associated with the receiver. Many tuned receivers have sensitivities on the order of one microvolt and are connected to an intentional aperture (the antenna), which are constructed for efficient reception of energy in the operating range of the receiver. The potential for degradation requires relatively stringent requirements to prevent platform problems.

There is no implied relationship between this requirement and NRS02 that addresses radiated susceptibility to electric fields. Attempts have been made quite frequently in the past to compare electric field radiated emission and susceptibility type requirements as a justification for deviations and waivers. While NRE02 is concerned with potential effects with antenna-connected receivers, NRS02 simulates fields resulting from antenna-connected transmitters.

Often, the same equipment item will be involved in influencing both requirements. A 30 watt VHF-AM radio with a typical blade antenna operating at 150 MHz can easily detect a 40 dB $\mu$ V/m electric field (approximately -81 dBm developed at receiver input) while in the receive mode. When this same piece of equipment transmits at the same 150 MHz frequency, it will produce a field of approximately 150 dB $\mu$ V/m (32 volts/metre) at a 1 metre distance. The two field levels are 110 dB apart.

The limit curves are based on experience with platform-level problems with antenna-connected receivers and the amount of shielding typically between antennas and equipment and associated wiring.

The limit curves for equipment in internal installations on fixed wing aircraft are placed for air vehicles that are not designed to have intentionally shielded volumes that are effective across the frequency range of the test. Some minimal shielding is present. The curve for equipment in external installations and helicopters is 10 dB more stringent because even this minimal shielding is not available.

These limits for the 30 to 400 MHz band, in particular, have been validated as being properly placed. It has become standard practice on some aircraft programs to use spectral analysis equipment wired to aircraft antennas to assess degradation due to radiated emissions from onboard equipment. Many problems due to out-of-limit conditions in this band have been demonstrated. It has also been determined that equipment meeting the limit generally does not cause problems. Most of this experience is on fighter size aircraft. The 20 dB/decade increase in the limit above 100 MHz is due to the aperture size of a tuned antenna ( $G\lambda^2/(4\pi)$ ) decreasing with frequency. The coupled power level from an isotropic tuned antenna will remain constant. The curve breaks at 100 MHz because of difficulty with maintaining a tuned antenna due to increasing physical size and the lower likelihood of coupling to the antenna with longer wavelengths.

In the past EUTs have been found to be susceptible to ripple voltages when fitted to platforms and hence must be tested to avoid problems when subjected to low frequency radiated fields which can couple onto interconnecting cabling. Although relatively inefficient, coupling to cabling at lower frequencies has been demonstrated innumerable times in EMI testing.

The limits for all land based equipment cover the same frequency range, however a 20dB difference exists between equipment categorised as being a fixed installation for sea systems (such as that associated with a permanent shore emplacement) and a mobile sea system (such as a man portable device). All equipment procured by the Army shall be tested to the more stringent limit while equipment procured for Air service deployed in a ground support role shall be tested to the less stringent limit. The 20 dB difference between the limits exists because of the general situations where the equipment is deployed. Mobile equipment is often very close to unprotected antennas such as installations in vehicles or tents or near physically small helicopter aircraft and therefore requires a harsher limit applied. The fixed sea systems and most air installations in a ground support role have less critical coupling situations with regard to antenna coupling.

The limit for surface ships is based on numerous documented incidents of case and cable radiation coupling to receiver antennas. The use of hand-held type transceivers below deck within a ship is increasing and can be plagued by excessive levels of interference below deck. The limit is more stringent than corresponding electric field radiation emissions requirements contained in military-related international agreements and standards such as those used by NATO.

Possible tailoring by the procuring activity for contractual documents is as follows. The limits could be adjusted based on the types of antenna-connected equipment on the platform and the degree of shielding present between the equipment, associated cabling, and the antennas. For example, substantial relaxation of the limit may be possible for equipment and associated cabling located totally within a shielded volume with known shielding characteristics. It may be desirable to tailor the frequency coverage of the limit to include only frequency bands where antenna-connected receivers are present. Some caution needs to be exercised in this regard since there is always the chance the equipment will be added in the future. For example, it is not uncommon to add communications equipment (such as HF radio) onboard an aircraft as different missions evolve.

**Test procedures:** Specific antennas are required by this test procedure for standardisation reasons. The intent is to obtain consistent results between different test facilities.

In order for adequate signal levels to be available to drive the measurement receivers, physically large antennas are necessary. Due to shielded room measurements, the antennas are required to be relatively close to the EUT, and the radiated field is not uniform across the antenna aperture. For electric field measurements below several hundred megahertz, the antennas do not measure the true electric field.

The 104 centimetre rod antenna has a theoretical electrical length of 0.5 metres and is considered to be a short monopole with an infinite ground plane. It would produce the true electric field if a sufficiently large counterpoise were used to form an image of the rod in the ground plane. However, there is not adequate room. The requirement to bond the counterpoise to the shielded room or earth ground, as applicable, is intended to improve its performance as a ground plane. The biconical and double ridged horn antennas are calibrated using far-field assumptions at a 1 metre distance. This technique produces standardised readings. However, the true electric field is obtained only above approximately 1 GHz where a far field condition exists for practical purposes.

Antenna factors are determined using the procedures of SAE ARP-958 or other acceptable standards. They are used to convert the voltage at the measurement receiver to the field strength at the antenna. Any RF cable loss and attenuator values must be added to determine the total correction to be applied.

Conical Log spiral antennas are convenient since they did not need to be rotated to measure both polarisation of the radiated field. The double-ridged horn is considered to be better for standardisation for several reasons. At some frequencies, the antenna pattern of the conical log spiral is not centred

on the antenna axis. The double-ridged horn does not have this problem. The circular polarisation of the conical log spiral creates confusion in its proper application. Electric fields from EUTs would rarely be circularly polarised. Therefore, questions are raised concerning the need for 3 dB correction factors to account for linearly polarised signals. The same issue is present when spiral conical antennas are used for radiated susceptibility testing. If a second spiral conical is used to calibrate the field correctly for a circularly polarised wave, the question arises whether a 3 dB higher field should be used since the EUT will respond more readily to linearly polarised fields of the same magnitude.

Other linearly polarised antennas such as log periodic can be used provided that measurements are taken from their phase centres. It is recognised that these types of antennas have sometimes been used in the past and have not necessarily produce the same results as the double-ridged horn. This was due to field variations across the antenna apertures and far field/near field issues caused by measurements not made to the phase centre of the antenna.

The stub radiator required by the procedure is simply a short wire (approximately 10 centimetres) connected to the centre conductor of a coaxial cable that protrudes from the end of the cable.

There are two different mounting schemes for baluns of available 104 centimetre rod antennas with respect to the counterpoise. Some are designed to be mounted underneath the counterpoise while others are designed for top mounting. Either technique is acceptable provided the desired 0.5 metre electrical length is achieved with the mounting scheme.

The 10 pF capacitor used with the rod antenna in paragraph 3.4c(3) of Method NRE02 as part of the system check simulates the capacitance of the rod element to the outside world. With the rod antenna, the electric field present induces a voltage in the rod that is applied to the balun circuitry. One of the functions of the balun is to convert the high impedance input of the antenna element to the 50  $\Omega$  impedance of the measurement receiver. The 10 pF capacitor ensures that the correct source impedance is present during the check. Some antennas have a 10 pF capacitor built into the rod balun for calibration purposes and some require that an external capacitor be used.

For measurement system checks, establishing the correct voltage at the input to the 10 pF capacitor can be confusing dependent upon the design of the antenna and the associated accessories. Since, the electrical length of the 104 cm rod is 0.5 metres, the conversion factor for the induced voltage at the input to the 10 pF capacitor is 6 dB/m. If the limit at the measurement system check frequency is 34 dB $\mu$ V/m, the required field level to use for measurement system check is 6 dB less than this value or 28 dB $\mu$ V/m. The voltage level that must be injected is:

$$28 \text{ dB}\mu\text{V/m} - 6 \text{ dB/m} = 22 \text{ dB}\mu\text{V}$$

Since the input impedance at the 10 pF capacitor is very high, a signal source must be loaded with 50  $\Omega$  (termination load or measurement receiver) to ensure that the correct voltage is applied. A "tee" connection can be used with the signal source connected to the first leg, the 50  $\Omega$  load connected to the second leg, and the centre conductor of the third leg connected to the 10 pF capacitor (barrel referenced to the balun case). Sometimes a feed-through accessory that acts as a voltage divider is supplied with a rod antenna for the purpose of determining antenna factors. The accessory usually includes the required 10 pF capacitor inside the accessory. If the accessory is used for injecting the measurement system check signal, caution needs to be observed. Since the accessory is intended for only determining antenna factors, the procedures provided with these accessories may not address the actual voltage that appears at the 10 pF capacitor. The design of the accessory needs to be reviewed to determine that the correct voltage is obtained. For a common design, the voltage at the capacitor is 14.6 dB less than the signal source level and 5.0 dB greater than the indication on the measurement receiver.

The antenna positioning requirements in this procedure are based on likely points of radiation and antenna patterns. At frequencies below several hundred MHz, radiation is most likely to originate from EUT cabling. The 104 centimetre rod and biconical antennas have wide pattern coverage. The equation in Figure NRE02-7 of Method NRE02 is based on the rod and biconical being placed at least

every 3 metres along the test set-up boundary. The double ridge horns have narrower beamwidths. However, the shorter wavelengths above 200 MHz will result in radiation from EUT apertures and portions of cabling close to EUT interfaces. The requirements for antenna positioning above 200 MHz are based on including EUT apertures and lengths of cabling at least one quarter wavelength.

All the specified antennas are linearly polarised. Above 30 MHz, measurements must be performed to measure both horizontal and vertical components of the radiated field. Measurements with the 104 centimetre rod are performed only for vertical polarisation. This antenna configuration is not readily adapted for horizontal measurements.

For equipment or subsystems that have enclosures or cabling in various parts of a platform, data may need to be taken for more than one configuration. For example, in an aircraft installation where a pod is located outside of aircraft structure and its associated cabling is internal to structure, two different limits may be applicable. Different sets of data may need to be generated to isolate different emissions from the pod housing and from cabling. The non-relevant portion of the equipment would need to be protected with appropriate shielding during each evaluation.

#### 6.23 NRE03, radiated emissions, antenna spurious and harmonic outputs, 10 kHz to 40 GHz

**Applicability and limits:** The requirements are essentially identical with NCE03 for transmitters in the transmit mode. There are no requirements for receivers or transmitters in the standby mode. Most of the discussion under NCE03 also applies to NRE03. A distinction between the requirements is that NRE03 testing includes effects due to antenna characteristics. The test itself is considerably more difficult.

**Test procedures:** Since the test procedure measures emissions radiating from an antenna connected to a controlled impedance, shielded, transmission line, the measurement results should be largely independent of the test set-up configuration. Therefore, it is not necessary to maintain the basic test set-up described in the main body of this standard.

The test procedure is laborious and will require a large open area to meet antenna separation distances. Equations in the test procedure specify minimum acceptable antenna separations based on antenna size and operating frequency of the EUT. Antenna pattern searches in both azimuth and elevation are required at the spurious and harmonic emissions to maximise the level of the detected signal and account for antenna characteristics.

Sensitivity of the measurement system may need enhancement by use of preamplifiers and the entire test needs to be co-ordinated with local frequency allocation authorities. All recorded data has to be corrected for space loss and antenna gain before comparisons to the limit.

As shown in Figures NRE03-1 and NRE03-2 of Method NRE03, shielding might be necessary around the measurement system and associated RF components to prevent the generation of spurious responses in the measurement receiver. The need for such shielding can be verified by comparing measurement runs with the input connector of the measurement receiver terminated in its characteristic impedance and with the EUT in both transmitting and stand-by modes or with the EUT turned off. Also, the receiving or transmit antenna may be replaced with a dummy load to determine if any significant effects are occurring through cable coupling.

The RF cable from the receive antenna to the measurement receiver should be kept as short as possible to minimise signal loss and signal pick-up.

The band-rejection filters and networks shown in Figures NRE03-1 and NRE03-2 of Method NRE03 are needed to block the transmitter fundamental and thus reduce the tendency of the measurement receiver to generate spurious responses or exhibit suppression effects because of the presence of strong out-of-band signals. These rejection networks and filters require calibration over the frequency range of test.

Some caution needs to be exercised in applying Table 2. In paragraph 3.4 of Method NRE03, a power monitor is used to measure the output power of the EUT. In conjunction with the antenna gain, this value is used to calculate the effective radiated power (ERP) of the equipment. In paragraph 3.4 of Method NRE03, the measurement receiver is used to measure the power from a receiving antenna. This result is also used to calculate an ERP. For the two measurements to be comparable, the measurement receiver bandwidth needs to be sufficiently large to include at least 90% of the power of the signal present at the tuned frequency. If the bandwidth in Table 2 is not appropriate, a suitable measurement receiver bandwidth should be proposed in the EMITP.

For measurement of the magnitude of harmonic and spurious emissions with respect of the fundamental, the bandwidths of Table 2 will normally produce acceptable results, regardless of whether the bandwidth is large enough to process 90% of the power. Since the signal bandwidth of harmonic and spurious emissions is usually the same as the fundamental, use of a common bandwidth for measuring both the fundamental and the emissions will provide a correct relative reading of the amplitudes.

6.24 NRS01, radiated susceptibility, magnetic fields, 30 Hz to 100 kHz

**Applicability and limits:** This requirement is specialised and intended primarily to ensure that performance of equipment potentially sensitive to low frequency magnetic fields is not degraded. NRE01 is a complimentary requirement governing the radiated magnetic field emissions from equipment and subsystems. The NRE01 discussion is also applicable to this requirement.

The Sea NRS01 limit was established by measurement of magnetic field radiation from power distribution components (transformers and cables), and the magnetic field environment of Sea platforms. The Sea NRS01 limit from 30 Hz to 2 kHz was derived from the worst case magnetic field radiation from a power transformer (~170 dBpT) and applicable cable types (DSGU-400), and takes into account the user equipment power line harmonic content and maximum anticipated power consumption. The Sea NRS01 limit above 2 kHz is based on the measured magnetic field environment of Sea platforms.

Land has maintained the basic relationship of the NRS01 and NRE01 limits having the same shape. The NRS01 limit is based on 5 millivolts (independent of frequency) being induced in a 12.7 centimetre diameter loop.

**Test procedures:** Laboratory tests have been performed to assess the possibility of using the 13.3 centimetre loop sensor specified in the NRE01 test procedure instead of the 4 centimetre loop sensor used in this test procedure to verify the radiated field. The testing revealed that the 13.3 centimetre loop sensor did not provide the desired result due to variation of the radiated field over the area of the loop sensor. Due to its smaller size, the 4 centimetre loop sensor provides an accurate measure of the field near the axis of the radiating loop. A correction factor curve to convert from the voltage indicated by the measurement receiver to the magnetic field in dBpT is required. Manufacturers use different construction techniques that cause the actual factor to vary somewhat. Where traceable calibration figures are not available it is necessary to use the manufacturers' supplied data.

The primary test procedure requires that testing be performed at each electrical interface connector. On some small size EUTs, connectors may be closely spaced such that more than one connector can be effectively illuminated for a particular loop position. The EMITP shall address this circumstance.

Helmholtz coils generate a relatively uniform magnetic field that is more representative of the environment experienced on some platforms, particularly submarines. For this reason, the AC Helmholtz coil test option is preferred for submarine applications. In addition to providing a more realistic test bed, Helmholtz coils will, in general, reduce test time. Application of the guidelines and analytical expressions presented herein should enable users to design and construct Helmholtz coils for NRS01 testing.

AC Helmholtz coils may be designed in accordance with the following guidance.

1. A closed form solution for the magnetic flux density produced along the axis of a series-driven system of two identical circular coils is:

$$B_z = \frac{\mu_o N I r^2}{2} \left( \frac{1}{(z^2 + r^2)^{3/2}} + \frac{1}{((d-z)^2 + r^2)^{3/2}} \right)$$

where,

- $B_z$  = magnetic flux density, Teslas  
 $\mu_o$  = permeability of free space, Henrys/metre  
 $N$  = number of turns (same for each coil)  
 $I$  = current, Amperes  
 $r$  = coil radius, metres  
 $d$  = coil separation, metres  
 $z$  = distance along common axis, metres

For a standard Helmholtz coil configuration,  $d = r$ . At the centre of the test volume ( $z = r/2$ ), the above expression can be simplified:

$$B_z \approx \frac{(8.99 \times 10^{-7}) N I}{r}$$

2. The coil impedance can be estimated using general expressions for an *RL* series circuit. The dominant term for frequencies below 100 kHz is the coil inductance that is the sum of each coil's series inductance (*L*) and the mutual inductance (*M*) between the two coils:

$$L_{\text{Total}} = 2(L + M)$$

where:

$$M = \alpha N^2 r \quad \alpha = 0.494 \times 10^{-6} \text{ Henrys/metre}$$

The series inductance can be estimated using the following expression for the external inductance of a circular coil where the wire bundle cross section is circular in shape and small relative to the coil radius:

$$L = N^2 r \mu_o \left[ \ln \left( \frac{16r}{a} \right) - 2 \right]$$

where:  $a$  = diameter of wire bundle cross section, metres

There are several practical limitations that must be considered when designing AC Helmholtz coils.

1. The coil drive current is limited by coil impedance. The dominant term in the coil impedance is the coil inductive reactance. Because it is proportional to the square of the number of turns (*N*), the coils should be designed with a minimum number of turns needed to meet the low frequency test limit. Depending on coil size, it may be necessary to construct the coils with one or more taps so the number of turns can be reduced at higher frequencies.
2. The coil self-resonant frequency must be greater than 100 kHz. At self-resonance, it may not be practical to generate sufficient drive current to achieve the test limit.
3. A series voltage drop will exist across each coil that is proportional to the product of the coil impedance and coil drive current. Because the voltage drops are separated in space by the distance between the coils, a voltage gradient will exist (electric field in V/m). This field is

maximum near the perimeter of circular coils. If the EUT is relatively small compared to the available test volume, this effect may not be a concern. However, if the EUT is near the coil perimeter, or if the electric field magnitude is significant relative to the NRS02 electric field susceptibility requirement, then steps should be taken to minimise the electric field.

It may not be practical using commonly available laboratory power amplifiers to achieve the NRS01 test limit for coils much larger than 1.22metres in diameter. Consideration should be given to tailoring the test limit if a larger Helmholtz coil is used. For example, it may be proposed that the radiated test level exceed the limit by 3 dB, rather than the 6 dB required for Helmholtz coils. Any tailoring requires approval from the procuring activity.

Prior to initial use, the coils must be tested to ensure they are capable of generating the required magnetic flux densities from 30 Hz to 100 kHz. Sufficient margin (2 to 3 dB) should be available to compensate for the potential loading effect of nearby metallic structures or magnetic material. It must be confirmed that the first indication of self-resonance appears above the NRS01 upper frequency limit of 100 kHz. For frequencies above 10 kHz, the magnitude of the electric field component in the test volume should be determined either by direct measurement, or it should be approximated by measuring the voltage drop across the coils and dividing by coil separation distance. Unless the electric field component is much less than the NRS03 electric field susceptibility limit, the coils should be enclosed in a non-continuous electrostatic shield to prevent ambiguity when interpreting susceptibility test results.

6.25 NRS02, radiated susceptibility, electric field, 50 kHz to 40 GHz

**Applicability and limits:** The requirements are applicable to both the EUT enclosures and EUT associated cabling. The basic concern is to ensure that equipment will operate without degradation in the presence of electromagnetic fields generated by antenna transmissions both onboard and external to the platform.

The EUT is subjected to lower frequency radiated fields (down to 50 kHz) to determine its vulnerability to emissions generated within the EUT's normal installation by other electronic/electrical components, such as those associated with switch mode power supplies.

There is no implied relationship between this requirement and NRE02. The NRE02 limit is placed primarily to protect antenna-connected receivers while NRS02 simulates fields resulting from antenna transmissions.

The limits specified for different platforms are simply based on levels expected to be encountered during the service life of the equipment. They do not necessarily represent the worst-case environment to which the equipment may be exposed. RF environments can be highly variable, particularly for emitters not located on the platform. The limits are placed at levels that are considered to be adequate to cover most situations.

In the past EUTs have been found to be susceptible to ripple voltages when fitted to platforms and hence must be tested to avoid problems when subjected to low frequency radiated fields.

An example, which demonstrates the variability of environments for ground installations and the need for effective tailoring of requirements, is the installation of equipment in a large ground-based radar facility. Some of these facilities transmit power levels over one megawatt and the back lobes from the antennas can be substantial. Suitable design levels for equipment that will be used in the facility or nearby need to be imposed.

For aircraft and ships, different limits are specified depending on whether the equipment receives protection from platform structure. This distinction is not made for Army ground systems, such as tanks, because the same equipment used inside a structure is often used in other applications where protection is not available.

The 200 volt/metre requirement for Aircraft is regardless of the location or criticality of the equipment. Portions of the external environment accepted for most Aircraft is higher than 200 volts/metre. Aircraft, especially rotary wing, have flight profiles that are almost exclusively nap-of-the-earth (NOE). The NOE profiles allow for much closer, and longer duration, encounters with high power emitters. This approach is similar to the FAA approach that recommends that Visual Flight Rules (VFR) helicopters be qualified to levels higher than fixed wing aircraft.

For submarines, the NRS02 limit distinguishes between equipment located internal versus external to the pressure hull. For equipment installed internal to the pressure hull, 10 volts/metre is specified above 30 MHz to account for portable transmitters used with the submarine. For equipment located external to the pressure hull, stricter limits are imposed to more closely reflect the electromagnetic environment. The external NRS02 limits should be applied only to equipment that is required to be fully operational when located above the waterline. Separate limits are specified, which are less severe, for equipment that is "external" to the pressure hull but located with the submarine superstructure (metallic boundary).

Using circularly polarised fields is not allowed due to problems detailed with using spiral conical antennas. Circularly polarised fields were convenient since they avoided the need to rotate a linearly polarised antenna to obtain both polarisation of the radiated field. However, problems existed with this antenna. At some frequencies, the antenna pattern of the conical log spiral is not centred on the antenna axis. Also, the circular polarisation of the conical log spiral creates confusion in its proper application. The EUT and associated cabling can be expected to respond more readily to linearly polarised fields. If a second spiral conical were used to calibrate the field radiated from the first spiral conical antenna, it would indicate an electric field 3 dB higher than a linearly polarised antenna. The question arises whether a 3 dB higher field should be used for a spiral conical transmit antenna to obtain response characteristics similar to a linearly polarised field. Similarly, if a spiral conical antenna were used to calibrate a linearly polarised field, the indication would be 3 dB below the true electric field strength.

Possible tailoring by the procuring activity for contractual documents is to modify the required levels and required frequency ranges based on the emitters on and near a particular installation. Actual field levels can be calculated from characteristics of the emitters, distances between the emitters and the equipment, and intervening shielding. MIL-HDBK-235 and Def Stan 08-46 provide information on land, air, and sea based RF emitters, both hostile and friendly, which contribute to the overall electromagnetic environment. The possible use of the equipment in other installations and the potential addition or relocation of RF emitters needs to be considered. Other possible tailoring is to change from the standard 1 kHz, square wave modulation or use additional modulations based on actual platform environments.

**Test procedures:** Test facilities are permitted to select appropriate electric field generating apparatus. Any electric field generating device such as antenna, long wire, TEM cell, reverberating chamber (using mode tuned techniques) or parallel strip line capable of generating the required electric field may be used. Fields should be maintained as uniform as possible over the test set-up boundary. Above 30 MHz, both horizontally and vertically polarised fields must be generated. This requirement may limit the use of certain types of apparatus. Only vertically polarised measurements are required below 30 MHz due to the difficulty of orienting available test equipment for horizontal measurements.

Monitoring requirements emphasise measuring true electric field. While emission testing for radiated electric fields does not always measure true electric field, sensors with adequate sensitivity are available for field levels generated for susceptibility testing. Physically small and electrically short sensors are required so that the electric field does not vary substantially over the pickup element resulting in the measurement of a localised field. Broadband sensors not requiring tuning are available.

The use of more than one sensor is acceptable provided all sensors are within the beamwidth of the transmit antenna. The effective field is determined by taking the average of the readings. For example, if the readings of three sensors are 30, 22, and 35 volts/metre, the effective electric field level is  $(30 + 22 + 35)/3 = 29$  volts/metre.

Different sensors may use various techniques to measure the field. At frequencies where far-field conditions do not exist, sensors must be selected which have electric field sensing elements. Sensors that detect magnetic field or power density and convert to electric field are not acceptable. Under far-field conditions, all sensors will produce the same result. Correction factors must be applied for modulated test signals for equivalent peak detection as discussed under paragraph 4.3.10.1 of the document. A typical procedure for determining the correction factor for these sensors is as follows:

1. Generate a field at a selected frequency using an unmodulated source.
2. Adjust the field to obtain a reading on the sensor display near full scale and note the value.
3. Modulate the field as required (normally 1 kHz pulse, 50% duty cycle) and ensure the field has the same peak value. A measurement receiver with the peak detector selected and receiving antenna can be used to make this determination.
4. Note the reading on the sensor display.
5. Divide the first reading by the second reading to determine the correction factor (Subtract the two readings if the field is displayed in terms of dB).
6. Repeat the procedure at several frequencies to verify the consistency of the technique.

Above 1 GHz, radiated fields usually exhibit far-field characteristics for test purposes due to the size of typical transmit antennas, antenna patterns, and distances to the EUT. Therefore, a double-ridged horn together with a measurement receiver will provide true electric field. Similarly, the particular sensing element in an isotropic sensor is not critical, and acceptable conversions to electric field can be made.

For equipment or subsystems that have enclosures or cabling in various parts of a platform, data may need to be taken for more than one configuration. For example, in an aircraft installation where a pod is located outside of aircraft structure and its associated cabling is internal to structure, two different limits may be applicable. Different sets of data may need to be generated to evaluate potential pod susceptibility due to coupling through the housing versus coupling from cabling. The non-relevant portion of the equipment would need to be protected with appropriate shielding.

Reverberating chambers, using mode-tuned techniques, have been popular for performing shielded effectiveness evaluations and, in some cases, have been used for radiated susceptibility testing of equipment and subsystems. The concept used in reverberating chambers is to excite available electromagnetic wave propagation modes to set up variable standing wave patterns in the chamber. A transmit antenna is used to launch an electromagnetic wave. An irregular shaped tuner is rotated to excite the different modes and modify the standing wave pattern in the chamber. Any physical location in the chamber will achieve same peak field strength at some position of the paddle wheel.

Reverberation chambers have the advantage of producing relatively higher fields than other techniques for a particular power input. Also, the orientation of EUT enclosures is less critical since the all portions of the EUT will be exposed to the same peak field at some paddle wheel position. The performance of a particular reverberation chamber is dependent upon a number of factors including dimensions, Q of the chamber, number of available propagation modes, and frequency range of use.

Some issues with reverberation chambers are as follows. The field polarisation and distribution with respect to the EUT layout are generally unknown at a point in time. If a problem is noted, the point of entry into the EUT may not be apparent.

Reverberation chambers are sometimes treated as a good tool to determine potential problem frequencies with conventional antenna procedures being used to evaluate areas of concern.

The performance of each chamber must be reviewed to determine the suitability of its use for reverberation testing over a particular frequency range.

Reverberation chambers should be constructed in accordance with the following guidance in order to function properly.

1. A tuner should be constructed of metal and installed with appropriate positioning equipment to allow the tuner to be rotated 360 degrees in at least 200 evenly spaced increments. The tuner should be constructed to be asymmetric with the smallest dimension of the tuner being at least  $\lambda/3$  of lowest frequency to be tested and the longest dimension of the tuner being approximately 75% of the smallest chamber dimension.
2. The enclosure shall be free of any materials that might exhibit absorptive properties such as tables, chairs, wood floors, sub-floors, shelves, and such. Support structures should be constructed from high density foam.
3. Transmit and receive antennas should be at least 1.0 metre ( $\lambda/3$  is the actual limitation) from any wall or object and should be positioned to prevent direct alignment between the main lobes of the two antennas or between the EUT and the main lobe of either antenna.
4. The lower frequency limit is dependent on chamber size. To determine the lower frequency limit for a given chamber, use one of the following methods:
  - a. Using the following formula, determine the number of possible modes (N) which can exist at a given frequency. If, for a given frequency, N is less than 100 then the chamber should not be used at or below that frequency.

$$N = \frac{8\pi}{3} a b d \frac{f^3}{c^3}$$

where: a, b, and d are the chamber internal dimensions in metres

f is the operation frequency in Hz

c is the speed of propagation ( $3 \times 10^8$  m/s)

- b. Use the methods detailed in RTCA DO-160, section 20.6, for determining the lowest useable frequency based on field uniformity.
5. In order to assure that the time response of the chamber is fast enough to accommodate pulsed waveform testing (other than the 1 kHz, 50% duty cycle, waveform specified), determination of the chamber time constant must be accomplished using the following procedure:
  - a. Calculate the chamber Q using:

$$Q = \left( \frac{16\pi^2 V}{\eta_{Tx} \eta_{Rx} \lambda^3} \right) \left( \frac{P_{ave\ rec}}{P_{forward}} \right)$$

Where  $\eta_{Tx}$  and  $\eta_{Rx}$  are the antenna efficiency factors for the Tx and Rx antennas respectively and can be assumed to be 0.75 for a log periodic antenna and 0.9 for a horn antenna.

V is the chamber volume ( $m^3$ ),  $\lambda$  is the free space wavelength (m) at the specific frequency.

$P_{ave\ rec}$  is the average received power over one tuner rotation.

$P_{forward}$  is the forward power input to the chamber over the tuner rotation at which  $P_{ave\ rec}$  was measured.

- b. Calculate the chamber time constant,  $\tau$ , using:

$$\tau = \frac{Q}{2\pi f}$$

Where Q is the value calculated above, and f is the frequency (Hz)

- c. If the chamber time constant is greater than 0.4 of the pulse width of the modulation waveform, absorber material must be added to the chamber or the pulse width must be increased. If absorber material is added, repeat the measurement and the Q calculation until the time constant requirement is satisfied with the least possible absorber material. A new  $CLF(f)$  must be defined if absorber material is required.
6. Prior to using the chamber, the effectiveness of the tuner should be evaluated at the upper and lower frequencies to be used and at points between the endpoints not to exceed 1 GHz spacing. To evaluate the stirring effectiveness, inject a CW signal into the chamber at the desired frequency and record the net received power at 200 positions of the tuner evenly spaced over a 360 degree rotation of the tuner. Determine the correlation coefficient between the original set of received power and subsequent sets obtained by rotating the last data point of the original set to the position of the first point and then shifting all the other points to the right as depicted below.

Original data	D1, D2, D3, D4, D5, . . . D200
Shifted data (1)	D200, D1, D2, D3, D4, . . . D199
Shifted data (2)	D199, D200, D1, D2, D3, . . . D198
Shifted data (3)	D198, D199, D200, D1, D2, . . . D197
Shifted data (4)	D197, D198, D199, D200, D1, . . . D196
Shifted data (5)	D196, D197, D198, D199, D200, D1, . . . D195

The correlation coefficient should drop to below 0.36 within five shifts of the data. This will ensure that the tuner is operating properly. If the tuner fails this test, then the tuner needs to be made either larger or more complex, or both.

7. National Bureau of Standards Technical Note 1092. "Design, Evaluation, and Use of a Reverberation Chamber for Performing Electromagnetic Susceptibility/Vulnerability Measurements" and National Institute of Standards and Technology Technical Note 1508, "Evaluation of the NASA Langley Research Center Mode-Stirred Chamber Facility," should be used as a guide in preparing a shielded room for reverberation measurements.

#### 6.26 NRS03, radiated susceptibility, transient, electromagnetic field

**Applicability and limits:** This requirement is primarily intended for EUTs to withstand the fast rise time, free field, transient environment of an electromagnetic pulse (EMP). It applies for equipment enclosures, which are directly exposed to the incident field outside of the platform structure or for equipment inside poorly shielded or unshielded platforms. This requirement may be tailored in adjustment of the curve amplitude either higher or lower based on degree of field enhancement or protection provided in the area of the platform where the equipment will be located. This requirement

is applicable only for EUT enclosures. The electrical interface cabling should be protected in shielded conduit. Potential equipment responses due to cable coupling are controlled under NCS09.

**Test procedures:** To protect the EUT and actual and simulated loads and signal equipment, all cabling should be treated with overall shielding; kept as short as possible within the test cell; and oriented to minimise coupling to the EMP fields.

The EMP field is simulated in the laboratory using bounded wave TEM radiators such as TEM cells and parallel plate transmission lines. To ensure the EUT does not significantly distort the field in the test volume, the largest EUT dimension should be no more than a third of the dimension between the radiating plates of the simulator. In these simulators the electric field is perpendicular to the surfaces of the radiator. Since the polarisation of the incident EMP field in the installation is not known the EUT must be tested in all orthogonal axes.

There is a requirement to first test at 10% of the specified limit and then increase the amplitude in steps of 2 or 3 until the specified limit is reached for several reasons. This test has the potential to burnout equipment and stating at lower levels provides a degree of protection. Also, the equipment may exhibit susceptibility problems at lower test levels that do not occur at higher test levels due to the presence of terminal protection devices (TPDs). At lower test levels, the devices might not actuate resulting in higher stresses on circuits than for higher levels where they do actuate.

Common mode signals can result on cables with inadequate isolation or leaky connectors in the presence of radiated fields. A method of checking for potential problems is as follows:

1. Measure the E-field with the B-dot or D-dot probe.
2. Invert the probe by rotating it 180 degrees.
3. Measure the E-field again and invert the signal.
4. Overlay and subtract the two signals.
5. The result is the common mode signal.

If any significant level is present, corrections to the set-up should be undertaken, such as tightening of connectors and introduction of additional isolation, such as better shielded cables, alternative routing, or shielding barriers.

6.27 NRS04, radiated susceptibility, magnetic field susceptibility (DC)

**Applicability and limits:** This requirement is specialised and intended primarily to ensure that performance of equipment potentially sensitive to DC magnetic fields is not degraded. EUTs may be required to operate in areas that are subjected to large fields either intentionally or unintentionally generated.

This requirement is performed to prove that equipment continues to function correctly on board a Ship where depermining and degaussing of the ship's hull takes place on a regular basis. It should be noted that the amount of field that the EUT will be subjected to will be dependant upon its location on the ship and the level applied should be adjusted accordingly, for this reason the procuring authority should define actual levels before testing commences.

If either Land or Air procuring authorities deploy EUTs in areas of high DC magnetic fields then it is unlikely that the specified level of 800 A/m is suitable for ensuring correct operation. The level applied shall be tailored to the actual environment that the EUT will be operating in.

This test procedure should be used when EUTs have components that are sensitive to magnetic fields such as CRTs, Hall effect circuitry, compasses or generating/sensing loops.

**Test procedures:** A slewed DC magnetic field must be applied to all equipment operating on submarines and surface ships using the Helmholtz coil specified in NRS01.

This test should be applied to each axis of the EUT for a continuous time period to establish that the EUT has suffered no detrimental effects. The field should be increased up to the desired test level at a rate of 1600 A/m/s and then maintained at this level for at least 5 seconds before being allowed to decay back to 0 A/m. This process should be repeated a sufficient number of times to establish that the EUT has not been adversely effected. This process should then be repeated with the field in the opposite direction, this is accomplished by reversing the connections to the coil.

Care must be taken to keep the EUT in the uniform portion of the field produced within the centre of the coil. The area of uniform field is dependant upon the physical size of the Helmholtz coil being used and no EUT tested should have any dimension greater than 1.1 x the radius of that coil.

For EUT (or units of a system) greater than 1m<sup>3</sup> or weighing more than 100kg it is considered generally impractical to apply the standard test method. For these equipment types, a localised test method shall be applied to all the areas of the equipment considered most likely to be susceptible. However it should be stressed that the normal method be used wherever possible and that the localised method be limited to exceptional circumstances.

For the purpose of the test, the EUT should be powered and in its normal mode of operation throughout and some means of indication should be present to establish its correct operation.

**7. APPLICABLE DOCUMENTS**

## 7.1 General

The documents listed here are specified within the AECTP 500 series.

## 7.2 Government documents

## 7.2.1 Specifications, Standards, and Handbooks

## STANDARDS

## MILITARY

MIL-STD-188-125	HEMP Protection for Ground-Based C4I Facilities Performing Critical, Time-Urgent Missions
MIL STD-461	Requirements for the Control of Electromagnetic Interference Characteristics of Subsystems and Equipment
MIL-STD-464A	Electromagnetic Environmental Effects Requirements for Systems
MIL-STD-469	Radar Engineering Design Requirements, Electromagnetic Compatibility
MIL-STD-704	Aircraft Electric Power Characteristics
Def Stan 08-46	The Electric, Magnetic and Electromagnetic Environment
Def Stan 59-41	Electromagnetic Compatibility

## NORTH ATLANTIC TREATY ORGANIZATION

STANAG 4235	Electrostatic Environmental Conditions Affecting the Design of Materiel for Use by NATO Forces
STANAG 4239	Electrostatic Discharge, Munition Test Procedures
STANAG 4324	Electromagnetic Radiation Hazard Assessment and Testing of Munitions and Associated Systems
STANAG 4327	Lightning Munition Assessment and Test Procedure
STANAG 4416	Nuclear Electromagnetic Pulse, Testing of Munitions containing EEDs

## HANDBOOKS

## MILITARY

MIL-HDBK-235	Electromagnetic (Radiated) Environment Considerations for Design and Procurement of Electrical and Electronic Equipment
MIL-HDBK-237	Guidance for Controlling Electromagnetic Environmental Effects on Platforms, Systems, and Equipment
MIL-HDBK-241	Design Guide for EMI Reduction in Power Supplies
MIL-HDBK-253	Guidance for the Design and Test of Systems Protected Against the Effects of Electromagnetic Energy
MIL-HDBK-423	HEMP Protection for Fixed and Transportable Ground-Based Facilities

## 7.2.2 Other Government documents, drawings, and publications.

The following Government documents, drawings, and publications specified herein are referenced solely to provide supplemental technical data. These documents are for informational purposes only.

## AIR FORCE SYSTEMS COMMAND (AFSC)

AFSC DH 1-4 Air Force Systems Command Design Handbook, EMC

## NATIONAL BUREAU OF STANDARDS (NBS)

Technical Note 1092 Design, Evaluation, and Use of a Reverberation Chamber for Performing Electromagnetic Susceptibility/Vulnerability Measurements

## NATIONAL INSTITUTE OF STANDARDS AND TECHNOLOGY (NIST)

Technical Note 1508 Evaluation of the NASA Langley Research Center Mode-Stirred Chamber Facility

## NATIONAL TELECOMMUNICATION AND INFORMATION AGENCY (NTIA)

NTIA Manual of Regulations & Procedures for Federal Radio Frequency Management

## US ARMY AMC MATERIEL READINESS SUPPORT ACTIVITY

AMC Pamphlet 706-410 Engineering Design Handbook, EMC

## US ARMY AVIATION AND TROOP COMMAND

ADS-37A-PRF Electromagnetic Environmental Effects (E<sup>3</sup>) Design And Verification Requirements

## 7.3. Non-Government publications

The following non-government documents specified herein are referenced solely to provide supplemental technical data. These documents are for informational purposes only

## AMERICAN NATIONAL STANDARDS INSTITUTE (ANSI)

ANSI/IEEE C63.2	Standard for Instrumentation, Electromagnetic Noise and Field Strength, 10 kHz to 40 GHz, Specifications
ANSI/IEEE C63.4	Standard for Electromagnetic Compatibility, Radio-Noise Emissions from Low Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 1 GHz, Methods of Measurement
ANSI/IEEE C63.14	Standard Dictionary for Technologies of Electromagnetic Compatibility (EMC), Electromagnetic Pulse (EMP), and Electrostatic Discharge (ESD)
ANSI/NCSL Z540-1	General Requirements for Calibration Laboratories And Measuring and Test Equipment

## AMERICAN SOCIETY FOR TESTING AND MATERIALS (ASTM)

ASTM E 380	Standard for Metric Practice (DoD adopted)
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## INTERNATIONAL STANDARDIZATION ORGANIZATION (ISO)

ISO 10012-1	Quality Assurance Requirements for Measuring Equipment
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## RADIO TECHNICAL COMMISSION FOR AERONAUTICS

DO-160	Environmental Conditions and Test Procedures for Airborne Equipment
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## SOCIETY OF AUTOMOTIVE ENGINEERS (SAE)

ARP 958	Electromagnetic Interference Measurement Antennas; Standard Calibration Requirements and Methods
ARP 1972	Recommended Measurement Practices and Procedures for EMC Testing

## Other Documents

BS EN 61000-4-2 1995	Electromagnetic compatibility (EMC) – Test and Measurement Techniques – Electrostatic Discharge Immunity Test
IEC 1000-4-2	International Electrotechnical Commission Electrostatic Discharge Requirement

## 8. DEFINITIONS

### 8.1 General

The terms used in this appendix are defined in ANSI C63.14. In addition, the following definitions are applicable for the purpose of the AECTP 500 series.

a. Above deck

An area on ships which is not considered to be "below deck" as defined herein.

b. Below deck

An area on ships which is surrounded by a metallic structure, or an area which provides significant attenuation to electromagnetic radiation, such as the metal hull or superstructure of a surface ship, the pressure hull of a submarine and the screened rooms in non-metallic ships.

c. External installation

An equipment location on a platform, which is exposed to the external electromagnetic environment, such as an aircraft cockpit, which does not use electrically conductive treatments on the canopy or windscreen.

d. Internal installation

An equipment location on a platform, which is totally inside an electrically conductive structure, such as a typical avionics bay in an aluminium skin aircraft.

e. Flight-line equipment

Any support equipment that is attached to or used next to an aircraft during pre-flight or post-flight operations such as uploading or downloading data, maintenance diagnostics, or equipment functional testing.

f. Metric units

Metric units are a system of basic measures, which are defined by the International System of Units based on "Le System International d'Unites (SI)", of the International Bureau of Weights and Measures. These units are described in ASTM E 380.

g. Non-developmental item

Non-developmental item is a broad, generic term that covers material available from a wide variety of sources with little or no development effort required by the Government.

h. Safety critical

Safety Critical in that the safety of personnel or third parties is placed at risk either directly or indirectly from malfunctioning of the equipment (and hence subsequently the materiel).

i. Mission Critical

Mission Critical in that malfunctioning or upset of the equipment functions either reduces, damages or prevents the materiel from performing its mission.

j. Non Critical

Non-Critical in that disturbance in the functional capability of the equipment does not degrade the overall performance of the materiel.

k. Test set-up boundary

The test set-up boundary includes all enclosures of the Equipment Under Test (EUT) and the 2 metres of exposed interconnecting leads (except for leads, which are shorter in the actual installation) and power leads required by paragraph 4.3.8.6.

## 8.2 Acronyms

ASW	Anti-submarine Warfare
BIT	Built-in-Test
CFC	Carbon Fibre Compound
CTL	Computed Transient Levels
CW	Continuous Wave
ECM	Electronic Countermeasures
EED	Electro Explosive Device
EMC	Electromagnetic Compatibility
EME	Electromagnetic Environment
EMI	Electromagnetic Interference
EMICP	Electromagnetic Interference Control Procedures
EMITP	Electromagnetic Interference Test Procedures
EMITR	Electromagnetic Interference Test Report
EMP	Electromagnetic Pulse
ERP	Effective Radiated Power
ESD	Electro Static Discharge
EUT	Equipment Under Test
FADEC	Fully Automated Digital Electronic Control
GIE	Group Indirect Effects
GPI	Ground Plane Interference
GFE	Government Furnished Equipment
LISN	Line Impedance Stabilization Network
MAD	Magnetic Anomaly Detection
NDI	Non-Developmental Item
NEMP	Nuclear Electro Magnetic Pulse
NOE	Nap-of-the-earth
RF	Radio Frequency
RMS	Root Mean Square
TEM	Transverse Electromagnetic
TPD	Terminal Protection Device
UPS	Uninterruptible Power Supplies
VFR	Visual Flight Rules
VSWR	Voltage Standing Wave Ratio

AECTP 500  
Edition 2  
Category 501

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# **NCE01**

## **Conducted Emissions, Power Leads, 30 Hz to 10 kHz**

### TABLE OF CONTENTS

<b>1</b>	<b>NCE01 APPLICABILITY.....</b>	<b>NCE01-2</b>
<b>2</b>	<b>NCE01 LIMITS.....</b>	<b>NCE01-2</b>
<b>3</b>	<b>NCE01 TEST PROCEDURE.....</b>	<b>NCE01-2</b>
	3.1 Purpose.....	NCE01-2
	3.2 Test equipment.....	NCE01-2
	3.3 Setup.....	NCE01-2
	3.4 Procedures.....	NCE01-3
	3.5 Data presentation.....	NCE01-3

## **NCE01**

### **Conducted Emissions, Power Leads, 30 Hz to 10 kHz**

#### **1 NCE01 APPLICABILITY**

This requirement is applicable for power leads, including returns, that obtain power from other sources not part of the Equipment Under Test (EUT) for Sea and Air applications. For AC applications, this requirement is applicable starting at the second harmonic of the EUT power frequency.

Reference should be made to the Applicability Tables 6 and 7 and paragraphs 6.4 and 6.8 contained in Category 501 before subjecting the EUT to this test method. This test method may be substituted by NCE05 where some procuring authorities require testing to a higher frequency.

#### **2 NCE01 LIMITS**

Conducted emissions on power leads shall not exceed the applicable values shown on Figure NCE01-1 for DC submarine applications, Figure NCE01-2 for 60 Hz submarine applications, Figure NCE01-3 for 400 Hz submarine applications and Figure NCE01-4 for air applications.

#### **3 NCE01 TEST PROCEDURE**

##### **3.1 Purpose**

This test procedure is used to verify that electromagnetic emissions from the EUT do not exceed the specified requirements for power input leads including returns.

##### **3.2 Test equipment**

The test equipment shall be as follows:

- a. Measurement receivers
- b. Current probes
- c. Signal generator
- d. Data recording device
- e. Oscilloscope
- f. Resistor (R)
- g. 50  $\mu$ H LISNs

##### **3.3 Setup**

The test setup shall be as follows:

- a. Maintain a basic test setup for the EUT as shown and described in Category 501, Figures 3 through to 6 and paragraph 4.3.8. The LISN may be removed or replaced with an alternative stabilization device when approved by the procuring activity.
- b. Calibration. Configure the test setup for the measurement system check as shown in Figure NCE01-5.
- c. EUT testing

- (1) Configure the test setup for compliance testing of the EUT as shown in Figure NCE01-6.
- (2) Position the current probe 50 mm from the LISN.

### 3.4 Procedures.

The test procedures shall be as follows:

- a. Turn on the measurement equipment and allow a sufficient time for stabilization.
- b. Calibration. Evaluate the overall measurement system from the current probe to the data output device.
  - (1) Apply a calibrated signal level, which is at least 6 dB below the applicable limit at 1 kHz, 3 kHz, and 10 kHz, to the current probe.
  - (2) Verify the current level, using the oscilloscope and load resistor; also, verify that the current waveform is sinusoidal.
  - (3) Scan the measurement receiver for each frequency in the same manner as a normal data scan. Verify that the data-recording device indicates a level within  $\pm 3$  dB of the injected level.
  - (4) If readings are obtained which deviate by more than  $\pm 3$  dB, locate the source of the error and correct the deficiency prior to proceeding with the testing.
- c. EUT testing. Determine the conducted emissions from the EUT input power leads including returns.
  - (1) Turn on the EUT and allow sufficient time for stabilization.
  - (2) Select an appropriate lead for testing and clamp the current probe into position.
  - (3) Scan the measurement receiver over the applicable frequency range, using the bandwidths and minimum measurement times specified in Table 2 of Category 501.
  - (4) Repeat 3.4b(4) for each power lead.

### 3.5 Data presentation.

Data presentation shall be as follows:

- a. Automatically and continuously plot amplitude versus frequency profiles on X-Y axis outputs. Manually gathered data is not acceptable except for plot verification.
- b. Display the applicable limit on each plot.
- c. Provide a minimum frequency resolution of 1% or twice the measurement receiver bandwidth, whichever is less stringent, and a minimum amplitude resolution of 1 dB for each plot.
- d. Provide plots for both the measurement and system check portions of the procedure.

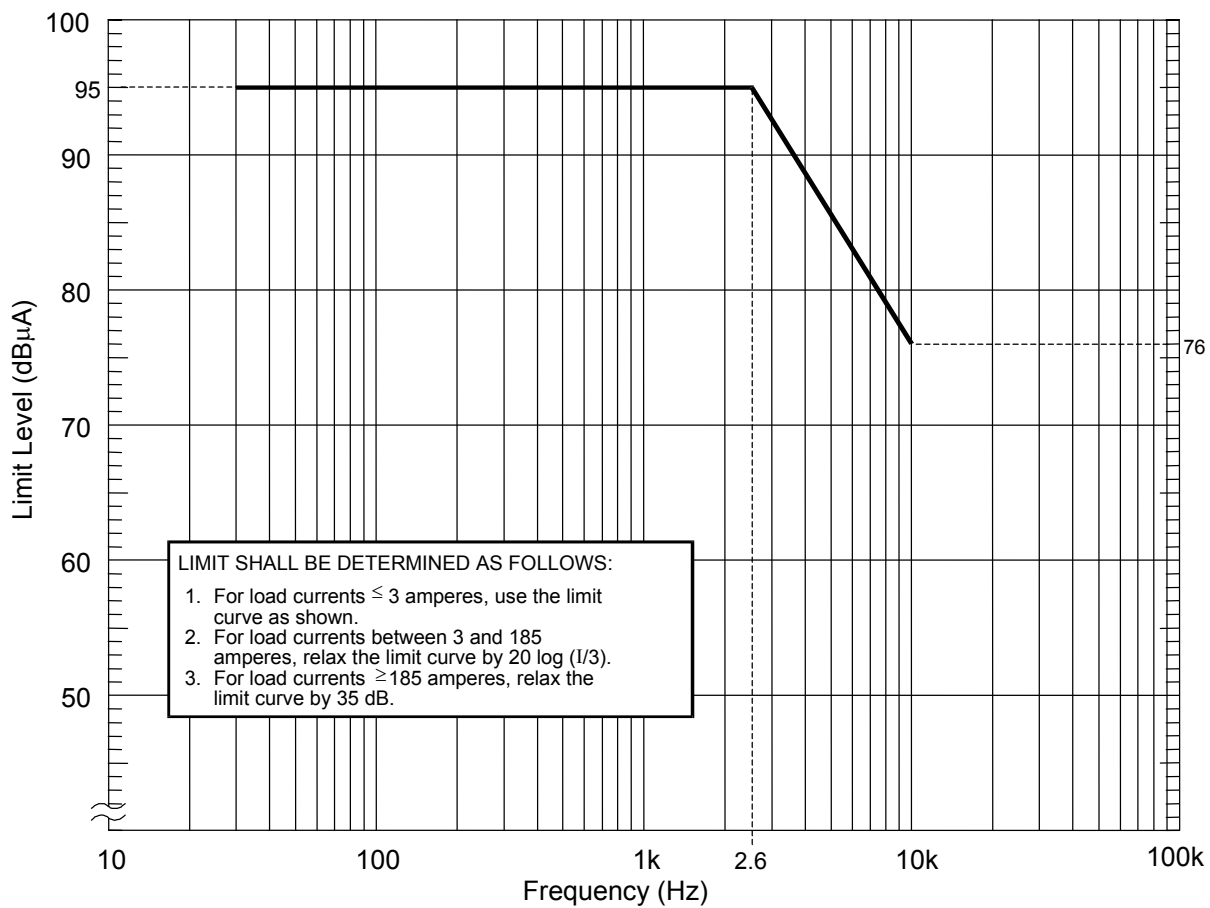


FIGURE NCE01-1 NCE01 limit for submarine applications, DC

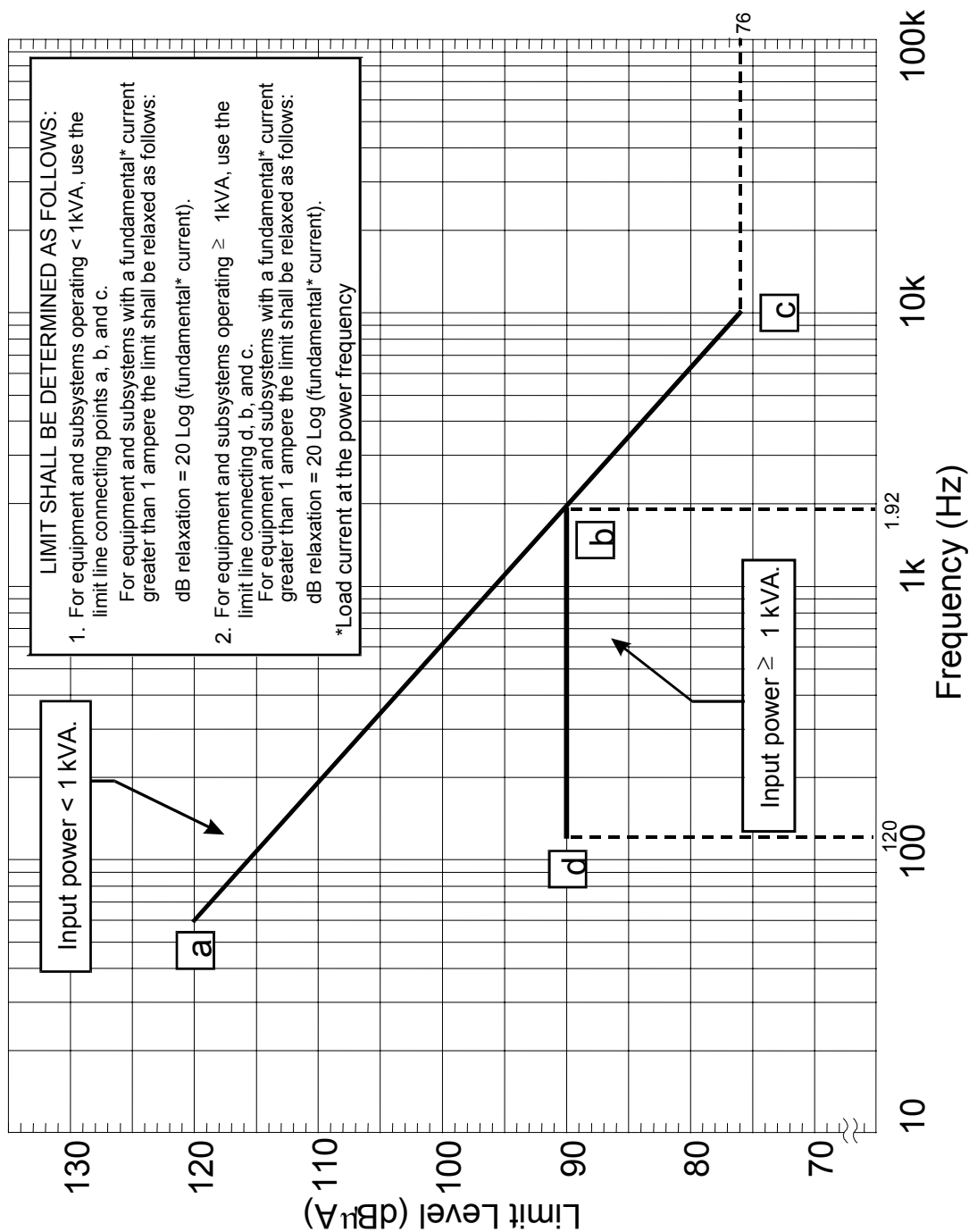


FIGURE NCE01-2 NCE01 limit for submarine applications, 60 Hertz

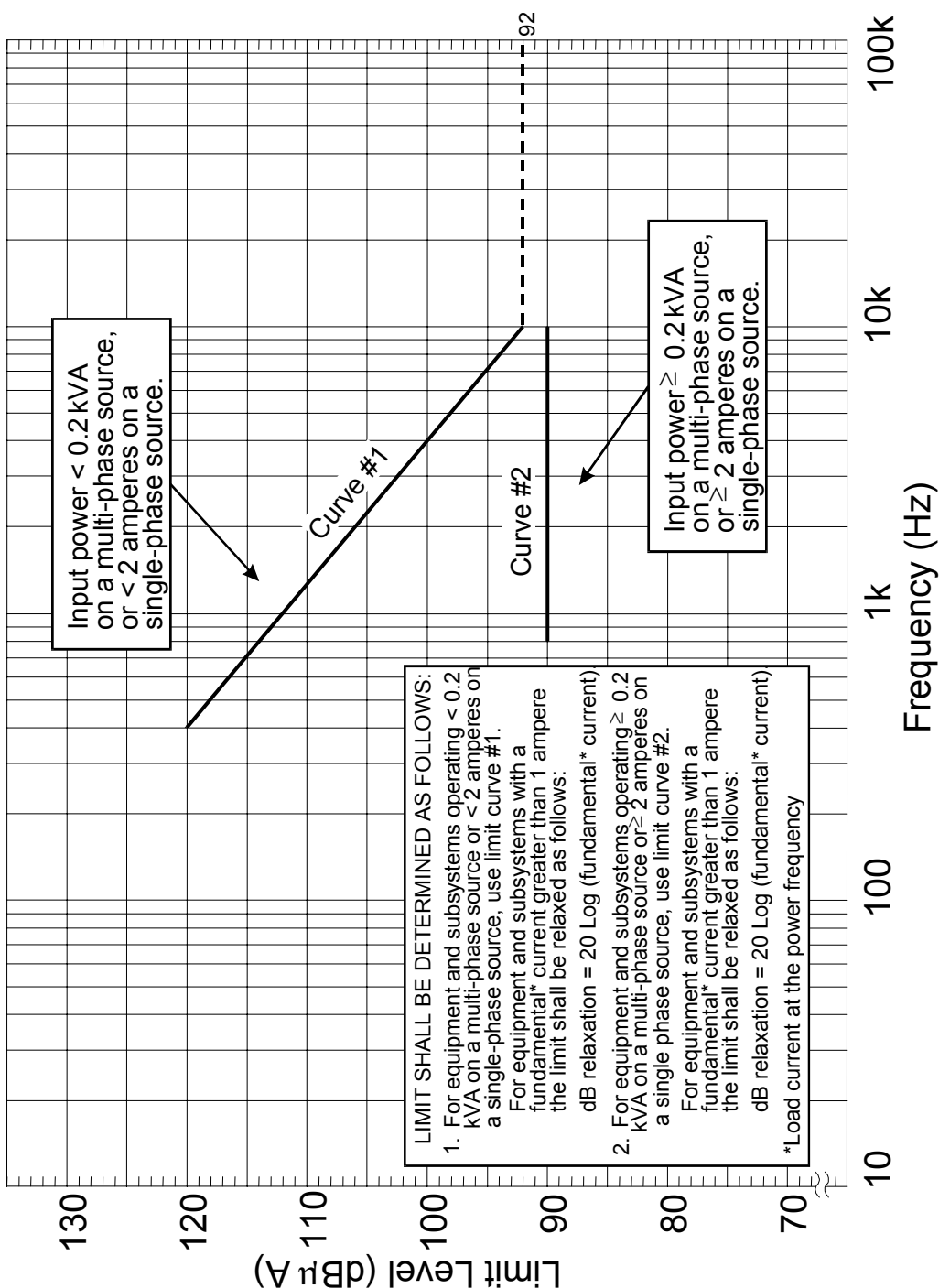
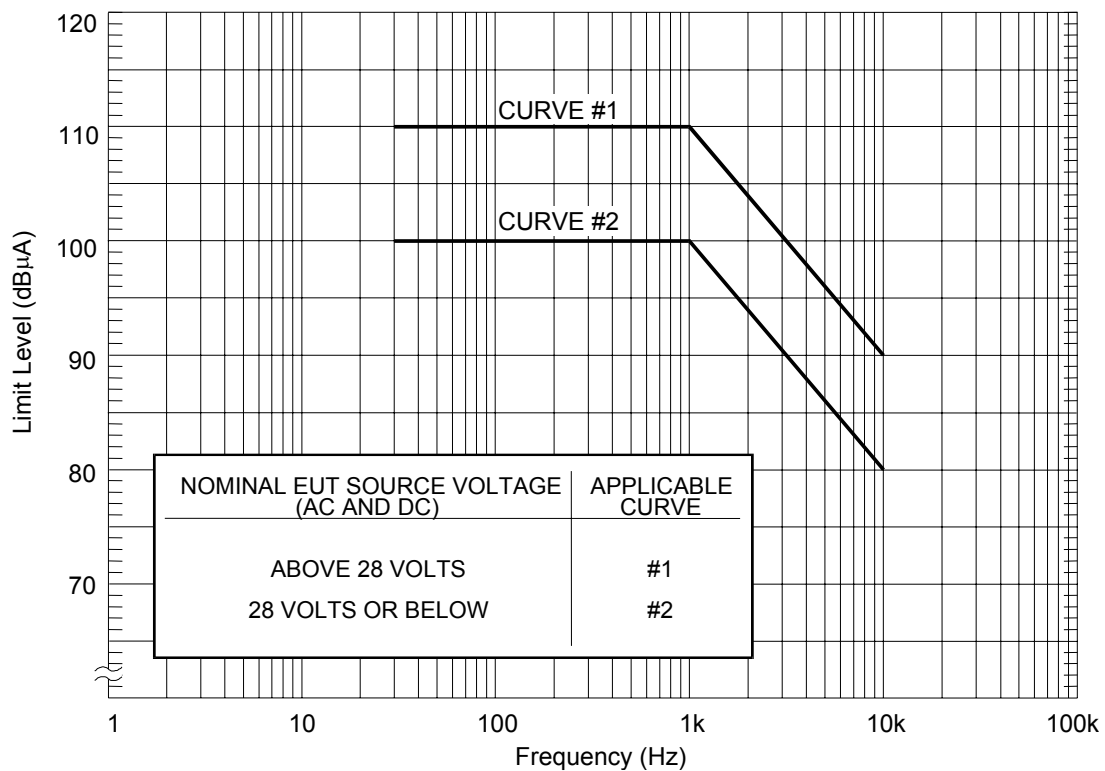
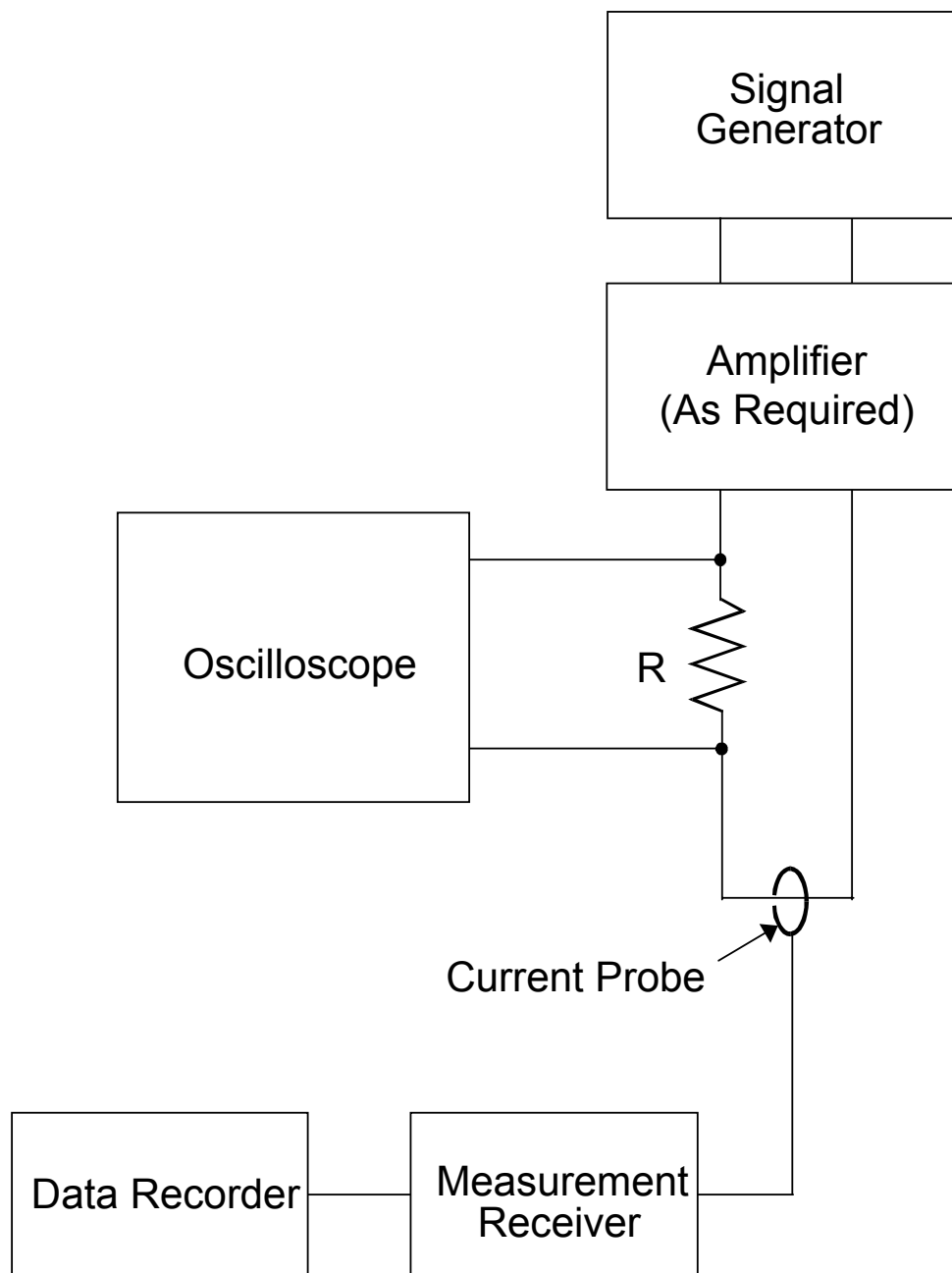


FIGURE NCE01-3 NCE01 limit for submarine applications, 400 Hertz



**FIGURE NCE01-4 NCE01 Limit for air applications**



**FIGURE NCE01-5 Measurement system check**

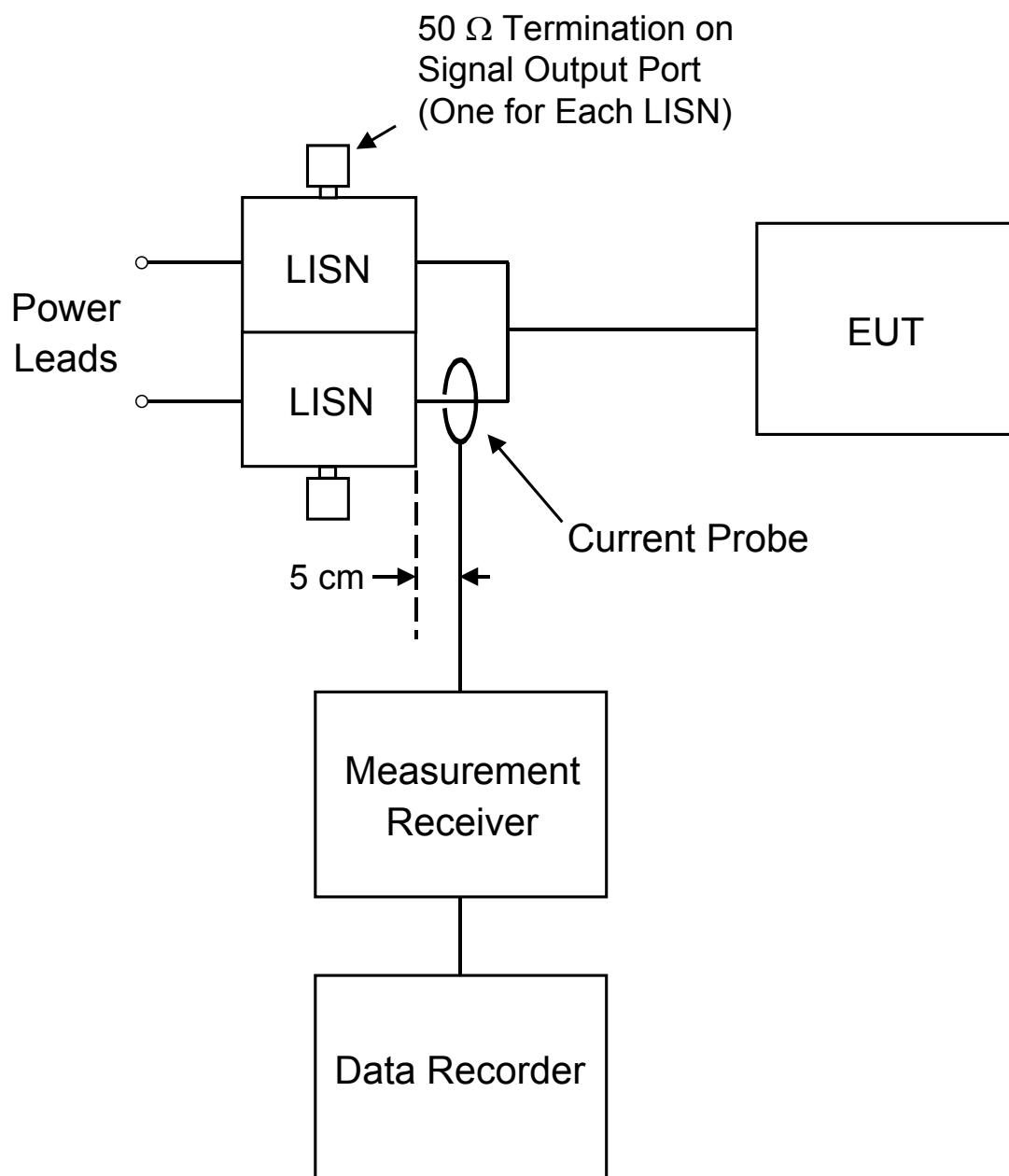


FIGURE NCE01-6 Measurement set-up

AECTP 500  
Edition 2  
Category 501  
Test NCE01

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## **NCE02** **Conducted Emissions, Power Leads, 10 kHz to 10 MHz**

### TABLE OF CONTENTS

<b>1</b>	<b>NCE02 APPLICABILITY.....</b>	<b>NCE02-2</b>
<b>2</b>	<b>NCE02 LIMITS.....</b>	<b>NCE02-2</b>
<b>3</b>	<b>NCE02 TEST PROCEDURE.....</b>	<b>NCE02-2</b>
	3.1 Purpose.....	NCE02-2
	3.2 Test equipment .....	NCE02-2
	3.3 Setup.....	NCE02-2
	3.4 Procedures.....	NCE02-3
	3.5 Data presentation.....	NCE02-3

## NCE02

### Conducted Emissions, Power Leads, 10 kHz to 10 MHz

#### 1 NCE02 APPLICABILITY

This requirement is applicable from 10 kHz to 10 MHz for all power leads, including returns that obtain power from other sources not part of the Equipment Under Test (EUT). Reference should also be made to paragraph 6.5 of Category 501.

#### 2 NCE02 LIMITS

Conducted emissions on power leads shall not exceed the applicable values shown on Figure NCE02-1

#### 3 NCE02 TEST PROCEDURE

##### 3.1 Purpose

This test procedure is used to verify that electromagnetic emissions from the EUT do not exceed the specified requirements for power input leads, including returns.

##### 3.2 Test equipment

The test equipment shall be as follows:

- a. Measurement receiver
- b. Data recording device
- c. Signal generator
- d. Attenuator, 20 dB, 50  $\Omega$
- e. Oscilloscope
- f. LISNs

##### 3.3 Setup

The test setup shall be as follows:

- a. Maintain a basic test setup for the EUT as shown and described in Category 501, Figures 3 through to 6 and paragraph 4.3.8.
- b. Calibration.
  - (1) Configure the test setup for the measurement system check as shown in Figure NCE02-2. Ensure that the EUT power source is turned off.
  - (2) Connect the measurement receiver to the 20 dB attenuator on the signal output port of the LISN.
- c. EUT testing.
  - (1) Configure the test setup for compliance testing of the EUT as shown in Figure NCE02-3.

- (2) Connect the measurement receiver to the 20 dB attenuator on the signal output port of the LISN.

### 3.4 Procedures

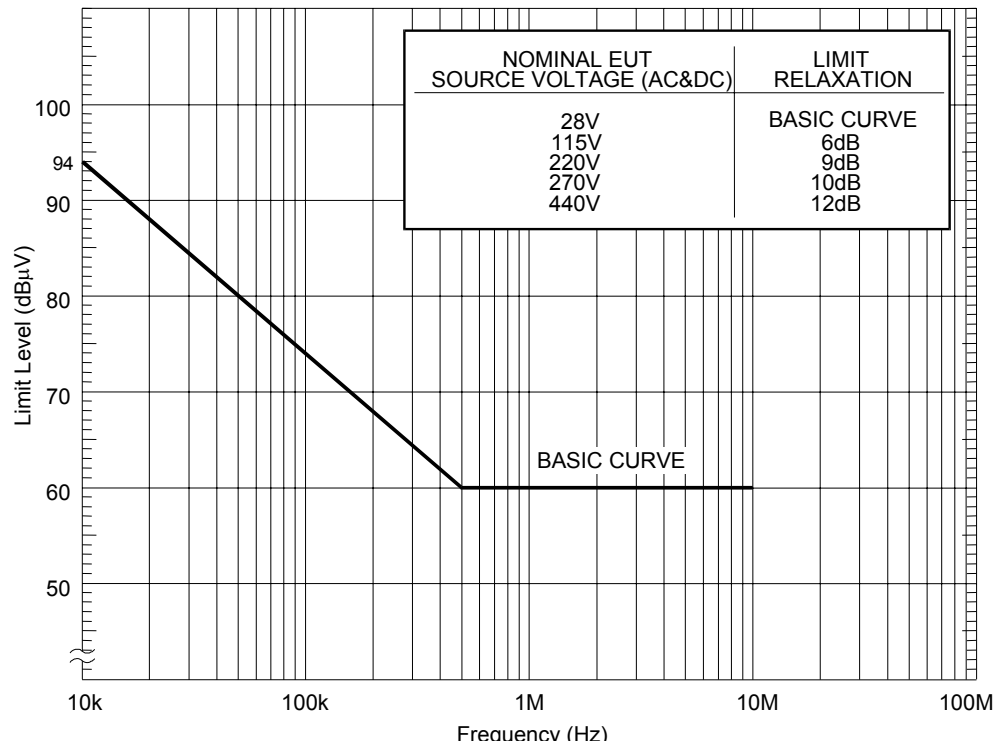
The test procedures shall be as follows:

- a. Calibration. Perform the measurement system check using the measurement system check setup of Figure NCE02-2.
  - (1) Turn on the measurement equipment and allow a sufficient time for stabilization.
  - (2) Apply a signal level that is at least 6 dB below the limit at 10 kHz, 100 kHz, 2 MHz and 10 MHz to the power output terminal of the LISN. At 10 kHz and 100 kHz, use an oscilloscope to calibrate the signal level and verify that it is sinusoidal. At 2 MHz and 10 MHz, use a calibrated output level directly from a 50  $\Omega$  signal generator.
  - (3) Scan the measurement receiver for each frequency in the same manner as a normal data scan. Verify that the measurement receiver indicates a level within  $\pm 3$ dB of the injected level. Correction factors shall be applied for the 20dB attenuator and the voltage drop due to the LISN 0.25 microfarad coupling capacitor.
  - (4) If readings are obtained which deviate by more than  $\pm 3$  dB, locate the source of the error and correct the deficiency prior to proceeding with the testing.
  - (5) Repeat 3.4a(2) through 3.4a(4) for each LISN.
- b. EUT testing. Perform emission data scans using the measurement setup of Figure NCE02-3.
  - (1) Turn on the EUT and allow a sufficient time for stabilization.
  - (2) Select an appropriate lead for testing.
  - (3) Scan the measurement receiver over the applicable frequency range, using the bandwidths and minimum measurement times in Table 2 of Category 501.
  - (4) Repeat 3.4b(2) and 3.4b(3) for each power lead.

### 3.5 Data presentation

Data presentation shall be as follows:

- a. Continuously and automatically plot amplitude versus frequency profiles on X-Y axis outputs. Manually gathered data is not acceptable except for plot verification.
- b. Display the applicable limit on each plot.
- c. Provide a minimum frequency resolution of 1% or twice the measurement receiver bandwidth, whichever is less stringent, and a minimum amplitude resolution of 1dB for each plot.
- d. Provide plots for both the measurement system check and measurement portions of the procedure.



**FIGURE NCE02-1** Limit (EUT power leads, AC and DC) for all applications

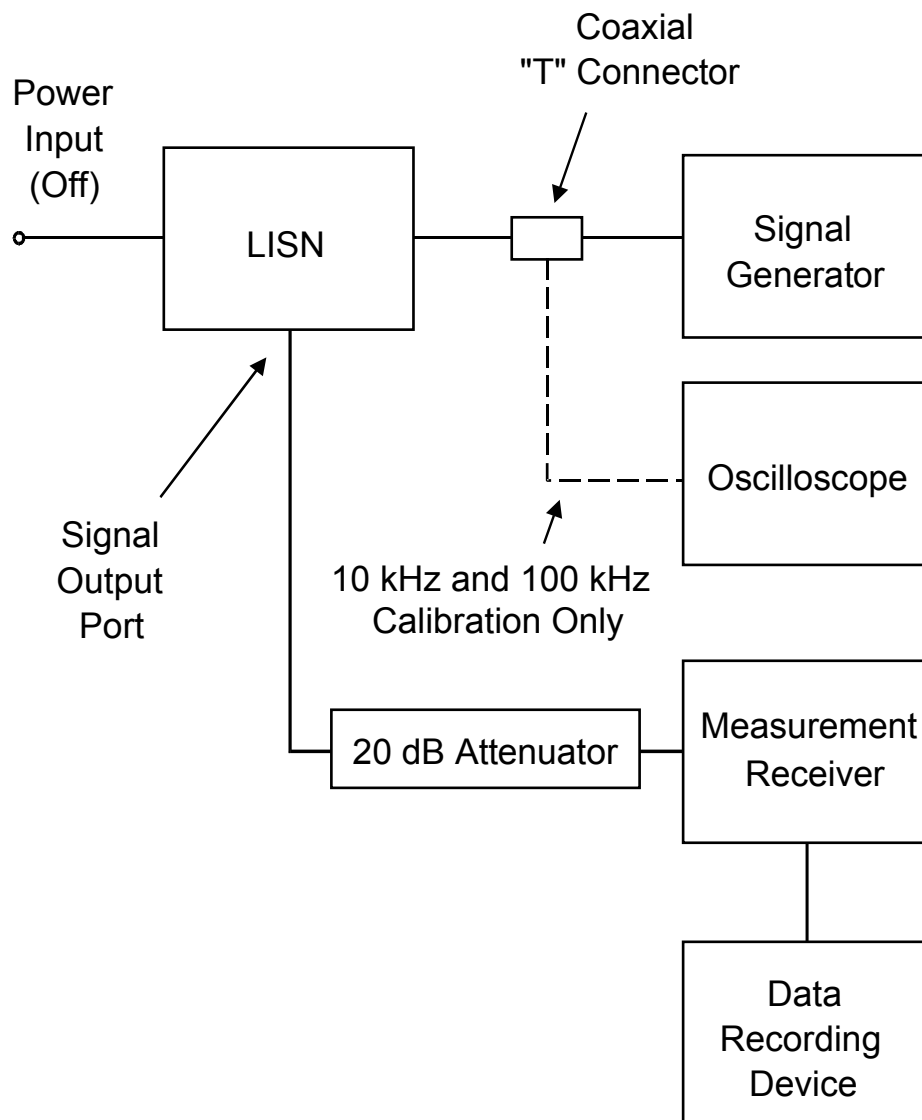
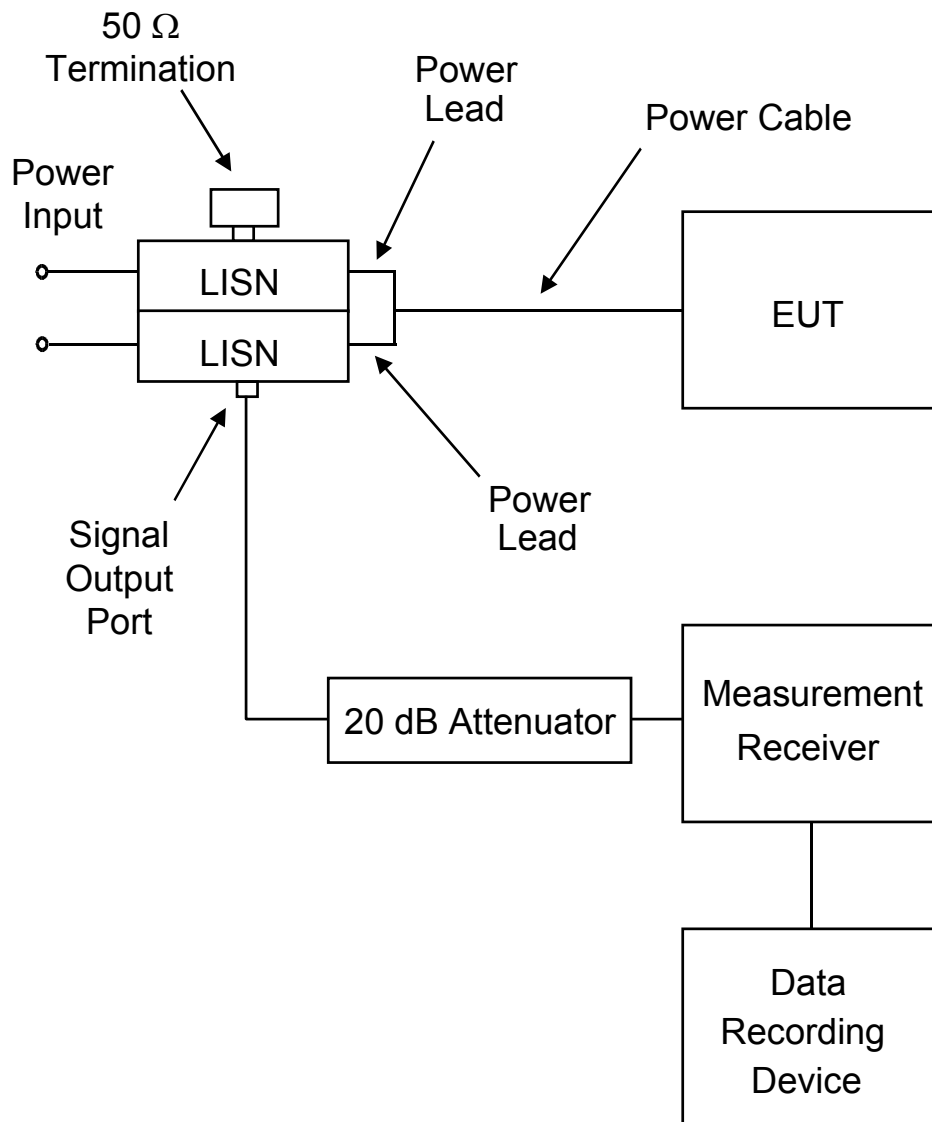


FIGURE NCE02-2 Measurement system check set-up



**FIGURE NCE02-3 Measurement Set-up**

## **NCE03**

### **Conducted Emissions, Antenna Terminal, 10 kHz to 40 GHz**

#### TABLE OF CONTENTS

<b>1</b>	<b>NCE03 APPLICABILITY.....</b>	<b>NCE03-2</b>
<b>2</b>	<b>NCE03 LIMITS.....</b>	<b>NCE03-2</b>
<b>3</b>	<b>NCE03 TEST PROCEDURE.....</b>	<b>NCE03-2</b>
3.1	Purpose.....	NCE03-2
3.2	Test equipment.....	NCE03-2
3.3	Setup.....	NCE03-3
3.4	Procedures.....	NCE03-3
3.4.1	Transmit mode for transmitters and amplifiers.....	NCE03-3
3.4.2	Receivers and stand-by mode for transmitters and amplifiers.....	NCE03-4
3.5	Data presentation.....	NCE03-5
3.5.1	Transmit mode for transmitters and amplifiers.....	NCE03-5
3.5.2	Receivers and stand-by mode for transmitters and amplifiers.....	NCE03-5

## NCE03

### Conducted Emissions, Antenna Terminal, 10 kHz to 40GHz

#### 1 NCE03 APPLICABILITY

This requirement is applicable to the antenna terminals of transmitters, receivers, and amplifiers. The requirement is not applicable to equipment designed with antennas permanently mounted to the equipment under test (EUT). The transmit mode portion of this requirement is not applicable within the EUT necessary bandwidth and within  $\pm 5$  percent of the fundamental frequency. Depending on the operating frequency range of the EUT, the start frequency of the test is as shown in Table NCE03-1:

EUT Operating Frequency Range	Start Frequency of Test
10 kHz to 3 MHz	10 kHz
3 MHz to 300 MHz	100 kHz
300 MHz to 3 GHz	1 MHz
3 GHz to 40 GHz	10 MHz

**TABLE NCE03-1**

The end frequency of the test is 40 GHz or twenty times the highest generated or received frequency within the EUT, whichever is less. For equipment using waveguide, the requirement does not apply below eight-tenths of the waveguide's cutoff frequency. NRE03 may be used as an alternative for NCE03 for testing transmitters with their operational antennas. NRE02 is applicable for emissions from antennas in the receive and standby modes for equipment designed with antennas permanently mounted to the EUT. Reference should also be made to paragraph 6.6 of Category 501

#### 2 NCE03 LIMITS

Conducted emissions at the EUT antenna terminal shall not exceed the values given below.

- a. Receivers: 34 dB $\mu$ V
- b. Transmitters and amplifiers (standby mode): 34 dB $\mu$ V
- c. Transmitters and amplifiers (transmit mode): Harmonics, except the second and third, and all other spurious emissions shall be at least 80 dB down from the level at the fundamental. The second and third harmonics shall be suppressed  $50 + 10 \log p$  (where  $p$  = peak power output in watts, at the fundamental) or 80 dB, whichever requires less suppression.

#### 3 NCE03 TEST PROCEDURE

##### 3.1 Purpose

This test procedure is used to verify that conducted emissions appearing at the antenna terminal of the EUT do not exceed specified requirements.

##### 3.2 Test equipment

The test equipment shall be as follows:

- a. Measurement receiver

- b. Attenuators, 50  $\Omega$
- c. Rejection networks
- d. Directional couplers
- e. Dummy loads, 50  $\Omega$
- f. Signal generators. For amplifier testing, a signal generator is required to drive the amplifier that provides the modulation used in the intended application and that has spurious and harmonic outputs that are down at least 6 dB greater than the applicable limit.
- g. Data recording device

### 3.3 Setup

It is not necessary to maintain the basic test setup for the EUT as shown and described in Category 501, Figures 3 through to 6 and paragraph 4.3.8. The test setup shall be as follows:

- a. Calibration. Configure the test setup for the signal generator path shown in Figures NCE03-1 through NCE03-3 as applicable. The choice of figures NCE03-1 or NCE03-2 is dependent upon the capability of the measuring equipment to handle the transmitter power.
- b. EUT Testing. Configure the test setup for the EUT path shown in Figures NCE03-1 through NCE03-3 as applicable. The choice of figures NCE03-1 or NCE03-2 is dependent upon the capability of the measuring equipment to handle the transmitter power.

### 3.4 Procedures

#### 3.4.1 Transmit mode for transmitters and amplifiers

The test procedure shall be as follows:

- a. Turn on the measurement equipment and allow a sufficient time for stabilization.
- b. Calibration.
  - (1) Apply a known calibrated signal level from the signal generator through the system check path at a mid-band fundamental frequency ( $f_0$ ).
  - (2) Scan the measurement receiver in the same manner as a normal data scan. Verify the measurement receiver detects a level within  $\pm 3$  dB of the expected signal.
  - (3) If readings are obtained which deviate by more than  $\pm 3$  dB, locate the source of the error and correct the deficiency prior to proceeding with the test.
  - (4) Repeat 3.4.1b(1) through 3.4.1b(3) at the end points of the frequency range of test.
- c. EUT Testing
  - (1) Turn on the EUT and allow sufficient time for stabilization.
  - (2) For transmitters, tune the EUT to the desired test frequency and apply the appropriate modulation for the EUT as indicated in the equipment specification. For amplifiers, apply an input signal to the EUT that has the appropriate frequency, power level, and modulation as indicated in the equipment specification. For transmitters and amplifiers for which these parameters vary, test parameters shall be chosen such that the worst case emissions spectrum will result.

- (3) Use the measurement path to complete the rest of this procedure.
- (4) Tune the test equipment to the operating frequency ( $f_0$ ) of the EUT and adjust for maximum indication.
- (5) Record the power level of the fundamental frequency ( $f_0$ ) and the measurement receiver bandwidth.
- (6) Insert the fundamental frequency rejection network, when applicable.
- (7) Scan the frequency range of interest and record the level of all harmonics and spurious emissions. Add all correction factors for cable loss, attenuators and rejection networks. Maintain the same measurement receiver bandwidth used to measure the power level of the fundamental frequency ( $f_0$ ) in 3.4.1c(5).
- (8) Verify spurious outputs are from the EUT and not spurious responses of the measurement system.
- (9) Repeat 3.4.1c(2) through 3.4.1c(8) for other frequencies as required by paragraphs 4.3.9.1 and 4.3.9.2 of Category 501.
- (10) Determine measurement path losses at each spurious frequency as follows:
  - (a) Replace the EUT with a signal generator.
  - (b) Retain all couplers and rejection networks in the measurement path.
  - (c) Determine the losses through the measurement path. The value of attenuators may be reduced to facilitate the end-to-end check with a low level signal generator.

### 3.4.2 Receivers and stand-by mode for transmitters and amplifiers

The test procedure shall be as follows:

- a. Turn on the measurement equipment and allow a sufficient time for stabilization.
- b. Calibration.
  - (1) Apply a calibrated signal level, which is 6 dB below the applicable limit, from the signal generator through the system check path at a midpoint test frequency.
  - (2) Scan the measurement receiver in the same manner as a normal data scan. Verify the measurement receiver detects a level within  $\pm 3$  dB of the injected signal.
  - (3) If readings are obtained which deviate by more than  $\pm 3$  dB, locate the source of the error and correct the deficiency prior to proceeding with the test.
  - (4) Repeat 3.4.2b(1) through 3.4.2b(3) at the end points of the frequency range of test.
- c. EUT Testing
  - (1) Turn on the EUT and allow sufficient time for stabilization.
  - (2) Tune the EUT to the desired test frequency and use the measurement path to complete the rest of this procedure.
  - (3) Scan the measurement receiver over the applicable frequency range, using the bandwidths and minimum measurement times of Table 2 in Category 501.
  - (4) Repeat 3.4.2c(2) and 3.4.2c(3) for other frequencies as required by paragraphs 4.3.9.1 and 4.3.9.2 of Category 501.

### 3.5 Data presentation

#### 3.5.1 Transmit mode for transmitters and amplifiers

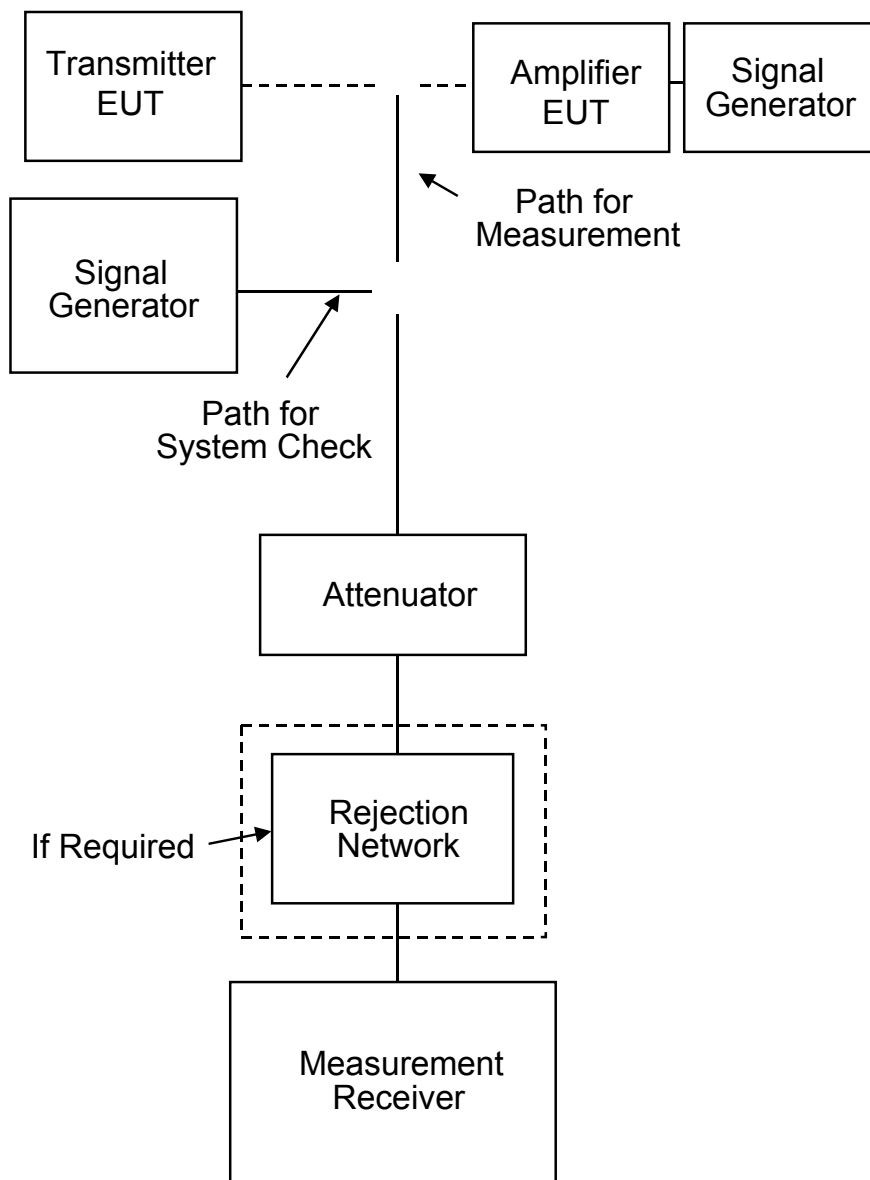
The data presentation shall be as follows:

- a. Continuously and automatically plot amplitude versus frequency profiles for each tuned frequency. Manually gathered data is not acceptable except for plot verification.
- b. Provide a minimum frequency resolution of 1% or twice the measurement receiver bandwidth, whichever is less stringent, and a minimum amplitude resolution of 1 dB for each plot.
- c. Provide tabular data showing  $f_0$  and frequencies of all harmonics and spurious emissions measured, power level of the fundamental and all harmonics and spurious emissions, dB down level, and all correction factors including cable loss, attenuator pads, and insertion loss of rejection networks.
- d. The relative dB down level is determined by subtracting the level in 3.4.1c(7) from that obtained in 3.4.1c(5).

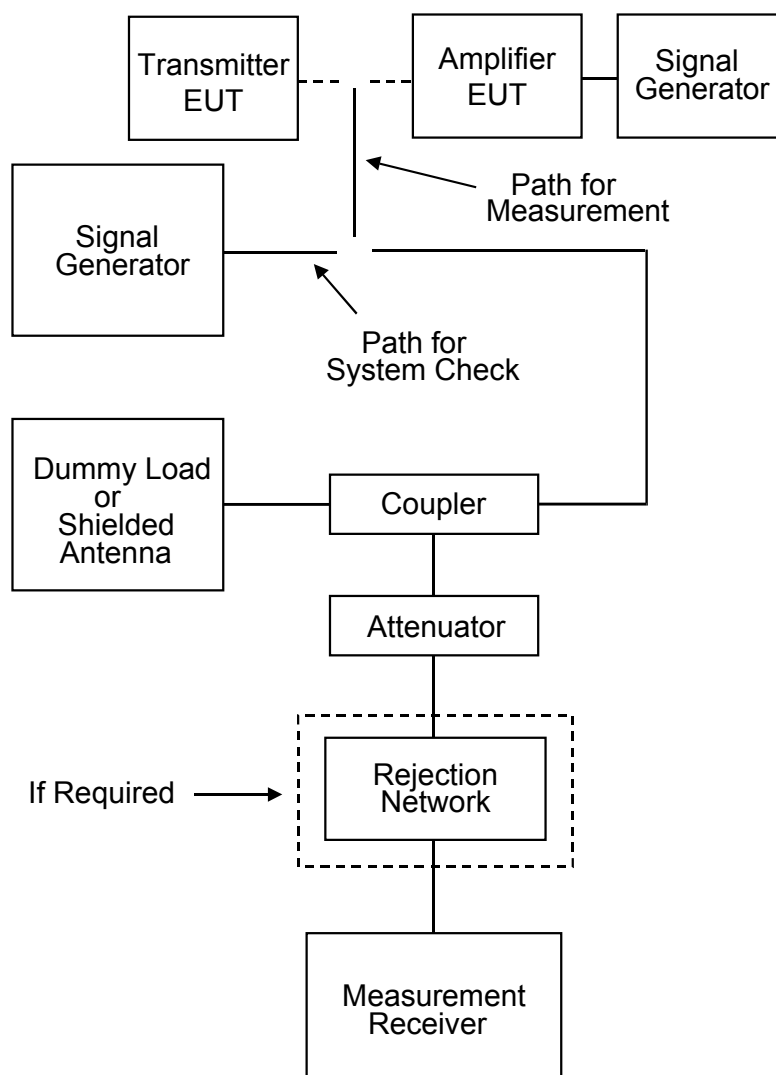
#### 3.5.2 Receivers and stand-by mode for transmitters and amplifiers

The data presentation shall be as follows:

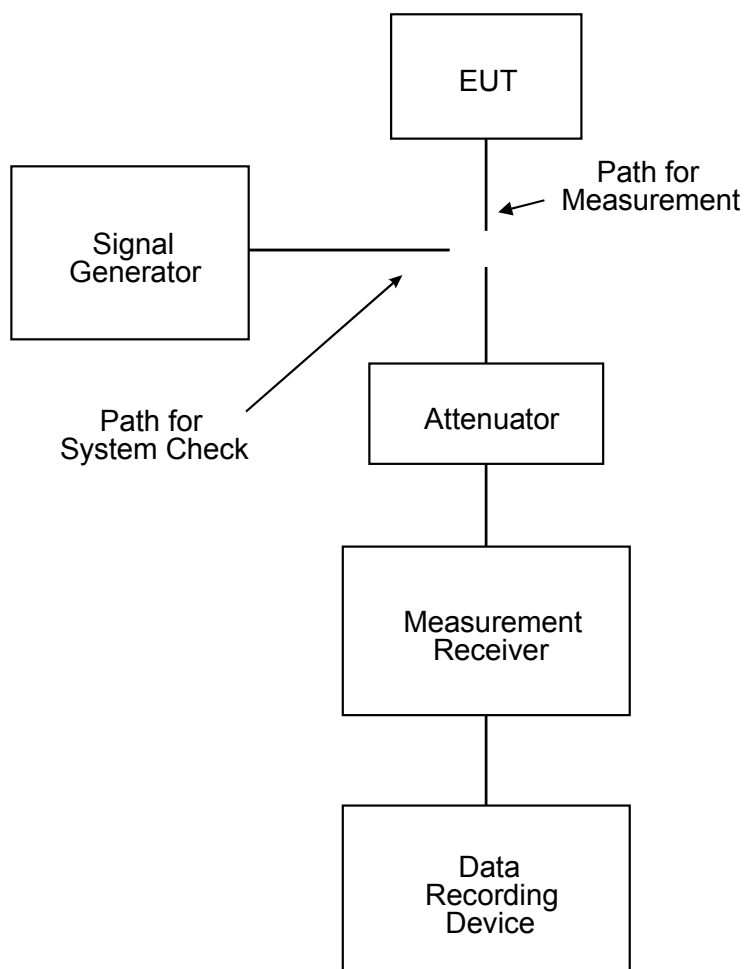
- a. Continuously and automatically plot amplitude versus frequency profiles for each tuned frequency. Manually gathered data is not acceptable except for plot verification.
- b. Display the applicable limit on each plot.
- c. Provide a minimum frequency resolution of 1% or twice the measurement receiver bandwidth, whichever is less stringent, and a minimum amplitude resolution of 1 dB for each plot.
- d. Provide plots for both the measurement and system check portions of the procedure.



**FIGURE NCE03-1** Set-up for low power transmitters and amplifiers



**FIGURE NCE03-2** Set-up for high power transmitters and amplifiers



**FIGURE NCE03-3** Set-up for receivers and stand-by mode for transmitters and amplifiers

# **NCE04**

## **Conducted Emissions Exported Transients on Primary Power Lines**

### TABLE OF CONTENTS

<b>1</b>	<b>NCE04 APPLICABILITY.....</b>	<b>NCE04-2</b>
<b>2</b>	<b>NCE04 LIMITS.....</b>	<b>NCE04-2</b>
	2.1 Test Limits For Land Service Use (28 Volt Systems) .....	NCE04-2
	2.2 Test Limits For Land Service Use (240 Volt AC Systems) .....	NCE04-3
	2.3 Test Limits (Sea Systems) .....	NCE04-3
	2.4 Test Limits (Aircraft Use) .....	NCE04-4
<b>3</b>	<b>NCE04 TEST PROCEDURE.....</b>	<b>NCE04-5</b>
	3.1 Purpose.....	NCE04-5
	3.2 Test equipment .....	NCE04-5
	3.3 Setup.....	NCE04-5
	3.4 Procedures.....	NCE04-6
	3.5 Data presentation.....	NCE04-7

## NCE04

# Conducted Emissions Exported Transients on Primary Power Lines

### 1 NCE04 APPLICABILITY

The purpose of this test is to control the amplitude and duration of transients appearing on primary power lines caused by the normal operation of the EUT and also as a result of switching on and off the power supply to the EUT. These transient emissions may couple via conduction and radiation from the power lines to other potentially susceptible equipment in the actual installation.

This test is applicable to AC & DC EUT power cables, which derive their power from an external supply serving other equipment in the actual installation. Where power cables, deriving their power from different sources, are run in bunches or with signal cables from other systems this test is required to check for cross coupling between them.

Reference should also be made to paragraph 6.7 of Category 501.

### 2 NCE04 LIMITS

Definition of both contactor switching and functional switching of the EUT are as follows:

- a. Contactor switching transients are generated by switching the EUT on and off using an external supply contactor of the type to be used in its final installation. If the contactor type is not known or unavailable, then an alternative of suitable type and current rating may be used.
- b. Functional switching transients are generated by switching the EUT on and off using the power switch on the EUT, if fitted. Additionally, functional switching transients may be generated by operation of the EUT, i.e. while operating the EUT over its normal operating sequence and exercising the EUT through its full range of functions.

Test limits for land, sea and air systems are as follows:

#### 2.1 Test Limits For Land Service Use (28 Volt Systems)

##### a. Contactor Switching

The maximum voltage excursion of the superimposed exported transient relative to the steady state voltage prior to disconnection when measured at 50 mm from the EUT shall not exceed:

- a.  $\pm 250$  V peak.
- b.  $\pm 150$  V peak for a period of longer than 10  $\mu$ s.
- c.  $\pm 100$  V peak for a period of longer than 5 ms.

##### b. Functional Switching

The maximum voltage excursion of the superimposed exported transient, relative to the steady state voltage, when measured at the LISN, shall not exceed  $\pm 30$  V peak during functional switching of the EUT.

## 2.2 Test Limits For Land Service Use (240 Volt AC Systems)

### a. For measurements at the EUT (Contactor Switching):

The maximum voltage excursion of the superimposed exported transient relative to the supply voltage waveform shall not exceed:

± 2000 V peak for 415 V 3-phase AC equipment

± 1100 V peak for 240 V 1-phase AC equipment

The period for which any individual voltage excursion of the transient exceeds:

± 1300 V peak for 415 V 3-phase AC equipment

± 730 V peak for 240 V 1-phase AC equipment

Shall not exceed 10  $\mu$ S. (measured from the time the voltage exceeds these limits to the time it returns to, and remains within, the limits).

The period for which the voltage excursion of the transient exceeds:

± 1000 V peak for 415 V 3-phase AC equipment

± 550 V peak for 240 V 1-phase AC equipment

Shall not exceed 5 ms (measured from the time the voltage exceeds these limits to the time it returns to, and remains within, the limits).

### b. For measurements at the LISN (EUT Function Switching):

The maximum superimposed voltage excursion of the exported transient relative to the supply voltage waveform shall not exceed:

± 200 V peak for 415 V 3-phase AC equipment

± 110 V peak for 240 V 1-phase AC equipment

## 2.3 Test Limits (Sea Systems)

### a. For measurements at the EUT (Contactor Switching):

The maximum voltage excursion of the superimposed exported transient, relative to the supply voltage waveform, shall not exceed:

± 2000 V peak for 440 V 3-phase AC equipment

± 600 V peak for 115 V 1-phase AC equipment

± 2000 V peak for 720 V DC equipment

± 960 V peak for 355 V DC equipment

± 480 V peak for 28 V DC equipment

The period for which any individual voltage excursion of the transient exceeds:

± 1300 V peak for 440 V 3-phase AC equipment

± 400 V peak for 115 V 1-phase AC equipment

± 1300 V peak for 720 V DC equipment

± 640 V peak for 355 V DC equipment

± 320 V peak for 28 V DC equipment

Shall not exceed 10  $\mu$ S. (measured from the time the voltage exceeds these limits to the time it returns to, and remains within, the limits).

The period for which the voltage excursion of the transient exceeds:

$\pm$  1000 V peak for 440 V 3-phase AC equipment

$\pm$  300 V peak for 115 V 1-phase AC equipment

$\pm$  1000 V peak for 720 V DC equipment

$\pm$  500 V peak for 355 V DC equipment

$\pm$  250 V peak for 28 V DC equipment

Shall not exceed 5 ms (measured from the time the voltage exceeds these limits to the time it returns to, and remains within, the limits).

b. For measurements at the LISN (EUT Functional Switching):

The maximum superimposed voltage excursion of the exported transient, relative to the supply voltage waveform, shall not exceed:

$\pm$  200 V peak for 440 V 3-phase AC equipment

$\pm$  60 V peak for 115 V 1-phase AC equipment

$\pm$  200 V peak for 720 V DC equipment

$\pm$  96 V peak for 355 V DC equipment

$\pm$  48 V peak for 28 V DC equipment

## 2.4 Test Limits (Aircraft Use)

a. For measurements at the EUT:

The maximum voltage excursion of the superimposed exported transient, relative to the supply voltage waveform, shall not exceed:

$\pm$  300 V peak for 200 V 3-phase AC equipment

$\pm$  300 V peak for 115 V single-phase AC equipment

$\pm$  100 V peak for 28 V DC equipment

The period for which any individual voltage excursion of the transient exceeds:

$\pm$  200 V peak for 200 V 3-phase AC equipment

$\pm$  200 V peak for 115 V single-phase AC equipment

$\pm$  100 V peak for 28 V DC equipment

Shall not exceed 10  $\mu$ S. (measured from the time the voltage exceeds these limits to the time it returns to, and remains within, the limits).

The period for which the voltage excursion of the transient exceeds:

$\pm$  160 V peak for 200 V 3-phase AC equipment

$\pm$  95 V peak for 115 V single-phase AC equipment

$\pm$  80 V peak for 28 V DC equipment

Shall not exceed 5 ms (measured from the time the voltage exceeds these limits to the time it returns to, and remains within, the limits).

b. For measurements at the LISN:

The maximum superimposed voltage excursion of the exported transient, relative to the supply voltage waveform, shall not exceed:

± 160 V peak for 200 V 3-phase AC equipment

± 90 V peak for 115 V single-phase AC equipment

± 30 V peak for 28 V DC equipment

These latter limits for measurements at the LISN should be tailored for individual project requirements to take into account the aircraft primary power supply characteristics.

### 3 NCE04 TEST PROCEDURE

#### 3.1 Purpose

The purpose of this test is to measure the amplitude and duration of transients appearing on primary power lines caused by the normal operation of the EUT and also as a result of switching on and off the power supply to the EUT. These transient emissions may couple via conduction and radiation from the power lines to other potentially susceptible equipment in the actual installation.

#### 3.2 Test equipment

The test equipment shall be as follows:

- a. Differential / Fast digital data acquisition oscilloscope
- b. Contactor
- c. Capacitor, 30,000  $\mu$ F
- d. Supply twin 'T' filter (AC supplies only)
- e. 50  $\mu$ F LISNs

#### 3.3 Setup

##### 3.3.1 The test setup shall be as follows:

- a. A typical test configuration is shown in figure NCE04-1.
- b. For all EUTs, a switch or contactor of the type normally intended to control the supply to the EUT shall be connected into the power lines. If the contactor is not part of the EUT and its type is not known or available then an alternative, of suitable type and current rating may be used. The contactor shall be inserted at the LISN end of the lines.
- c. The oscilloscope probe shall be connected to the power lines at a distance of 50mm from the EUT connector when recording contactor switching transients and a distance of 50mm from the LISN terminals when recording EUT functional switching transients. NCE04-2 and NCE04-3 show typical test layouts for DC and AC lines respectively.
- d. For AC supplies, a twin 'T' notch filter may be used to filter the power supply frequency. (see paragraph 5.7 of Category 501) With the power frequency filtered, any transients shown on the oscilloscope are relative to the AC waveform when measured between the transient's peak and the oscilloscope's reference level.
- e. Alternatively, a fast digitising data acquisition oscilloscope may be used. Although the power supply frequency is not filtered, measurement of all transient types can be made with reference to the AC waveform. This is achieved by reducing the timebase, effectively zooming in on the transient using the data stored within the oscilloscope.

- f. It should be noted that different limits may apply for systems operating at power line frequencies or voltages other than those specified in this section.
- g. Where a probe / filter combination circuit suitable for recording transients on AC supply lines is used, the measured transient values must be corrected for any attenuation caused.

3.3.2 Prior to performing the test the contactor shall be validated. To ascertain that transient levels consistent with contact bounce do not mask those caused by the EUT, the test house shall ensure that the contactor meets the following validation:

- a. The set up shall be based on that given in figures NCE04-2 and NCE04-3 except that the EUT is replaced by a resistive load drawing the same current with a 10 $\mu$ F capacitor on each lead to the ground plane and the oscilloscope probes connected directly onto either side of the contactor. The value of the load shall be such that the same current is drawn from the power source as when the EUT is connected.
- b. At least 10 operations with the contactor making and breaking shall be monitored, 5 with the oscilloscope +ve triggered and 5 -ve. The worst case transient shall be used to assess whether the contactor is suitable for purpose.
- c. The maximum excursion of the transient caused by the contactor bounce shall not exceed 50% of the appropriate test limit.

#### 3.4 Procedures

The test locations for land, sea and air systems are as follows:

##### 3.4.1 Tests For Land Service Use (DC and AC systems)

- a. For DC supplies the transient voltage shall be measured between the positive line and the ground plane and also between the zero volt return line and the ground plane.
- b. For AC lines the transient voltage shall be measured:
  - (1) For single-phase supplies between the phase line and ground plane, the neutral line and ground plane and between lines.
  - (2) For 3-phase supplies between phases, A to B, A to C, B to C and between each phase line and ground plane.

##### 3.4.2 Tests for Sea Systems Use (DC and AC systems)

- a. For DC lines the transient voltage shall be measured between the positive line and zero volt return line, between the positive line and the ground plane and also between the zero volt return line and the ground plane.
- b. For AC lines the transient voltage shall be measured:
  - (1) For single-phase supplies between the phase line and ground plane, the neutral line and ground plane and between lines.
  - (2) For 3-phase supplies between phases, A to B, A to C, B to C and between each phase line and ground plane.

**NOTE** For test purposes the AC power frequency may be reduced to 50 Hz instead of the normal 60 Hz if the EUT can operate without degradation at this frequency.

### 3.4.3 Tests for Aircraft Use (DC and AC systems)

- a. For DC lines the transient voltage shall be measured between the positive line and zero volt return line, between the positive line and the ground plane and also between the zero volt return line and the ground plane.
- b. For AC lines the transient voltage shall be measured:
  - (1) For single-phase AC lines the transient voltage shall be measured between the phase line and the neutral line, between the phase line and the ground plane and also between the neutral line and the ground plane.
  - (2) For 3-phase AC lines the transient voltage shall be measured between each of the phase lines, between each phase line to the ground plane, between each phase line to the neutral line and also between the neutral line and the ground plane.

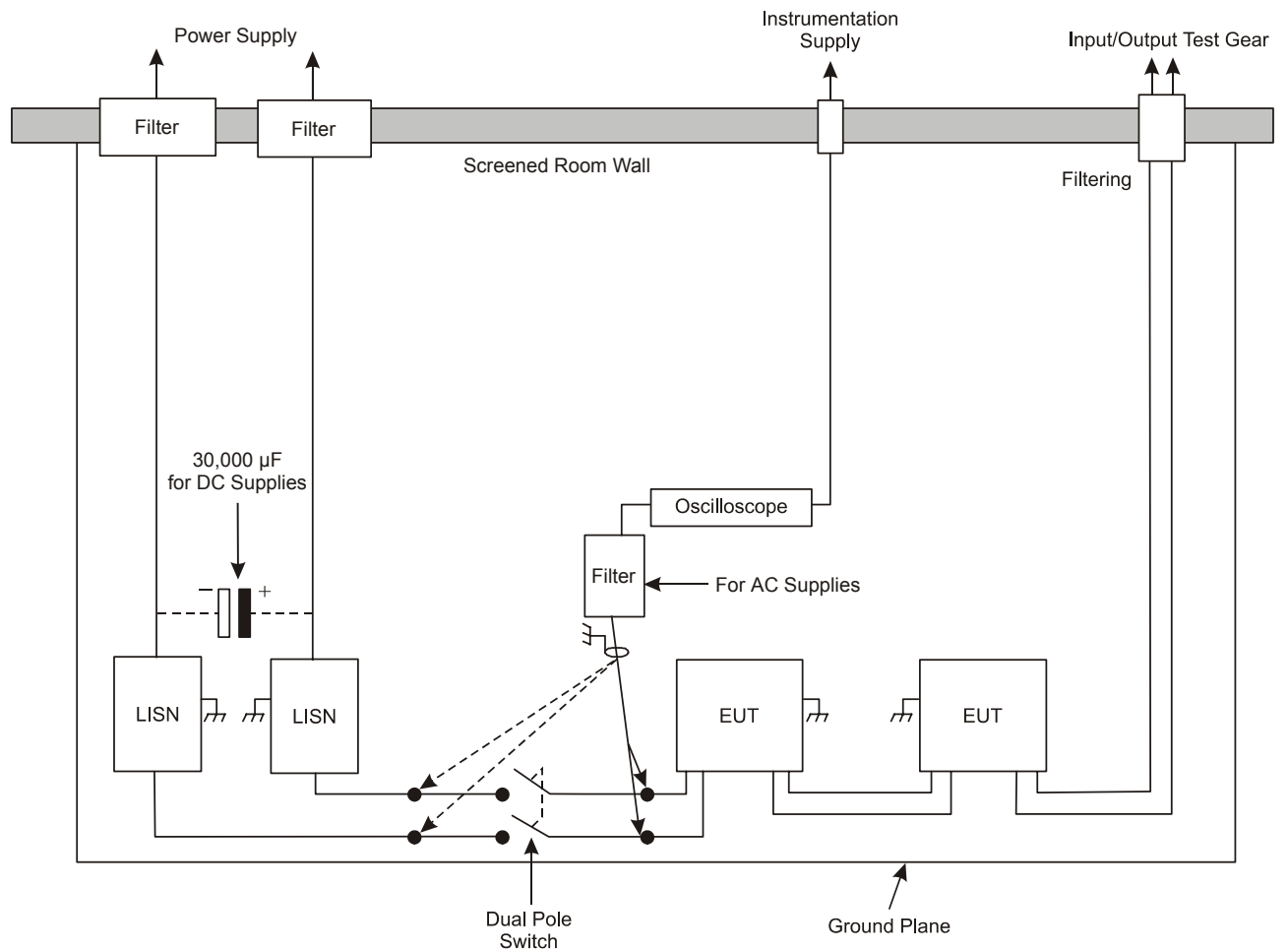
### 3.4.4 The test method is detailed below:

- a. The EUT shall be monitored for both contactor and functional switching as detailed in the EMC test plan.
- b. The EUT shall be switched on and off by means of the EUT power switch (if fitted) and the external contactor. At least 20 switching operations shall be undertaken on each switch, 10 operations for +ve trigger and 10 for –ve trigger.
- c. Functional switching due to EUT operation shall be performed until the test engineer is satisfied that the highest transient levels have been recorded. This shall cover the EUT's normal operating sequence and exercising the EUT through its full range of functions.

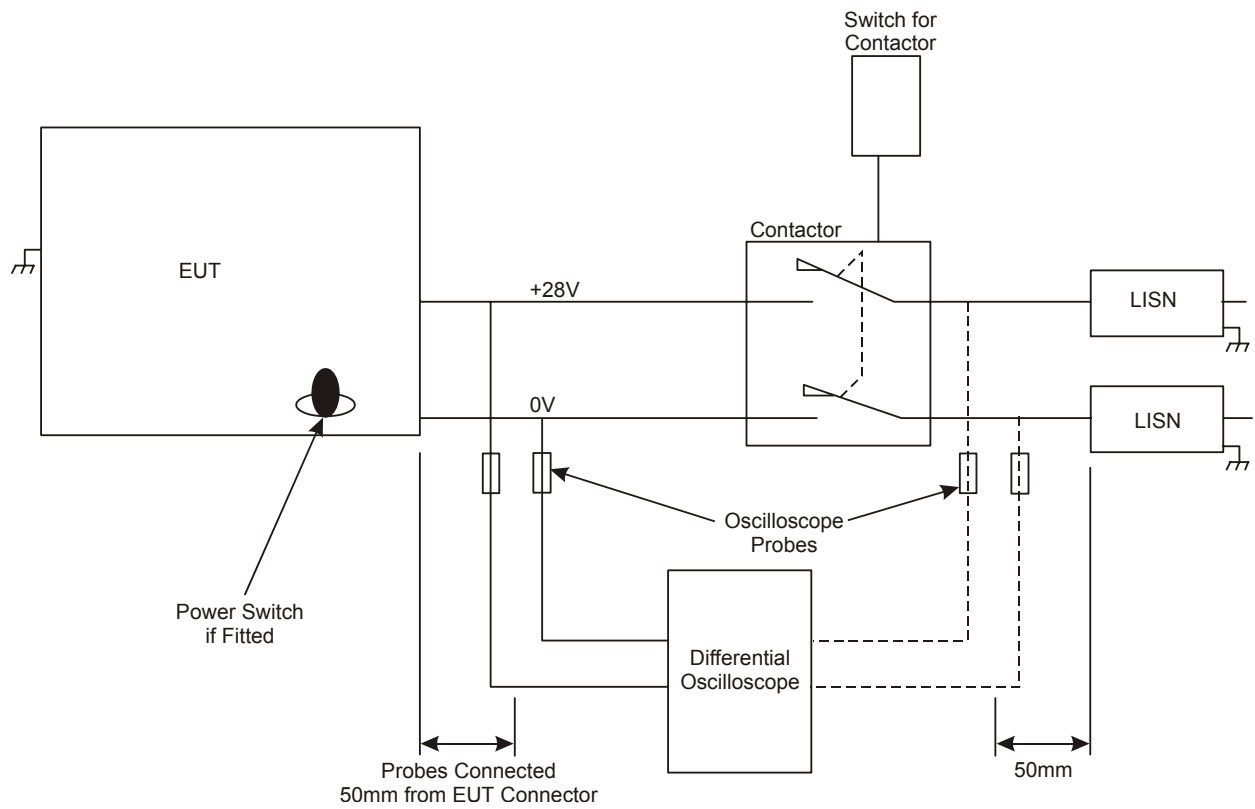
### 3.5 Data presentation

Data presentation shall be as follows:

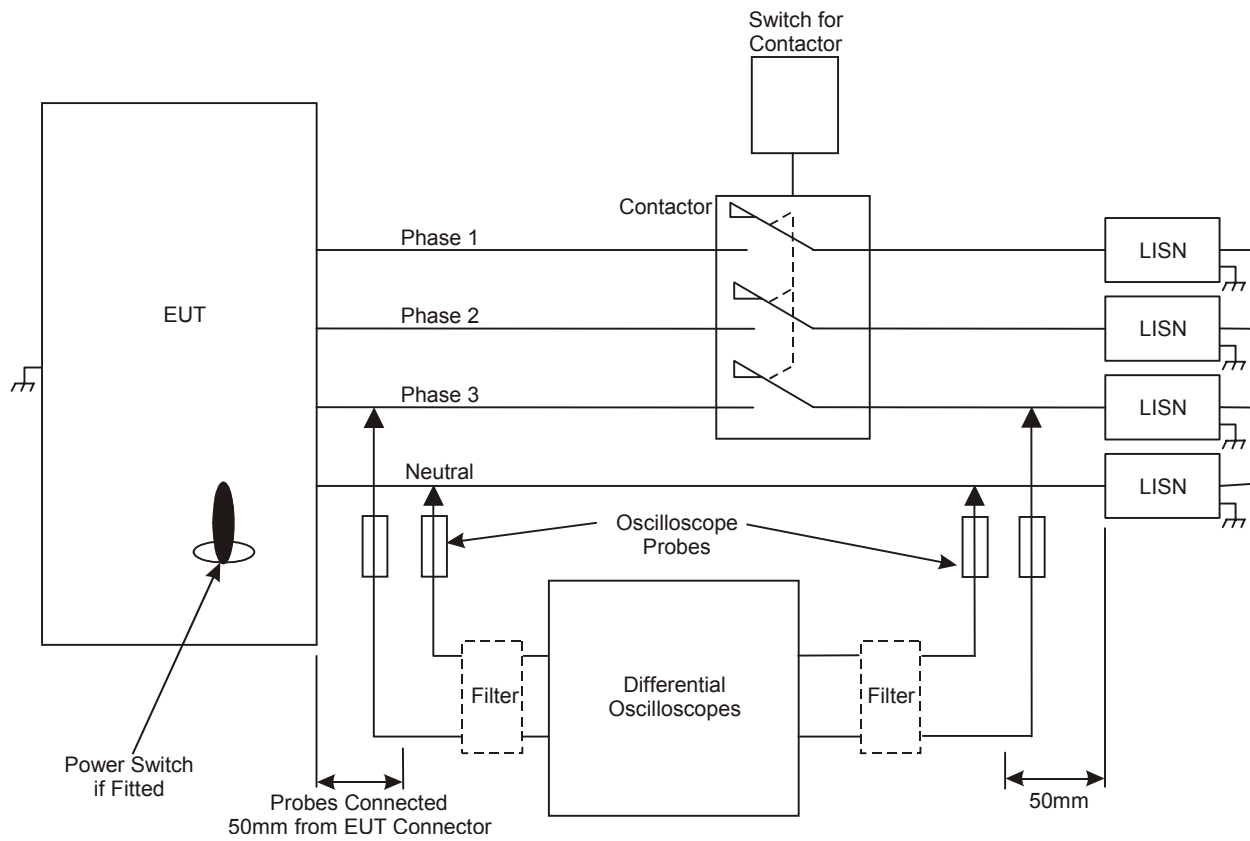
- a. An automatically produced plot of amplitude versus time for each observed transient on each line tested shall be retained by the test house. Manually gathered data is not acceptable except for plot verification.
- b. Examples of the transient plots giving the highest amplitudes will be included in any test report produced. Such plots will show suitable scaling graduation in both time and amplitude to enable an unambiguous comparison with the standard.
- c. A table giving details of duration and amplitude of all transients observed, together with the applicable limit will be included in any test report produced.
- d. Records of probe location, test condition, time/date of test, together with the name of the responsible test engineer (who performed the test) must be retained by the test house.



**FIGURE NCE04-1 Typical Test Configuration**



**FIGURE NCE04-2 Typical Test Configuration, DC Supply Lines**



**FIGURE NCE04-3 Typical Test Configuration, AC Supply Lines**

**NCE05**  
**Conducted Emissions, Power, Signal and Control Leads,**  
**30 Hz to 150 MHz**

TABLE OF CONTENTS

<b>1</b>	<b>NCE05 APPLICABILITY.....</b>	<b>NCE05-2</b>
<b>2</b>	<b>NCE05 LIMITS.....</b>	<b>NCE05-2</b>
<b>3</b>	<b>NCE05 TEST PROCEDURE.....</b>	<b>NCE05-2</b>
	3.1 Purpose.....	NCE05-2
	3.2 Test equipment.....	NCE05-2
	3.3 Setup.....	NCE05-3
	3.4 Procedures.....	NCE05-3
	3.5 Data presentation.....	NCE05-4

## **NCE05**

### **Conducted Emissions, Power, Signal and Control Leads, 30 Hz to 150 MHz**

#### **1 NCE05 APPLICABILITY**

This requirement is applicable for power leads, including returns, that obtain power from other sources not part of the EUT and for all signal and control leads (particular attention should be given to those cables that connect to other systems not part of the EUT) for Sea, Air and Land applications.

For AC applications, this requirement is applicable starting at the second harmonic of the EUT power frequency.

Reference should also be made to paragraph 6.8 and the Applicability Tables 6 and 7 in Category 501 before subjecting the EUT to this test method. Where some procuring authorities require testing to a higher frequency then NCE05 should be used.

#### **2 NCE05 LIMITS**

Conducted emissions on power, control and signal leads shall not exceed the applicable values shown on Figure NCE05-1 for Sea applications, Figure NCE05-2 for Air applications and Figure NCE05-3 for Land applications.

#### **3 NCE05 TEST PROCEDURE**

##### **3.1 Purpose**

This test procedure is used to verify that electromagnetic emissions from the EUT do not exceed the specified requirements for power input leads (including returns) and Signal and Control leads.

##### **3.2 Test equipment**

The test equipment shall be as follows:

- a. Measurement receivers
- b. Current probes
- c. Signal generator
- d. Data recording device
- e. Oscilloscope
- f. Resistor (R)
- g. 5 $\mu$ H LISNs

### 3.3 Setup

The test setup shall be as follows:

- a. Maintain a basic test setup for the EUT as shown and described in Category 501, Figures 3 through to 6 and paragraph 4.3.8. The 50 $\mu$ H LISN will need to be replaced with a 5 $\mu$ H LISN meeting the characteristic curve shown in Category 501 Figure 10.
- b. Calibration. Configure the test setup for the measurement system check as shown in Figure NCE05-4.
- c. EUT testing.
  - (1) Configure the test setup for compliance testing of the EUT as shown in Figure NCE05-5 or Figure NCE05-6 for power or control and signal lines respectively.
  - (2) For power lead measurements position the current probe 50 mm from the LISN.
  - (3) The probe is positioned 50 mm from the EUT for signal, control and secondary power leads. Where the backshell of the connector prevents this then the probe will be positioned as close as possible and a record made of its exact location.
  - (4) On signal, control and secondary power leads measurements above 30 MHz must be performed at both ends. Leads that are less than 1 metre in length need not be subjected to testing.

### 3.4 Procedures.

The test procedures shall be as follows:

- a. Turn on the measurement equipment and allow a sufficient time for stabilization.
- b. Calibration. Evaluate the overall measurement system from the current probe to the data output device.
  - (1) Apply a calibrated signal level, which is at least 6 dB below the applicable limit at 1 kHz, 3 kHz, and 10 kHz, 100 kHz, 1 MHz, 10 MHz and 150 MHz to the current probe.
  - (2) Verify the current level, using the oscilloscope and load resistor; also, verify that the current waveform is sinusoidal.
  - (3) Scan the measurement receiver for each frequency in the same manner as a normal data scan. Verify that the data recording device indicates a level within  $\pm 3$  dB of the injected level.
  - (4) If readings are obtained which deviate by more than  $\pm 3$  dB, locate the source of the error and correct the deficiency prior to proceeding with the testing.
- c. EUT testing. Determine the conducted emissions from the EUT input power leads, signal and control leads plus secondary power leads including returns.
  - (1) Turn on the EUT and allow sufficient time for stabilization.
  - (2) Select an appropriate lead for testing and clamp the current probe into position.
  - (3) Scan the measurement receiver over the applicable frequency range, using the bandwidths and minimum measurement times specified in Table 2 of Category 501.
  - (4) Repeat 3.4c(3) for each power, control and signal lead.

Note: In some instances EUT's with high current requirements may fail to meet the limit due to the amplitude of AC power frequency harmonics, in such cases guidance should be sought from the procuring authority whether these failures are acceptable. Failures due to harmonic content are limited to a frequency of ten times the fundamental.

### 3.5 Data presentation

Data presentation shall be as follows:

- a. Continuously and automatically plot amplitude versus frequency profiles on X-Y axis outputs. Manually gathered data is not acceptable except for plot verification.
- b. Display the applicable limit on each plot.
- c. Provide a minimum frequency resolution of 1% or twice the measurement receiver bandwidth, whichever is less stringent, and a minimum amplitude resolution of 1 dB for each plot.
- d. Provide plots for both the measurement and system check portions of the procedure.

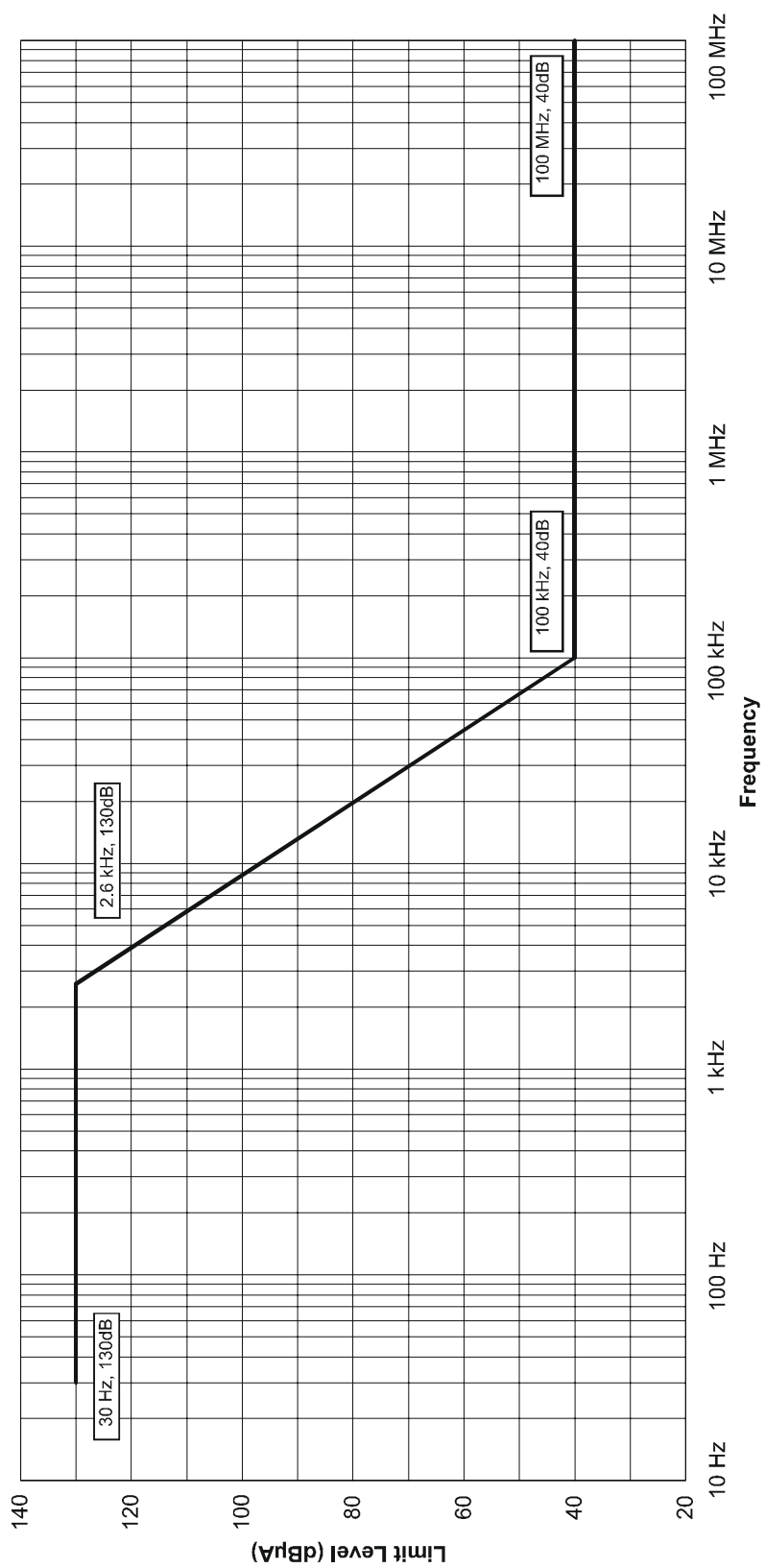


FIGURE NCE05-1 - Limit for Sea Applications (DC, 60Hz and 400Hz)

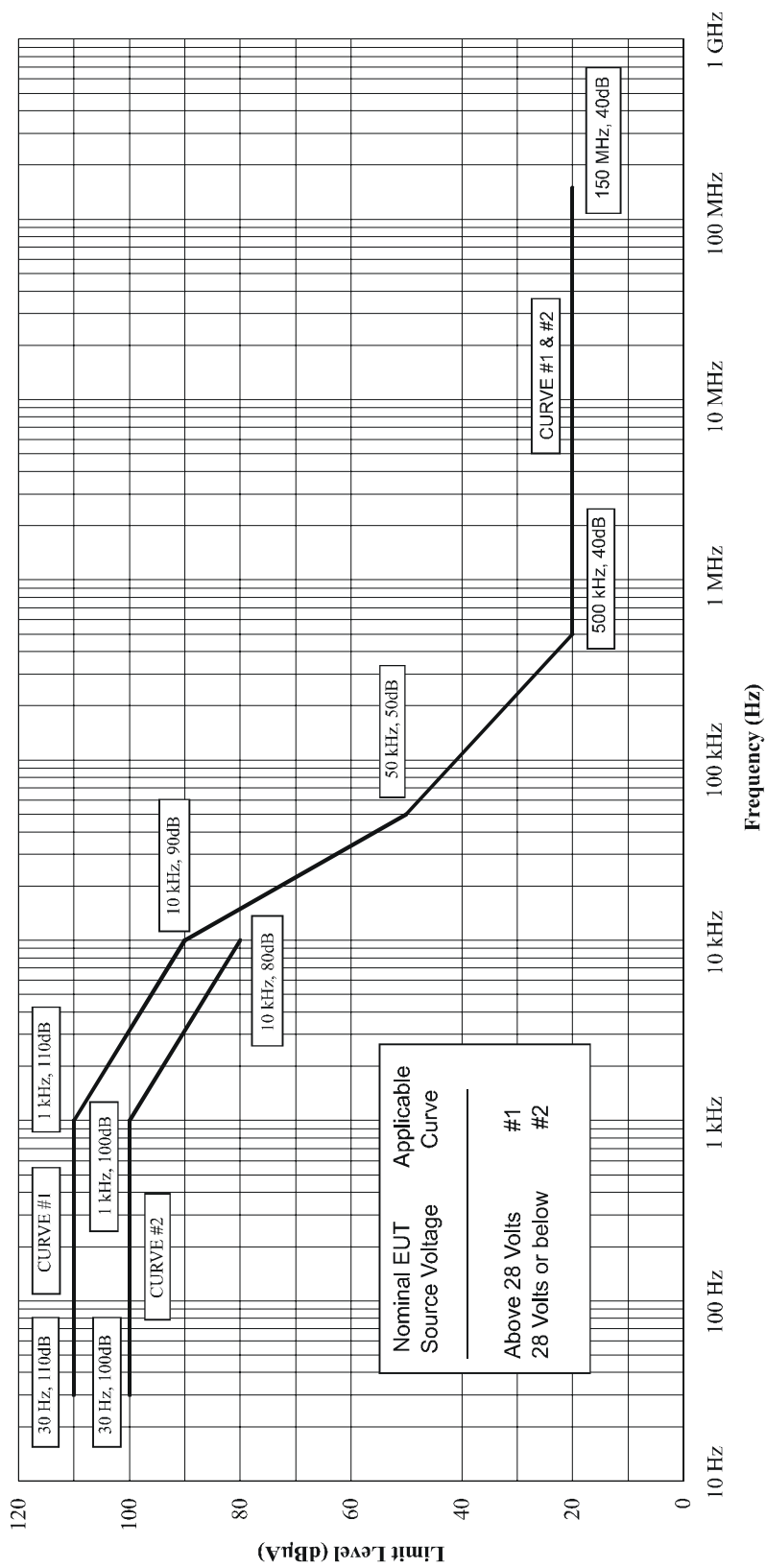


FIGURE NCE05-2 - Limit for Air Applications

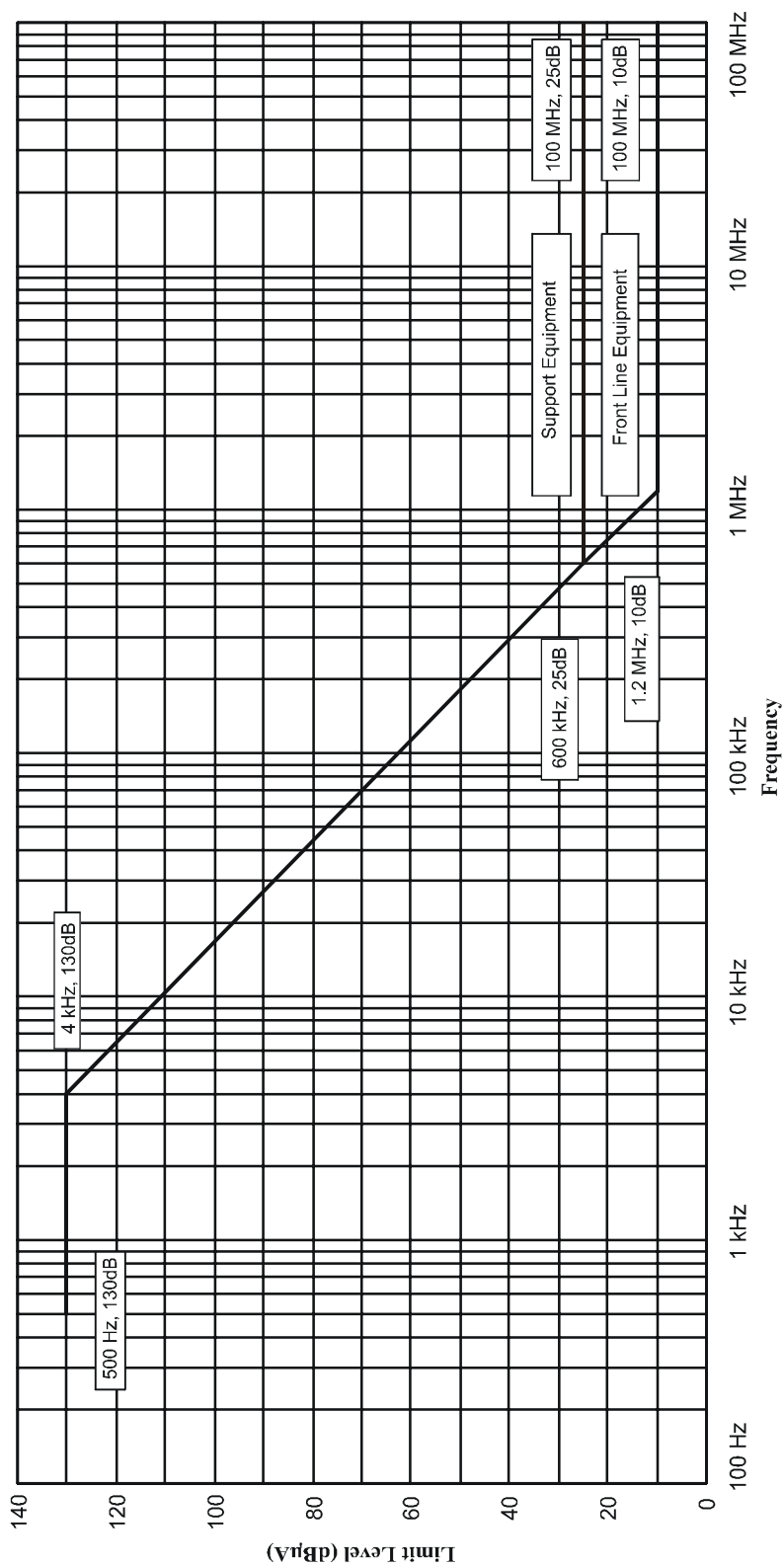
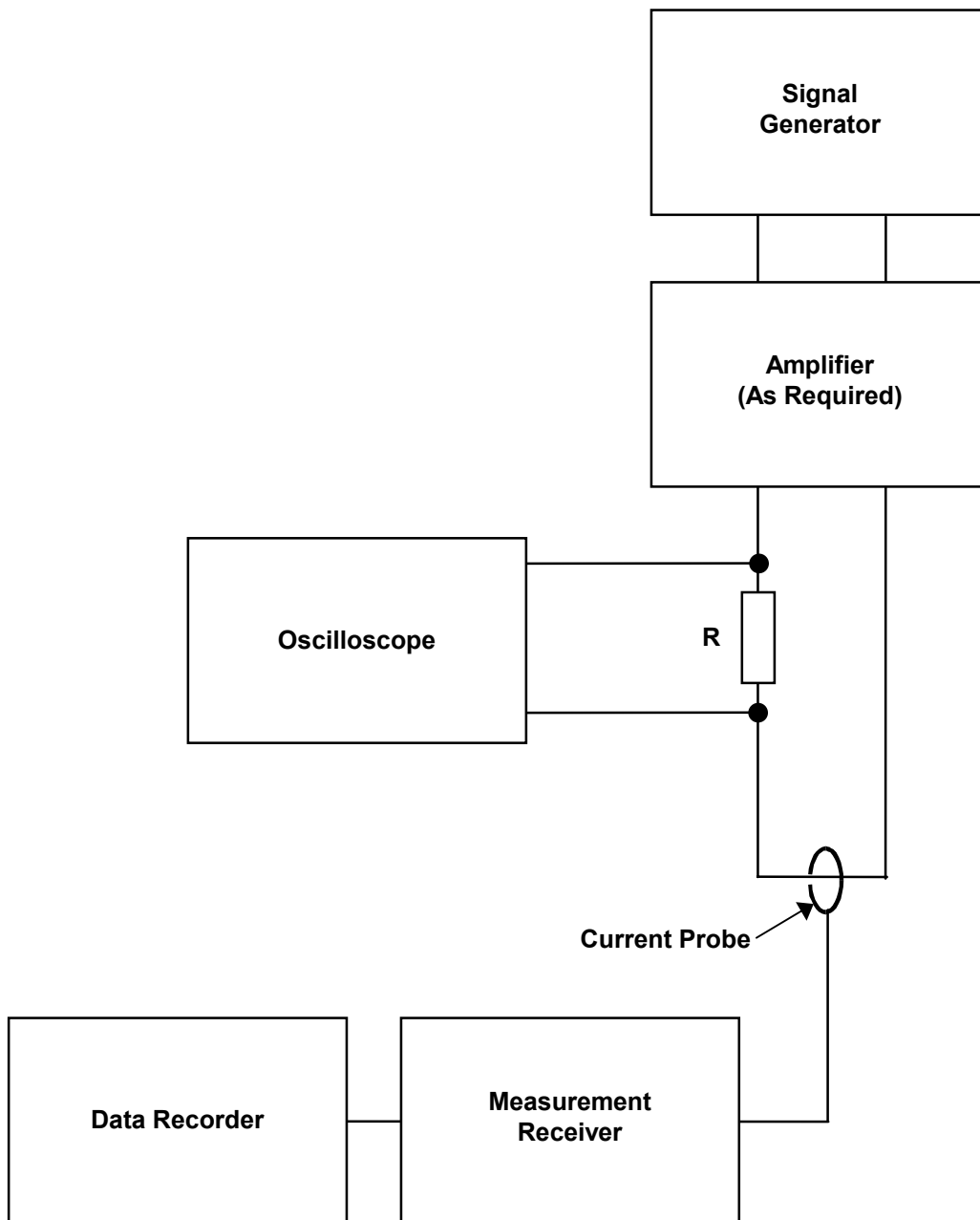


FIGURE NCE05-3 - Limit for Land Applications



**FIGURE NCE05-4 Measurement system check.**

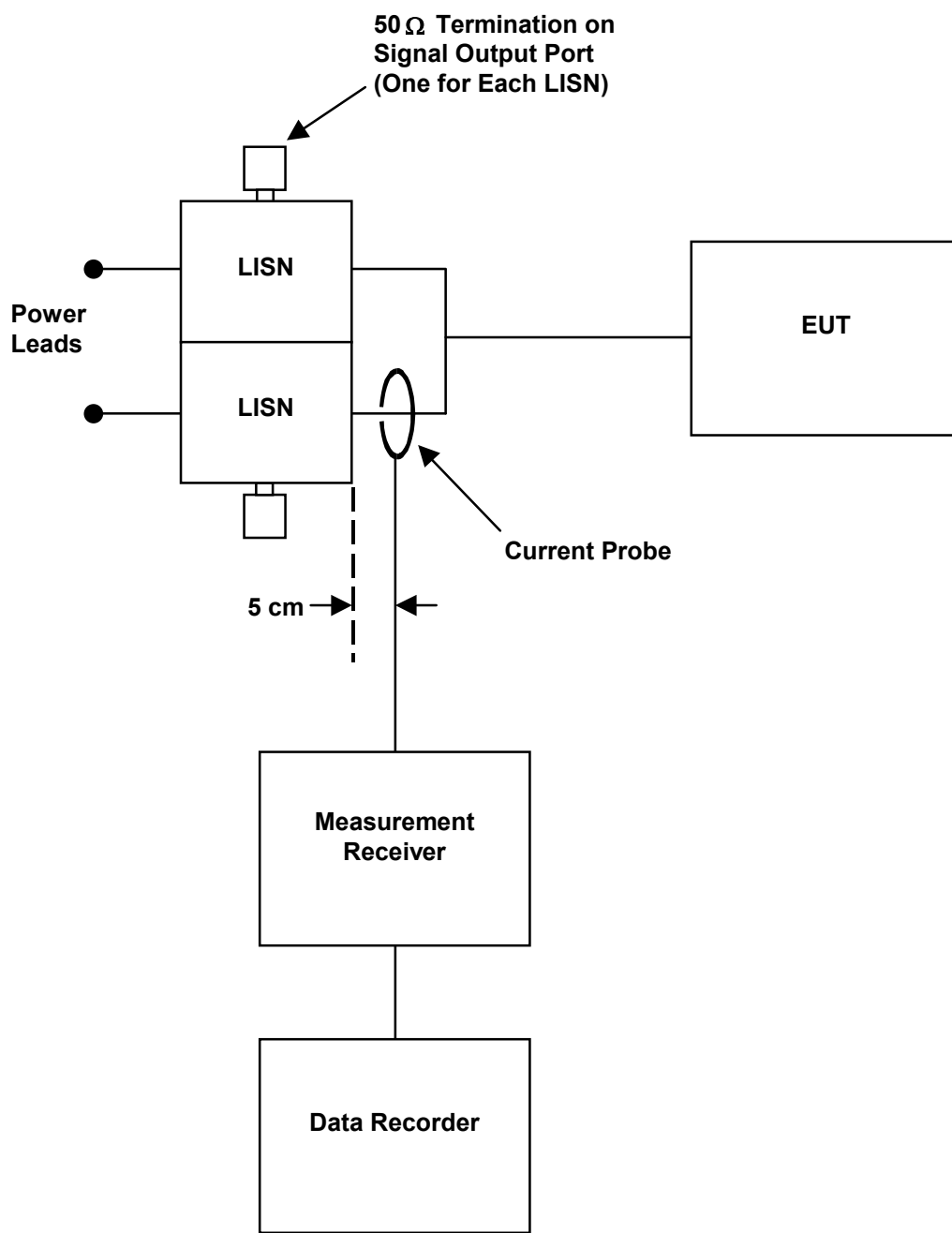
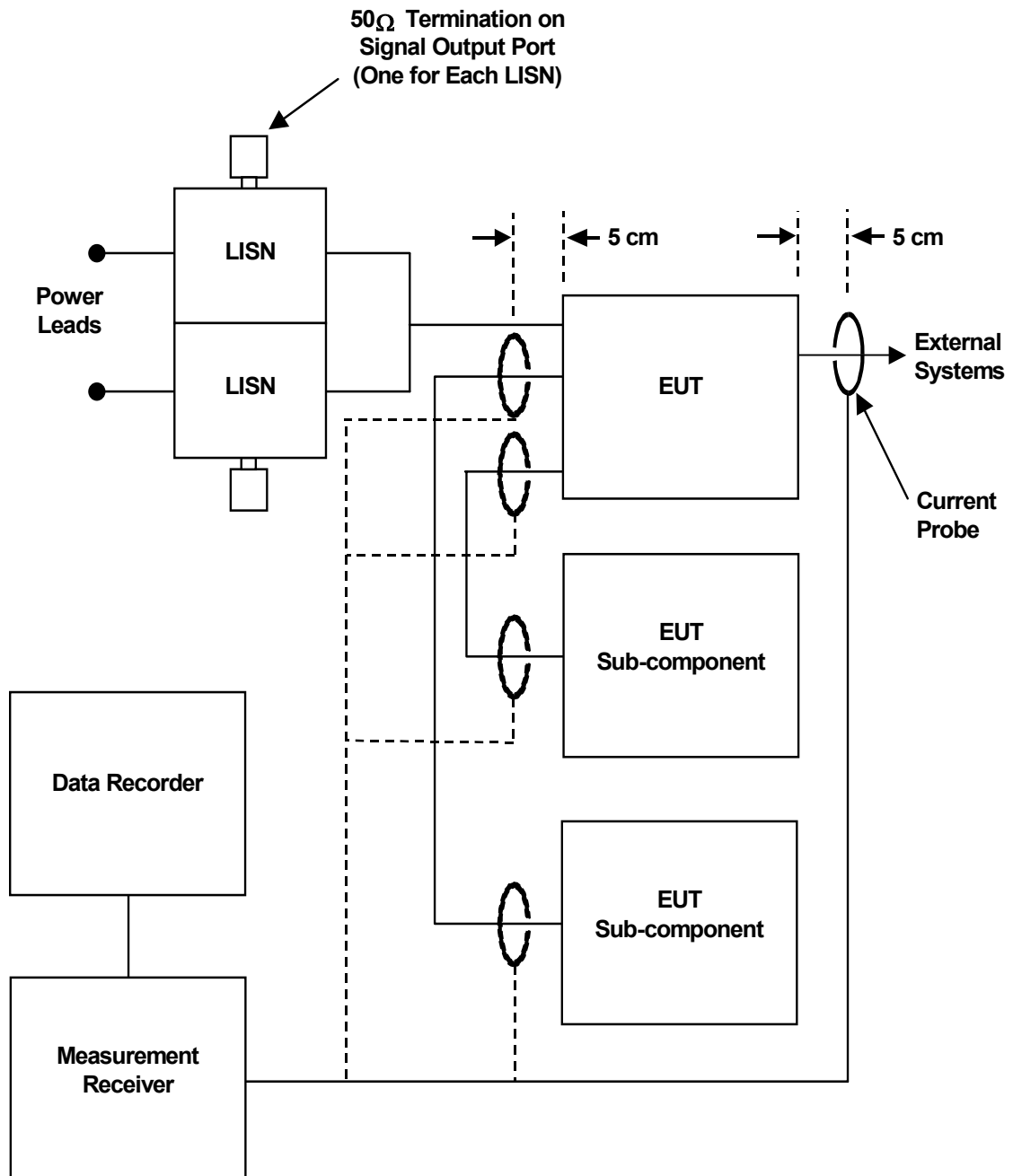


FIGURE NCE05-5 Measurement set-up for Power leads.



**FIGURE NCE05-6 Measurement set-up for Signal and Control leads.**

Note : Additional current probe positions shown with dashed lines.

# **NCS01**

## **Conducted Susceptibility, Power Leads, 30 Hz to 150 kHz**

### TABLE OF CONTENTS

<b>1</b>	<b>NCS01 APPLICABILITY.....</b>	<b>NCS01-2</b>
<b>2</b>	<b>NCS01 LIMIT .....</b>	<b>NCS01-2</b>
<b>3</b>	<b>NCS01 TEST PROCEDURE.....</b>	<b>NCS01-2</b>
	3.1 Purpose.....	NCS01-2
	3.2 Test equipment .....	NCS01-2
	3.3 Setup.....	NCS01-3
	3.4 Procedures.....	NCS01-3
	3.5 Data presentation.....	NCS01-4

## **NCS01**

### **Conducted Susceptibility, Power Leads, 30 Hz to 150 kHz**

#### **1 NCS01 APPLICABILITY**

This requirement is applicable to equipment and subsystem AC and DC input power leads, not including returns. If the EUT is DC operated, this requirement is applicable over the frequency range of 30 Hz to 150 kHz. If the EUT is AC operated, this requirement is applicable starting from the second harmonic of the EUT power frequency and extending to 150 kHz. Reference should also be made to paragraph 6.9 of Category 501.

Note. If test NCS07 is also to be performed on the EUT at the same time then it is permissible to limit the upper frequency of this test to 50 KHz.

#### **2 NCS01 LIMIT**

The EUT shall not exhibit any malfunction, degradation of performance, or deviation from specified indications, beyond the tolerances indicated in the individual equipment or subsystem specification, when subjected to a test signal with voltage levels as specified in Figure NCS01-1. The requirement is also met when the power source is adjusted to dissipate the power level shown in Figure NCS01-2 in a 0.5  $\Omega$  load and the EUT is not susceptible.

#### **3 NCS01 TEST PROCEDURE**

##### **3.1 Purpose**

This test procedure is used to verify the ability of the EUT to withstand signals coupled onto input power leads.

##### **3.2 Test equipment**

The test equipment shall be as follows:

- a. Signal generator
- b. Power amplifier
- c. Oscilloscope
- d. Coupling transformer
- e. Capacitor, 10  $\mu$ F
- f. Isolation transformer
- g. Resistor, 0.5  $\Omega$
- h. LISNs

### 3.3 Setup

The test setup shall be as follows:

- a. Maintain a basic test setup for the EUT as shown and described in Category 501, Figures 3 through to 6 and paragraph 4.3.8.
- b. Calibration. Configure the test equipment in accordance with Figure NCS01-3. Set up the oscilloscope to monitor the voltage across the 0.5  $\Omega$  resistor.
- c. EUT testing.
  - (1) For DC or single phase AC power, configure the test equipment as shown in Figure NCS01-4.
  - (2) For three phase ungrounded power, configure the test setup as shown in Figure NCS01-5.
  - (3) For three phase wye power (four power leads), configure the test setup as shown in Figure NCS01-6.

### 3.4 Procedures.

The test procedures shall be as follows:

- a. Turn on the measurement equipment and allow sufficient time for stabilization.
- b. Calibration.
  - (1) Set the signal generator to the lowest test frequency.
  - (2) Increase the applied signal until the oscilloscope indicates the voltage level corresponding to the maximum required power level specified for the limit. Verify the output waveform is sinusoidal.
  - (3) Record the setting of the signal source.
  - (4) Scan the required frequency range for testing and record the signal source setting needed to maintain the required power level.
- c. EUT Testing.
  - (1) Turn on the EUT and allow sufficient time for stabilization. CAUTION: Exercise care when performing this test since the "safety ground" of the oscilloscope is disconnected due to the isolation transformer and a shock hazard may be present.
  - (2) Set the signal generator to the lowest test frequency. Increase the signal level until the required voltage or power level is reached on the power lead. (Note: Power is limited to the level calibrated in 3.4b(2)).
  - (3) While maintaining at least the required signal level, scan through the required frequency range at a rate no greater than specified in Table 3 of Category 501.
  - (4) Susceptibility evaluation.
    - (a) Monitor the EUT for degradation of performance.
    - (b) If susceptibility is noted, determine the threshold level in accordance with paragraph 4.3.10.4.3 of Category 501 and verify that it is above the limit.

- (5) Repeat 3.4c(2) through 3.4c(4) for each power lead, as required. For three phase ungrounded power, the measurements shall be made according to the following table:

Coupling Transformer in Line	Voltage Measurement From
A	A to B
B	B to C
C	C to A

**TABLE NCS01-1**

For three phase wye power (four leads) the measurements shall be made according to the following table:

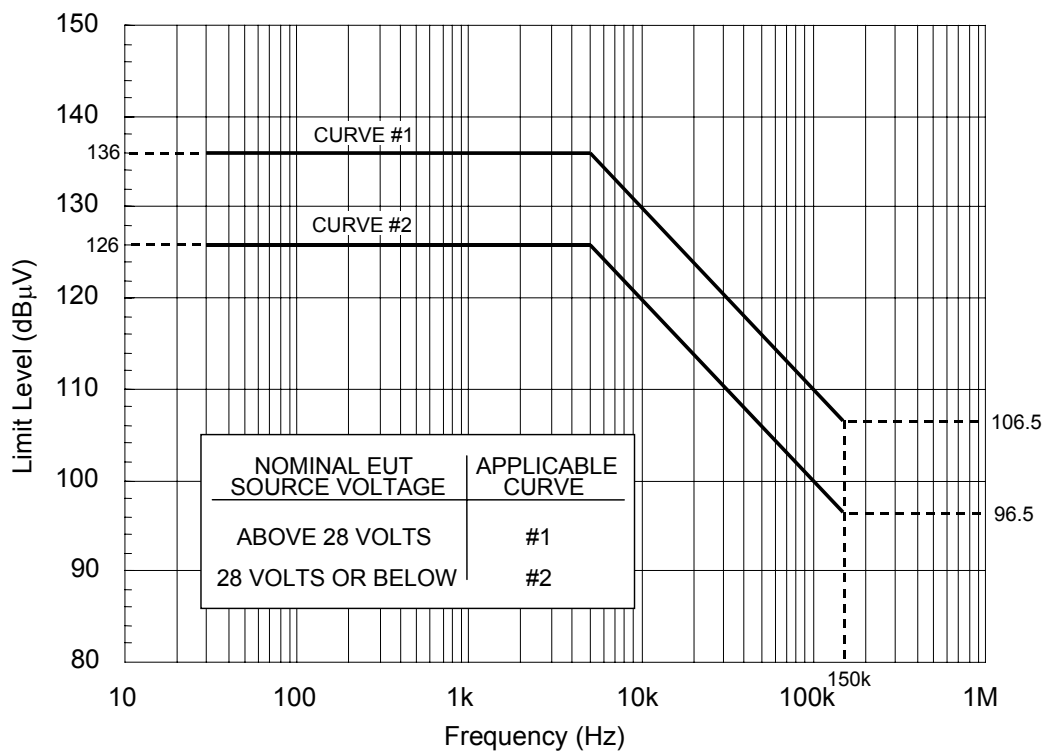
Coupling Transformer in Line	Voltage Measurement From
A	A to neutral
B	B to neutral
C	C to neutral

**TABLE NCS01-2**

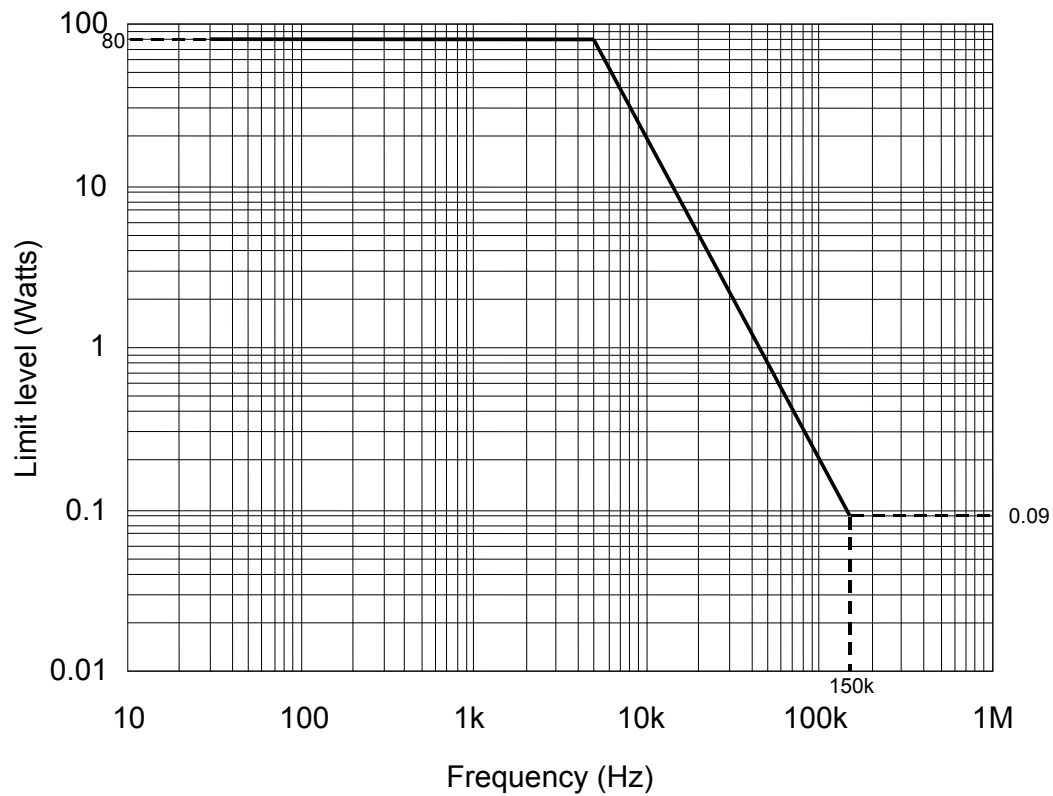
### 3.5 Data presentation.

Data presentation shall be as follows:

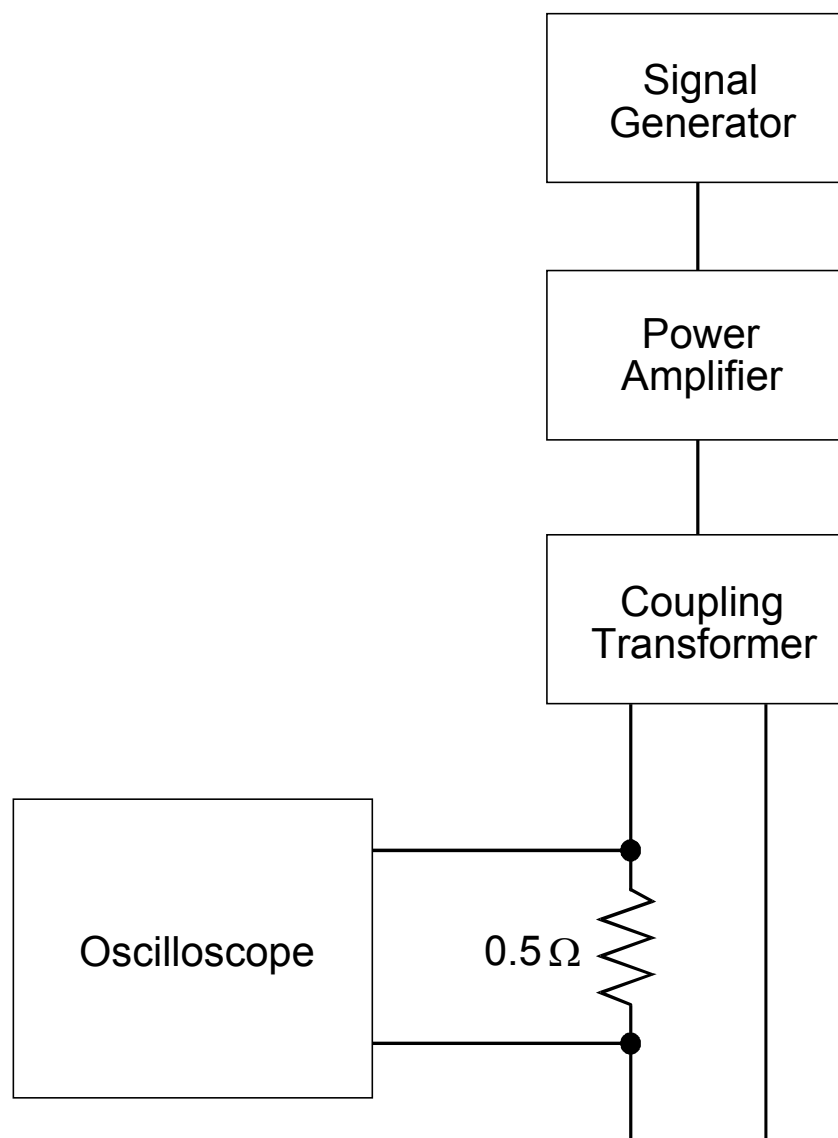
- a. Provide graphical or tabular data showing the frequencies and amplitudes at which the test was conducted for each lead.
- b. Provide data on any susceptibility thresholds and the associated frequencies that were determined for each power lead.
- c. Provide indications of compliance with the applicable requirements for the susceptibility evaluation specified in 3.4c for each lead.



**FIGURE NCS01-1 Voltage Limit for all applications.**



**FIGURE NCS01-2 Power Limit for all applications.**



**FIGURE NCS01-3 Calibration.**

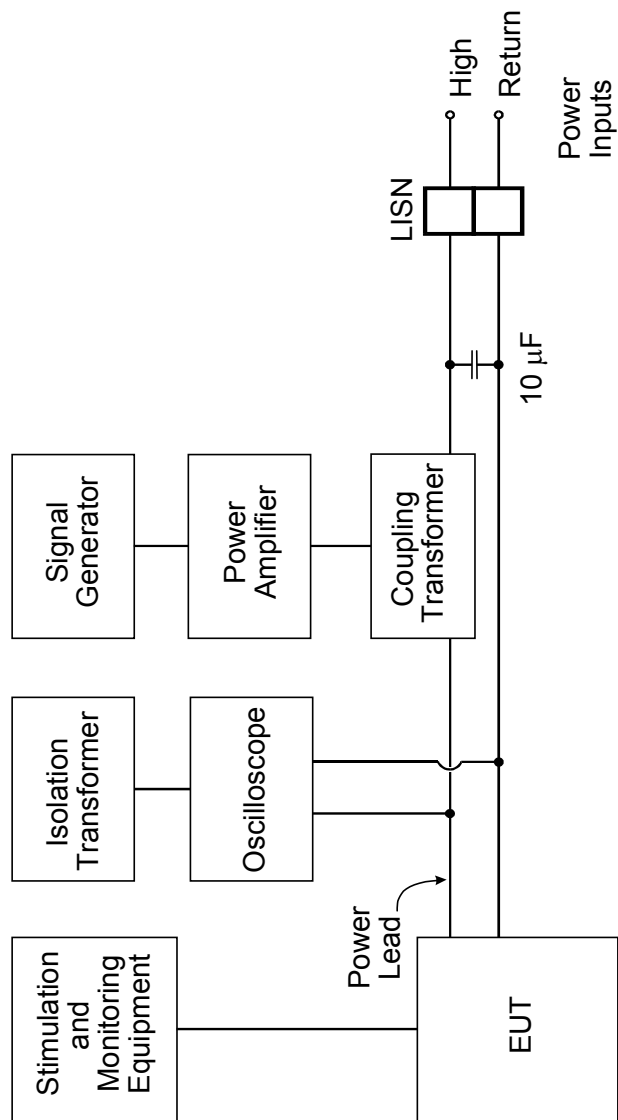
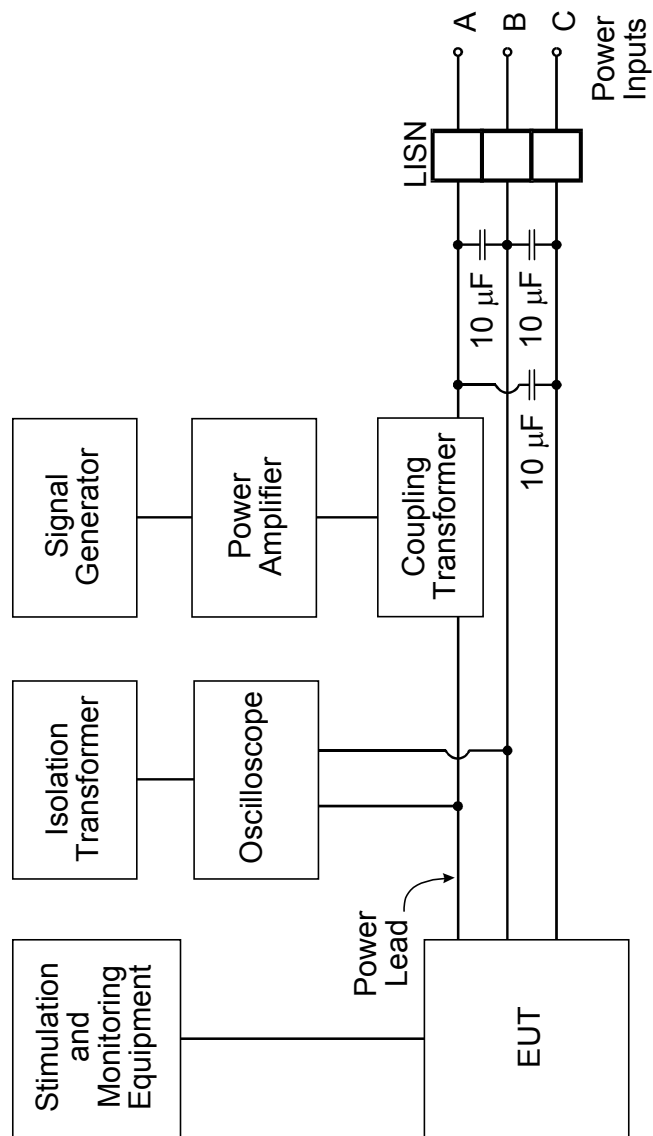
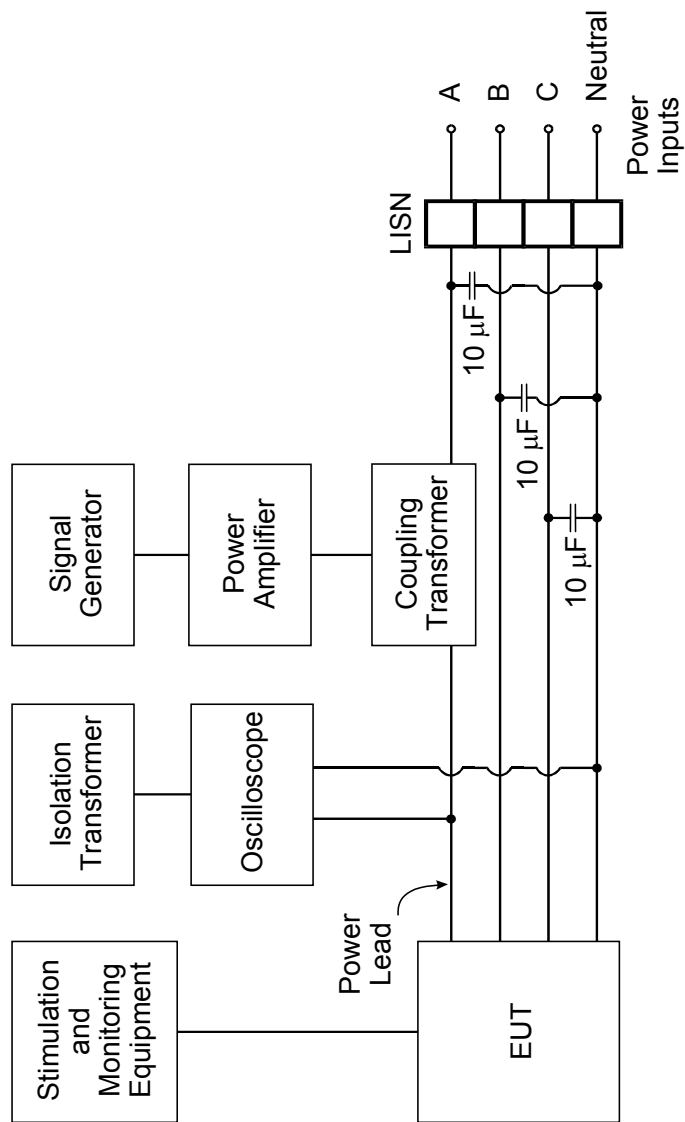


FIGURE NCS01-4 Signal injection, DC or single phase AC.



**FIGURE NCS01-5** Signal Injection, 3-phase ungrounded.



**FIGURE NCS01-6** Signal Injection, 3-phase wye.

**NCS02**  
**Conducted Susceptibility, Control and Signal Leads,**  
**30 Hz to 50 kHz**

TABLE OF CONTENTS

<b>1</b>	<b>NCS02 APPLICABILITY.....</b>	<b>NCS02-2</b>
<b>2</b>	<b>NCS02 LIMITS.....</b>	<b>NCS02-2</b>
<b>3</b>	<b>NCS02 TEST PROCEDURE.....</b>	<b>NCS02-2</b>
	3.1 Purpose.....	NCS02-2
	3.2 Test equipment.....	NCS02-2
	3.3 Setup.....	NCS02-3
	3.4 Procedures.....	NCS02-3
	3.5 Data presentation.....	NCS02-3

## **NCS02**

### **Conducted Susceptibility, Control and Signal Leads, 30 Hz to 50 kHz**

#### **1 NCS02 APPLICABILITY**

This test is applicable to all control and signals leads connected to the EUT. This test is also applicable to cable forms, which include power supply leads together with other lines to the EUT via an external cable. Reference should also be made to paragraph 6.10 of Category 501.

#### **2 NCS02 LIMITS**

Limits are shown in figures NCS02-2 and NCS02-3, for Air use and for both Sea and Land service use, respectively.

#### **3 NCS02 TEST PROCEDURE**

##### **3.1 Purpose**

This test determines whether the equipment interconnect circuit configuration will accept a level of induced voltages caused by the installation environment. This test procedure relates specifically to interfering signals derived from the power frequency and its harmonics as well as audio frequency signals that are generated by other on-board equipment or systems. Such interfering signals can be coupled to sensitive circuits within the EUT through its wiring.

##### **3.2 Test equipment**

The test equipment shall be as follows:

- a. Signal generator
- b. Power amplifier, low output impedance
- c. Ammeter
- d. Capacitor, 30000  $\mu$ F
- e. 5  $\mu$ H or 50  $\mu$ H LISNs

### 3.3 Setup

The test setup shall be as follows:

- a. A typical test layout is shown in Figure NCS02-1.

### 3.4 Procedures

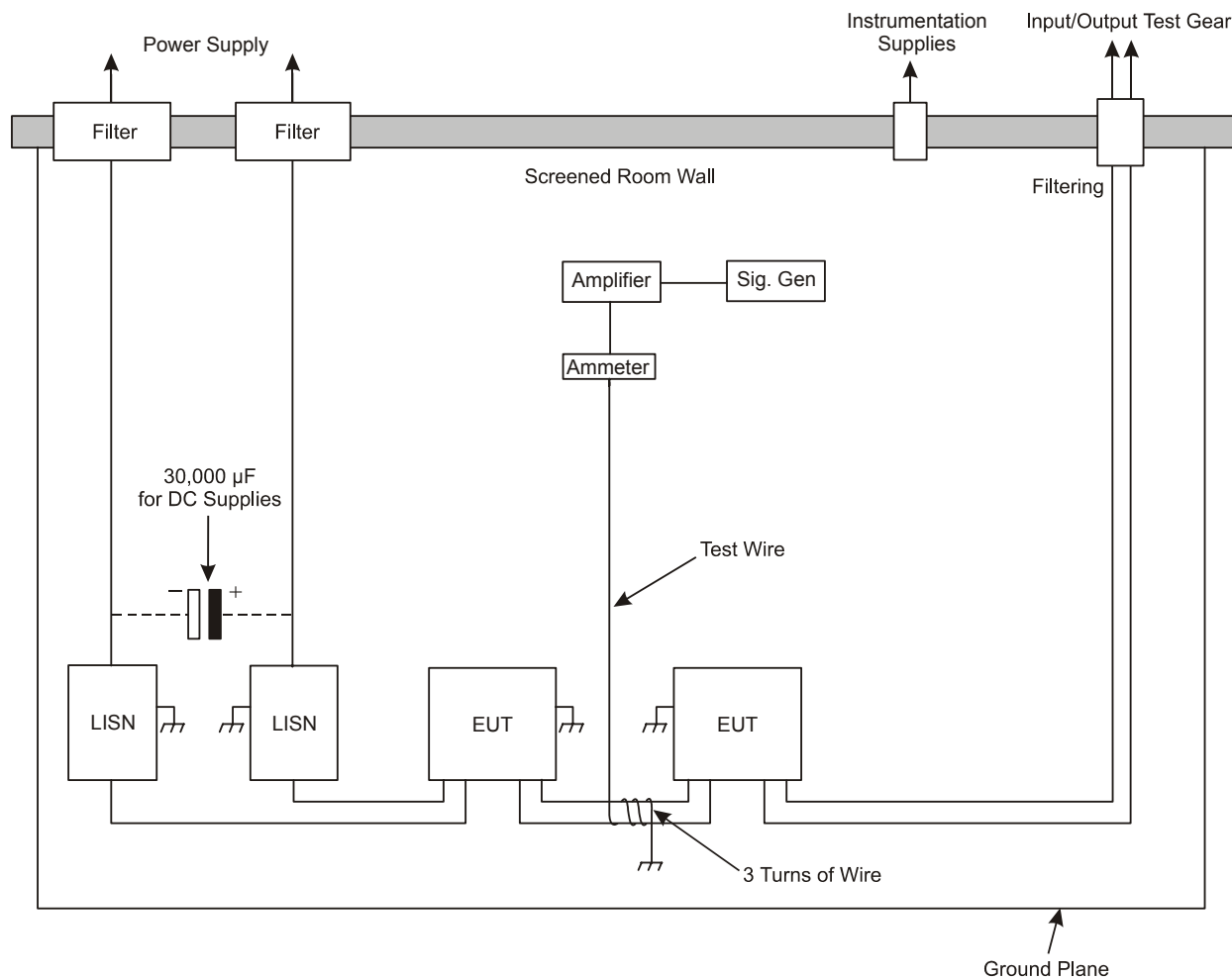
The test procedures shall be as follows:

- a. The test wire shall be closely coupled to each cable bundle to be tested by wrapping three turns over a straight cable length of 1 metre.
- b. The test wire shall be energised with the specified current over the required frequency range and monitored by means of a suitable method and device (e.g. ammeter/test receiver, voltmeter/resistor, current probe, etc.) capable of measuring up to 50 kHz.
- c. Should malfunctions be found during this test the current shall be reduced until the threshold is established and then recorded.

### 3.5 Data presentation

Data presentation shall be as follows:

- a. Any malfunction, failure or damage of the equipment shall be investigated and recorded in the test report.



**FIGURE NCS02-1 Typical Test Configuration**

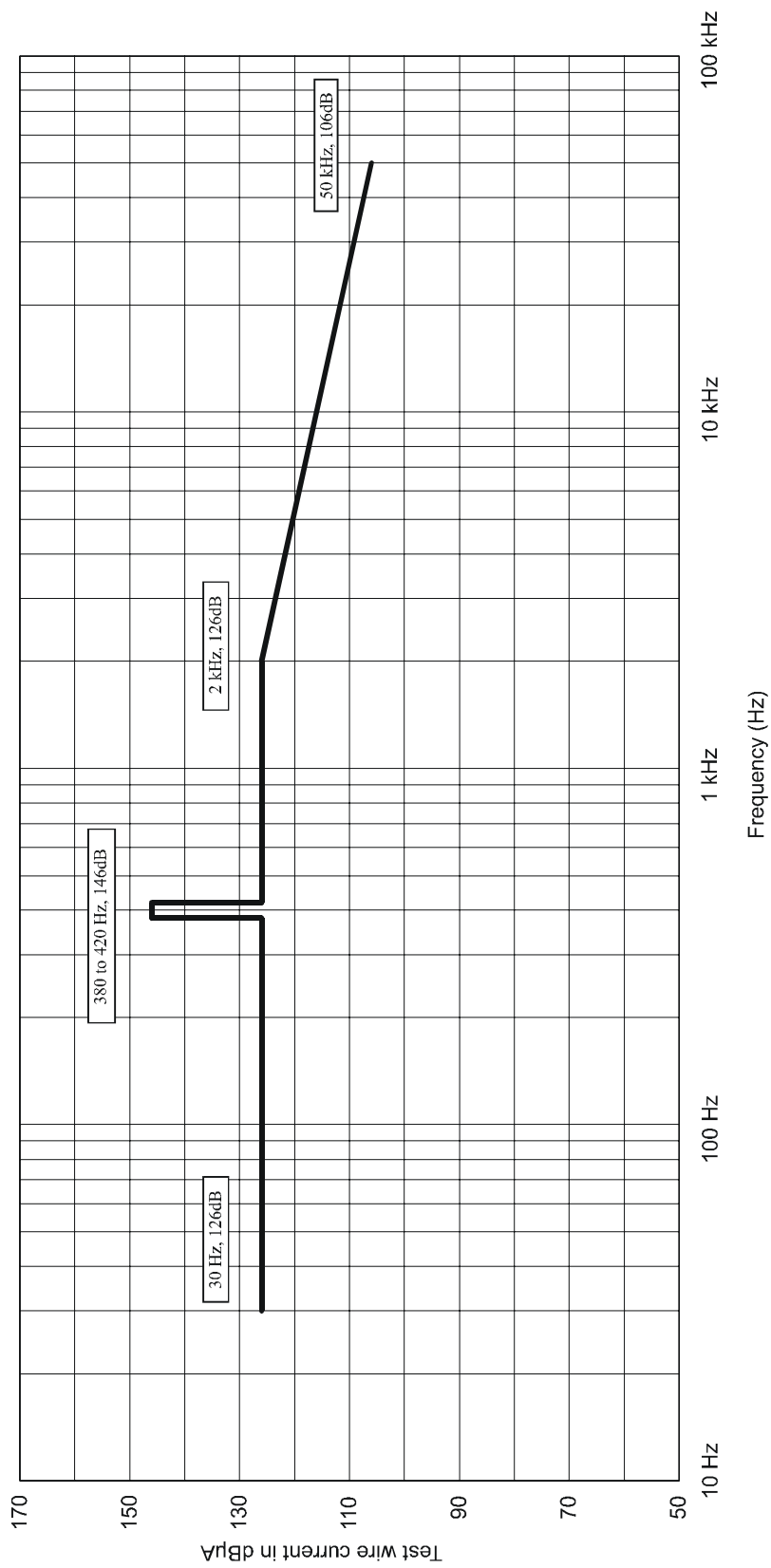


FIGURE NCS02-2 Limit for Air Applications

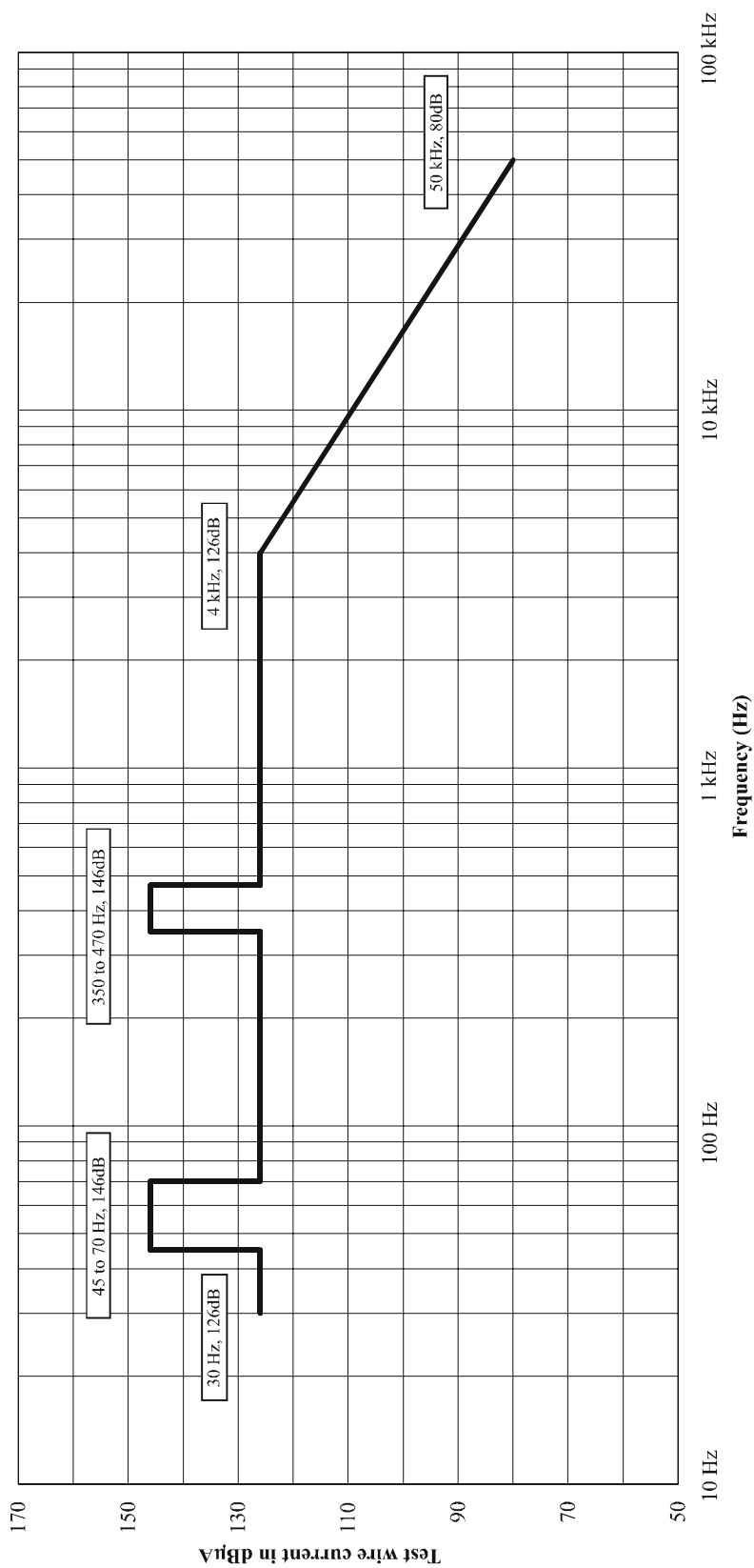


FIGURE NCS02-3 Limit for Land and Sea Applications

**NCS03**  
**Conducted Susceptibility, Antenna Port, Intermodulation**  
**15 kHz to 10 GHz**

TABLE OF CONTENTS

<b>1</b>	<b>NCS03 APPLICABILITY</b> .....	<b>NCS03-2</b>
<b>2</b>	<b>NCS03 LIMIT</b> .....	<b>NCS03-2</b>
<b>3</b>	<b>NCS03 TEST PROCEDURES</b> .....	<b>NCS03-2</b>
	3.1 Purpose.....	NCS03-2
	3.2 Test requirements .....	NCS03-2

## **NCS03**

### **Conducted Susceptibility, Antenna Port, Intermodulation 15 kHz to 10 GHz**

#### **1 NCS03 APPLICABILITY**

This receiver front-end susceptibility requirement is applicable to equipment and subsystems, such as communications receivers, RF amplifiers, transceivers, radar receivers, acoustic receivers, and electronic warfare receivers as specified in the individual procurement specification. Reference should also be made to paragraph 6.11 of Category 501.

#### **2 NCS03 LIMIT**

The EUT shall not exhibit any intermodulation products beyond specified tolerances when subjected to the limit requirement provided in the individual procurement specification.

#### **3 NCS03 TEST PROCEDURES**

##### 3.1 Purpose

This test procedure is used to determine the presence of intermodulation products that may be caused by undesired signals at the EUT antenna input terminals.

##### 3.2 Test requirements

The required test equipment, setup, procedures, and data presentation shall be determined on a case-by-case basis in accordance with the guidance provided in paragraph 6.11 of Category 501.

**NCS04**  
**Conducted Susceptibility, Antenna Port, Rejection of Undesired**  
**Signals, 30 Hz to 20 GHz**

TABLE OF CONTENTS

<b>1</b>	<b>NCS04 APPLICABILITY.....</b>	<b>NCS04-2</b>
<b>2</b>	<b>NCS04 LIMIT .....</b>	<b>NCS04-2</b>
<b>3</b>	<b>NCS04 TEST PROCEDURES .....</b>	<b>NCS04-2</b>
	3.1 Purpose.....	NCS04-2
	3.2 Test requirements .....	NCS04-2

## **NCS04**

### **Conducted Susceptibility, Antenna Port, Rejection of Undesired Signals, 30 Hz to 20 GHz**

#### **1 NCS04 APPLICABILITY**

This receiver front-end susceptibility requirement is applicable to equipment and subsystems, such as communications receivers, RF amplifiers, transceivers, radar receivers, acoustic receivers, and electronic warfare receivers as specified in the individual procurement specification. Reference should also be made to paragraph 6.12 of Category 501.

#### **2 NCS04 LIMIT**

The EUT shall not exhibit any undesired response beyond specified tolerances when subjected to the limit requirement provided in the individual procurement specification.

#### **3 NCS04 TEST PROCEDURES**

##### **3.1 Purpose**

This test procedure is used to determine the presence of spurious responses that may be caused by undesired signals at the EUT antenna input terminals.

##### **3.2 Test requirements**

The required test equipment, setup, procedures, and data presentation shall be determined on a case-by-case basis in accordance with the guidance provided in paragraph 6.12 of Category 501.

**NCS05**  
**Conducted Susceptibility, Antenna Port, Cross Modulation**  
**30 Hz to 20 GHz**

TABLE OF CONTENTS

<b>1</b>	<b>NCS05 APPLICABILITY.....</b>	<b>NCS05-2</b>
<b>2</b>	<b>NCS05 LIMIT .....</b>	<b>NCS05-2</b>
<b>3</b>	<b>NCS05 TEST PROCEDURES .....</b>	<b>NCS05-2</b>
	3.1 Purpose.....	NCS05-2
	3.2 Test requirements .....	NCS05-2

## **NCS05**

### **Conducted Susceptibility, Antenna Port, Cross Modulation 30 Hz to 20 GHz**

#### **1 NCS05 APPLICABILITY**

This receiver front-end susceptibility requirement is applicable only to receivers that normally process amplitude-modulated RF signals, as specified in the individual procurement specification. Reference should also be made to paragraph 6.13 of Category 501.

#### **2 NCS05 LIMIT**

The EUT shall not exhibit any undesired response, due to cross modulation, beyond specified tolerances when subjected to the limit requirement provided in the individual procurement specification.

#### **3 NCS05 TEST PROCEDURES**

##### **3.1 Purpose**

This test procedure is used to determine the presence of cross-modulation products that may be caused by undesired signals at the EUT antenna terminals.

##### **3.2 Test requirements**

The required test equipment, setup, procedures, and data presentation shall be determined in accordance with the guidance provided in paragraph 6.13 of Category 501.

## **NCS06**

### **Conducted Susceptibility, Structure Current, 60 Hz to 100 kHz**

#### TABLE OF CONTENTS

<b>1</b>	<b>NCS06 APPLICABILITY.....</b>	<b>NCS06-2</b>
<b>2</b>	<b>NCS06 LIMIT .....</b>	<b>NCS06-2</b>
<b>3</b>	<b>NCS06 TEST PROCEDURES .....</b>	<b>NCS06-2</b>
3.1	Purpose .....	NCS06-2
3.2	Test equipment .....	NCS06-2
3.3	Setup .....	NCS06-2
3.4	Procedures .....	NCS06-3
3.5	Data Presentation .....	NCS06-3

## NCS06

### Conducted Susceptibility, Structure Current, 60 Hz to 100 kHz

#### 1 NCS06 APPLICABILITY

This requirement is applicable to equipment and subsystems that have an operating frequency range of 100 kHz or less and an operating sensitivity of 1  $\mu\text{V}$  or less (such as 0.5  $\mu\text{V}$ ). Handheld equipment is exempt from this requirement. Reference should also be made to paragraph 6.14 of Category 501.

#### 2 NCS06 LIMIT

The EUT shall not exhibit any malfunction, degradation of performance, or deviation from specified indications, beyond the tolerances indicated in the individual equipment or subsystem specification, when subjected to the values shown on Figure NCS06-1.

#### 3 NCS06 TEST PROCEDURES

##### 3.1 Purpose

This test procedure is used to verify the ability of the EUT to withstand structure currents.

##### 3.2 Test equipment

The test equipment shall be as follows:

- a. Signal generator
- b. Amplifier (if required)
- c. Isolation transformers
- d. Current probe
- e. Measurement receiver
- f. Resistor, 0.5  $\Omega$
- g. Coupling transformer

##### 3.3 Setup

The test setup shall be as follows:

- a. It is not necessary to maintain the basic test setup for the EUT as shown and described in Category 501 Figures 3 through to 6 and paragraph 4.3.8.
- b. Calibration. No special calibration is required.
- c. EUT testing.
  - (1) As shown in Figure NCS06-2, configure the EUT and the test equipment (including the test signal source, the test current measurement equipment, and the equipment required for operating the EUT or measuring performance degradation) to establish a single-point ground for the test setup using the EUT ground terminal.
    - (a) Using isolation transformers, isolate all AC power sources. For DC power, isolation transformers are not applicable.

- (b) Disconnect the safety ground leads of all input power cables.
  - (c) Place the EUT and the test equipment on non-conductive surfaces to enable a single point ground to be established.
- (2) The test points for the injected currents shall be as follows:
- (a) Equipment that will not be rack mounted. At diagonal extremes across only the mounting surface.
  - (b) Rack mounted equipment. At diagonal extremes across all surfaces of the equipment.
  - (c) Deck resting equipment. At diagonal extremes across all surfaces of the equipment.
  - (d) Bulkhead mounted equipment. At diagonal extremes across rear surface of the equipment.
  - (e) Cables (all mounting methods). Between cable armour, which is terminated at the EUT, and the single point ground established for the test setup. This requirement shall also apply to cable shields and conduit, unless they have a single point ground.
- (3) Connect the signal generator and resistor to a selected set of test points. Attachment to the test points shall be by conductors that are perpendicular to the test surface for a length of at least 50 cm.

### 3.4 Procedures

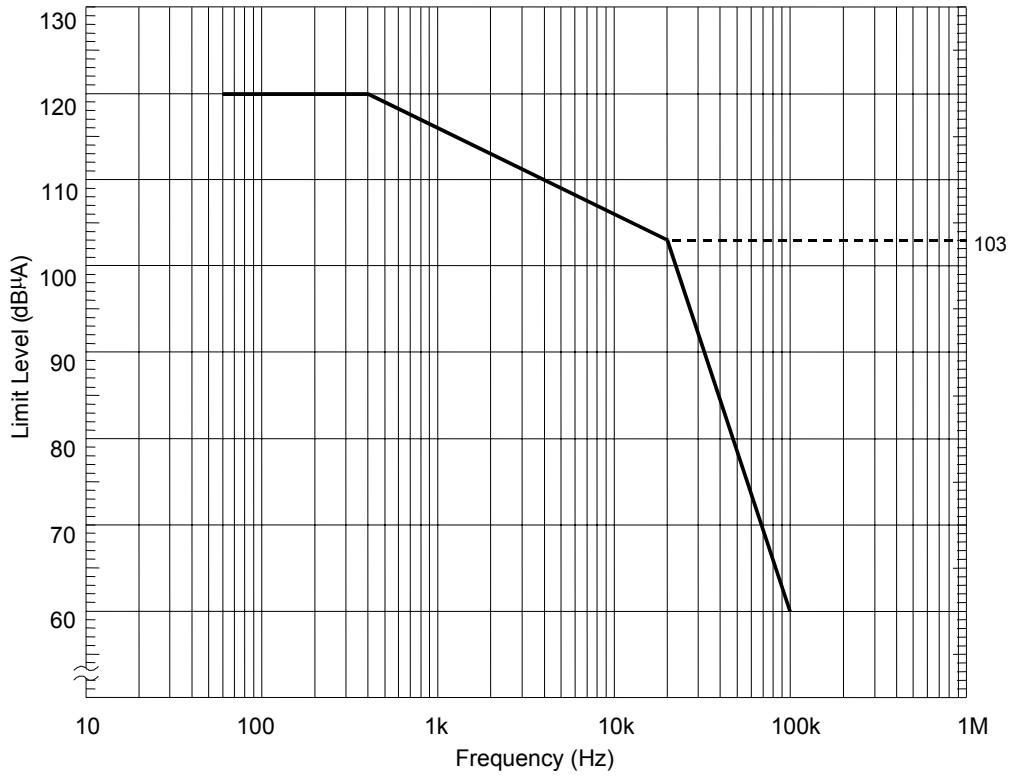
The test procedures shall be as follows:

- a. Turn on the EUT and measurement equipment and allow sufficient time for stabilisation.
- b. Set the signal generator to the lowest required frequency. Adjust the signal generator to the required level as a minimum. Monitor the current with the current probe and measurement receiver.
- c. Scan the signal generator over the required frequency range in accordance with Table 3 of Category 501, while maintaining the current level at least to the level specified in the applicable limit. Monitor the EUT for susceptibility.
- d. If susceptibility is noted, determine the threshold level in accordance with paragraphs 4.3.10.4.3 of Category 501 and verify that it is above the applicable limit.
- e. Repeat 3.4b through 3.4d for each diagonal set of test points on each surface of the EUT to be tested.

### 3.5 Data Presentation

Data presentation shall be as follows:

- a. Provide a table showing the mode of operation, susceptible frequency, current threshold level, current limit level, and susceptible test points.
- b. Provide a diagram of the EUT showing the location of each set of test points.



**FIGURE NCS06-1 Limit for all applications.**

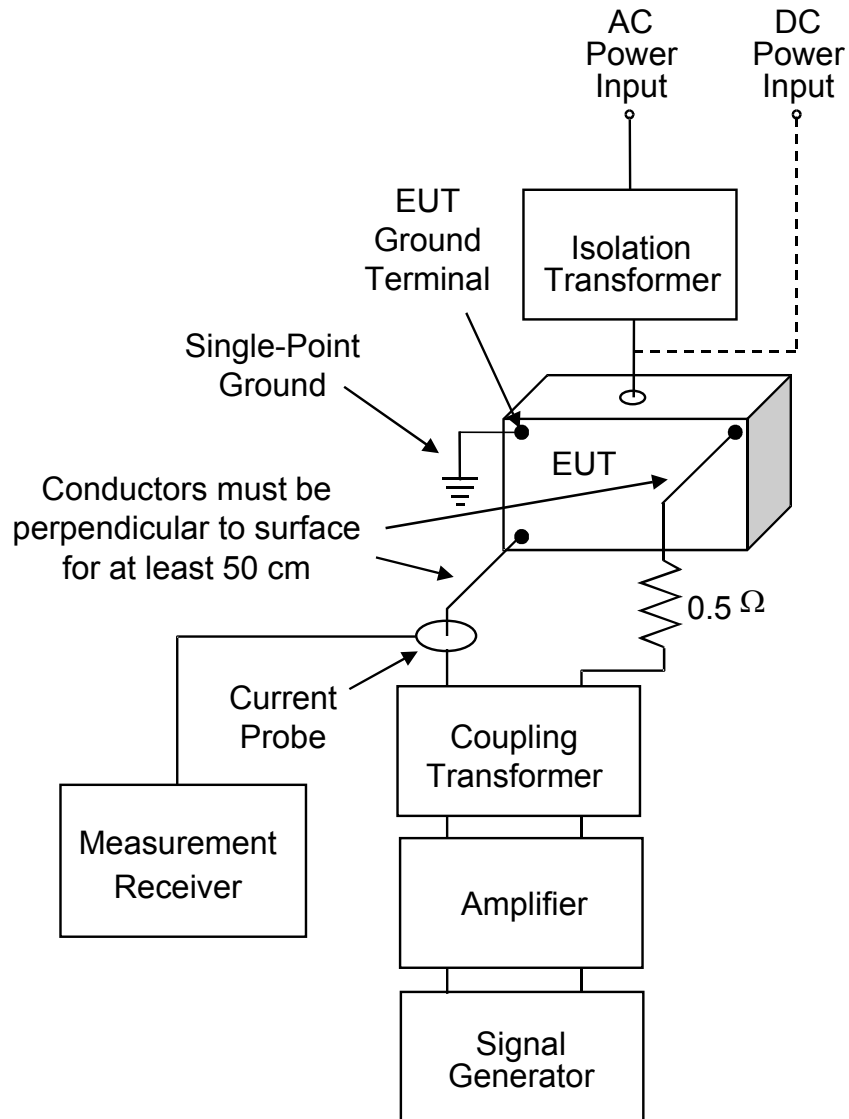


FIGURE NCS06-2 Test Configuration.

AECTP 500  
Edition 2  
Category 501  
Test NCS06

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**NCS07**  
**Conducted Susceptibility, Bulk Cable Injection**  
**10 kHz to 200 MHz**

TABLE OF CONTENTS

<b>1</b>	<b>NCS07 APPLICABILITY</b> .....	<b>NCS07-2</b>
<b>2</b>	<b>NCS07 LIMIT</b> .....	<b>NCS07-2</b>
<b>3</b>	<b>NCS07 TEST PROCEDURES</b> .....	<b>NCS07-2</b>
	3.1 Purpose.....	NCS07-2
	3.2 Test equipment .....	NCS07-2
	3.3 Setup.....	NCS07-3
	3.4 Procedures.....	NCS07-3
	3.5 Data presentation.....	NCS07-4

## **NCS07**

### **Conducted Susceptibility, Bulk Cable Injection**

### **10 kHz to 200 MHz**

#### **1 NCS07 APPLICABILITY**

This requirement is applicable to all interconnecting cables, including power cables. Reference should also be made to paragraph 6.15 of Category 501.

The purpose of this test is to confirm that RF signals in the range 10 kHz to 200 MHz, when coupled on to the interconnecting cable looms and power supply lines of an EUT, will not cause a degradation in performance. In addition this test will provide an amplitude/frequency malfunction signature for the system which, when compared with the levels of current on the looms (or cables) caused by onboard and external transmitting sources measured during clearance trials, will assist in the establishment of adequate safety margins.

- a. Cable looms which connect the EUT to other equipments in the total system (including primary power lines) and those interconnecting units of the EUT are subject to this test. Cable looms can be tested as a whole or individual wires can be tested.

**NOTE** For a system with built in redundancy, e.g. a quadruplex flight control system, simultaneous injections on several looms may be required by the Project Manager.

#### **2 NCS07 LIMIT**

The EUT shall not exhibit any malfunction, degradation of performance, or deviation from specified indications beyond the tolerances indicated in the individual equipment or subsystem specification, when subjected to a injection probe drive level which has been pre-calibrated to the appropriate current limit shown in Figure NCS07-1 and is modulated as specified below. The appropriate limit curve in Figure NCS07-1 shall be selected from Table NCS07-1. Requirements are also met if the EUT is not susceptible at forward power levels sensed by the coupler that are below those determined during calibration provided that the actual current induced in the cable under test is 6 dB or greater than the calibration limit.

#### **3 NCS07 TEST PROCEDURES**

##### **3.1 Purpose**

This test procedure is used to verify the ability of the EUT to withstand RF signals coupled onto EUT associated cabling.

##### **3.2 Test equipment**

The test equipment shall be as follows:

- a. Measurement receivers
- b. Current injection probes (maximum insertion loss shown in Figure NCS07-2, minimum insertion loss is recommended, not required. Reference should also be made to Figure 21 and 6.14 in Category 501).
- c. Current probes

- d. Calibration fixture: coaxial transmission line with 50  $\Omega$  characteristic impedance, coaxial connections on both ends, and space for an injection probe around the centre conductor.
- e. Directional couplers
- f. Signal generators
- g. Plotter
- h. Attenuators, 50  $\Omega$
- i. Coaxial loads, 50  $\Omega$
- j. Power amplifiers
- k. 50  $\mu$ H LISNs

### 3.3 Setup

The test setup shall be as follows:

- a. Maintain a basic test setup for the EUT as shown and described in Category 501 Figures 3 through to 6 and paragraph 4.3.8.
- b. Calibration. Configure the test equipment in accordance with Figure NCS07-3 for calibrating injection probes.
  - (1) Place the injection probe around the centre conductor of the calibration fixture.
  - (2) Terminate one end of the calibration fixture with a 50  $\Omega$  load and terminate the other end with an attenuator connected to measurement receiver A.
- c. EUT Testing. Configure the test equipment as shown in Figure NCS07-4 for testing.
  - (1) Place the injection and monitor probes around a cable bundle interfacing with an EUT connector.
  - (2) Locate the monitor probe 5 cm from the connector. If the overall length of the connector and backshell exceeds 5 cm, position the monitor probe as close to the connector's backshell as possible.
  - (3) Position the injection probe 5 cm from the monitor probe.

### 3.4 Procedures

The test procedures shall be as follows:

- a. Turn on the measurement equipment and allow sufficient time for stabilization.
- b. Calibration. Perform the following procedures using the calibration setup.
  - (1) Set the signal generator to 10 kHz, unmodulated.
  - (2) Increase the applied signal until measurement receiver A indicates the current level specified in the applicable limit is flowing in the center conductor of the calibration fixture.
  - (3) Record the "forward power" to the injection probe indicated on measurement receiver B.
  - (4) Scan the frequency band from 10 kHz to 200 MHz and record the forward power needed to maintain the required current amplitude.

- c EUT Testing. Perform the following procedures on each cable bundle interfacing with each electrical connector on the EUT including complete power cables (high sides and returns). Also perform the procedures on power cables with the power returns and chassis grounds (green wires) excluded from the cable bundle. For connectors, which include both interconnecting leads and power, perform the procedures on the entire bundle, on the power leads (including returns and grounds) grouped separately, and on the power leads grouped with the returns and grounds removed.
- (1) Turn on the EUT and allow sufficient time for stabilization.
  - (2) Susceptibility evaluation.
    - (a) Set the signal generator to 10 kHz with 1 kHz pulse modulation, 50% duty cycle.
    - (b) Apply the forward power level determined under 3.4b(4) to the injection probe while monitoring the induced current.
    - (c) Scan the required frequency range in accordance with paragraph 4.3.10.4. and Table 3 of Category 501 while maintaining the forward power level at the calibration level determined under 3.4b(4), or the maximum current level for the applicable limit, whichever is less stringent.
    - (d) Monitor the EUT for degradation of performance during testing.
    - (e) Whenever susceptibility is noted, determine the threshold level in accordance with paragraph 4.3.10.4.3 of Category 501 and verify that it is above the applicable requirement.
    - (f) For EUTs with redundant cabling for safety critical reasons such as multiple data buses, use simultaneous multi-cable injection techniques.

### 3.5 Data presentation

Data presentation shall be as follows:

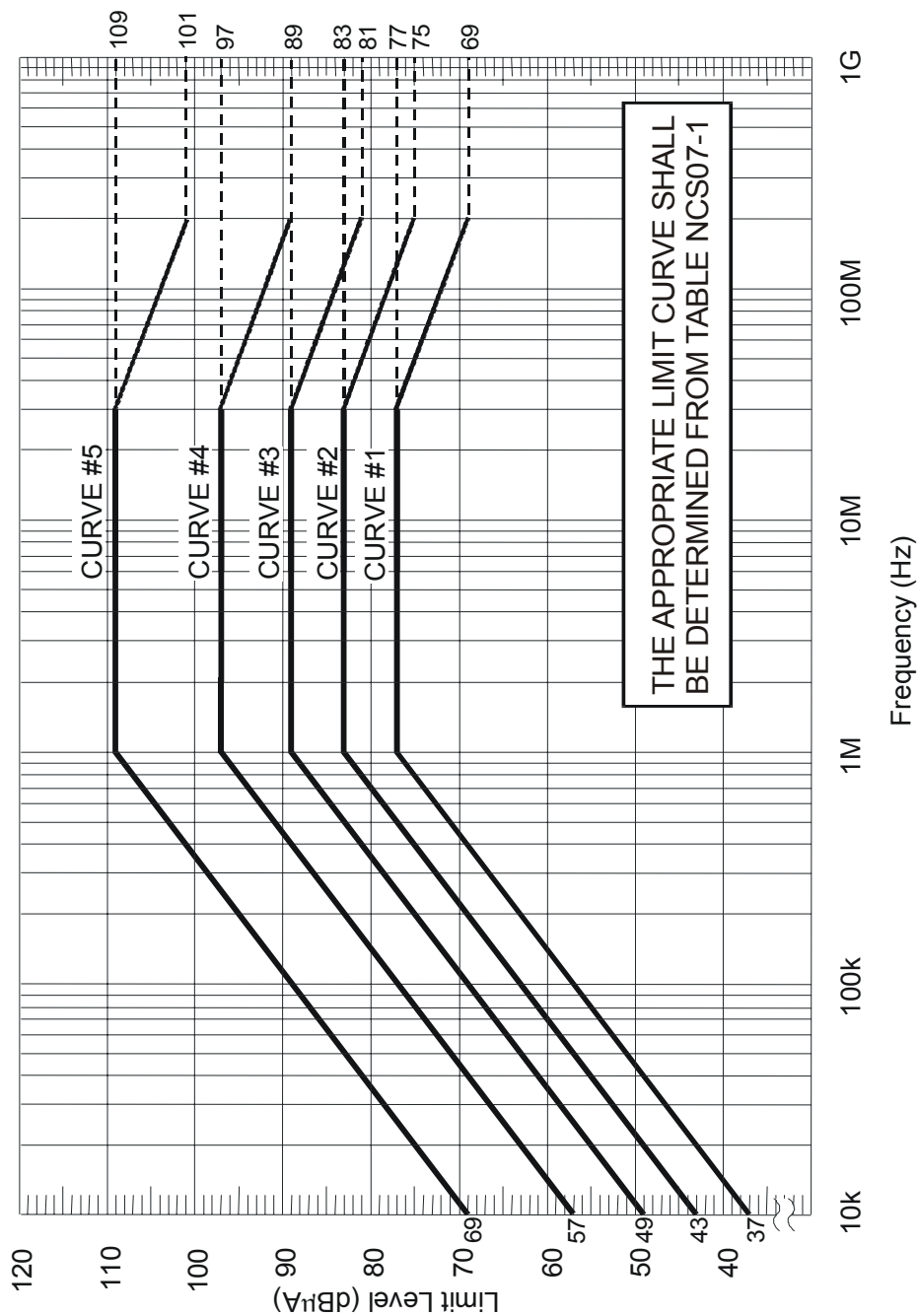
- a. Provide amplitude versus frequency plots for the forward power levels required to obtain the calibration level as determined in 3.4b.
- b. Provide tables showing scanned frequency ranges and statements of compliance with the requirements for the susceptibility evaluation of 3.4c(2) for each interface connector. Provide any susceptibility thresholds that were determined, along with their associated frequencies.

LIMIT CURVE # FROM FIGURE NCS07-1										
PLATFORM	AIRCRAFT (EXTERNAL OR SAFETY CRITICAL)	AIRCRAFT INTERNAL	ALL SHIPS (ABOVE DECKS) AND SUBMARINES (EXTERNAL)*	SHIPS (METALLIC) (BELOW DECKS)	SHIPS (NON-METALLIC) (BELOW DECKS)	SUBMARINES (INTERNAL)	GROUND	SPACE		
10 KHZ	L 5	5	2	2	2	-	3	3		
TO	S 5	3	2	2	2	1	2	3		
2 MHZ	A 5	3	-	-	-	-	2	3		
2 MHZ	L 5	5	5	2	4	-	4	3		
TO	S 5	5	5	2	4	1	2	3		
30 MHZ	A 5	3	-	-	-	-	2	3		
30 MHZ	L 5	5	5	2	2	-	4	3		
TO	S 5	5	5	2	2	2	2	3		
200 MHZ	A 5	3	-	-	-	-	2	3		

KEY L = LAND  
S = SEA  
A = AIR

\*For equipment located external to the pressure hull of a submarine but within the superstructure, use SHIPS (METALLIC) (BELOW DECKS)

TABLE NCS07 – 1 Limit Curves



**FIGURE NCS07-1 Calibration limit for all applications.**

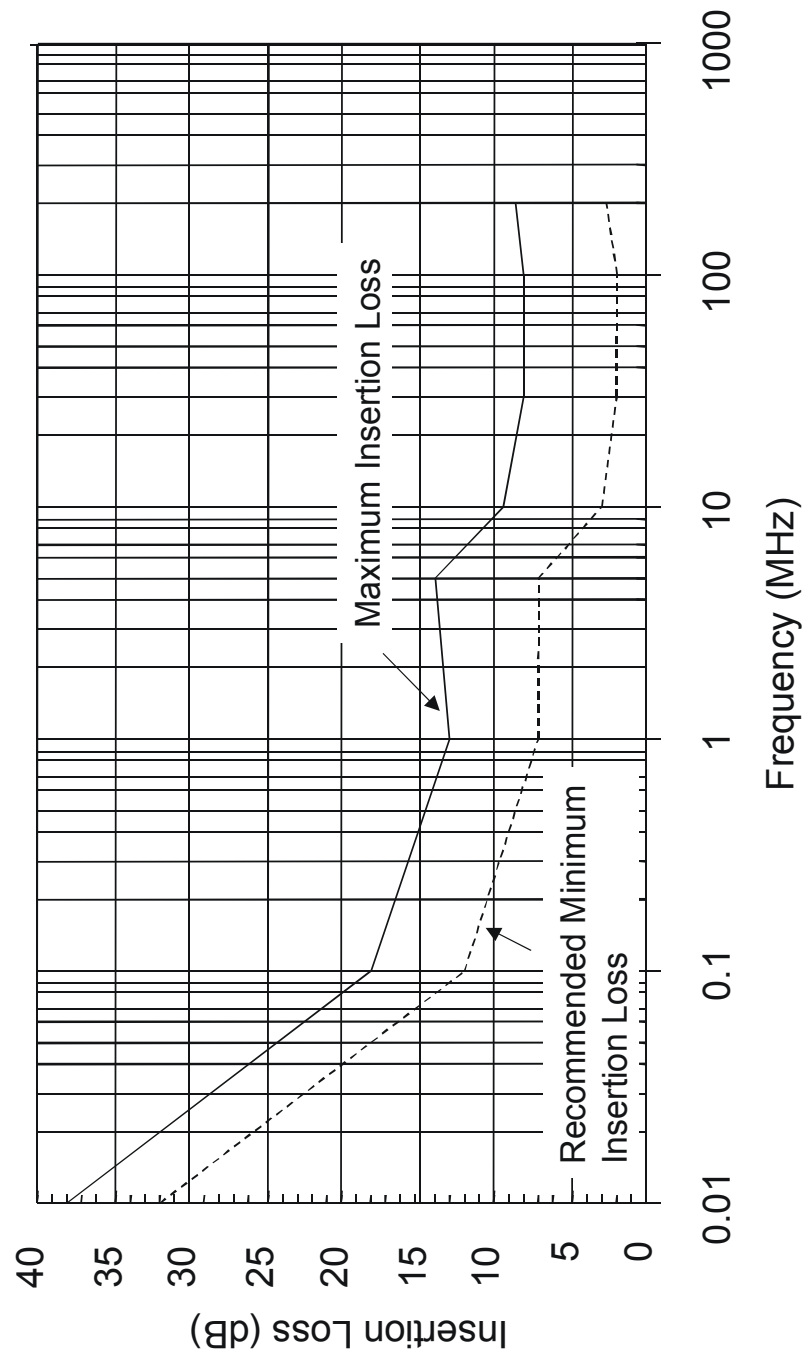
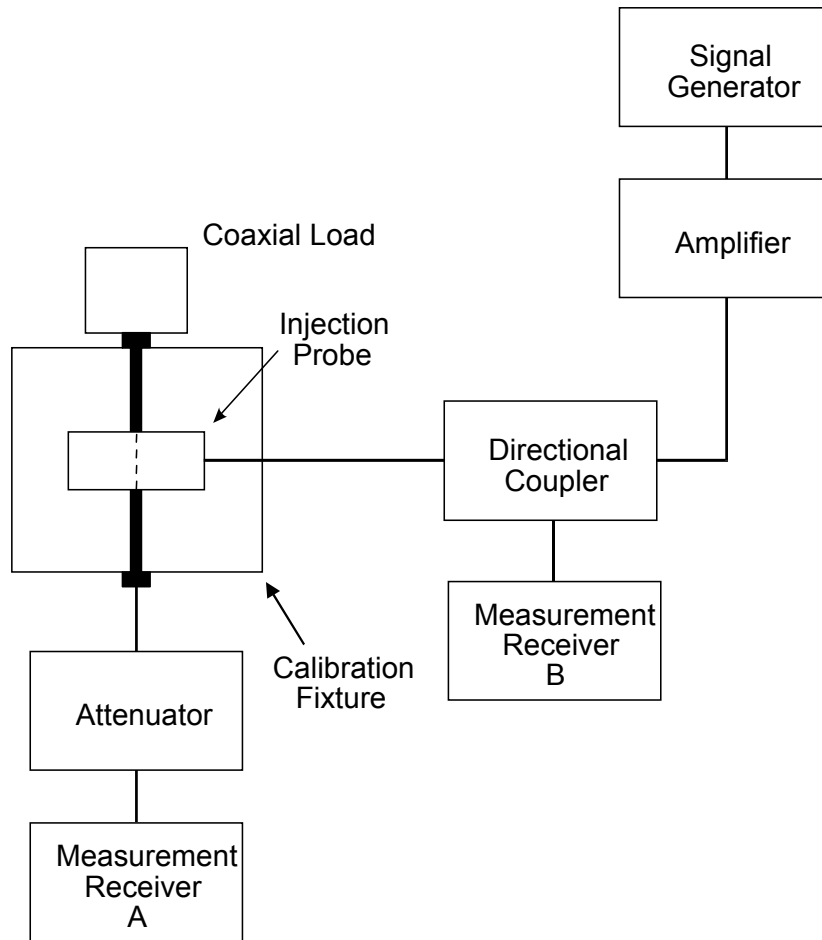
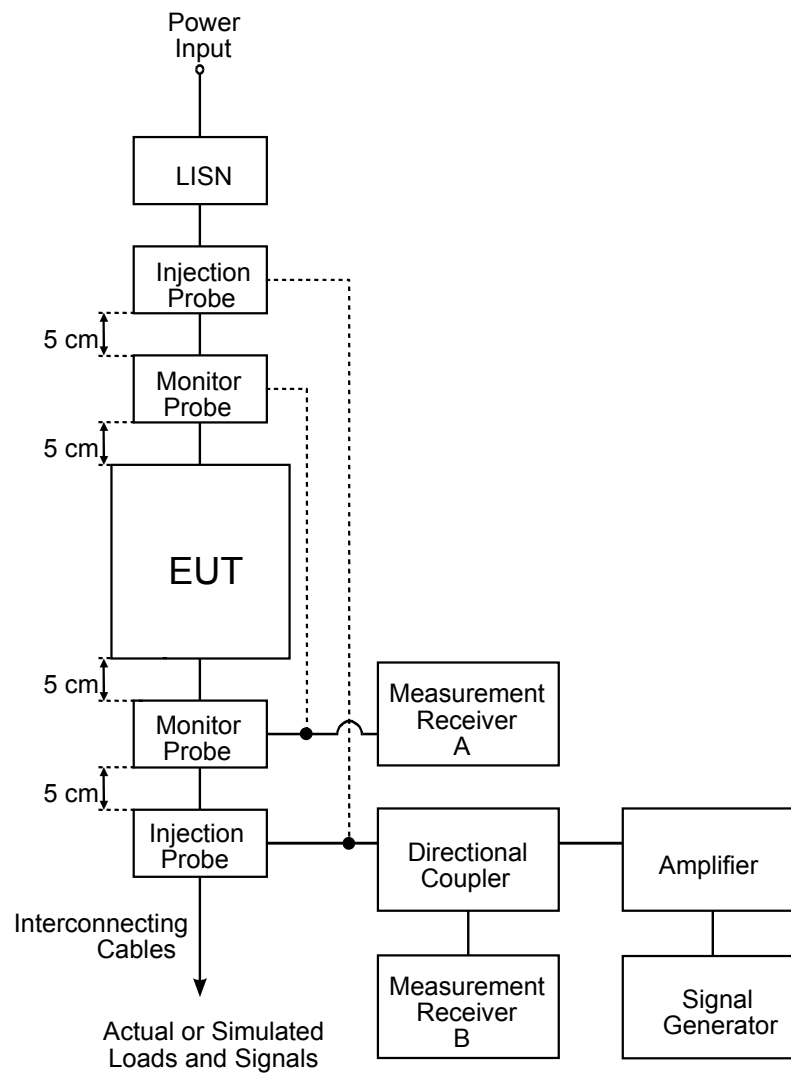


FIGURE NCS07-2 Maximum insertion loss for injection probes.



**FIGURE NCS07-3 Calibration set-up.**



**FIGURE NCS07-4 Bulk cable injection evaluation.**

AECTP 500  
Edition 2  
Category 501  
Test NCS07

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# **NCS08**

## **Conducted Susceptibility, Bulk Cable Injection Impulse Excitation**

### TABLE OF CONTENTS

<b>1</b>	<b>NCS08 APPLICABILITY.....</b>	<b>NCS08-2</b>
<b>2</b>	<b>NCS08 LIMIT .....</b>	<b>NCS08-2</b>
<b>3</b>	<b>NCS08 TEST PROCEDURE.....</b>	<b>NCS08-2</b>
3.1	Purpose.....	NCS08-2
3.2	Test equipment .....	NCS08-2
3.3	Setup.....	NCS08-2
3.4	Procedures.....	NCS08-3
3.5	Data presentation.....	NCS08-4

## NCS08

### Conducted Susceptibility, Bulk Cable Injection Impulse Excitation

#### 1 NCS08 APPLICABILITY

This requirement is applicable to all aircraft, space, and ground systems interconnecting cables, including power cables. The requirement is also applicable for surface ship and submarine subsystems and equipment when specified by the procuring activity. Reference should also be made to paragraph 6.16 of Category 501.

#### 2 NCS08 LIMIT

The EUT shall not exhibit any malfunction, degradation of performance, or deviation from specified indications, beyond the tolerances indicated in the individual equipment or subsystem specification, when subjected to a pre-calibrated signal having rise and fall times, pulse width, and amplitude as specified in Figure NCS08-1 at a 30 Hz rate for one minute.

#### 3 NCS08 TEST PROCEDURE

##### 3.1 Purpose

This test procedure is used to verify the ability of the EUT to withstand impulse signals coupled onto EUT associated cabling.

##### 3.2 Test equipment

The test equipment shall be as follows:

- a. Pulse generator, 50  $\Omega$ , charged line (coaxial)
- b. Current injection probe
- c. Drive cable, 50  $\Omega$  2 metres, 0.5 dB or less insertion loss at 500 MHz
- d. Current Probe
- e. Calibration fixture: coaxial transmission line with 50  $\Omega$  characteristic impedance, coaxial connections on both ends, and space for an injection probe around the centre conductor.
- f. Oscilloscope, 50  $\Omega$  input impedance
- g. Attenuators, 50  $\Omega$
- h. Coaxial loads, 50  $\Omega$
- i. 50  $\mu$ H LISNs

##### 3.3 Setup

The test setup shall be as follows:

- a. Maintain a basic test setup for the EUT as shown and described in Category 501 Figures 3 through 6 and paragraph 4.3.8.

- b. Calibration. Configure the test equipment in accordance with Figure NCS08-2 for calibrating the injection probe.
  - (1) Place the injection probe around the centre conductor of the calibration fixture.
  - (2) Terminate one end of the calibration fixture with a coaxial load and terminate the other end with an attenuator connected to an oscilloscope with 50  $\Omega$  input impedance
- c. EUT testing. Configure the test equipment as shown in Figure NCS08-3 for testing.
  - (1) Place the injection probe around a cable bundle interfacing with an EUT connector.
  - (2) Locate the monitor probe 5 cm from the connector. If the overall length of the connector and backshell exceeds 5 cm, position the monitor probe as close to the connector back shell as possible.
  - (3) Position the injection probe 5 cm from the monitor probe.

### 3.4 Procedures.

The test procedures shall be as follows:

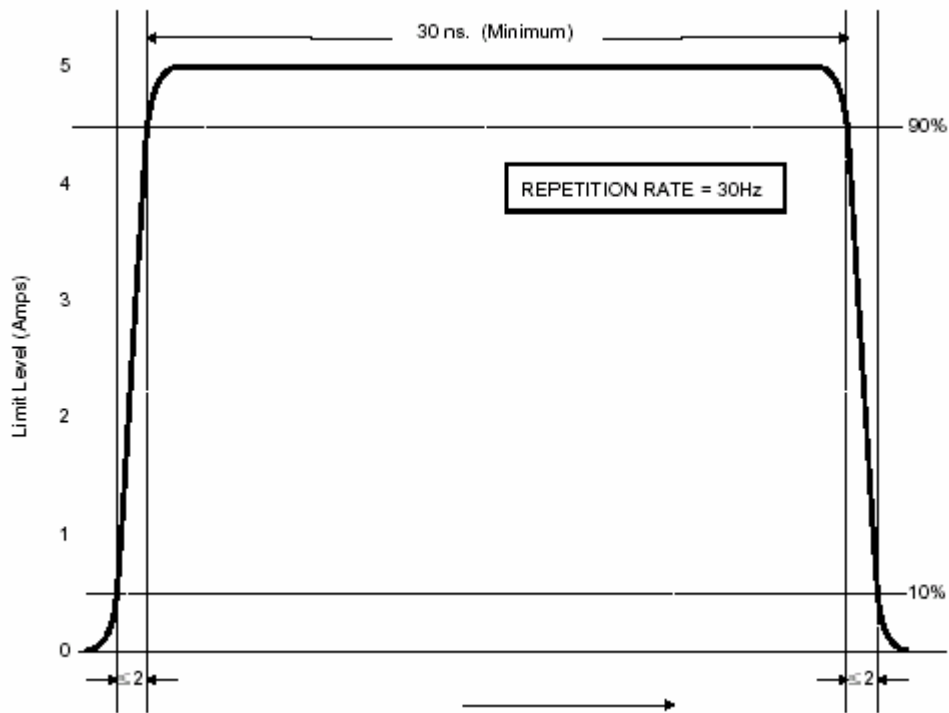
- a. Turn on the measurement equipment and allow sufficient time for stabilization.
- b. Calibration. Perform the following procedures using the calibration setup.
  - (1) Adjust the pulse generator source for the risetime, pulse width, and pulse repetition rate requirements specified in the requirement.
  - (2) Increase the signal applied to the calibration fixture until the oscilloscope indicates that the current level specified in the requirement is following in the centre conductor of the calibration fixture.
  - (3) Verify that the rise time, fall time, and pulse width portions of the waveform have the correct durations and that the correct repetition rate is present. The precise pulse shape will not be reproduced due to the inductive coupling mechanism.
  - (4) Record the pulse generator amplitude setting.
- c. EUT Testing.
  - (1) Turn on the EUT and allow sufficient time for stabilization
  - (2) Susceptibility evaluation
    - a. Adjust the pulse generator, as a minimum, for the amplitude determined in 3.4(b)
    - b. Apply the test signal at the pulse repetition rate and for the duration specified in the requirement.
    - c. Monitor the EUT for degradation of performance during testing.
    - d. Whenever susceptibility is noted, determine the threshold level in accordance with paragraph 4.3.10.4.3 of Category 501 and verify that it is above the limit.
    - e. Record the peak current in the cable as indicated on the oscilloscope.

- f. Repeat 3.4c(2)(a) through to 3.4c(2)(e) on each cable bundle interfacing with each electrical connector on the EUT. For power cable, perform 3.4c(2)(a) through to 3.4c(2)(e) on complete power cables (high sides and returns) and on the power cables with the power returns and chassis grounds (green wires) excluded from the cable bundle. For connectors which include both interconnecting leads and power, perform 3.4c(2)(a) through to 3.4c(2)(e) on the entire bundle, on the power leads (including returns and grounds) grouped separately, and on the power leads grouped with the returns and grounds removed.

### 3.5 Data presentation.

Data presentation shall be as follows:

- a. Provide tables showing statements of compliance with the requirement for the susceptibility evaluation of 3.4c(2) and the induced current level for each interface connector.
- b. Provide any susceptibility thresholds that were determined.
- c. Provide oscilloscope photographs on injected waveforms with test data.



**FIGURE NCS08-1** NCS08 signal characteristics for all applications.

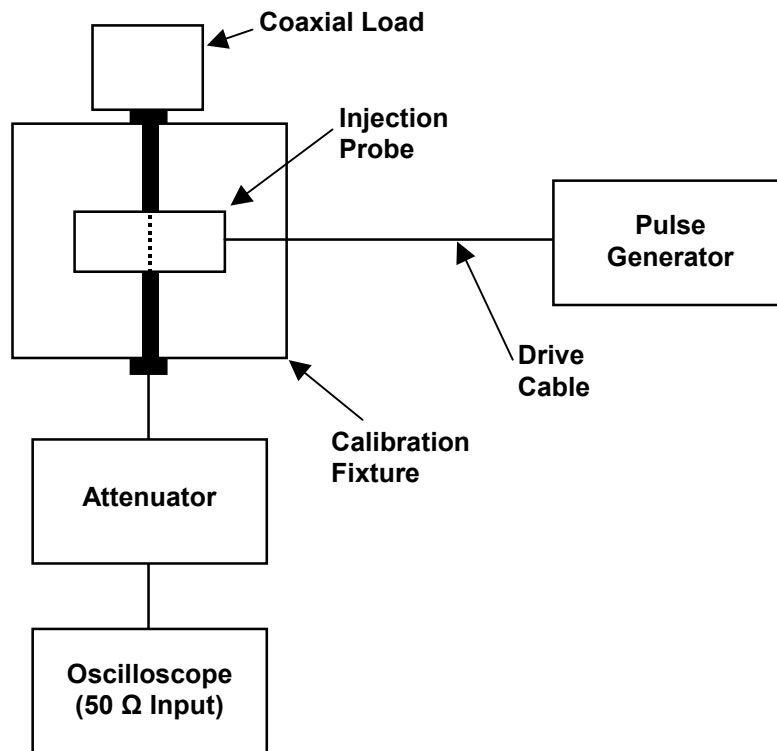


FIGURE NCS08-2 Calibration set-up.

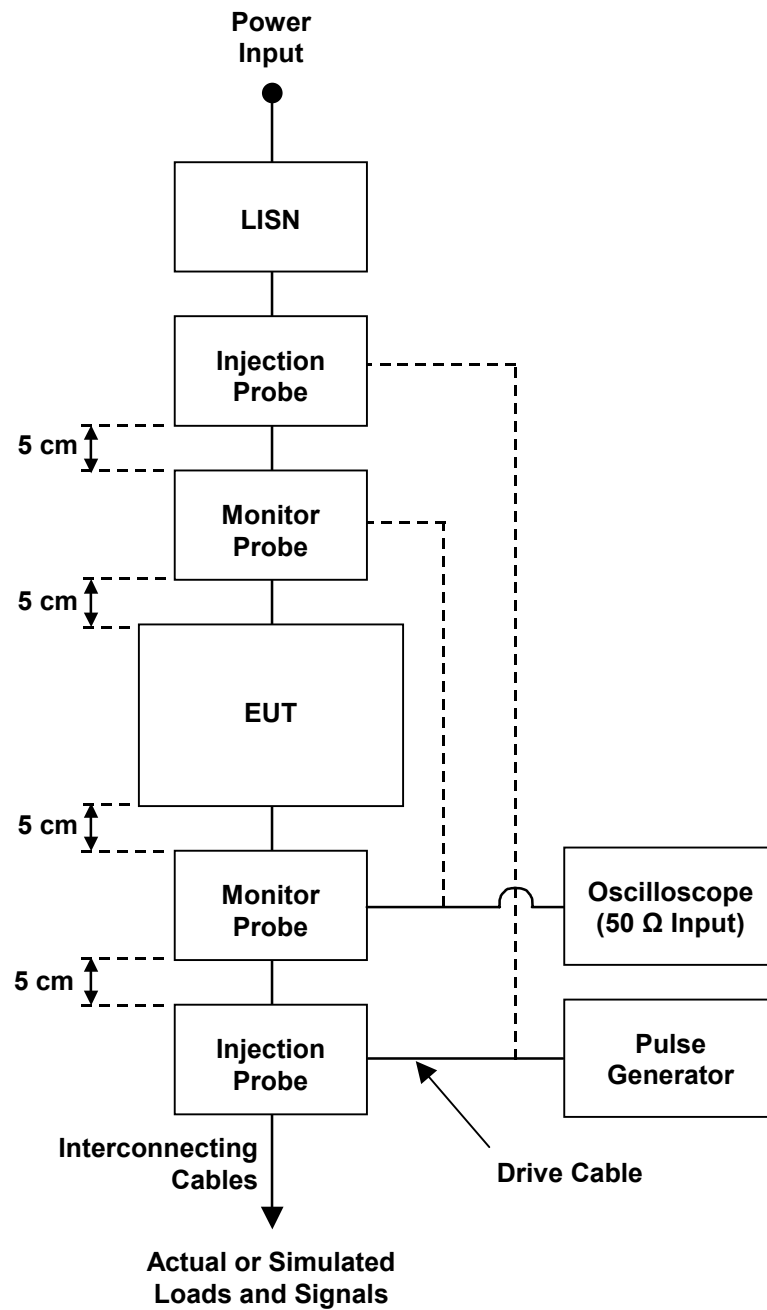


FIGURE NCS08-3 Bulk Current Injection.

AECTP 500  
Edition 2  
Category 501  
Test NCS08

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NCS08-8

ORIGINAL

**NCS09**  
**Conducted Susceptibility, Damped Sinusoidal Transients,**  
**Cables and Power Leads, 10 kHz to 100 MHz**

TABLE OF CONTENTS

<b>1</b>	<b>NCS09 APPLICABILITY.....</b>	<b>NCS09-2</b>
<b>2</b>	<b>NCS09 LIMIT.....</b>	<b>NCS09-2</b>
<b>3</b>	<b>NCS09 TEST PROCEDURES.....</b>	<b>NCS09-2</b>
	3.1 Purpose.....	NCS09-2
	3.2 Test equipment.....	NCS09-2
	3.3 Setup.....	NCS09-3
	3.4 Procedures.....	NCS09-3
	3.5 Data presentation.....	NCS09-4

## **NCS09**

### **Conducted Susceptibility, Damped Sinusoidal Transients, Cables and Power Leads, 10 kHz to 100 MHz**

#### **1 NCS09 APPLICABILITY**

This requirement is applicable to all interconnecting cables, including power cables, and individual high side power leads. Power returns and neutrals need not be tested individually. Reference should also be made to paragraph 6.17 in Category 501.

#### **2 NCS09 LIMIT**

The EUT shall not exhibit any malfunction, degradation of performance, or deviation from specified indications, beyond the tolerances indicated in the individual equipment or subsystem specification, when subjected to a signal having the waveform shown in Figure NCS09-1 and having a maximum current as specified in Figure NCS09-2. The limit is applicable across the entire specified frequency range. As a minimum, compliance shall be demonstrated at the following frequencies: 0.01, 0.1, 1, 10, 30, and 100 MHz. If there are other frequencies known to be critical to the equipment installation, such as platform resonances, compliance shall also be demonstrated at those frequencies. The test signal repetition rate shall be no greater than one pulse per second and no less than one pulse every two seconds. The pulses shall be applied for a period of five minutes.

#### **3 NCS09 TEST PROCEDURES**

##### **3.1 Purpose**

This test procedure is used to verify the ability of the EUT to withstand damped sinusoidal transients coupled onto EUT associated cables and power leads.

##### **3.2 Test equipment**

The test equipment shall be as follows:

- a. Damped sinusoid transient generator,  $\leq 100$  ohm output impedance
- b. Current injection probe
- c. Oscilloscope, 50 ohm input impedance
- d. Calibration fixture: Coaxial transmission line with 50 ohm characteristic impedance, coaxial connections on both ends, and space for an injection probe around the centre conductor
- e. Current probes
- f. Waveform recording device
- g. Attenuators, 50 ohm
- h. Measurement receivers
- i. Power amplifiers
- j. Coaxial loads, 50 ohm
- k. Signal generators
- l. Directional couplers

- m. 50  $\mu$ H LISNs

### 3.3 Setup

The test setup shall be as follows:

- a. Maintain a basic test setup for the EUT as shown and described in Figures 2 through 6 and paragraph 4.3.8 of Category 501.
- b. Calibration. Configure the test equipment in accordance with Figure NCS09-3 for verification of the waveform.
- c. EUT Testing:
  - (1) Configure the test equipment as shown in Figure NCS09-4.
  - (2) Place the injection and monitor probes around a cable bundle interfacing an EUT connector.
  - (3) Locate the monitor probe 5 cm from the connector. If the overall length of the connector and backshell exceeds 5 cm, position the monitor probe as close to the connector's backshell as possible.
  - (4) Position the injection probe 5 cm from the monitor probe.

### 3.4 Procedures

The test procedures shall be as follows:

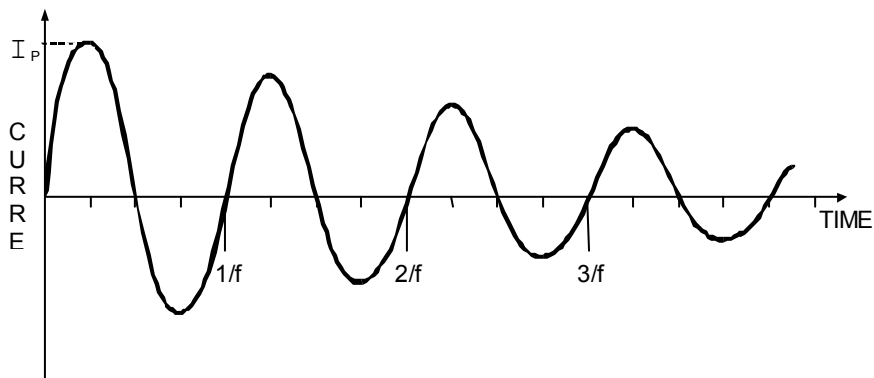
- a. Turn on the measurement equipment and allow sufficient time for stabilization.
- b. Calibration. Perform the following procedures using the calibration setup for waveform verification.
  - (1) Set the frequency of the damped sine generator at 10 kHz.
  - (2) Adjust the amplitude of the signal from the damped sine generator to the level specified in the requirement.
  - (3) Record the damped sine generator settings.
  - (4) Verify that the waveform complies with the requirements.
  - (5) Repeat 3.4b(2) through 3.4b(4) for each frequency specified in the requirement and those identified in 3.4c(2).
- c. EUT testing  
Perform the following procedures, using the EUT test setup on each cable bundle interfacing with each connector on the EUT including complete power cables. Also perform tests on each individual high side power lead (individual power returns and neutrals are not required to be tested).
  - (1) Turn on the EUT and measurement equipment to allow sufficient time for stabilization.
  - (2) Set the damped sine generator to a test frequency.
  - (3) Apply the test signals to each cable or power lead of the EUT sequentially. Slowly increase the damped sinewave generator output level to provide the specified current, but not exceeding the pre-calibrated generator output level. Record the peak current obtained.
  - (4) Monitor the EUT for degradation of performance.

- (5) If susceptibility is noted, determine the threshold level in accordance with Category 501 paragraph 4.3.10.4.3 and verify that it is above the specified requirements.
- (6) Repeat 3.4c(2) through 3.4c(5) for each test frequency as specified in the requirement. Repeat testing in 3.4c for the power-off condition.

### 3.5 Data presentation

Data presentation shall be as follows:

- a. Provide a list of the frequencies and amplitudes at which the test was conducted for each cable and lead.
- b. Provide data on any susceptibility thresholds and the associated frequencies that were determined for each connector and power lead.
- c. Provide indications of compliance with the requirements for the susceptibility evaluation specified in 3.4c for each interface connector.
- d. Provide oscilloscope photographs of injected waveforms with test data.



NOTES: 1. Normalized waveform:  $e^{-(\pi f t)/Q} \sin(2 \pi f t)$

Where:

$f$  = Frequency (Hz)

$t$  = Time (sec)

$Q$  = Damping factor,  $15 \pm 5$

2. Damping factor ( $Q$ ) shall be determined as follows:

$$Q = \frac{\pi(N - 1)}{\ln(I_P/I_N)}$$

Where:

$Q$  = Damping factor

$N$  = Cycle number (i.e.  $N = 2, 3, 4, 5, \dots$ )

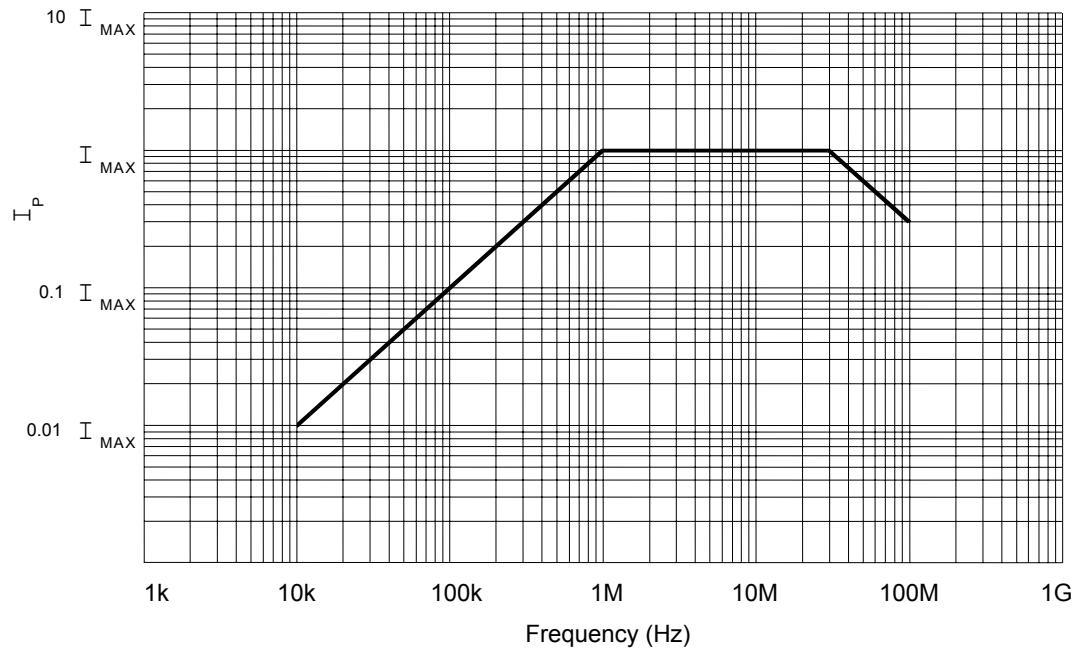
$I_P$  = Peak current at 1<sup>st</sup> cycle

$I_N$  = Peak current at cycle closest to 50% decay

$\ln$  = Natural log

3.  $I_P$  as specified in Figure NCS09-2

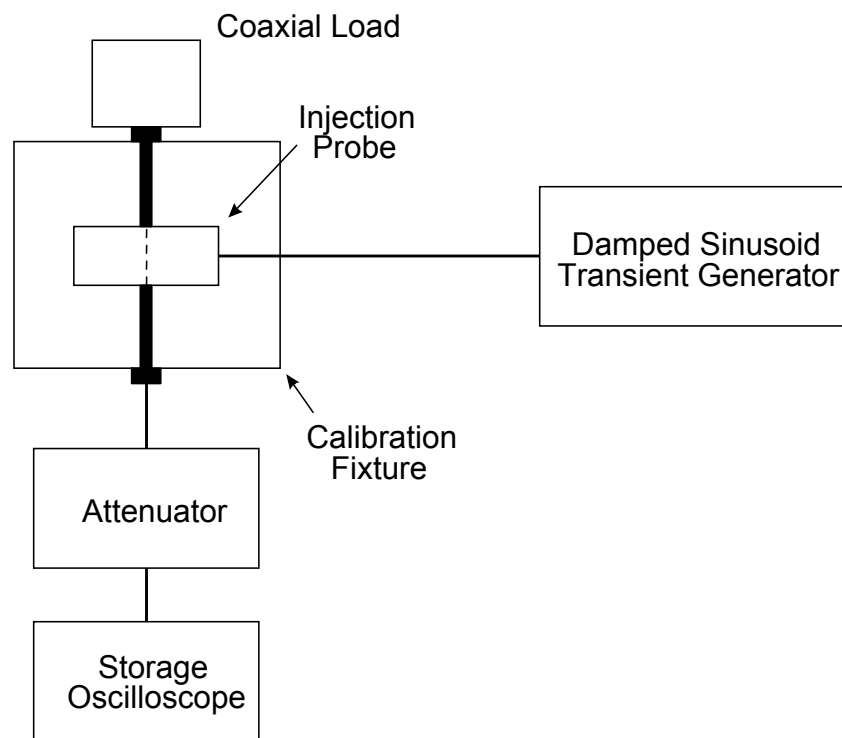
**FIGURE NCS09-1** Typical NCS09 Damped Sinusoidal Waveform.



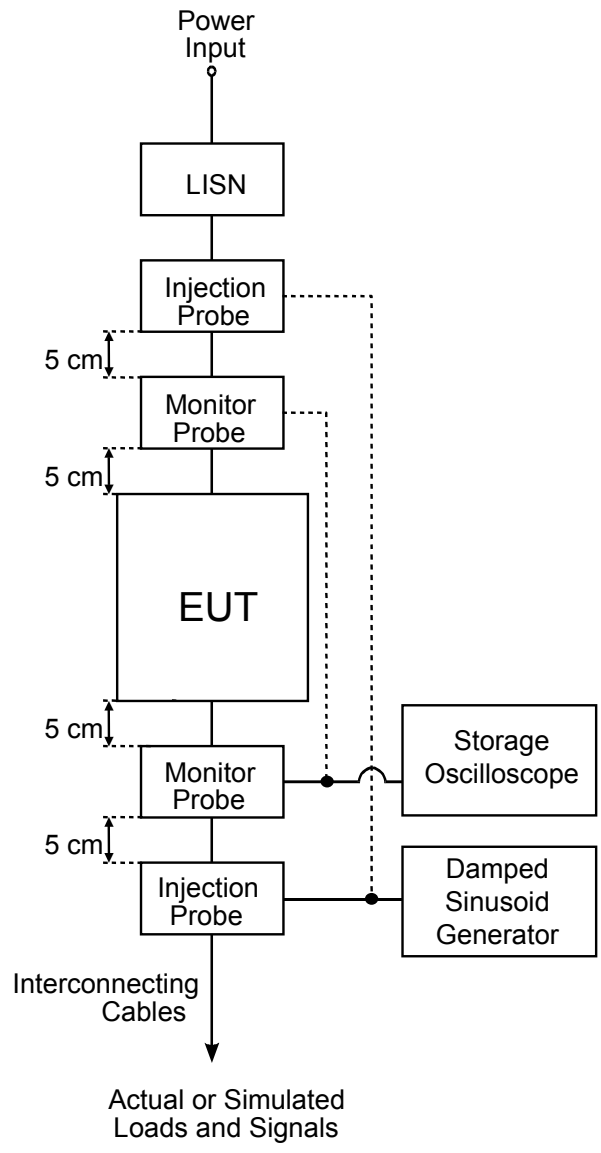
NOTES:

1. For Army and Navy procurements,  $I_{MAX}$  = 10 amperes
2. For Air Force procurements,  $I_{MAX}$  = 5 amperes

**FIGURE NCS09-2 NCS09 Limit for all Applications.**



**FIGURE NCS09-3** Typical Test Set-Up for Calibration of Test Waveform



**FIGURE NCS09-4** Typical Set-Up for Bulk Cable Injection of Damped Sinusoidal Transients

# **NCS10**

## **Conducted Susceptibility, Imported Lightning Transient Susceptibility (Aircraft)**

### TABLE OF CONTENTS

<b>1. NCS10 APPLICABILITY.....</b>	<b>NCS10-2</b>
<b>2. NCS10 LIMITS.....</b>	<b>NCS10-3</b>
<b>3. NCS10 TEST PROCEDURE.....</b>	<b>NCS10-3</b>
3.1 Purpose.....	NCS10-3
3.2 Test equipment .....	NCS10-3
3.3 Setup.....	NCS10-4
3.4 Procedures.....	NCS10-6
3.5 Data presentation.....	NCS10-8

## **NCS10**

### **Conducted Susceptibility Imported Lightning Transient Susceptibility (Aircraft)**

#### **1. NCS10 APPLICABILITY**

The test applies to all equipment fitted with electronic and active components, particularly non-linear items such as transistors or integrated circuits etc. for use in aircraft or any airforce procured land or ship based equipment, which may be considered flight safety critical for aircraft operation. Other types of equipment such as Motors, generators, relays, solenoids and transformers shall also be considered with regard to their function and vulnerability.

Because there is a close connection between the design requirements for protection against lightning Group Indirect Effects (GIE) and those covering EMC and Nuclear Electromagnetic Pulse (NEMP) considerations, the Lightning Protection Plan shall take account of EMC Requirements, and also of NEMP requirements if applicable. Lightning requirements shall be co-ordinated with these other requirements and any conflict of requirements in particular instances shall be noted in the Risk Assessment and proposals included for resolving the conflict.

Interface load boxes and exercising equipment shall, in respect of grounding and bonding, be representative of the installation including the mounting trays.

The test levels applied to equipment are derived from the locations and positions of the installed equipment. The maximum amplitudes for the test waveforms are chosen according to equipment categories A-D as shown in Table NCS10-1.

If any two units of an EUT are mounted less than 0.5 metres apart and their ground bonding points are to the same part of the aircraft structure, then this test is not applicable to the two units separately. In this case the two units will be regarded as a single EUT with their ground bonding leads joined together and tested with respect to other units comprising the EUT.

If any two units of an EUT are mounted less than 0.5 metres apart and have any of their ground bonding points connected to different parts of the aircraft structure, then the units shall be tested separately.

Some of the more complex EUTs may require clarification of the test method and approval of test plans and procedures by the respective Project Office.

The test object must contain all the pieces of equipment included in the system, all interconnecting wire bundles and all sensors that input critical or essential data into the system. Occasionally a piece of equipment may be omitted if its function can be represented by a simulated input, dummy load or be interfaced with a diagnostic equipment as long as such a substitution does not affect system susceptibility to a lightning related upset. Any substitution of system equipment, as described above, should be documented in the test plan and approved by the certification authorities prior to conducting the test. Depending upon the criticality of the sensor, additional testing of the sensor may be required. Reference should also be made to paragraph 6.18 of Category 501.

## 2. NCS10 LIMITS

The limits are shown in Table NCS10-1.

Category	Peak waveform amplitude, current and voltage					
	Short		Intermediate		Long	
	(V)	(A)	(V)	(A)	(V)	(A)
A	125	250	125	250	N/A	N/A
B	300	600	300	600	2000	1000
C	750	1500	750	1500	2000	3000
D	1600	3200	1600	3200	2000	10000

**TABLE NCS10-1 Peak Waveform Amplitude Limits.**

**NOTE** Some branches of the EUT harness will be very low impedance (shielded cables) and some high impedance (unshielded cables). The low impedance cables will have high current flow (up to 10,000 A) and the high impedance cables will have high voltages induced at the maximum generator outputs. It is important to note that the applicable limit is met when either the peak current or voltage reaches the required level.

When testing equipment using the long waveform if the voltage limit is reached before the current limit, testing should be stopped and then recommenced using the Intermediate waveform at CAT D levels.

## 3. NCS10 TEST PROCEDURE

### 3.1 Purpose

A direct lightning strike to an aircraft will result in the coupling of electrical transients to equipment wiring, including the EUT ground bonding straps. The purpose of this test is to ensure that these transients will not cause damage, malfunction or unacceptable performance degradation of the equipment. These performance criteria will be defined in the EMITP.

**NOTE:** Test NCE01 or NCE05 must have been performed prior to this test being conducted and repeated once testing has been completed. Reference paragraph 4.3.10.4.4 of Category 501.

### 3.2 Test equipment

The test equipment shall be as follows:

- a. Pulse generators: These generators provide a single uni-directional current pulse, which is injected into an equipment ground bonding lead to simulate the current induced by a direct lightning strike on an aircraft. Three different pulse waveforms are specified as 'short', 'intermediate', and 'long' in terms of pulse rise-time and duration; they are illustrated in Figure NCS10-1. The specific performance characteristics of the generator are as follows:
  - (1) Pulse characteristics Table NCS10-2 specifies the output waveform required of each type of pulse generator and shows the maximum peak short circuit current and maximum peak open circuit voltage to be provided.
  - (2) Amplitude control Equipment intended for operation in an exposed electromagnetic environment require testing with the high current and voltage levels shown in Table NCS10-2. For equipment to be operated in a protected electromagnetic environment, the current and voltage test levels are reduced by a factor of about 13 for both the short and intermediate pulses. The current for the long pulse is reduced by a factor of 10 but no reduction is made in the open circuit voltage.

Control of amplitude to meet the different test levels is essential while preserving the required waveform.

- (3) Generator design. A separate generator is likely to be required for each of the three waveforms.

The generator output requirements as specified in Table NCS10-2 shall be verified. The source impedance shall be verified at the output terminals and all other parameters verified using the output leads which will be used subsequently to connect the pulse generator to the EUT. Verification of both positive and negative polarity output waveforms are required. The output leads should be of solid copper, preferably not exceeding 75 mm in length with a cross-section of 25 mm x 2 mm.

Pulse Duration	Short	Intermediate	Long
Rise time to pk ( $\mu$ s)	0.1 (see Note 1)	6.4	50
Fall time to zero from start ( $\mu$ s)	6.4 (see Note 2)	-	-
Fall time to 50 % pk from start ( $\mu$ s)		70	500
Max short circuit current (kA)	0.32	1.0	10
Max open circuit voltage (kV)	1.6	5.0	2.0
Generator Source Impedance ( $\Omega$ )	5.0	5.0	0.2

**TABLE NCS10-2 Pulse Waveform and Output Characteristics.**

NOTE 1 This is the maximum time allowed to reach peak amplitude. All other times have a tolerance of  $\pm 20\%$ .

NOTE 2 After the zero crossing the pulse amplitude is permitted to undershoot but by no more than 20% of peak amplitude.

- b. Oscilloscope
- c. Current Monitor
- d. Capacitor, 30,000  $\mu$ F
- e. 5  $\mu$ H LISNs

### 3.3 Setup

#### 3.3.1 The test setup shall be as follows:

- a. A typical test layout is shown in Figure NCS10-4. The EUT should be laid out in accordance with the requirements of Category 501. It should be functioning and configured in a manner representative of the actual aircraft installation. Care must be taken to ensure that the LISNs used are rated to withstand the currents and voltages used in this test.
- b. The EUT must be isolated from the ground plane using 50 mm thick insulating material capable of withstanding the maximum test voltage.
- c. If special-to-type test, exercising equipment or other units, which do not form part of the operational EUT configuration are present, it must be confirmed that the grounding and bonding philosophy is fully representative of the aircraft installation. This is to ensure that the injected currents and voltages will be distributed around the EUT in a representative manner. It must also be ensured that equipment not part of the EUT are not affected by the testing and cannot give rise to erroneous fault conditions.

- d. Interconnecting layout cable bundles must be laid out in such a manner as to minimise any non-representative inductive interactions, i.e. only bunch together those cable bundles that would be run together in the aircraft installation.
- e. Identify the main grounding point for each unit of the EUT.
- f. Disconnect all local EUT grounding straps from the test facility ground plane, i.e. those grounding straps, safety grounds, signal grounds etc. which are intended to be grounded to the same part of the aircraft structure within 0.5 metres of the EUT. Connect the disconnected ends together to form an isolated grounding point for the EUT.
- g. Connect the pulse generator between the facility ground plane and the isolated EUT grounding point using the same test leads that were used for the calibration procedure.

#### 3.3.2 System Operating Mode(s):

- a. System operating modes should be considered prior to test. It is often required to test in multiple modes (i.e. for a Fully Automated Digital Electronic Control [FADEC] approach, take-off, cruise) and it must be established that all critical aspects of the system are adequately tested. The modes selected for testing and rationale should be defined clearly in the EMITP.

#### 3.3.3 System Configuration:

- a. Control of wire configuration, wire length, system layout and system grounding should be in accordance with applicable installation control drawings to the extent they are practical.

#### 3.3.4 External Ground Terminal:

- a. When external terminals are available for ground connection on the EUT, the terminal shall be connected to the ground plane to ensure safe operating conditions during the test, unless otherwise specified in the EMITP. The length of the ground connection defined in the installation instructions shall be used. If a length is not defined, approximately 30 cm of a representative wire or ground strap can be used.

#### 3.3.5 Interconnecting Cable Bundles:

- a. All EUT interconnecting wiring (e.g., shielded wires, twisted wires, etc.) cable bundles and RF transmission lines shall be in accordance with the applicable installation and interface control drawings or diagrams. Physical and electrical characteristics of wire bundle configurations, must match the actual installation as closely as possible. Actual production configuration wire bundles should be used where practical.
- b. Cables shall be bundled in a manner similar to that of the intended aircraft installation and supported approximately 50 mm above the ground plane. For complex cable bundle configuration, all cable bundles and interconnected loads should be kept separated from each other as much as is practical to minimise coupling effects between cables.
- c. Unless otherwise specified the cable bundle shall be at least 3.3 metres. When the length of an interconnecting cable bundle is greater than the test bench, the cable bundle should be arranged with the excess length zig-zagged at the back of the test bench approximately 50mm above the ground plane.
- d. Some special installations may require very long cable bundle lengths which cannot be accommodated on the test bench: therefore the recommended maximum length of the interconnecting cable bundles for these tests shall not exceed 15 metres. The exception to this limitation is where cable bundle lengths are matched or specified to a particular

length for phase match or similar reasons.

### 3.3.6 Power Leads:

- a. For cable bundle tests, power and return leads normally bundles with the control / signal leads shall remain in the cable bundle and only be separated from the bundle just prior to the cable bundle exiting the test area. These leads shall then be connected to the LISNs.
- b. When the actual aircraft cable bundle configuration is unknown or when power and / or return leads are normally routed separately from the control / signal leads, the power and return leads should be broken out of the cable bundle near the connector of the EUT and run separately to the LISNs. Under these conditions, the length of the leads to the LISNs shall not exceed 1 metre unless otherwise specified in the applicable equipment specification.
- c. When the return lead is a local ground (less than 1 metre length), this lead may be grounded directly to the test bench, in accordance with the applicable installation and interface control drawings or diagrams.

### 3.3.7 Interface Loads and Support Equipment:

- a. Cable bundle tests ideally should be performed on fully functioning equipment. EUTs should be suitably loaded actual interface equipment.
- b. When the interface equipment must be simulated, the simulated electrical, electronic and / or electromechanical characteristics of the loads should be representative of the aircraft installation. To avoid altering the voltage and current distributions in the cable bundles, the electrical / electronic loads should simulate the actual load line-to-line and line-to-ground impedances (including stray capacitance) as far as is practical.
- c. Care should be taken that any test configuration, simulated load or monitoring equipment does not alter the susceptibility or immunity of the EUT. Support equipment may require protection from the effects of the applied transients in order to avoid upset or damage.

### 3.3.8 Dummy Antenna or Loads:

- a. For the purpose of this test, antenna cables may be terminated in a load equal to the cable characteristic impedance, or a dummy antenna. The dummy antenna, if used shall be shielded and be designed to have electrical characteristics closely simulating the in-service antenna. It shall also contain electrical components normally used in the antenna, such as filters, crystal diodes, synchros and motors.

## 3.4 Procedures

The following safety considerations should be observed:

- a. The pulse generators used in these tests produce lethal voltages and suitable safety precautions must be taken. All personnel must be made aware of the potential hazards and instructed to follow the approved safety procedures of the Test House responsible for the conduct of the tests.
- b. When testing with the Long Waveform, in particular, it is advisable for personnel in the vicinity of the EUT to wear eye protection. Some components have been known to explode and project debris over distances of several metres.
- c. Some types of pulse generators can produce a high intensity burst of noise when they are fired. All personnel should be made aware of this and advised to wear ear protection.

### 3.4.1 Generator Performance Verification

- a. Connect the transient generator to the primary inputs of the injection transformer, see Figure NCS10-5.
- b. For each generator, record the voltage waveform with the calibration loop open and the current waveform with the calibration loop shorted. For the Single Stroke test verify the relevant waveshape parameters identified in Figure NCS10-1 and verify that the maximum designated test level (A or V) of Table NCS10-1 can be achieved.

### 3.4.2 Test Procedures

- a. Switch the EUT on and ensure that it is operating in accordance with the EMITP.
- b. Operate the pulse generator and increase the output from zero up to the test limit in steps not exceeding 10% of the required test limit. Apply at least 3 transients at each step, with a delay of at least 8s between each.
- c. If a malfunction occurs, record the applied peak current and voltage levels.
- d. If no malfunction occurs, increase the generator output until the peak current or peak voltage test limits is reached and then apply 10 transients, separated by at least 8 seconds, over a period of not more than 2 minutes. Record a typical set of the current and voltage waveforms that appear between the equipment case and earth
- e. Repeat the above procedure for both positive and negative polarity pulses.

### 3.4.3 Application of Test Waveforms

The Short waveform shall be applied to all EUTs. If it is known that a particular equipment is intended to be installed in an aircraft with a well-bonded, low impedance, largely metallic structure then the Intermediate pulse waveform shall be applied in addition to the Short pulse.

For equipment that is intended to be installed in largely Carbon Fibre Composite (CFC) airframes or equipment whose interconnecting wiring is run in areas covered by CFC panels then the Long pulse waveform shall be applied in place of the Intermediate waveform.

If it is not known where the equipment is to be installed then guidance should be sought from the relevant project office.

The four test categories are:

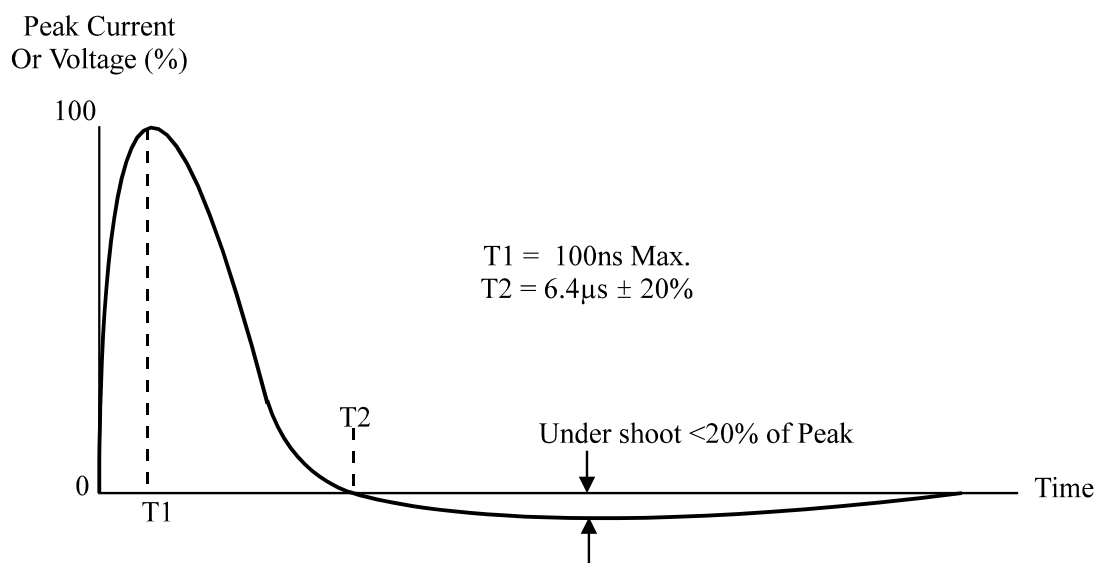
- a. CAT A Equipment and cabling installed in a protected electromagnetic environment such as a completely enclosed avionics bay in a metallic aircraft.
- b. CAT B Equipment and cabling installed in a partially exposed electromagnetic environment such as the cockpit of an aircraft with a largely metallic structure.
- c. CAT C Equipment and cabling bonded to the same part of the aircraft structure and installed in an exposed electromagnetic environment where large portions of the airframe are constructed from poorly conducting or CFC materials.
- d. CAT D Equipment and cabling bonded to different parts of the aircraft structure and installed in an exposed electromagnetic environment where large portions of the airframe are constructed from poorly conducting or CFC materials.

Where equipment and cables can be defined in more than one of the above categories then the test levels associated with the more severe environment shall be applied.

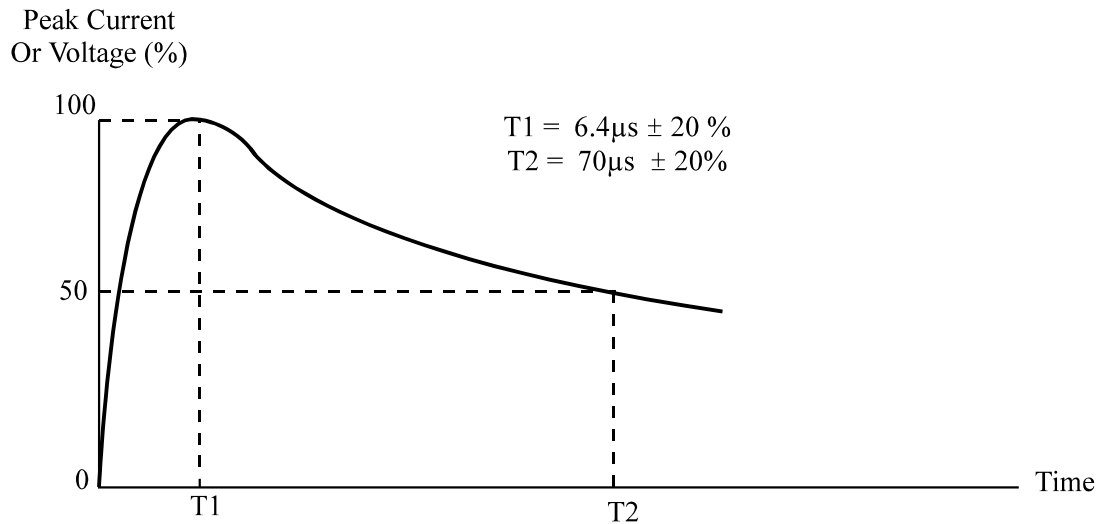
### 3.5 Data presentation

Data presentation shall be as follows:

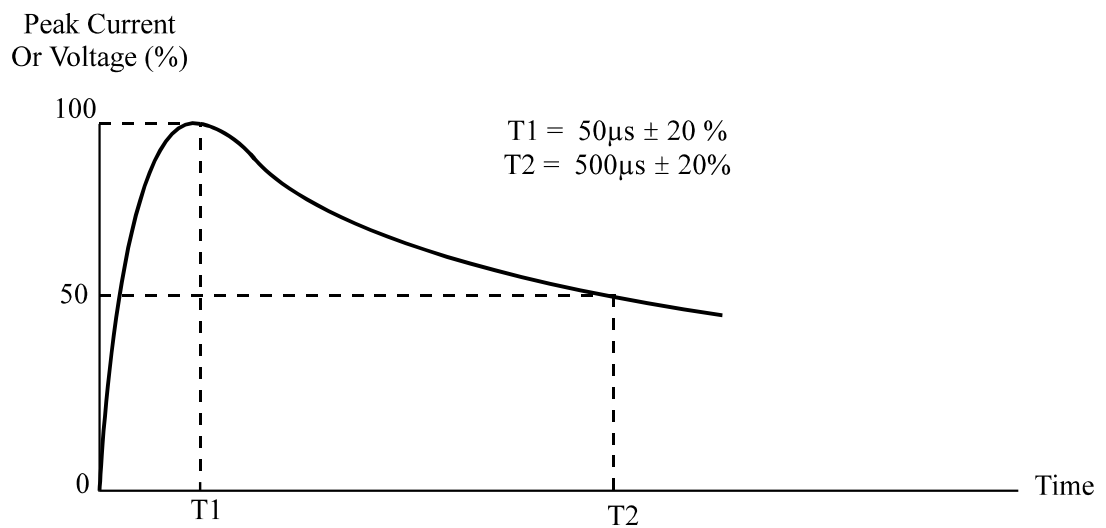
- a. Any malfunction, failure or damage of the equipment shall be investigated and recorded in the test report. If necessary, photographs of the damage shall be included.
- b. Where any oscillograms of the induced transient waveform are to be included in the test report, each oscillogram shall contain, as a minimum, the following information:
- c. Details of cable under test
- d. EUT mode of operation
- e. X axis – volts per division
- f. Y axis – time per division
- g. Transient Polarity
- h. Respective amplitudes achieved



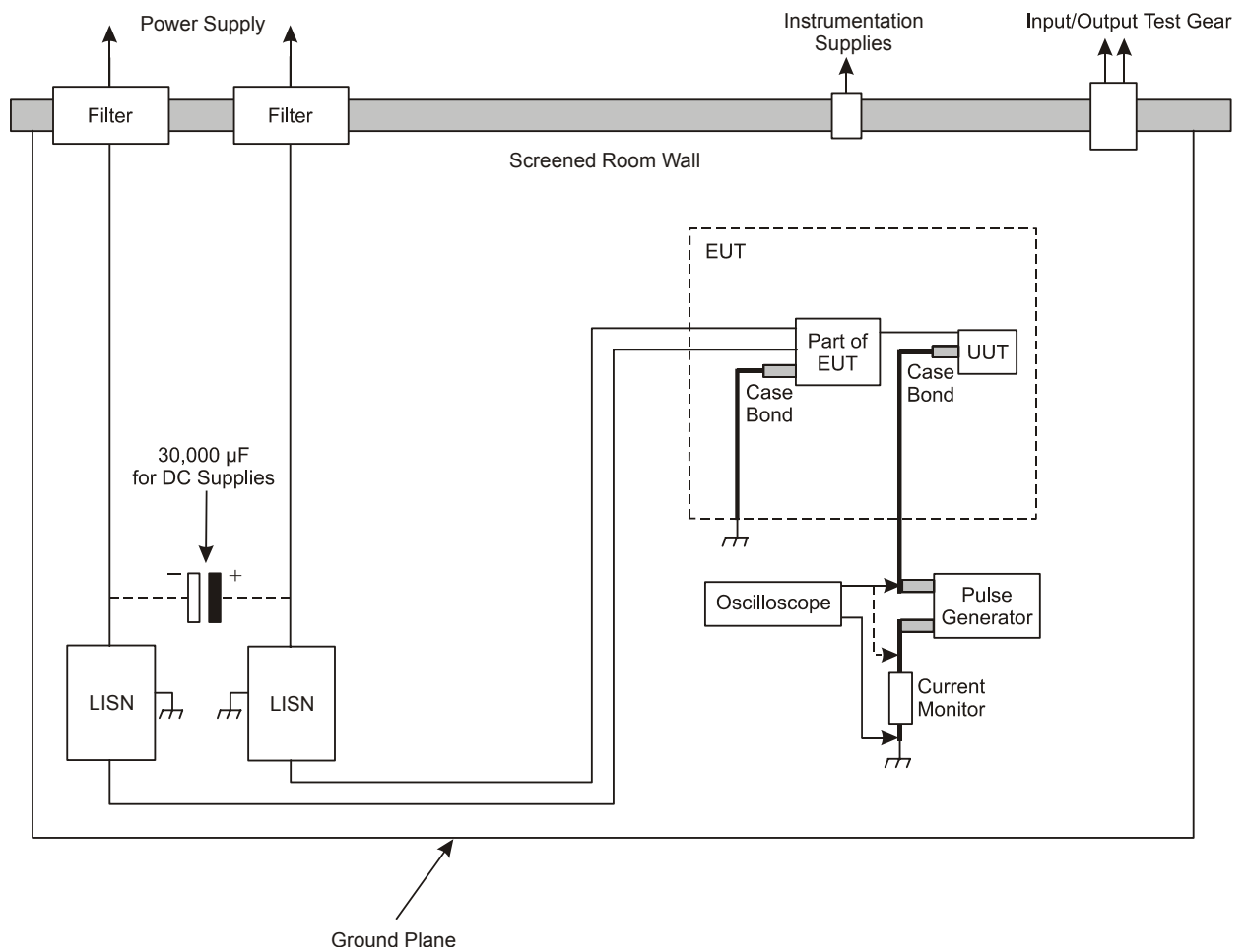
**FIGURE NCS10-1 Short Waveform.**



**FIGURE NCS10-2 Intermediate Waveform.**



**FIGURE NCS10-3 Long Waveform.**



**FIGURE NCS10-4 Typical Test Configuration.**

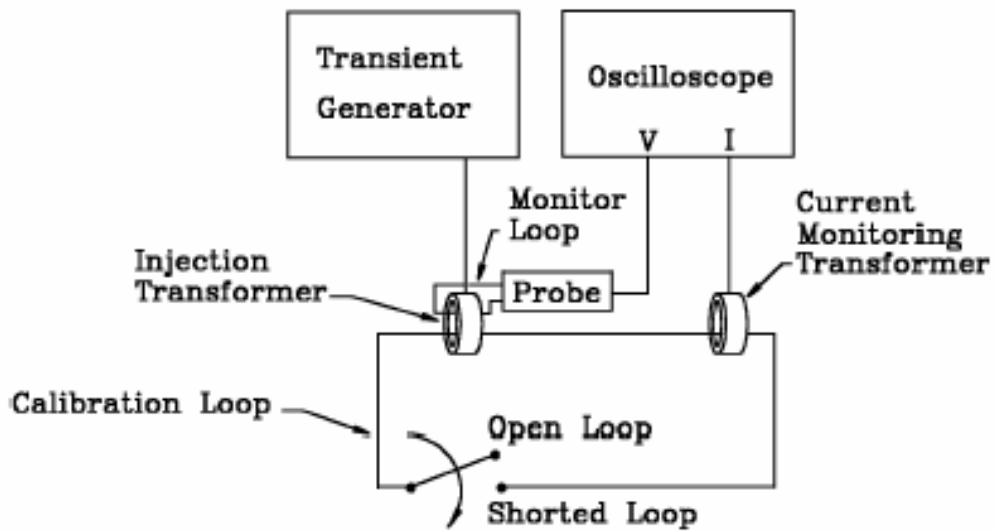


FIGURE NCS10-5 Typical Generator Performance Verification Set-up.

AECTP 500  
Edition 2  
Category 501  
Test NCS10

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# **NCS11**

## **Conducted Susceptibility, Imported Low Frequency Susceptibility Power Lines (Sea Systems)**

### TABLE OF CONTENTS

<b>1</b>	<b>NCS11 APPLICABILITY.....</b>	<b>NCS11-2</b>
<b>2</b>	<b>NCS11 LIMITS.....</b>	<b>NCS11-2</b>
<b>3</b>	<b>NCS11 TEST PROCEDURE.....</b>	<b>NCS11-2</b>
	3.1 Purpose.....	NCS11-2
	3.2 Test equipment.....	NCS11-2
	3.3 Setup.....	NCS11-3
	3.4 Procedures.....	NCS11-3
	3.5 Data presentation.....	NCS11-4

# NCS11

## Conducted Susceptibility Imported Low Frequency Susceptibility Power Lines (Sea Systems)

### 1 NCS11 APPLICABILITY

This test applies to all equipment in use in the Sea Systems environment connected to ship and submarine power supplies. Positive-going and negative-going, damped sinewave transients between 10 to 16 kHz, are to be applied to individual supply lines of a EUT, for both AC and DC incoming supplies. Battery operated equipment which may be connected to a platform supply, for example, during battery charging, shall also be subjected to this test. Reference should also be made to paragraph 6.19 of Category 501.

### 2 NCS11 LIMITS

The EUT shall continue to function properly, during and after the application of the transients whose levels are specified in Table NCS11-2.

**NOTE** When applying transients to the EUT the peak voltage recorded on the oscilloscope may be different from that seen during the generator check if the input impedance of the EUT and LISN in series is different from  $10 \Omega \pm 5\%$  at the frequency of the transient.

### 3 NCS11 TEST PROCEDURE

#### 3.1 Purpose

The purpose of this test is to confirm that the EUT will withstand imported low frequency transients imposed upon its power supply lines. This test simulates the effect of voltage transients observed due to switching of machines and other loads on ship and submarine power supply systems.

#### 3.2 Test equipment

The test equipment shall be as follows:

- a. Transient generator
- b. Differential Oscilloscope Probe
- c. Oscilloscope
- d. Resistor,  $10 \Omega \pm 5\%$
- e. 5  $\mu$ H LISNs
- f. Capacitor, 30,000  $\mu$ F

The generator is intended to simulate imported low frequency damped sinusoid transients, imposed on power lines. The generator shall incorporate an output transformer having a secondary winding to be connected in series with the power line under test. The generator shall be capable of providing three alternative fixed output voltages. The specific performance characteristics of the generator output, when the secondary winding is terminated with a  $10 \Omega \pm 5\%$  low inductance resistor, are shown in Table NCS11-1 with typical waveforms given in Figures NCS11-1 and NCS11-2.

Output voltage (Vpk) $\pm$ 10% (Note 1)	600	750	2500
Frequency (kHz) $\pm$ 10% (Note 2)	15.9	15.9	10.9
Relative amplitude of 3 <sup>rd</sup> 1/2 cycle (Note 3)	0.6 – 0.8	0.6 – 0.8	0.2 – 0.3
Output impedance ( $\Omega$ ) $\pm$ 10% (Note 4)	0.15	0.4	2.5

**TABLE NCS11-1 Generator performance characteristics.**

NOTE 1 Specified as the amplitude of the first half cycle i.e. Vpk.

NOTE 2 Calculated from the combined duration of the first three half cycles.

NOTE 3 Calculated by dividing the peak voltage of the third cycle by Vpk..

NOTE 4 Specified as the value of resistance which, when connected across the secondary winding, reduces the winding voltage (amplitude of first half cycle) to half the open circuit voltage.

### 3.3 Setup

The test setup shall be as follows:

- a. A typical test layout is shown in Figure NCS11-3.
- b. The equipment under test shall be installed in the test house in such a way as to accurately simulate the intended platform installation. The secondary of the injection transformer shall be wired into each line under test at the LISN end.
- c. Prior to the in-line connection of the transient generator secondary winding, the output of the generator, when terminated with a  $10 \Omega \pm 5\%$  low inductance resistor, shall be checked to be compliant with the test levels shown in Table NCS11-2.

EUT Supply Voltage (V)	Peak Voltage Across 10 $\Omega$ Resistor (V)
440 V 60Hz 170 - 720 V DC	2500 $\pm$ 15%
115V 60/400Hz	750 $\pm$ 10%
24 V DC	600 $\pm$ 10%

**TABLE NCS11-2 Level of Applied Transients.**

### 3.4 Procedures

The test procedures shall be as follows:

- a. Conducted emission test NCE01 must have been performed prior to performing this test.

**NOTE** If this test has been performed as part of the trial then this is acceptable.

- b. With the transient generator connected in series with the supply line under test, the EUT is to be checked for correct function and operation prior to the application of the transients.
- c. Each supply line in turn shall then be subjected to twelve positive-going applications of the transient using the generator output settings appropriate to the EUT supply voltage as shown in Table NCS11-3 followed by twelve negative-going transients. These transients shall be applied at a rate of one every 2 to 5 seconds.
- d. The generator output waveform shall be monitored on the oscilloscope. The voltage induced into the cable under test and photographs of the induced transient waveform may be recorded for inclusion in the test report.
- e. During each transient application, the EUT shall be monitored for degradation of performance, damage or malfunction as defined in the EMC test plan. When testing digital systems it may be necessary to apply a greater number of transients to ensure detection of any malfunction. In this case, the EMITP should include some guidance to ensure capture of a malfunction during test.
- f. On completion of all transient applications, conducted emission test NCE01 shall be repeated to confirm that any power line filter have not been damaged. This resultant emission profile shall be assessed against the NCE01 result obtained prior to the transient application. This shall determine whether any damage to the EUT occurred during application of the transients, i.e. Filtering or other component damage. Should any significant changes in emission profile be evident then a FAIL result shall be recorded for this test even if the emission profile has been reduced due to the application of the transient.

**NOTE** The conducted emission assessment is not intended to show compliance against the NCE01 limits but is used solely to compare the 'before' and 'after' emission profiles.

### 3.5 Data presentation

Data presentation shall be as follows:

- a. Any malfunction, failure or damage of the equipment shall be investigated and recorded in the test report.
- b. Where any oscilloscope photographs of the induced transient waveform are to be included in the test report, each photograph shall contain, as a minimum, the following information:

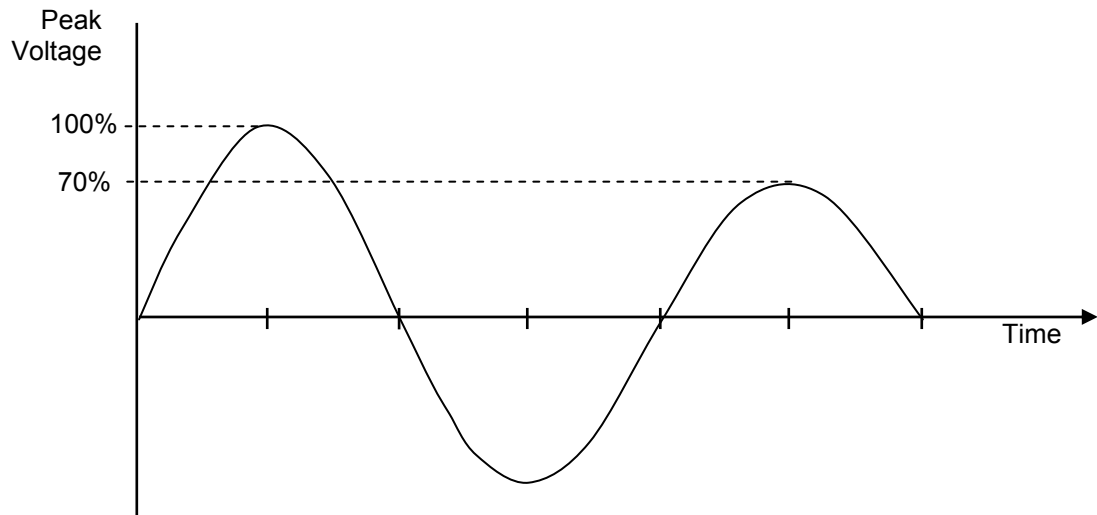
Details of cable under test

EUT mode of operation

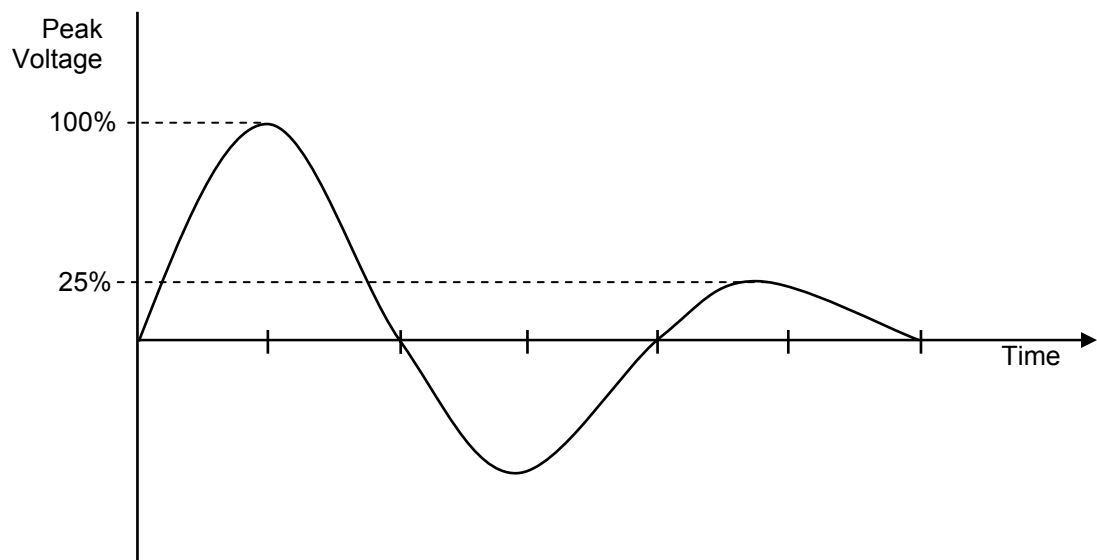
X axis – volts per division

Y axis – time per division

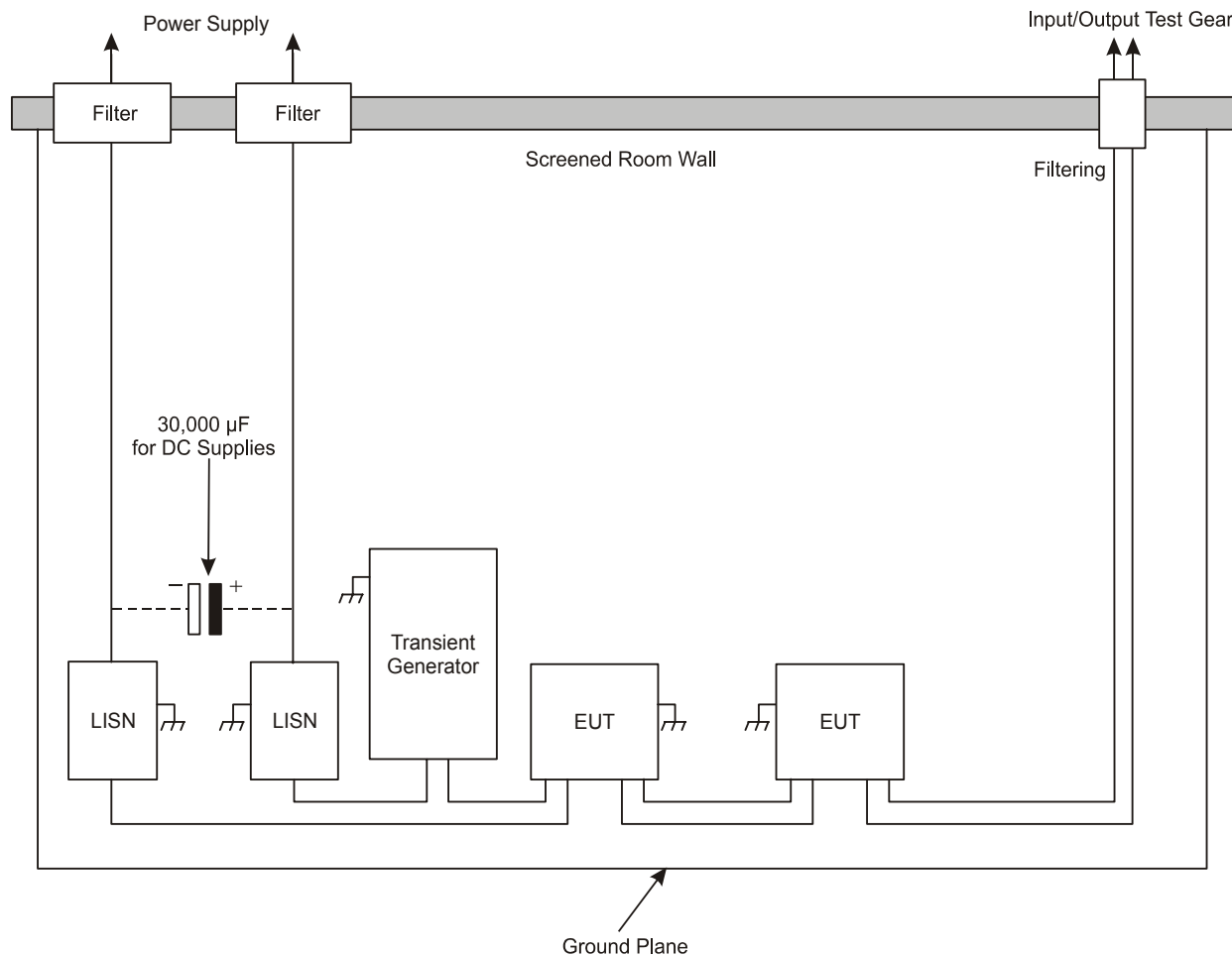
Transient polarity



**FIGURE NCS11-1** Typical Transient Waveform (600V and 750V transients).



**FIGURE NCS11-2** Typical Transient Waveform (2500V transients).



**FIGURE NCS11-3 Typical Test Configuration.**

# **NCS12**

## **Electrostatic Discharge**

### TABLE OF CONTENTS

<b>1</b>	<b>NCS12 APPLICABILITY.....</b>	<b>NCS12-2</b>
<b>2</b>	<b>NCS12 LIMIT .....</b>	<b>NCS12-2</b>
<b>3</b>	<b>NCS12 TEST PROCEDURE.....</b>	<b>NCS12-3</b>
	3.1 Purpose.....	NCS12-3
	3.2 Test equipment .....	NCS12-3
	3.3 Setup.....	NCS12-4
	3.4 Procedures.....	NCS12-5
	3.5 Data presentation.....	NCS12-5

## NCS12

### Electrostatic Discharge

#### 1 NCS12 APPLICABILITY

The purpose of this test is to determine whether electrostatic discharges (ESD) transferred to equipment by personnel contact will damage the EUT or lead to the malfunctioning and degradation of its performance

In service, electrostatic discharges result from charges built up by friction between materials, such as clothing, and inadvertently transferred to equipment by personnel, either directly or indirectly. This test simulates the above process by the use of a high voltage generator, charge storage capacitor and discharge probe.

This test applies to all Air equipment fitted with electronic and active components, particularly non-linear items such as transistors or integrated circuits etc, including Land and Sea Systems equipment if operated in an air-conditioned or protected environment.

This test method utilises the contact technique of applying large ESD transients to EUTs and the limits and equipment classifications are as shown below. The discharges are normally directed to points on the front panel of the EUT, e.g. keyboards, knobs, switches, buttons and indicators, LEDs, slots, grilles, connectors and any metallic parts on the outside of the EUT electrically isolated from ground. Specific points shall be detailed in the EMITP. Where the EMITP specifies non-conductive surfaces to be tested, the contact method shall be substituted by the air discharge method.

Reference should also be made to paragraph 6.20 of Category 501.

#### 2 NCS12 LIMIT

Equipment shall withstand discharges as specified above at charging voltages appropriate to the Category of the equipment, without malfunction or disturbance.

For Air service the tests shall be applied at one of two severity levels, depending on the category of the equipment:

- a. Category A Safety critical in that the safety of personnel or third parties is placed at risk either directly or indirectly from malfunctioning of the equipment (and hence subsequently the materiel).
- b. Category B Mission critical in that malfunctioning or upset of the equipment functions either reduces, damages or prevents the materiel from performing the mission.

ESD testing of Air service equipment not in either of these categories is not normally required but is at the discretion of the Procuring Agencies.

Land service equipment should be subjected to this test method where it is likely to be deployed in environments that give rise to ESD events, such as the dry atmospheric conditions associated with desert scenarios or air-conditioned rooms.

It is not normally required that sea service equipment be subjected to this test method, however if the EUT is to be deployed within an air conditioned environment then this test should be performed.

All equipment deployed in a support role within a classroom or office environment is subject to this test.

Charging Voltage (kV)	Category A Safety critical	Category B Mission critical
2	No	Yes
4	Yes	Yes
6	Yes	Yes
8	Yes	No

**TABLE NCS12-1 Application of Charging Voltages by Equipment Category.**

NOTE 1: For Munitions testing, the test levels and methods in STANAGs 4235 and 4239 shall be applied.

NOTE 2: When using the air discharge method, a level of 15 kV must be applied in addition to those shown in Table NCS12-1 for both Category A and Category B EUTs.

### 3 NCS12 TEST PROCEDURE

#### 3.1 Purpose

The ESD generator is intended to simulate the current pulse, which arises when a person carrying an electric charge dissipates that charge on contact with the equipment under test (EUT).

#### 3.2 Test equipment

##### a. ESD Generator - Characteristics of the ESD generator

**Basic design of generator:** The basic circuit of the generator is shown in Figure NCS12-1. A capacitor ( $C_s$ ) can be charged to a specified voltage and then discharged through the series resistor ( $R_d$ ) and discharge tip using either the "contact" or "air" discharge methods. In the contact discharge method the discharge tip is held in contact with the EUT and the discharge actuated by the discharge switch within the generator. In the air discharge method the charged electrode of the generator is brought close to the EUT and the discharge actuated by a spark to the EUT. The discharge tip geometry for both air and contact discharge methods is shown in Figure NCS12-2.

**Output waveform:** The output current waveform, when the generator is discharged through a  $2\ \Omega$  calibration resistance, is defined by the rise time to peak. The current, as a percentage of the peak value, shall be measured 30 ns from the start of the waveform and then 60 ns from start. A typical waveform is shown in Figure NCS12-3. The rise time (10% to 90% of peak amplitude) is in the range 0.7 ns to 1.0 ns, the current at 30 ns is nominally 53% of peak amplitude and at 60 ns, 27% of peak amplitude. The generator output waveform will be dependent, to some extent, on the inductance of the generator earthing lead. For this reason the same physical lead, in as far as possible the same physical configuration, shall be used both for verifying generator performance and for testing the equipment. It is important that the test oscilloscope (recommended minimum bandwidth 1 GHz) is adequately shielded from energy radiated by the electrostatic discharge and from energy conducted into its power supply.

**Waveform verification:** Prior to application of the test the output waveform of the ESD generator must be verified, this is performed with an oscilloscope and a discharge target fixed on a conductive mounting plate measuring 1.5 m x 1.5 m. The Oscilloscope is connected to the rear of the target via an attenuator so that the voltage seen at its input

is reduced to levels that will not damage the instrument. An oscilloscope with a minimum bandwidth of 1 GHz with a storage facility must be used to capture and display the fast rise times of the pulse generated. The oscilloscope should be well shielded from the ESD generator so as not to be adversely effected by the pulse and it may be necessary to insert additional screening between it and the target. An earth return lead connects the generator to a stud on the aluminium sheet to complete the circuit, see Figure NCS12-4 for the calibration set up.

b. ESD Generator Performance

Characteristics Figure NCS12-5 shows a typical ESD calibration circuit arrangement. The required output current characteristics, using contact discharge and calculated from the voltage measured across the 2  $\Omega$  resistor, are shown in Table NCS12-2 for four test voltages.

Required Charging Voltage (kV)	1st Peak Discharge Current (A $\pm$ 10%)	Current (A $\pm$ 30%) after 30 ns	Current (A $\pm$ 30%) after 60 ns
2	7.5	4	2
4	15.0	8	4
6	22.5	12	6
8	30.0	16	8

**TABLE NCS12-2 ESD Generator Output Requirements.**

NOTE 3: The required rise time (10% to 90% of peak current) shall be in the range 0.7ns to 1.0ns for all charging voltages.

The general outline technical characteristics of the generator shall be compliant with Table NCS12-3.

Characteristic	Performance Requirement
Discharge storage capacitor	150 pF $\pm$ 10%
Discharge Resistor	330 $\Omega$ $\pm$ 10%
Extra High Tension (EHT) output	Up to 15 kV DC
EHT metering	2 kV to 12 kV $\pm$ 5%
Output polarity	Positive and negative (switchable)
Holding time	The ESD generator shall be able to hold its charge for at least 5 s without falling below 90% of its pre-set value.
Discharge modes	(a) Single discharge (b) Repetitive discharge (c) Contact discharge
Output current	The output current waveform developed in the 2 $\Omega$ calibration resistor shall be as shown in Figure NCS12-3.

**TABLE NCS12-3 Outline Technical Characteristics of ESD Generator.**

3.3 Setup

The test setup shall be as follows:

- a. The EUT shall be set up as shown in Figure NCS12-6 and in order to minimise the impact of environmental parameters on test results, the tests shall be carried out under the following laboratory conditions:
- (1) Ambient Temperature: 15°C to 35°C
  - (2) Relative Humidity: 30 % to 60 %

- b. Verify the test waveform using an oscilloscope and test target.
- c. Connect any EUT earth bond connections to the ground reference plane and support EUT on 50 mm stand offs above ground plane surface.
- d. Connect the discharge return lead to the ground reference plane.

#### 3.4 Procedures.

The test procedures shall be as follows:

- a. The tests shall be conducted by applying discharges to each of the specified application points listed in the EMITP, using the charging voltage sequence 2, 4, 6 and 8 kV until the limit for the EUT category is reached. For each charging voltage, five discharges shall be applied at each point for each polarity, allowing a 10s interval between discharges. The tests shall be repeated for each mode of operation of the EUT and all malfunctions and disturbances, whether temporary or permanent, shall be recorded.
- b. Where the air discharge method is used on non-conductive surfaces the generator will be set to a repetition rate of 20 pulses per second and the generator's discharge tip should be moved slowly across the area to be tested. The test engineer should note any discharges seen and their effect on the EUT's operation in the test report.

#### 3.5 Data presentation.

Data presentation shall be as follows:

- a. A clear record of all discharge points, either in a table or as a diagram, must be kept by the test house and included in the EMITR.
- b. Descriptions of any failure observed should be recorded with the appropriate level and contact position and included in the EMITR.
- c. Graphical evidence of the discharge gun's compliance with the specified waveform during the verification test should be retained by the test house and included in the EMITR.
- d. All malfunctions, disruptions or anomalous behaviour of the EUT during ESD, whether such manifestations occur during charging of the ESD generator, during the discharge, or during recovery shall be recorded in the EMITR.

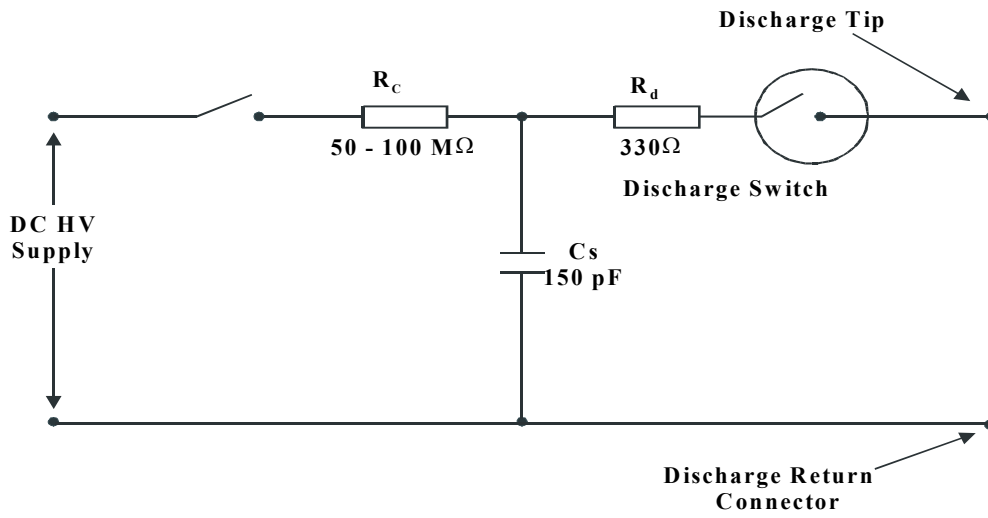


FIGURE NCS12-1 Simplified Circuit Diagram of the ESD Generator.

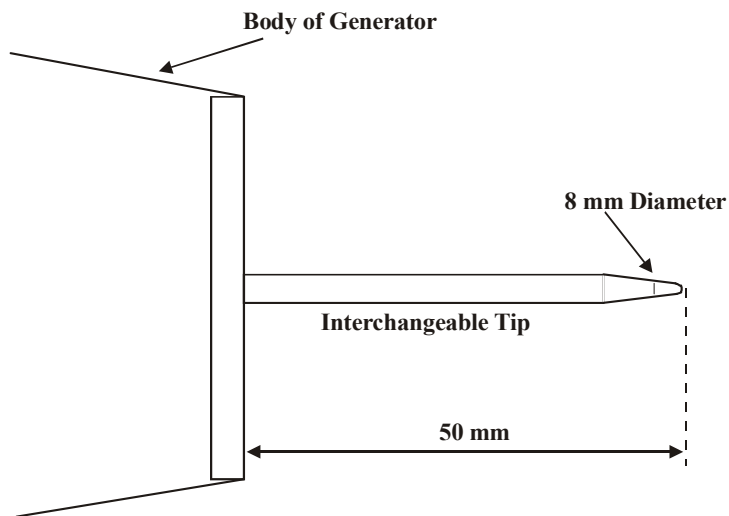


FIGURE NCS12-2 ESD Generator Discharge Tip Geometry.

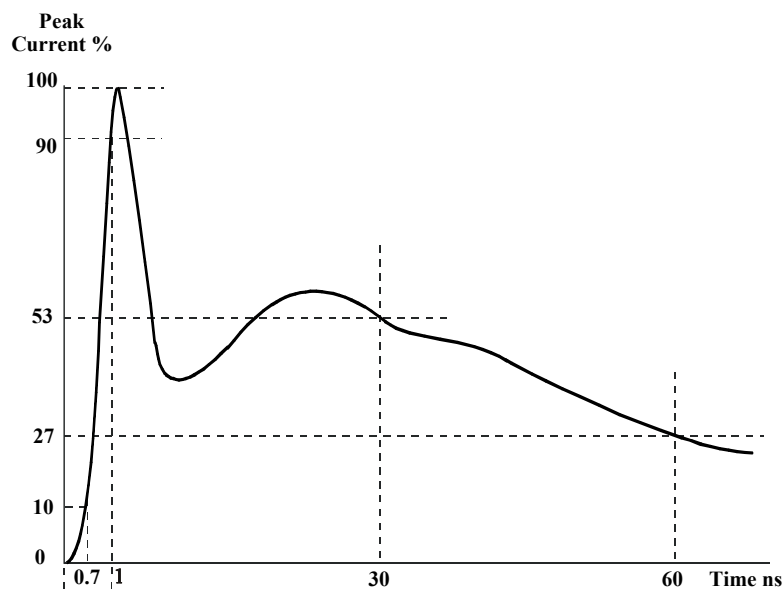


FIGURE NCS12-3 Typical Type 4 ESD Waveform.

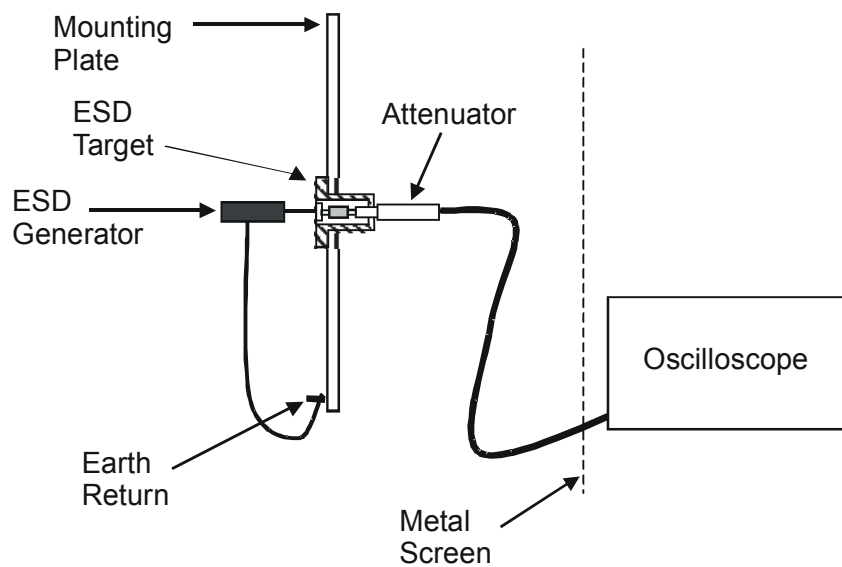


FIGURE NCS12-4 Generator Calibration set-up.

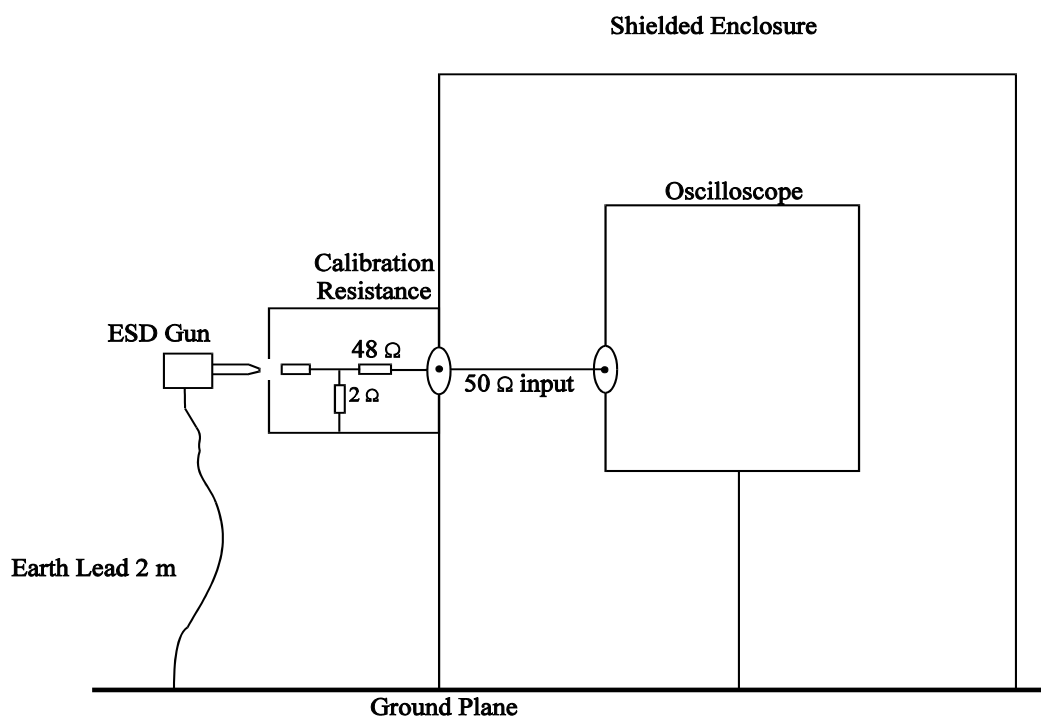


FIGURE NCS12-5 ESD Calibration Arrangement.

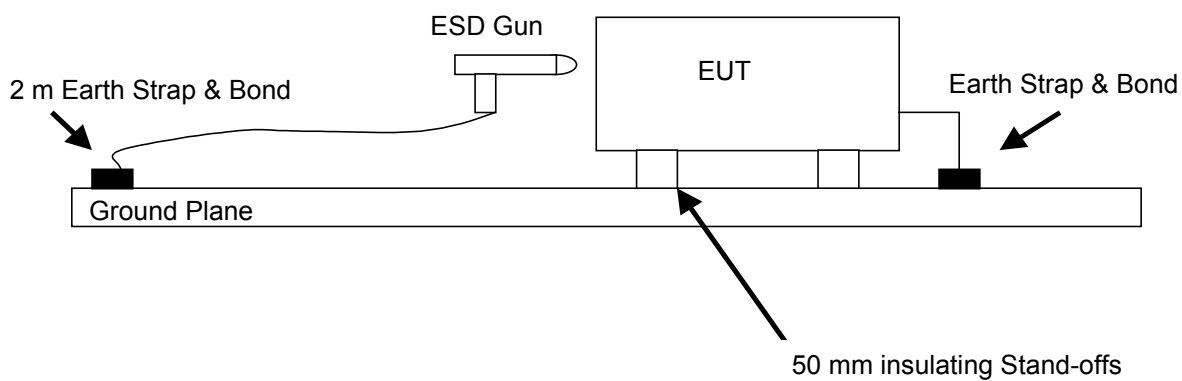


FIGURE NCS12-6 Typical Test Configuration.

# **NRE01**

## **Radiated Emissions, Magnetic Field, 30 Hz to 100 kHz**

### TABLE OF CONTENTS

<b>1</b>	<b>NRE01 APPLICABILITY.....</b>	<b>NRE01-2</b>
<b>2</b>	<b>NRE01 LIMIT .....</b>	<b>NRE01-2</b>
<b>3</b>	<b>NRE01 TEST PROCEDURES .....</b>	<b>NRE01-2</b>
	3.1 Purpose.....	NRE01-2
	3.2 Test Equipment.....	NRE01-2
	3.3 Setup.....	NRE01-2
	3.4 Procedures.....	NRE01-3
	3.5 Data Presentation .....	NRE01-3

## **NRE01**

### **Radiated Emissions, Magnetic Field, 30 Hz to 100 kHz**

#### **1 NRE01 APPLICABILITY**

This requirement is applicable for radiated emissions from equipment and subsystem enclosures, including electrical cable interfaces. The requirement does not apply to radiation from antennas. Aircraft fitted with Anti-Submarine Warfare (ASW) capability should be tested using the Sea application limit. Reference should also be made to paragraph 6.21 of Category 501.

#### **2 NRE01 LIMIT**

Magnetic field emissions shall not be radiated in excess of the levels shown in Figures NRE01-1 to NRE01-3 at a distance of 7 centimeters.

#### **3 NRE01 TEST PROCEDURES**

##### **3.1 Purpose**

This test procedure is used to verify that the magnetic field emissions from the EUT and its associated electrical interfaces do not exceed specified requirements.

##### **3.2 Test Equipment**

The test equipment shall be as follows:

- a. Measurement receivers
- b. Data recording device
- c. Loop sensor having the following specifications:
  - (1) Diameter: 13.3 cm
  - (2) Number of turns: 36
  - (3) Wire: 7-41 Litz wire (7 strand, No. 41 AWG)
  - (4) Shielding: Electrostatic
  - (5) Correction factor See manufacturer's data for factors to convert measurement receiver readings to decibels above one picotesla (dBpT).
- d. 50 $\mu$ H LISNs
- e. Ohmmeter
- f. Signal generator

##### **3.3 Setup**

The test setup shall be as follows:

- a. Maintain a basic test setup for the EUT as shown and described in Category 501 figures 3 through to 6 and paragraph 4.3.8.
- b. Calibration. Configure the measurement setup as shown in Figure NRE01-4.

- c. EUT Testing. Configure the measurement receiving loop and EUT as shown in Figure NRE01-5.

### 3.4 Procedures

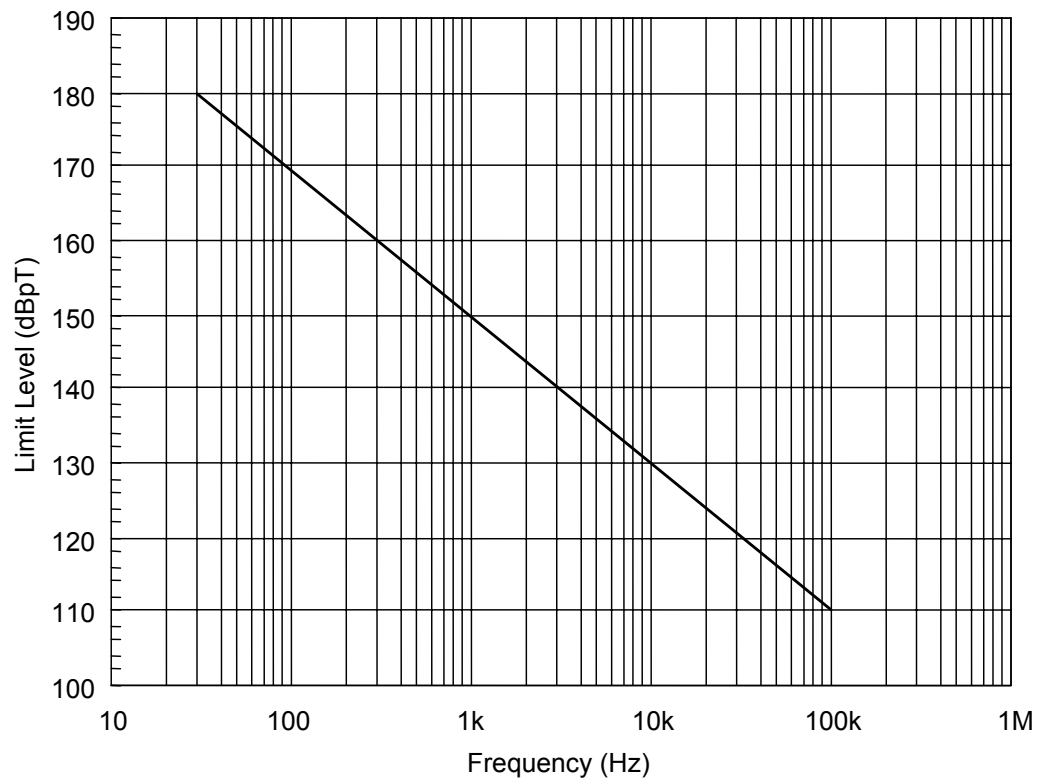
The test procedures shall be as follows:

- a. Turn on the measurement equipment and allow sufficient time for stabilization.
- b. Calibration.
  - (1) Apply a calibrated signal level, which is at least 6 dB below the limit (limit minus the loop sensor correction factor), at a frequency of 50 kHz. Tune the measurement receiver to a center frequency of 50 kHz. Record the measured level.
  - (2) Verify that the measurement receiver indicates a level within  $\pm 3$  dB of the injected signal level.
  - (3) If readings are obtained which deviate by more than  $\pm 3$  dB, locate the source of the error and correct the deficiency prior to proceeding with the testing.
  - (4) Using an ohmmeter, verify that the resistance of the loop sensor winding is approximately  $10 \Omega$ .
- c. EUT Testing
  - (1) Turn on the EUT and allow sufficient time for stabilization.
  - (2) Locate the loop sensor 7 cm from the EUT face or electrical interface connector being probed. Orient the plane of the loop sensor parallel to the EUT faces and parallel to the axis of connectors.
  - (3) Scan the measurement receiver over the applicable frequency range to locate the frequencies of maximum radiation, using the bandwidths and minimum measurement times of Table 2 of Category 501.
  - (4) Tune the measurement receiver to one of the frequencies or band of frequencies identified in 3.4c(3) above.
  - (5) Monitor the output of the measurement receiver while moving the loop sensor (maintaining the 7 cm spacing) over the face of the EUT or around the connector. Note the point of maximum radiation for each frequency identified in 3.4c(4).
  - (6) At 7 cm from the point of maximum radiation, orient the plane of the loop sensor to give a maximum reading on the measurement receiver and record the reading.
  - (7) Repeat 3.4c(4) through 3.4c(6) for at least two frequencies of maximum radiation per octave of frequencies below 200 Hz and for at least three frequencies of maximum radiation per octave above 200 Hz.
  - (8) Repeat 3.4c(2) through 3.4c(7) for each face of the EUT and for each EUT electrical connector.

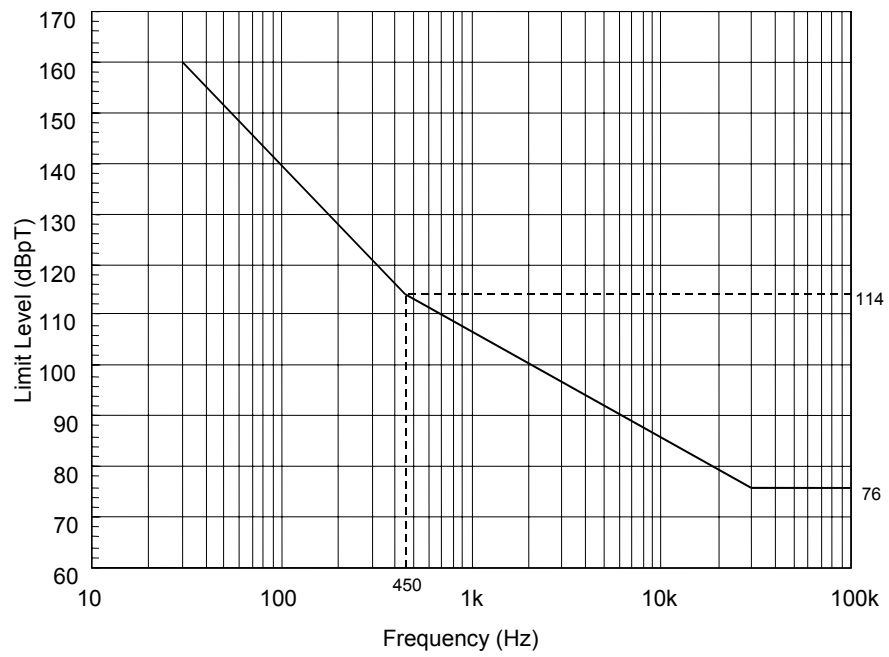
### 3.5 Data Presentation

Data presentation shall be as follows:

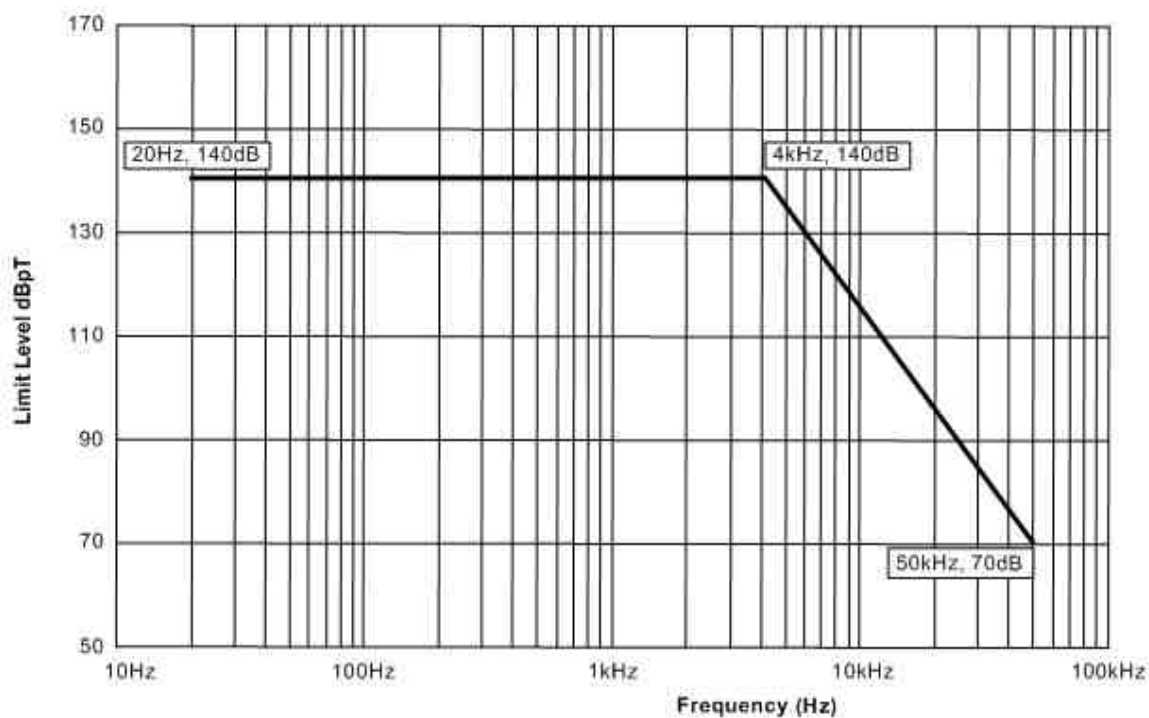
- a. Provide graphs of scans and tabular listings of each measurement frequency, mode of operation, measured magnetic field, and magnetic field limit level.



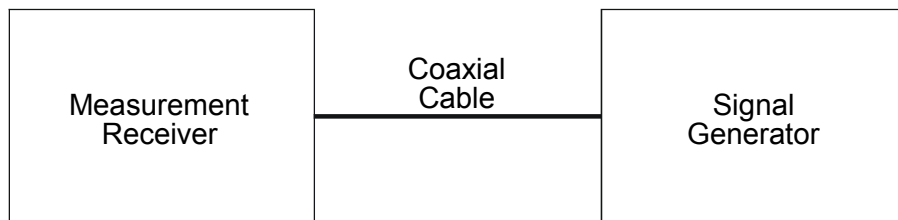
**FIGURE NRE01-1** Limit for all Land applications.



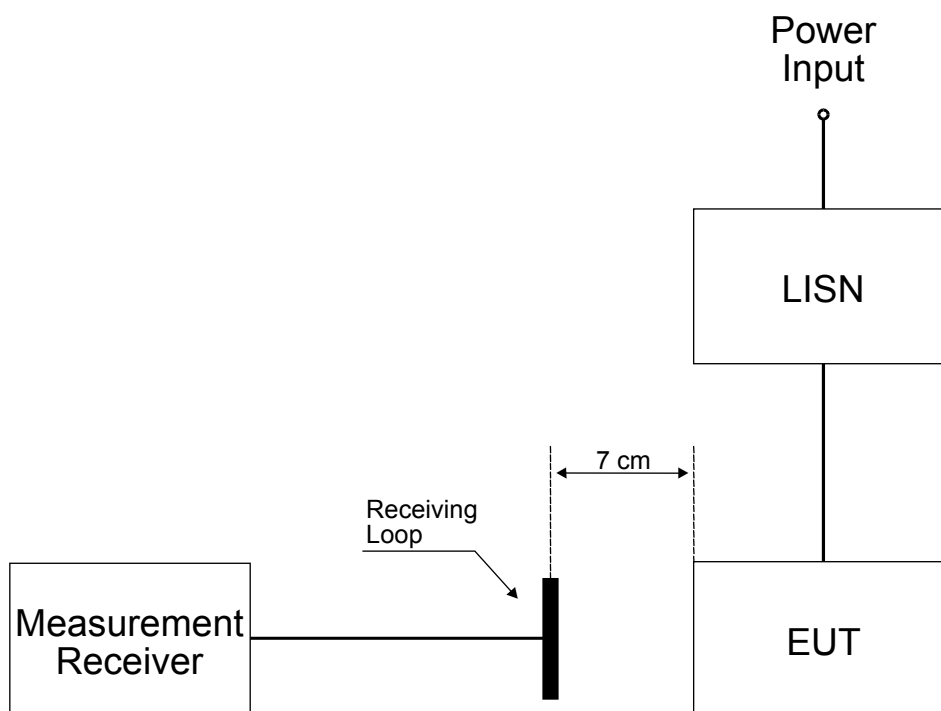
**FIGURE NRE01-2** Limit for all Sea applications.



**FIGURE NRE01-3** Limit for all Air applications.



**FIGURE NRE01-4 Calibration configuration.**



**FIGURE NRE01-5 Basic test set-up.**

AECTP 500  
Edition 2  
Category 501  
Test NRE01

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## **NRE02** **Radiated Emissions, Electric Field, 10 kHz to 18 GHz**

### TABLE OF CONTENTS

<b>1</b>	<b>NRE02 APPLICABILITY.....</b>	<b>NRE02-2</b>
<b>2</b>	<b>NRE02 LIMITS.....</b>	<b>NRE02-2</b>
<b>3</b>	<b>NRE02 TEST PROCEDURES .....</b>	<b>NRE02-2</b>
3.1	Purpose.....	NRE02-2
3.2	Test Equipment.....	NRE02-2
3.3	Setup.....	NRE02-3
3.4	Procedures.....	NRE02-4
3.5	Data Presentation .....	NRE02-5

## **NRE02**

### **Radiated Emissions, Electric Field, 10 kHz to 18 GHz**

#### **1 NRE02 APPLICABILITY**

This requirement is applicable for radiated emissions from equipment and subsystem enclosures, all interconnecting cables, and antennas designed to be permanently mounted to EUTs (receivers and transmitters in standby mode). The requirement does not apply at the transmitter fundamental frequencies.

The requirement is for testing from 10 kHz to 18 GHz for all applications with an option to restrict testing to 1 GHz or 10 times the highest intentionally generated frequency (whichever is higher) for all applications except those associated with Air where testing must be performed to 18 GHz. Reference should also be made to paragraph 6.22 of Category 501.

#### **2 NRE02 LIMITS**

Electric field emissions shall not be radiated in excess of those shown in Figures NRE02-1 through NRE02-4. Above 30 MHz, the limits shall be met for both horizontally and vertically polarized fields.

#### **3 NRE02 TEST PROCEDURES**

##### **3.1 Purpose**

This test procedure is used to verify that electric field emissions from the EUT and its associated cabling do not exceed specified requirements.

##### **3.2 Test Equipment**

The test equipment shall be as follows:

- a. Measurement receivers
- b. Data recording device
- c. Antennas
  - (1) 10 kHz to 30 MHz, 104 cm rod with impedance matching network
    - (a) When the impedance matching network includes a preamplifier (active rod), observe the overload precautions in paragraph 4.3.7.3 of Category 501.
    - (b) Use a square counterpoise measuring at least 60 cm on a side.
  - (2) 30 MHz to 200 MHz, Biconical, 137 cm tip to tip
  - (3) 200 MHz to 1 GHz, Double ridge horn, 69.0 by 94.5 cm opening
  - (4) 1 GHz to 18 GHz, Double ridge horn, 24.2 by 13.6 cm opening
- d. Signal generators
- e. Stub radiator
- f. Capacitor, 10 pF
- g. 50  $\mu$ H LISNs

### 3.3 Setup

The test setup shall be as follows:

- a. Maintain a basic test setup for the EUT as shown and described in Category 501 Figures 2 through to 6 and paragraph 4.3.8. Ensure that the EUT is oriented such that the surface that produces the maximum radiated emissions is toward the front edge of the test setup boundary.
- b. Calibration. Configure the test equipment as shown in Figure NRE02-5.
- c. EUT testing.
  - (1) For shielded room measurements, electrically bond the rod antenna counterpoise to the ground plane using a solid metal sheet that is greater than or equal to the width of the counterpoise. The maximum DC resistance between the counterpoise and the ground plane shall be 2.5 m $\Omega$ . For bench top setups using a metallic ground plane, bond the counterpoise to this ground plane. Otherwise, bond the counterpoise to the floor ground plane. For measurements outside a shielded enclosure, electrically bond the counterpoise to earth ground.
- d. Antenna Positioning.
  - (1) Determine the test setup boundary of the EUT and associated cabling for use in positioning of antennas.
  - (2) Use the physical reference points on the antennas shown in Figure NRE02-6 for measuring heights of the antennas and distances of the antennas from the test setup boundary.
  - (3) Position antennas 1 metre from the front edge of the test setup boundary for all setups.
  - (4) Position all antennas except the 104 cm rod antenna 120 cm above the floor ground plane.
  - (5) Ensure that no part of any antenna is closer than 1 metre from the walls and 0.5 metres from the ceiling of the shielded enclosure.
  - (6) For test setups using bench tops, additional positioning requirements for the rod antenna and distance above the bench ground plane are shown in Figure NRE02-6.
  - (7) For free standing setups, electrically bond and mount the 104 cm rod antenna matching network to the floor ground plane without a separate counterpoise.
  - (8) The number of required antenna positions depends on the size of the test setup boundary and the number of enclosures included in the setup. Use the following criteria to determine the individual antenna positions:
    - (a) For testing below 200 MHz: Setups with the side edges of the boundary 3 m or less, only one position is required and the antenna shall be centred with respect to the side edges of the boundary. Setups with the side edges of the boundary greater than 3 m, use multiple antenna positions at spacings as shown in Figure NRE02-7. Determine the number of antenna positions (N) by dividing the edge-to-edge boundary distance (in metres) by 3 and rounding up to an integer.
    - (b) For testing from 200 MHz up to 1 GHz: Place the antenna in a sufficient number of positions such that the entire width of each EUT enclosure and the

first 35 cm of cables and leads interfacing with the EUT enclosure are within the 3 dB beamwidth of the antenna.

- (c) For testing at 1 GHz and above: Place the antenna in a sufficient number of positions such that the entire width of each EUT enclosure and the first 7 cm of cables and leads interfacing with the EUT enclosure are within the 3 dB beamwidth of the antenna.

### 3.4 Procedures

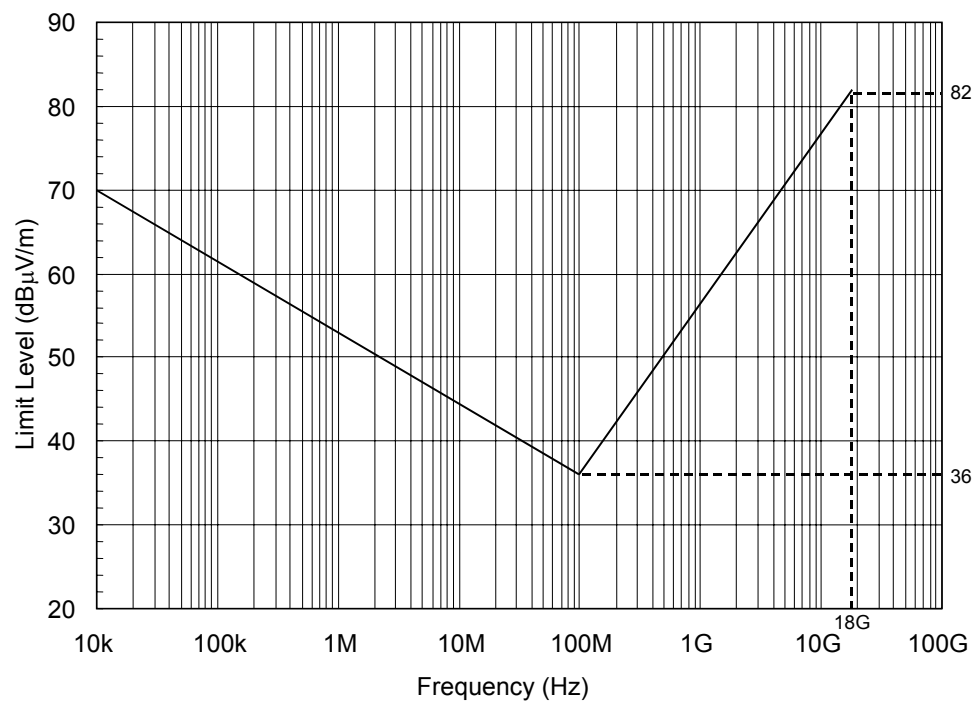
The test procedures shall be as follows:

- a. Verify that the ambient requirements specified in paragraph 4.3.4 of Category 501 are met. Take plots of the ambient when required by the referenced paragraph.
- b. Turn on the measurement equipment and allow a sufficient time for stabilization.
- c. Using the system check path of Figure NRE02-5, perform the following evaluation of the overall measurement system from each antenna to the data output device at the highest measurement frequency of the antenna. For rod antennas that use passive matching networks, the evaluation shall be performed at the center frequency of each band. For active rod antennas, the evaluation shall be performed at the lowest frequency of test, at a mid-band frequency, and at the highest frequency of test.
  - (1) Apply a calibrated signal level, which is at least 6 dB below the limit (limit minus antenna factor), to the coaxial cable at the antenna connection point.
  - (2) Scan the measurement receiver in the same manner as a normal data scan. Verify that the data recording device indicates a level within  $\pm 3$  dB of the injected signal level.
  - (3) For the 104 cm rod antenna, remove the rod element and apply the signal to the antenna matching network through a 10 pF capacitor connected to the rod mount.
  - (4) If readings are obtained which deviate by more than  $\pm 3$  dB, locate the source of the error and correct the deficiency prior to proceeding with the testing.
- d. Using the measurement path of Figure NRE02-5, perform the following evaluation for each antenna to demonstrate that there is electrical continuity through the antenna.
  - (1) Radiate a signal using an antenna or stub radiator at the highest measurement frequency of each antenna.
  - (2) Tune the measurement receiver to the frequency of the applied signal and verify that a received signal of appropriate amplitude is present. Note: This evaluation is intended to provide a coarse indication that the antenna is functioning properly. There is no requirement to accurately measure the signal level.
- e. Turn on the EUT and allow sufficient time for stabilization.
- f. Using the measurement path of Figure NRE02-5, determine the radiated emissions from the EUT and its associated cabling.
  - (1) Scan the measurement receiver for each applicable frequency range, using the bandwidths and minimum measurement times in Table 2 of Category 501.
  - (2) Above 30 MHz, orient the antennas for both horizontally and vertically polarized fields.
  - (3) Take measurements for each antenna position determined under 3.3d(3) above.

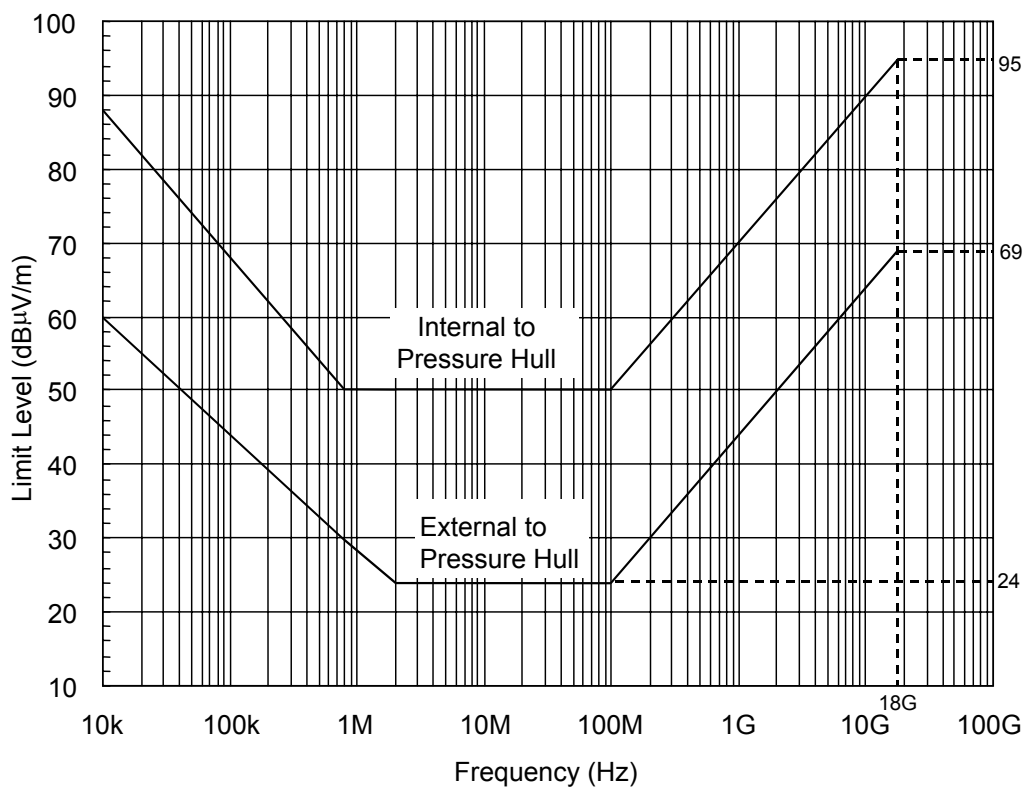
### 3.5 Data Presentation

Data presentation shall be as follows:

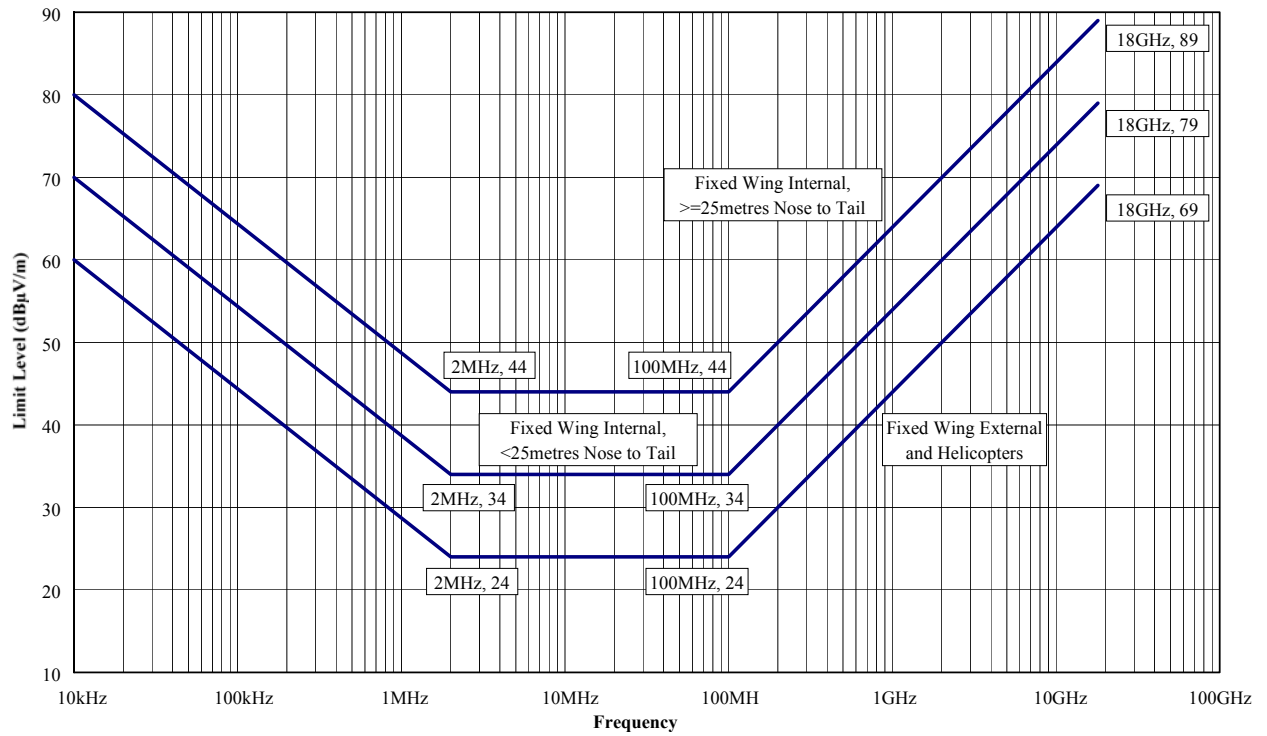
- Continuously and automatically plot amplitude versus frequency profiles. Manually gathered data is not acceptable except for plot verification. Vertical and horizontal data for a particular frequency range shall be presented on separate plots or shall be clearly distinguishable in black or white format for a common plot.
- Display the applicable limit on each plot.
- Provide a minimum frequency resolution of 1% or twice the measurement receiver bandwidth, whichever is less stringent, and a minimum amplitude resolution of 1 dB for each plot.
- Provide plots for both the measurement and system check portions of the procedure.
- Provide a statement verifying the electrical continuity of the measurement antennas as determined in 3.4d.



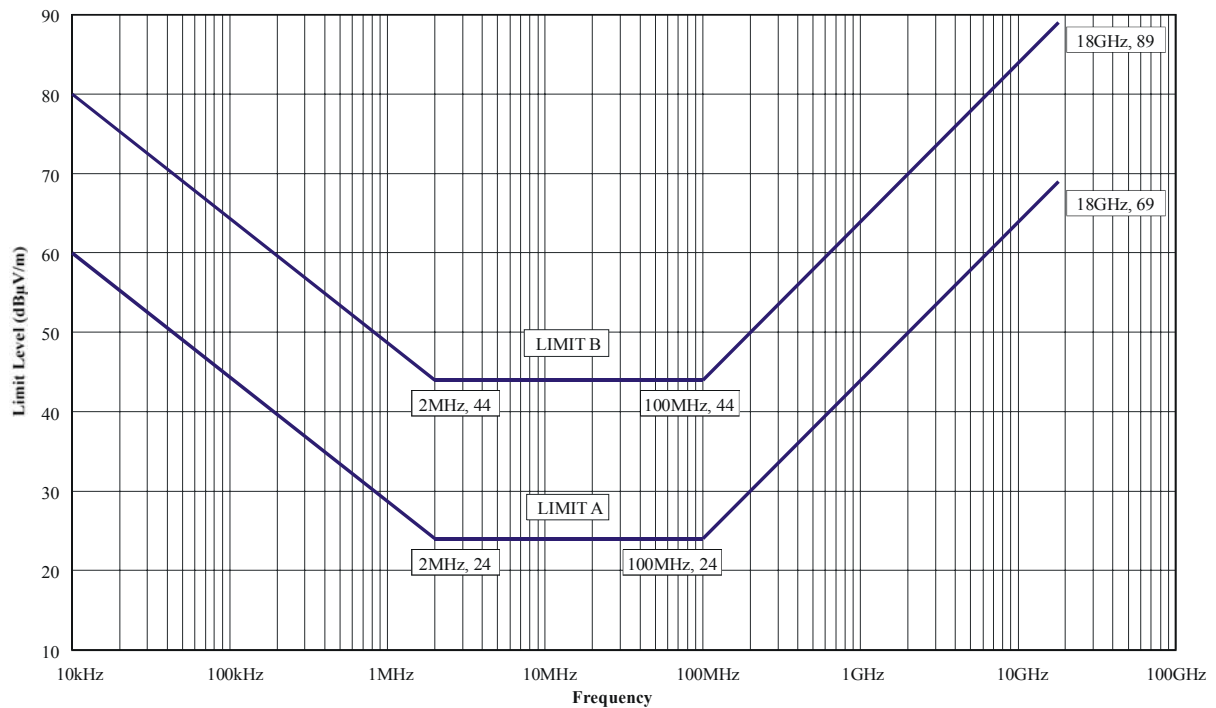
**FIGURE NRE02-1 Limit for sea applications (except submarines).**



**FIGURE NRE02-2** Limit for submarine applications.



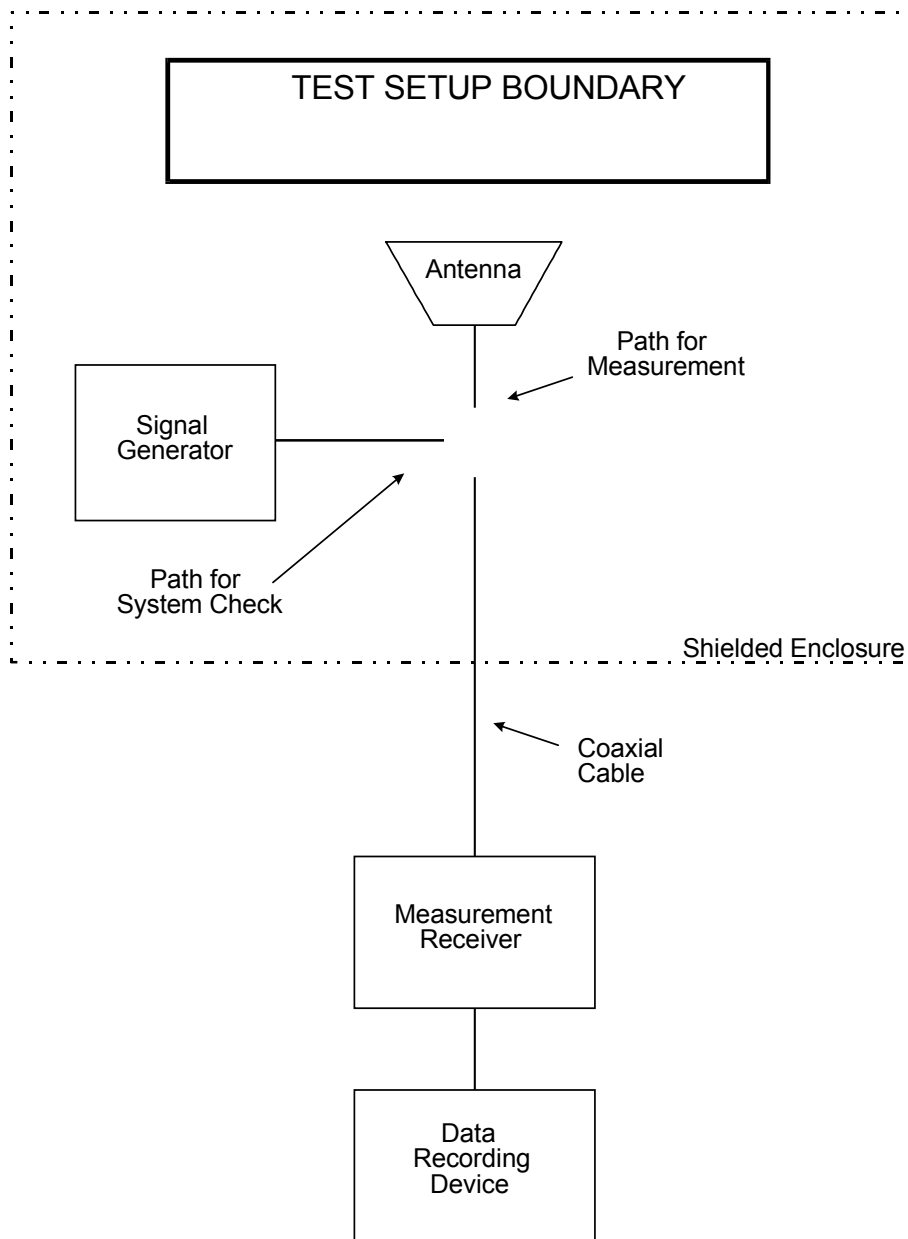
**FIGURE NRE02-3 Limits for air and space system application.**



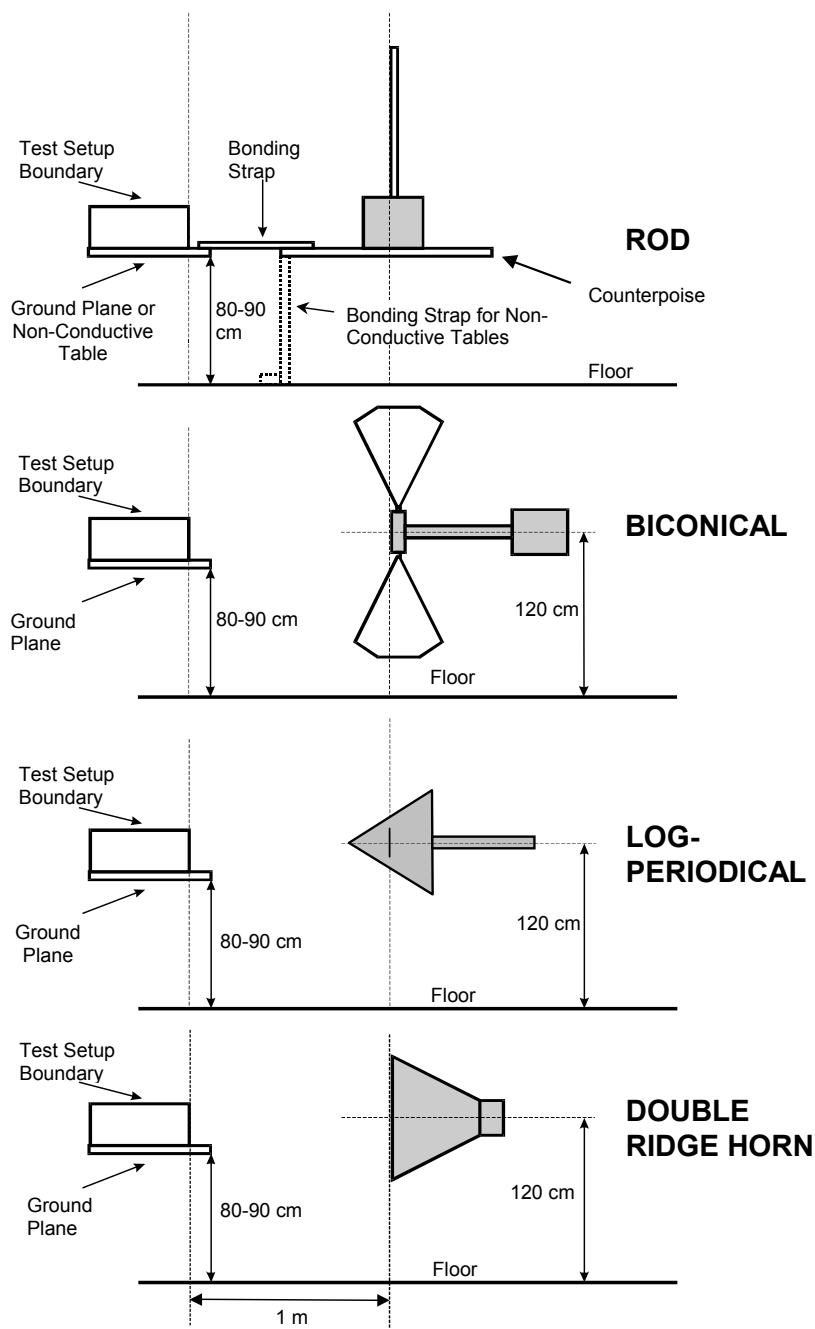
**FIGURE NRE02-4 Limits for land application.**

NOTE 1 : The use of limit A above is reserved for all land based EUTs procured for Army use and mobile sea systems, (such as man portable equipment) deployed in a land based role.

NOTE 2 : Limit B is utilised for fixed Sea system installations such as those associated with port and RADAR emplacements, ground support equipment deployed for Air applications is also covered by this limit.



**FIGURE NRE02-5 Basic test set-up.**



**FIGURE NRE02-6** Antenna positioning.

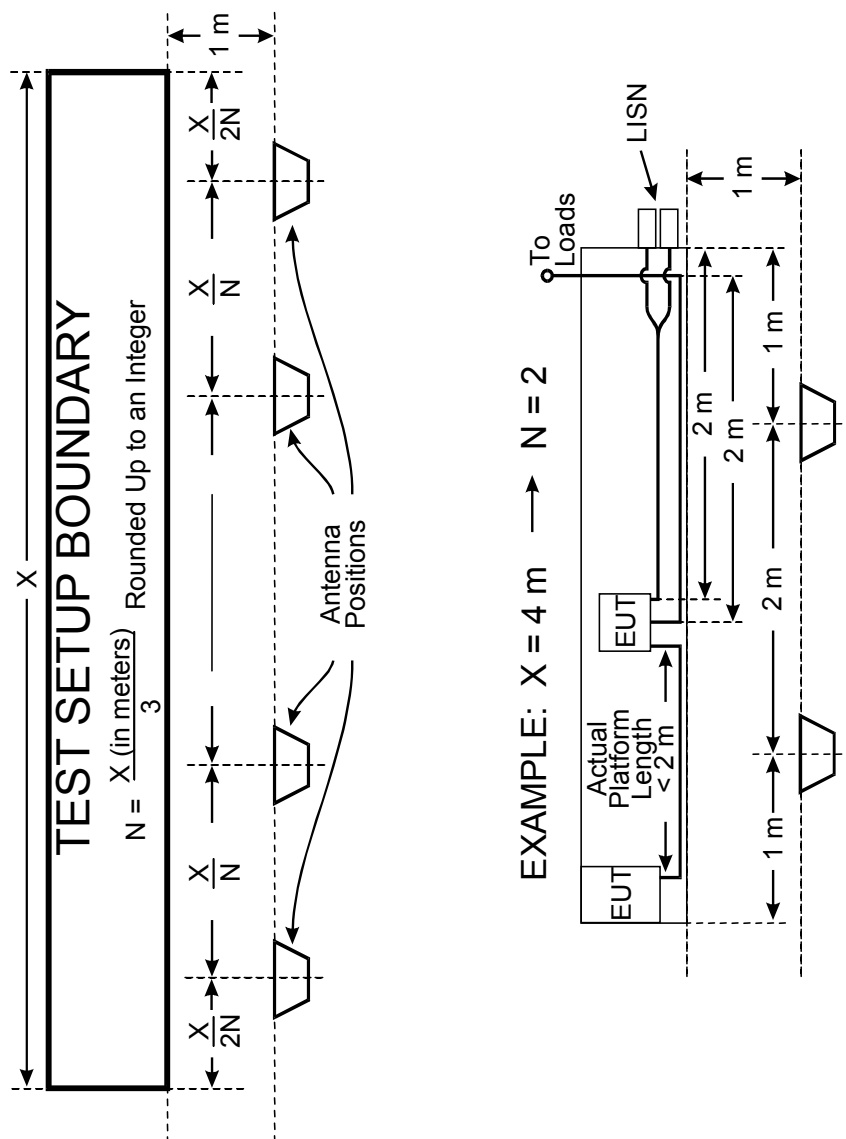


FIGURE NRE02-7 Multiple antenna positions.

AECTP 500  
Edition 2  
Category 501  
Test NRE02

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**NRE03**  
**Radiated Emissions, Antenna Spurious and Harmonic Outputs,**  
**10 kHz to 40 GHz**

TABLE OF CONTENTS

<b>1</b>	<b>NRE03 APPLICABILITY</b> .....	<b>NRE03-2</b>
<b>2</b>	<b>NRE03 LIMITS</b> .....	<b>NRE03-2</b>
<b>3</b>	<b>NRE03 TEST PROCEDURES</b> .....	<b>NRE03-2</b>
	3.1 Purpose.....	NRE03-2
	3.2 Test Equipment.....	NRE03-2
	3.3 Setup.....	NRE03-3
	3.4 Procedures.....	NRE03-3
	3.5 Data Presentation .....	NRE03-4

## NRE03

### Radiated Emissions, Antenna Spurious and Harmonic Outputs, 10 kHz to 40 GHz

#### 1 NRE03 APPLICABILITY

This requirement may be used as an alternative for NCE03 when testing transmitters with their intended antennas. NCE03 is the preferred requirement unless the equipment or subsystem design characteristics preclude its use. The requirement is not applicable within the EUT necessary bandwidth and within  $\pm 5$  percent of the fundamental frequency. Depending on the operating frequency range of the EUT, the start frequency of the test is shown in Table NRE03-1:

Operating Frequency Range (EUT)	Start Frequency of Test
10 kHz to 3 MHz	10 kHz
3 MHz to 300 MHz	100 kHz
300 MHz to 3 GHz	1 MHz
3 GHz to 40 GHz	10 MHz

**TABLE NRE03-1**

The end frequency of the test is 40 GHz or twenty times the highest generated frequency within the EUT, whichever is less. For equipment using waveguide, the requirement does not apply below eight-tenths of the waveguide's cut-off frequency. Reference should also be made to paragraph 6.23 of Category 501.

#### 2 NRE03 LIMITS

Harmonics, except the second and third, and all other spurious emissions shall be at least 80 dB down from the level at the fundamental. The second and third harmonics shall be suppressed to  $50 + 10 \log p$  (where  $p$  = peak power output in watts, at the fundamental) or 80 dB, whichever requires less suppression.

#### 3 NRE03 TEST PROCEDURES

##### 3.1 Purpose

This test procedure is used to verify that radiated spurious and harmonic emissions from transmitters do not exceed the specified requirements.

##### 3.2 Test Equipment

The test equipment shall be as follows:

- a. Measurement receiver
- b. Attenuators, 50  $\Omega$
- c. Antennas
- d. Rejection networks
- e. Signal generators

- f. Power monitor

### 3.3 Setup

It is not necessary to maintain the basic test setup for the EUT as shown and described in Category 501, Figures 2 through 6 and paragraph 4.3.8. The test setup shall be as follows:

- a. Calibration. Configure the test setup for the signal check path shown in Figure NRE03-1 or NRE03-2 as applicable.
- b. EUT Testing. Configure the test setup for the measurement path shown in Figure NRE03-1 or NRE03-2 as applicable.

### 3.4 Procedures

The test procedures shall be as follows:

- a. The measurements must be performed in the far field of the transmitting frequency. Consequently, the far-field test distance must be calculated prior to performing the test using the relationships below:

R = distance between transmitter antenna and receiver antenna.

D = maximum physical dimension of transmitter antenna.

d = maximum physical dimension of receiver antenna.

$\lambda$  = wavelength of frequency of the transmitter.

All dimensions are in metres.

For transmitter frequencies less than or equal to 1.24 GHz, the greater distance of the following relationships shall be used:

$$R = 2D^2/\lambda \qquad R = 3\lambda$$

For transmitter frequencies greater than 1.24 GHz, the separation distance shall be calculated as follows:

$$\text{For } 2.5 D < d \text{ use } \qquad R = 2D^2/\lambda$$

$$\text{For } 2.5 D \geq d \text{ use } \qquad R = (D+d)^2/\lambda$$

- b. Turn on the measurement equipment and allow sufficient time for stabilisation.
- c. Calibration.
  - (1) Apply a known calibrated signal level from the signal generator through the system check path at a midband fundamental frequency ( $f_0$ ).
  - (2) Scan the measurement receiver in the same manner as a normal data scan. Verify the measurement receiver detects a level within  $\pm 3$  dB of the expected signal.
  - (3) If readings are obtained which deviate by more than  $\pm 3$  dB, locate the source of the error and correct the deficiency prior to proceeding with the test.
  - (4) Repeat 3.4c(1) through 3.4c(3) for two other frequencies over the frequency range of test.
- d. EUT Testing.
  - (1) Turn on the EUT and allow a sufficient time for stabilisation.
  - (2) Tune the EUT to the desired test frequency and use the measurement path to complete the rest of this procedure.

- (3) Tune the test equipment to the measurement frequency ( $f_o$ ) of the EUT and adjust for maximum indication.
- (4) For transmitters where a power monitor can be inserted, measure the modulated transmitter power output P, using a power monitor while keying the transmitter. Convert this power level to units of dB relative to 1 watt (dBW). Calculate the Effective Radiated Power (ERP) by adding the EUT antenna gain to this value. Record the resulting level for comparison with that obtained in 3.4d(6).
- (5) Key the transmitter with desired modulation. Tune the measurement receiver for maximum output indication at the transmitted frequency. If either or both of the antennas have directivity, align both in elevation and azimuth for maximum indication. Verbal communication between sites via radiotelephone will facilitate this process. Record the resulting maximum receiver meter reading and the measurement receiver bandwidth.
- (6) Calculate the transmitter ERP in dBW, based on the receiver meter reading V, using the following equation:

$$\text{ERP} = V + 20 \log R + \text{AF} - 135$$

Where:

V = reading on the measurement receiver in dB $\mu$ V

R = distance between transmitter and receiver antennas in meters

AF = antenna factor of receiver antenna in dB (1/m)

Compare this calculated level to the measured level recorded in 3.4d(4). The compared results should agree within  $\pm 3$  dB. If the difference exceeds  $\pm 3$  dB, check the test setup for errors in measurement distance, amplitude calibration, power monitoring of the transmitter, frequency tuning or drift and antenna boresight alignment. Assuming that the results are within the  $\pm 3$  dB tolerance, the ERP becomes the reference for which amplitudes of spurious and harmonics will be compared to determine compliance with standard limits.

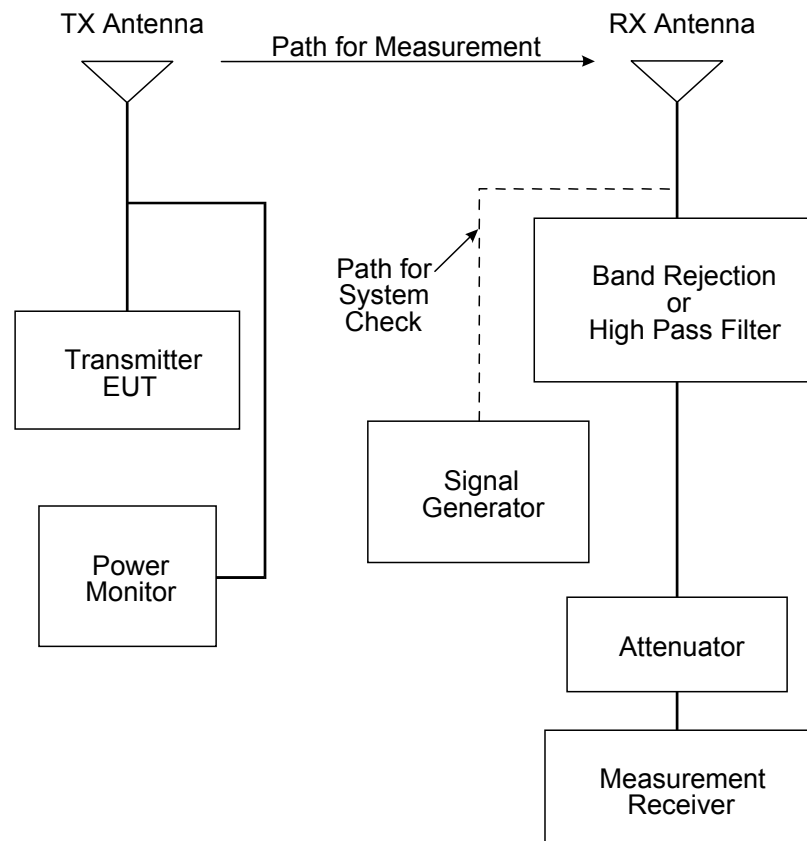
- (7) With the rejection network filter connected and tuned to  $f_o$ , scan the measurement receiver over the frequency range of test to locate spurious and harmonic transmitted outputs. It may be necessary to move the measuring system antenna in elevation and azimuth at each spurious and harmonic output to assure maximum levels are recorded. Maintain the same measurement receiver bandwidth used to measure the fundamental frequency in 3.4d(5).
- (8) Verify that spurious outputs are from the EUT and not spurious responses of the measurement system or the test site ambient.
- (9) Calculate the ERP of each spurious output. Include all correction factors for cable loss, amplifier gains, filter loss, and attenuator factors.
- (10) Repeat 3.4d(2) through 3.4d(9) for other  $f_o$  of the EUT.

### 3.5 Data Presentation

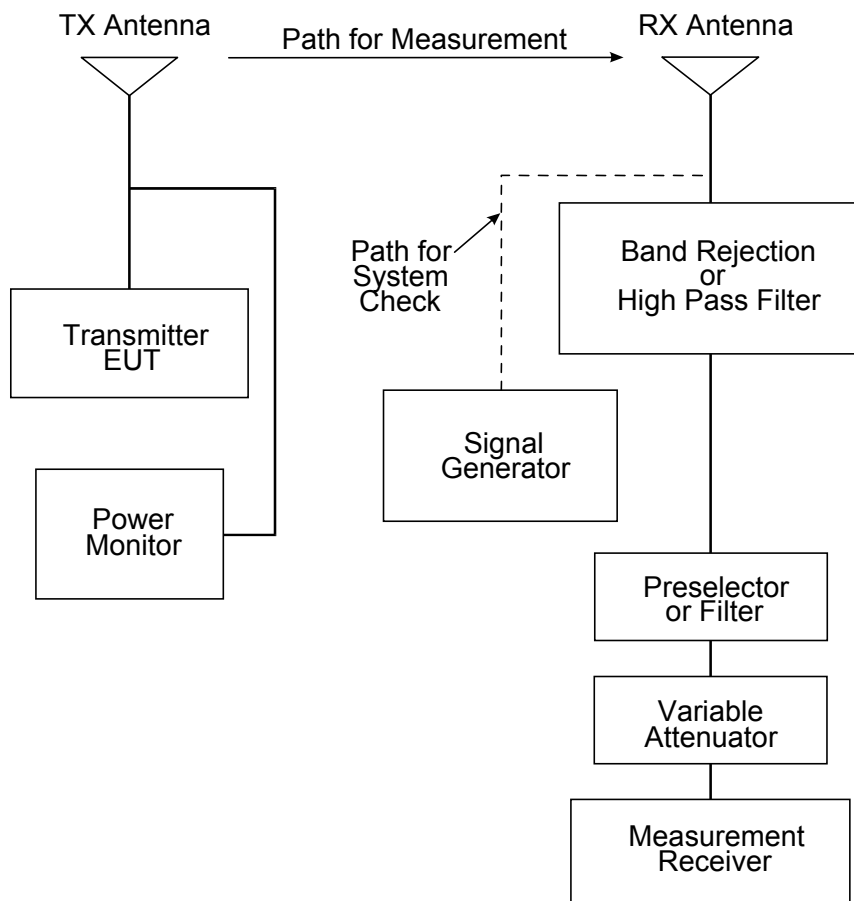
Data presentation shall be as follows:

- a. Provide tabular data showing fundamental frequency ( $f_o$ ) and frequency of all harmonics and spurious emissions measured, the measured power monitor level and the calculated ERP of the fundamental frequency, the ERP of all spurious and harmonics emissions measured, dB down levels, and all correction factors including cable loss, attenuator pads, amplifier gains, insertion loss of rejection networks and antenna gains.

- b. The relative dB down level is determined by subtracting the level in 3.4d(6) from that recorded in 3.4d(9).



**FIGURE NRE03-1**  
**Calibration and test set-up for radiated harmonics and spurious emissions, 10 kHz to 1 GHz.**



**FIGURE NRE03-2**  
Calibration and test set-up for radiated harmonics and spurious emissions, 1 GHz to 40 GHz.

# NRS01

## Radiated Susceptibility, Magnetic Field, 30 Hz to 100 kHz

### TABLE OF CONTENTS

<b>1</b>	<b>NRS01 APPLICABILITY.....</b>	<b>NRS01-2</b>
<b>2</b>	<b>NRS01 limit .....</b>	<b>NRS01-2</b>
<b>3</b>	<b>NRS01 TEST PROCEDURES .....</b>	<b>NRS01-2</b>
	3.1 Purpose .....	NRS01-2
	3.2 Test Equipment .....	NRS01-2
	3.3 Setup .....	NRS01-3
	3.4 Procedures .....	NRS01-3
	3.5 Data Presentation .....	NRS01-4
<b>4</b>	<b>NRS01 alternative test procedures – AC Helmholtz coil.....</b>	<b>NRS01-5</b>
	4.1 Purpose .....	NRS01-5
	4.2 Test Equipment .....	NRS01-5
	4.3 Setup .....	NRS01-5
	4.4 Procedures .....	NRS01-6
	4.5 Data Presentation .....	NRS01-6

## **NRS01**

### **Radiated Susceptibility, Magnetic Field, 30 Hz to 100 kHz**

#### **1 NRS01 APPLICABILITY**

This requirement is applicable to equipment and subsystem enclosures, including electrical cable interfaces. The requirement is not applicable for electromagnetic coupling via antennas. The requirement is applicable for equipment intended to be installed on Aircraft, Army ground equipment and all equipment deployed on Ships. For an EUT comprising a number of units, each unit with potentially sensitive components shall be tested individually. The interconnecting cables do not have to be subjected to this test. Reference should also be made to paragraph 6.24 of Category 501

#### **2 NRS01 LIMIT**

The EUT shall not exhibit any malfunction, degradation of performance, or deviation from specified indications, beyond the tolerances indicated in the individual equipment or subsystem specification, when subjected to the magnetic fields shown in Figures NRS101-1 and NRS101-2.

#### **3 NRS01 TEST PROCEDURES**

##### **3.1 Purpose**

This test procedure is used to verify the ability of the EUT to withstand radiated magnetic fields.

##### **3.2 Test Equipment**

The test equipment shall be as follows:

- a. Signal source
- b. Radiating loop having the following specifications
  - (1) Diameter: 12 cm
  - (2) Number of turns: 20
  - (3) Wire: No. 12 insulated copper
  - (4) Magnetic flux density:  $9.5 \times 10^7$  pT/ampere of applied current at a distance of 5 cm from the plane of the loop.
- c. Loop sensor having the following specifications:
  - (1) Diameter: 4 cm
  - (2) Number of turns: 51
  - (3) Wire: 7-41 Litz wire (7 Strand, No. 41 AWG)
  - (4) Shielding: Electrostatic
  - (5) Correction Factor: See manufacturer's data for factors to convert measurement receiver readings to decibels above one picotesla (dBpT).
- d. Measurement receiver or narrowband voltmeter
- e. Current probe

- f. 50  $\mu$ H LISNs

### 3.3 Setup

The test setup shall be as follows:

- a. Maintain a basic test setup for the EUT as shown and described in Category 501 Figures 3 through 6 and paragraph 4.3.8.
- b. Calibration. Configure the measurement equipment, radiating loop, and loop sensor as shown in Figure NRS01-3.
- c. EUT Testing Configure the test as shown in Figure NRS01-4.

### 3.4 Procedures

The test procedures shall be as follows:

- a. Turn on the measurement equipment and allow sufficient time for stabilisation.
- b. Calibration.
  - (1) Set the signal source to a frequency of 1 kHz and adjust the output to provide a magnetic flux density of 110 dBpT as determined by the reading obtained on measurement receiver A and the relationship given in 3.2b(4).
  - (2) Measure the voltage output from the loop sensor using measurement receiver B.
  - (3) Verify that the output on measurement receiver B is within  $\pm 3$  dB of the expected value based on the antenna factor and record this value.
- c. EUT Testing.
  - (1) Turn on the EUT and allow sufficient time for stabilisation.
  - (2) Select test frequencies as follows:
    - (a) Locate the loop sensor 5 cm from the EUT face or electrical interface connector being probed. Orient the plane of the loop sensor parallel to the EUT faces and parallel to the axis of connectors.
    - (b) Supply the loop with sufficient current to produce magnetic field strengths at least 10 dB greater than the applicable limit but not to exceed 15 amps (183 dBpT).
    - (c) Scan the applicable frequency range. Scan rates up to 3 times faster than the rates specified in Table 3 of Category 501 are acceptable.
    - (d) If susceptibility is noted, select no less than three test frequencies per octave at those frequencies where the maximum indications of susceptibility are present.
    - (e) Reposition the loop successively to a location in each 30 by 30 cm area on each face of the EUT and at each electrical interface connector, and repeat 3.4c(2)(c) and 3.4c(2)(d) to determine locations and frequencies of susceptibility.
    - (f) From the total frequency data where susceptibility was noted in 3.4c(2)(c) through 3.4c(2)(e), select 3 frequencies per octave over the applicable frequency range.
  - (3) At each frequency determined in 3.4c(2)(f), apply a current to the radiating loop that corresponds to the applicable limit. Move the loop to search for possible locations of susceptibility with particular attention given to the locations determined

in 3.4c(2)(e) while maintaining the loop 5 cm from the EUT surface or connector.  
Verify that susceptibility is not present.

### 3.5 Data Presentation

Data presentation shall be as follows:

- a. Provide tabular data showing verification of the calibration of the radiating loop in 3.4b.
- b. Provide tabular data, diagrams, or photographs showing the applicable test frequencies and locations determined in 3.4c(2)(e) and 3.4c(2)(f).
- c. Provide graphical or tabular data showing frequencies and threshold levels of susceptibility.

## 4 NRS01 ALTERNATIVE TEST PROCEDURES – AC HELMHOLTZ COIL

This test procedure may be substituted for the 3.0 procedures above, provided that the EUT size versus coil size constraints of 4.3b can be satisfied.

### 4.1 Purpose

This test procedure is an alternative technique used to verify the ability of the EUT to withstand radiated magnetic fields.

### 4.2 Test Equipment

The test equipment shall be as follows:

- a Signal source
- b Series-wound AC Helmholtz coil
- c Loop sensor having the following specifications (same as NRE01 loop):
  - (1) Diameter: 13.3 cm
  - (2) Number of turns: 36
  - (3) Wire: 7-41 Litz wire (7 strand, No. 41 AWG)
  - (4) Shielding: Electrostatic
  - (5) Correction factor See manufacturer's data for factors to convert measurement receiver readings to decibels above one picotesla (dBpT).

Note: It is permissible to use loop sensors having different characteristics to those above with the proviso that any loop used has dimensions smaller than 1.1 x the coil radius and has correction factors traceable to national standards.

- d. Measurement receiver or narrowband voltmeter
- e. Current probe
- f. LISNs

### 4.3 Setup

The test setup shall be as follows:

- a. Maintain a basic test setup for the EUT as shown and described in Category 501 Figures 3 through 6 and paragraph 4.3.8.
- b. Calibration.
  - (1) Configure the radiating system as shown in Figure NRS01-5. Select coil spacing based on the physical dimensions of the EUT enclosure.
  - (2) For an EUT with dimensions less than one coil radius, use a standard Helmholtz configuration (coils separated by one coil radius). Place the field-monitoring loop in the centre of the test volume.
  - (3) For an EUT with dimensions greater than one coil radius, use the optional configuration. Select a coil separation such that the plane of the EUT face is at least 5 cm from the plane of the coils and such that the separation between the coils does not exceed 1.5 radii. Place the field-monitoring probe in the plane of either coil at its centre.
- c. EUT Testing.

- (1) Configure the test as shown in Figure NRS01-6, using the same coil spacing arrangement as determined for calibration under 4.3b.
- (2) Position the coils such that the plane of the EUT faces is in parallel with the plane of the coils.

#### 4.4 Procedures

The test procedures shall be as follows:

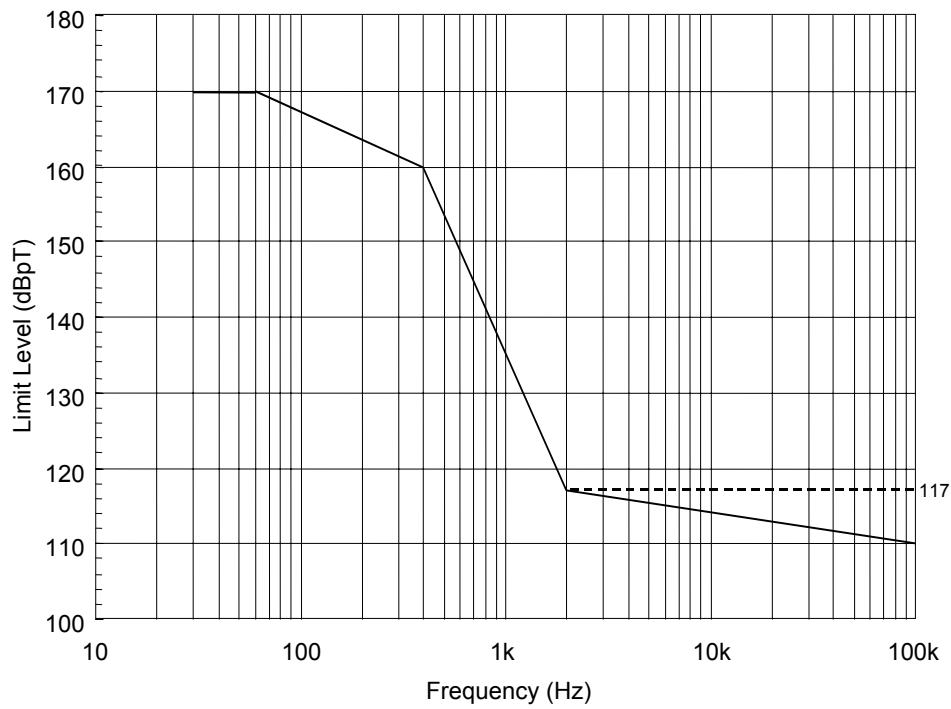
- a. Turn on the measurement equipment and allow sufficient time for stabilisation.
- b. Calibration.
  - (1) Set the signal source to a frequency of 1 kHz and adjust the output current to generate a magnetic flux density of 110 dBpT as determined by the reading obtained on measurement receiver A.
  - (2) Measure the voltage output from the loop sensor using measurement receiver B.
  - (3) Verify that the output on measurement receiver B is within  $\pm 3$  dB of the expected value based on the antenna factor and record this value.
- c. EUT Testing.
  - (1) Turn on the EUT and allow sufficient time for stabilisation.
  - (2) Select test frequencies as follows:
    - (a) Supply the Helmholtz coil with sufficient current to produce magnetic field strengths at least 6 dB greater than the applicable limit.
    - (b) Scan the applicable frequency range. Scan rates up to 3 times faster than the rates specified in Table 3 of Category 501 are acceptable.
    - (c) If susceptibility is noted, select no less than three test frequencies per octave at those frequencies where the maximum indications of susceptibility are present.
    - (d) Reposition the Helmholtz coils successively over all areas on each face of the EUT (in all three axes), including exposure of any electrical interface connectors, and repeat 4.4c(2)(b) and 4.4c(2)(c) to determine locations and frequencies of susceptibility.
    - (e) From the total frequency data where susceptibility was noted in 4.4c(2)(b) through 4.4c(2)(d), select three frequencies per octave over the applicable frequency range.
  - (3) At each frequency determined in 4.4c(2)(e), apply a current to the Helmholtz coil that corresponds to the applicable NRS01 limit. Move the coils to search for possible locations of susceptibility with particular attention given to the locations determined in 4.4c(2)(d). Ensure the EUT remains centred between the coils, or the coils remain 5 cm from the EUT surface, as applicable. Verify that susceptibility is not present.

#### 4.5 Data Presentation

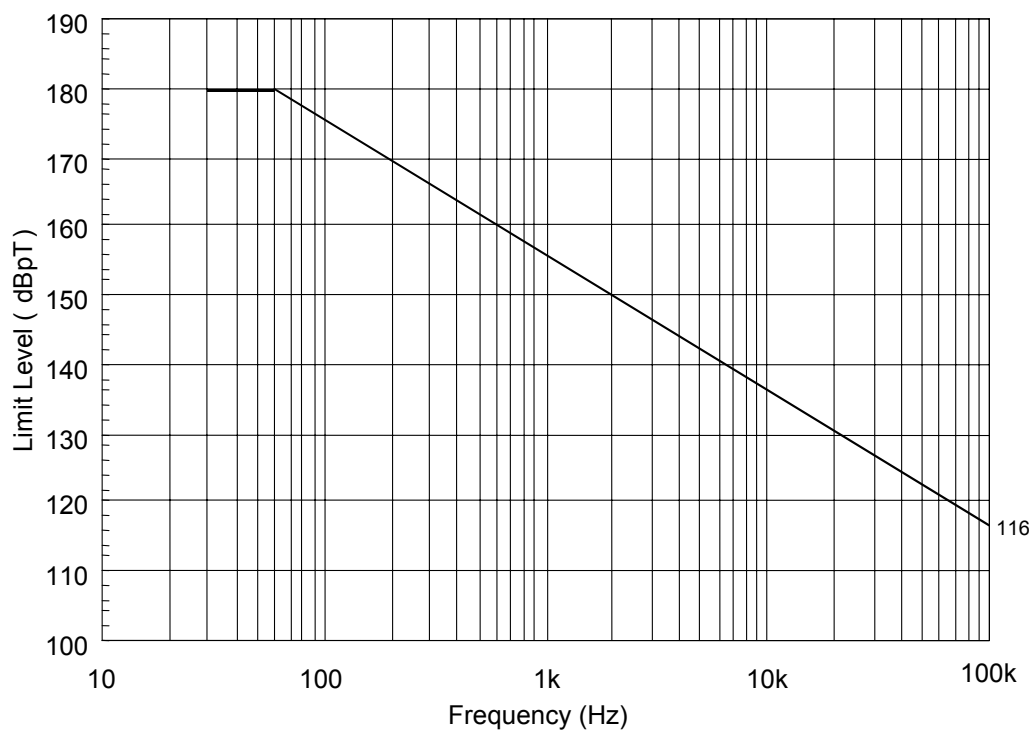
Data presentation shall be as follows:

- a. Provide tabular data showing verification of the calibration of the Helmholtz coils in 4.4b.
- b. Provide tabular data, diagrams, or photographs showing the applicable test frequencies and locations determined in 4.4c(2)(d) and 4.4c(2)(e).

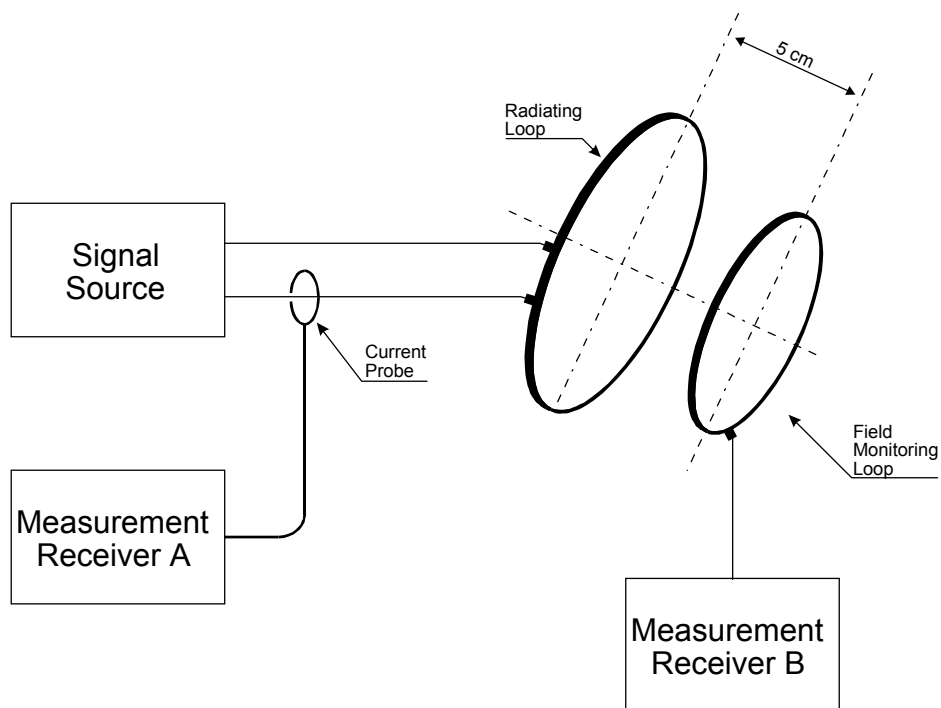
- c. Provide graphical or tabular data showing frequencies and threshold levels of susceptibility.



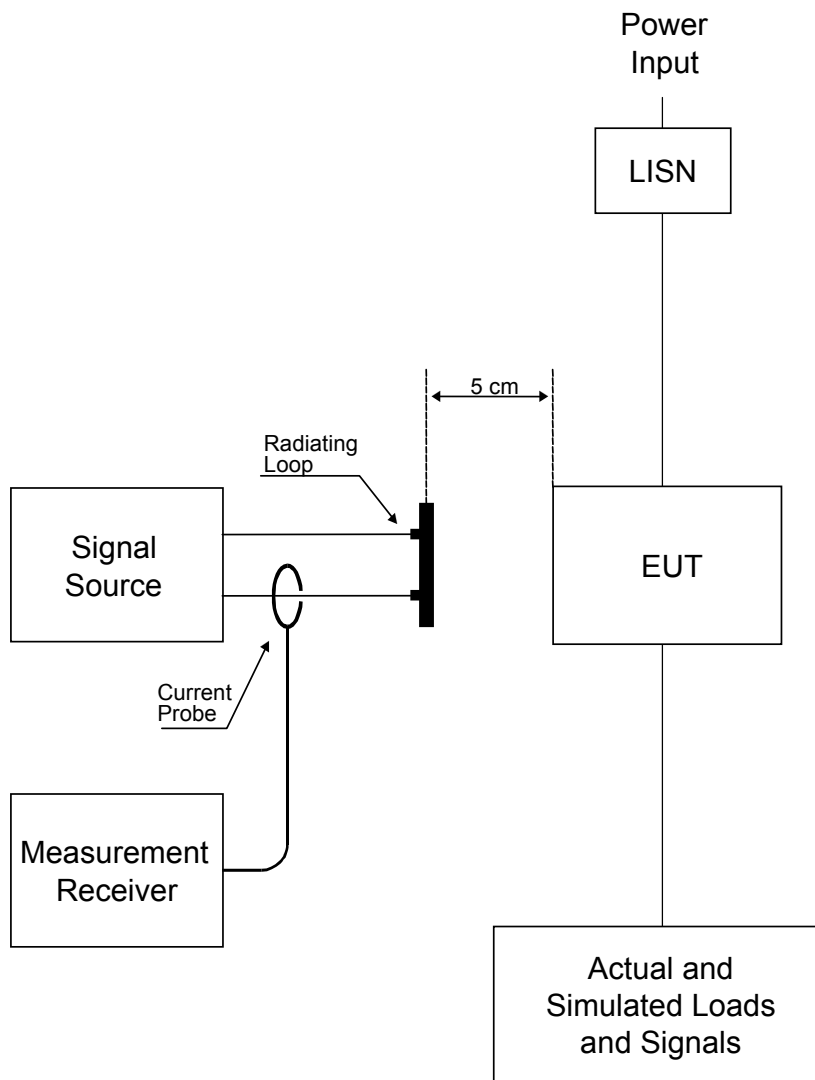
**FIGURE NRS01-1** Limit for all Air and Sea applications.



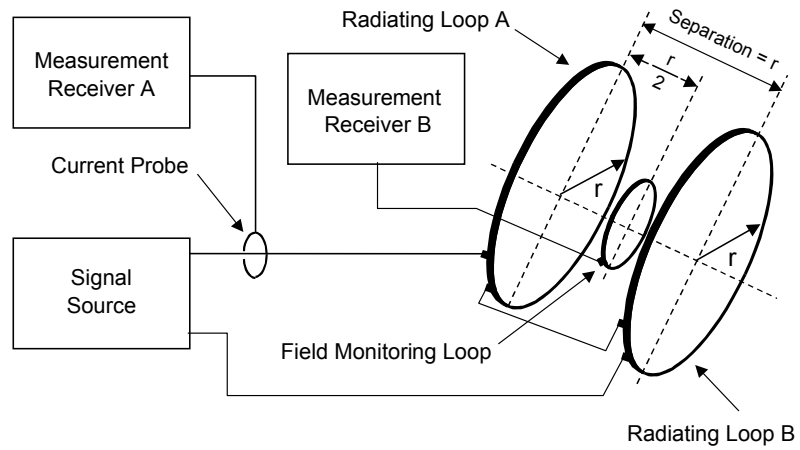
**FIGURE NRS01-2**      **Limit for all Land applications.**



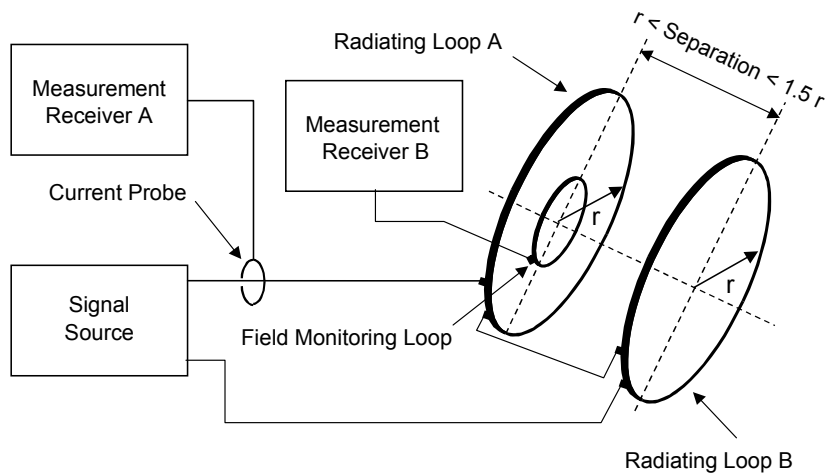
**FIGURE NRS01-3** Calibration of the radiating system.



**FIGURE NRS01-4 Basic test set-up.**

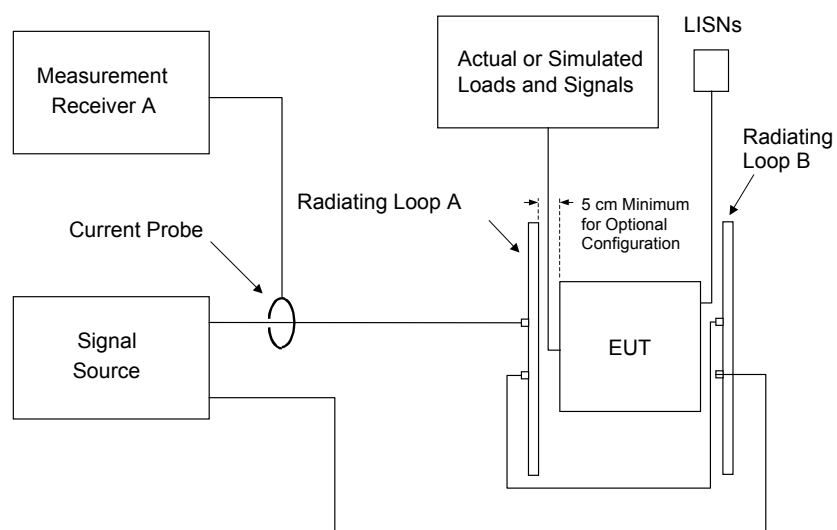


Standard Configuration



Optional Configuration

**FIGURE NRS01-5 Calibration of Helmholtz coils.**



Note: One axis position of three required is shown

**FIGURE NRS01-6** Test set-up for Helmholtz coils.

## **NRS02** **Radiated Susceptibility, Electric Field, 50 kHz to 40 GHz**

### TABLE OF CONTENTS

<b>1</b>	<b>NRS02 APPLICABILITY.....</b>	<b>NRS02-2</b>
<b>2</b>	<b>NRS02 LIMITS.....</b>	<b>NRS02-2</b>
<b>3</b>	<b>NRS02 TEST PROCEDURES .....</b>	<b>NRS02-2</b>
	3.1 Purpose.....	NRS02-2
	3.2 Test Equipment.....	NRS02-2
	3.3 Setup.....	NRS02-3
	3.4 Procedures.....	NRS02-4
	3.5 Data Presentation .....	NRS02-5
<b>4</b>	<b>NRS02 ALTERNATIVE TEST PROCDURES – REVERBERATION CHAMBER (mode-tuned) .....</b>	<b>NRS02-6</b>
	4.1 Purpose.....	NRS02-6
	4.2 Test equipment .....	NRS02-6
	4.3 Setup.....	NRS02-6
	4.4 Procedure.....	NRS02-7
	4.5 Data Presentation .....	NRS02-8

## **NRS02**

### **Radiated Susceptibility, Electric Field, 50 kHz to 40 GHz**

#### **1 NRS02 APPLICABILITY**

This requirement is applicable to equipment and subsystem enclosures and all interconnecting cables. The requirement is for testing from 50 kHz to 1 GHz for all applications with an option to test above 1 GHz at the procurement authority's discretion. Testing shall not exceed 40 GHz.

The requirement at the tuned frequency of an antenna-connected receiver is 20 dB above the NRE02 limit associated with the particular platform application.

Reference should also be made to paragraph 6.25 of Category 501.

#### **2 NRS02 LIMIT**

The EUT shall not exhibit any malfunction, degradation of performance, or deviation from specified indications, beyond the tolerances indicated in the individual equipment or subsystem specification, when subjected to the radiated electric fields listed in Table NRS02-1 and modulated as specified below. Up to 30 MHz, the requirement shall be met for vertically polarised fields. Above 30 MHz, the requirement shall be met for both horizontally and vertically polarised fields. Circular polarised fields are not acceptable.

#### **3 NRS02 TEST PROCEDURES**

##### **3.1 Purpose**

This test procedure is used to verify the ability of the EUT and associated cabling to withstand electric fields.

##### **3.2 Test Equipment**

The test equipment shall be as follows:

- a. Signal generators
- b. Power amplifiers
- c. Receive antennas
- d. Transmit antennas
- e. Electric field sensors (physically small - electrically short)
- f. Measurement receiver
- g. Power meter
- h. Directional coupler
- i. Attenuator
- j. Data recording device
- k. 50  $\mu$ H LISNs

### 3.3 Setup

The test setup shall be as follows:

- a. Maintain a basic test setup for the EUT as shown and described in Category 501 Figures 2 through to 6 and paragraph 4.3.8.
- b. For electric field calibration, electric field sensors are required from 50 kHz to 1 GHz. Either field sensors or receive antennas may be used above 1 GHz (see 3.2c and 3.2e).
- c. Configure test equipment as shown in Figure NRS02-1.
- d. Calibration.
  - (1) Placement of electric field sensors (see 3.3b). Position sensors 1 metre from, and directly opposite, the transmit antenna as shown in Figures NRS02-2 and NRS02-3 and a minimum of 30 cm above the ground plane. Do not place sensors directly at corners or edges of EUT components.
  - (2) Placement of receive antennas (see 3.3b). Prior to placement of the EUT, position the receive antenna, as shown in Figure NRS02-4, on a dielectric stand at the position and height above the ground plane where the centre of the EUT will be located.
- e. EUT testing.
  - (1) Placement of transmit antennas. Antennas shall be placed 1 metre from the test setup boundary as follows:
    - (a) 50 kHz to 200 MHz
      - (1) Test setup boundaries  $\leq 3$  metres. Centre the antenna between the edges of the test setup boundary. The boundary includes all enclosures of the EUT and the 2 metres of exposed interconnecting and power leads required in Category 501 paragraph 4.3.8.6. Interconnecting leads shorter than 2 metres are acceptable when they represent the actual platform installation.
      - (2) Test setup boundaries  $> 3$  metres. Use multiple antenna positions (N) at spacings as shown in Figure NRS02-3. The number of antenna positions (N) shall be determined by dividing the edge-to-edge boundary distance (in metres) by 3 and rounding up to an integer.
    - (b) 200 MHz and above. Multiple antenna positions may be required as shown in Figure NRS02-2. Determine the number of antenna positions (N) as follows:
      - (1) For testing from 200 MHz up to 1 GHz, place the antenna in a sufficient number of positions such that the entire width of each EUT enclosure and the first 35 cm of cables and leads interfacing with the EUT enclosure are within the 3 dB beamwidth of the antenna.
      - (2) For testing at 1 GHz and above, place the antenna in a sufficient number of positions such that the entire width of each EUT enclosure and the first 7 cm of cables and leads interfacing with the EUT enclosure are within the 3 dB beamwidth of the antenna.
  - (2) Maintain the placement of electric field sensors as specified in 3.3d(1) above.

### 3.4 Procedures

The test procedures shall be as follows:

- a. Turn on the measurement equipment and EUT and allow a sufficient time for stabilisation.
- b. Assess the test area for potential RF hazards and take necessary precautionary steps to assure safety of test personnel.
- c. Calibration.
  - (1) Electric field sensor procedure. Record the amplitude shown on the electric field sensor display unit due to EUT ambient. Reposition the sensor, as necessary, until this level is < 10% of the applicable field strength to be used for testing.
  - (2) Receive antenna procedure (> 1 GHz).
    - (a) Connect a signal generator to the coaxial cable at the receive antenna connection point (antenna removed). Set the signal source to an output level of 0 dBm at the highest frequency to be used in the present test setup. Tune the measurement receiver to the frequency of the signal source.
    - (b) Verify that the output indication is within  $\pm 3$  dB of the applied signal, considering all appropriate losses. If larger deviations are found, locate the source of the error and correct the deficiency before proceeding.
    - (c) Connect the receive antenna to the coaxial cable as shown in Figure NRS02-4. Set the signal source to 1 kHz pulse modulation, 50% duty cycle. Using an appropriate transmit antenna and amplifier, establish an electric field at the test start frequency. Gradually increase the electric field level until it reaches the applicable limit.
    - (d) Scan the test frequency range and record the required input power levels to the transmit antenna to maintain the required field.
    - (e) Repeat procedures 3.4.c (2)(a) through 3.4(2)(d) whenever the test setup is modified or an antenna is changed.
- d. EUT Testing.
  - (1) E-Field sensor procedure.
    - (a) Set the signal source to 1 kHz pulse modulation, 50% duty cycle, and using appropriate amplifier and transmit antenna, establish an electric field at the test start frequency. Gradually increase the electric field level until it reaches the applicable limit.
    - (b) Scan the required frequency ranges in accordance with the rates and duration's specified in Table 3 of Category 501. Maintain field strength levels in accordance with the applicable limit. Monitor EUT performance for susceptibility effects.
  - (2) Receive antenna procedure.
    - (a) Remove the receive antenna and reposition the EUT in conformance with 3.3a.
    - (b) Set the signal source to 1 kHz pulse modulation, 50% duty cycle. Using an appropriate amplifier and transmit antenna, establish an electric field at the

test start frequency. Gradually increase the input power level until it corresponds to the applicable level recorded during the calibration routine.

- (c) Scan the required frequency range in accordance with the rates and duration's specified in Table III while assuring the correct transmitter input power is adjusted in accordance with the calibration data collected. Constantly monitor the EUT for susceptibility conditions.
- (3) If susceptibility is noted, determine the threshold level in accordance with paragraph 4.3.10.4.3 of Category 501 and verify that it is above the limit.
- (4) Perform testing over the required frequency range with the transmit antenna vertically polarised. Repeat the testing above 30 MHz with the transmit antenna horizontally polarised.
- (5) Repeat 3.4d for each transmit antenna position required by 3.3e.

NOTE: Some NATO members may require additional modulation types applied over some or all of the frequency range tested. The Procuring Authority should be consulted with regard to other required modulations such as a pulse modulation of 1  $\mu$ S width with a prf of 1kHz used to mimic the effect of co-located radar systems.

### 3.5 Data Presentation

Data presentation shall be as follows:

- a. Provide graphical or tabular data showing frequency ranges and field strength levels tested.
- b. Provide graphical or tabular data listing (antenna procedure only) all calibration data collected to include input power requirements used versus frequency, and results of system check in 3.4c(2)(c) and 3.4c(2)(d).
- c. Provide the correction factors necessary to adjust sensor output readings for equivalent peak detection of modulated waveforms.
- d. Provide graphs or tables listing any susceptibility thresholds that were determined along with their associated frequencies.
- e. Provide diagrams or photographs showing actual equipment setup and the associated dimensions.

## 4 NRS02 ALTERNATIVE TEST PROCEDURES – REVERBERATION CHAMBER (MODE-TUNED)

These procedures may be substituted for the 3.0 procedures above over the frequency range of 200 MHz to 40 GHz. The lower frequency limit is dependent on chamber size. To determine the lower frequency limit for a given chamber, use the following formula to determine the number of possible modes (N), which can exist at a given frequency. If, for a given frequency, N is less than 100 then the chamber should not be used at or below that frequency.

$$N = \frac{8\pi}{3}abd \frac{f^3}{c^3}$$

Where: a, b, and d are the chamber internal dimensions in metres

f is the operation frequency in Hz

c is the speed of propagation ( $3 \times 10^8$  m/s)

### 4.1 Purpose

This test procedure is an alternative technique used to verify the ability of the EUT and associated cabling to withstand electric fields.

### 4.2 Test equipment

The test equipment shall be as follows:

- a. Signal generators
- b. Power amplifiers
- c. Receive antennas
  - (1) 200 MHz to 1 GHz, log periodic or double ridge horns.
  - (2) 1 GHz to 18 GHz, double ridge horns.
  - (3) 18 GHz to 40 GHz, other antennas as approved by the procuring activity.
- d. Transmit antennas
- e. Electric field sensors (physically small - electrically short), each axis independently displayed
- f. Measurement receiver
- g. Power meter
- h. Directional coupler
- i. Attenuator, 50 ohm
- j. Data recording device
- k. LISNs

### 4.3 Setup

The test setup shall be as follows:

- a. Install the EUT in a reverberation chamber using the basic test setup for the EUT as shown and described in Category 501 Figures 3 through 6 and paragraph 4.3.8. The EUT shall be at least 1.0 metre from the chamber walls, the tuner, and antennas.

- b. For electric field calibration, electric field sensors (4.2.e) are required from 200 MHz to 1 GHz. Either field sensors or receive antennas may be used above 1 GHz (see 4.2c and 4.2e).
- c. Configure the test equipment as shown in Figures NRS02-5 and NRS02-6. The same configuration is used for both calibration and EUT testing. Both the transmit and receive antennas shall be present in the chamber for all calibration and EUT testing, including for the electric-field probe technique. Unused receive antennas shall be terminated in 50 ohms.

#### 4.4 Procedure

The test procedures shall be as follows:

- a. Calibration. Use the following procedure to determine the electric field strength that will be created inside the chamber when a fixed amount of RF energy is injected into the chamber.
  - (1) Receive antenna procedure.
    - (a) Adjust the RF source to inject an appropriate forward power (unmodulated) into the chamber at the start frequency of the test.
    - (b) Measure the level at the receive antenna using the measurement receiver.
    - (c) Rotate the tuner 360 degrees using the minimum number of steps required from Table NRS02-2. Allow the paddle wheel to dwell at each position for a period corresponding to a minimum of 1.5 times the response time of the measurement receiver.
    - (d) Record the maximum amplitude of the signal received and use the following formula to derive a calibration factor for the field strength created inside the chamber. ( $P_{r-max}$  and  $P_{forward}$  in watts;  $\lambda$  in metres).
$$\text{Calibration factor} = \frac{8\pi}{\lambda} \sqrt{5 \left( \frac{P_{r-max}}{P_{forward}} \right)} \text{ V/m (for one watt)}$$
    - (e) Repeat the procedure in frequency steps no greater than 2% of the preceding frequency until 1.1 times the start frequency is reached. Continue the procedure in frequency steps no greater than 10% of the preceding frequency, thereafter.
  - (2) Electric field probe procedure.
    - (a) Adjust the RF source to inject an appropriate forward power ( $P_{forward}$ ) (unmodulated) into the chamber at the start frequency of the test.
    - (b) Rotate the tuner 360 degrees using the minimum number of steps required from Table NRS02-2. Allow the tuner to dwell at each position for a period corresponding to a minimum of 1.5 times the probe response time.
    - (c) Record the maximum amplitude from the receive antenna ( $P_{r-max}$ ) and from each element of the probe and use the following formula to derive a calibration factor for the field strength created inside the chamber. (Probe reading in V/m and  $P_{forward}$  in watts).

$$\text{Calibration factor} = \sqrt{\frac{(E_{x-\max} + E_{y-\max} + E_{z-\max})^2}{3}} / P_{\text{forward}} \quad \text{V/m (for one watt)}$$

- (d) Repeat the procedure in frequency steps no greater than 2% of the preceding frequency until 1.1 times the start frequency is reached. Continue the procedure in frequency steps no greater than 10% of the preceding frequency, thereafter.
- b. EUT testing. The same antennas used for calibration shall be used for EUT testing.
- (1) Turn on the measurement equipment and allow a sufficient time for stabilisation.
  - (2) Set the RF source to the start frequency of the test with 1 kHz pulse modulation, 50 % duty cycle.
  - (3) Calculate the amount of RF power needed to create the desired field strength by determining the difference (in dB decibel differences are the same for both field strength and power, there is a square law relationship between field strength and power in real numbers) between the desired field strength and the field strength obtained during the calibration. Adjust the chamber peak forward power to this value. Interpolation between calibration points is required.
  - (4) Adjust the measurement receiver to display the received signal at the receive antenna to verify that an electric field is present.
  - (5) Rotate the tuner 360 degrees using the minimum of steps shown in Table NRS02-2. Allow the tuner to dwell at each position for the duration specified in Table 3 of Category 501. As the tuner rotates, maintain the forward power required to produce field levels at the applicable limit as determined from the calibration.
  - (6) Scan the required frequency range in accordance with the maximum frequency step sizes and durations specified in Table 3 of Category 501. Monitor EUT performance for susceptibility effects.
  - (7) If susceptibility is noted, determine the threshold level in accordance with paragraph 4.3.10.4.3 of Category 501 and verify that it is above the limit.

#### 4.5 Data Presentation

Data presentation shall be as follows:

- a. Provide graphical or tabular data showing frequency ranges and field strength levels tested.
- b. Provide graphical or tabular data listing of all calibration data collected to include input power requirements used versus frequency and results of calibration in 4.4a(1)(d) and 4.4.a (2)(c).
- c. Provide the correction factors necessary to adjust sensor output readings for equivalent peak detection of modulated waveforms.
- d. Provide graphs or tables listing any susceptibility thresholds that were determined along with their associated frequencies.
- e. Provide diagrams or photographs showing the actual equipment setup and the associated dimensions.
- f. Provide the data certifying the baseline performance of the shielded room as a properly functioning reverberation chamber over a defined frequency range.

PLATFORM		LIMIT LEVEL (VOLTS/METRE)									
FREQ RANGE		AIRCRAFT (EXTERNAL OR SAFETY CRITICAL)	AIRCRAFT INTERNAL	ALL SHIPS (ABOVE DECKS) AND SUBMARINES (EXTERNAL)*	SHIPS (METALLIC) (BELOW DECKS)	SHIPS (NON-METALLIC) (BELOW DECKS)	SUBMARINES (INTERNAL)	GROUND	SPACE		
50kHz	L	10	10	10	10	10	10	10	-	10	-
To	S	10	10	10	10	10	10	10	-	10	-
2MHz	A	10	10	10	10	10	-	10	-	10	-
2MHz	L	200	200	200	10	50	-	50	20	20	20
To	S	200	200	200	10	50	5	10	20	20	20
30MHz	A	200	20	--	-	-	-	10	20	20	20
30MHz	L	200	200	200	10	10	-	50	20	20	20
To	S	200	200	200	10	10	10	10	20	20	20
1GHz	A	200	20	-	-	-	-	10	20	20	20
1GHz	L	200	200	200	10	10	-	50	20	20	20
To	S	200	200	200	10	10	10	50	20	20	20
18GHz	A	200	60	-	-	-	-	50	20	20	20
18GHz	L	200	200	200	10	10	-	50	20	20	20
To	S	200	60	200	10	10	10	50	20	20	20
40GHz	A	200	60	-	-	-	-	50	20	20	20

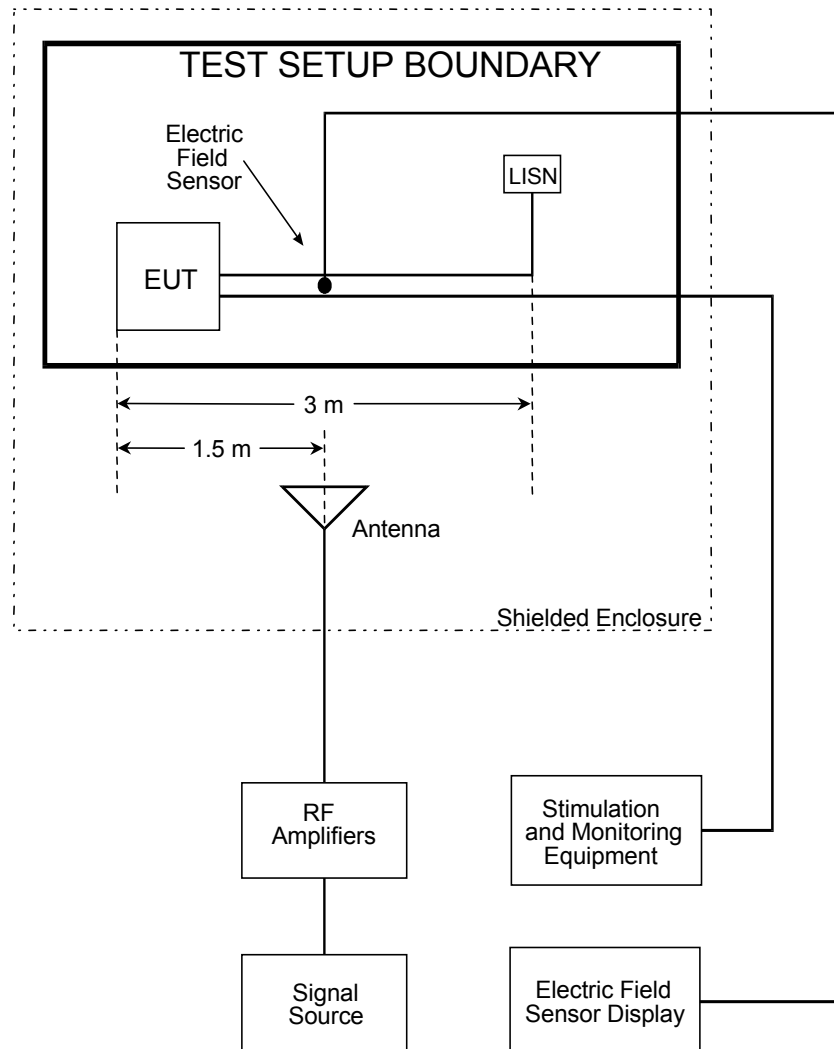
\*For equipment located external to the pressure hull of a submarine but within the superstructure, use SHIP (METALLIC) (BELOW DECKS)

KEY L = Land  
S = Sea  
A = Air

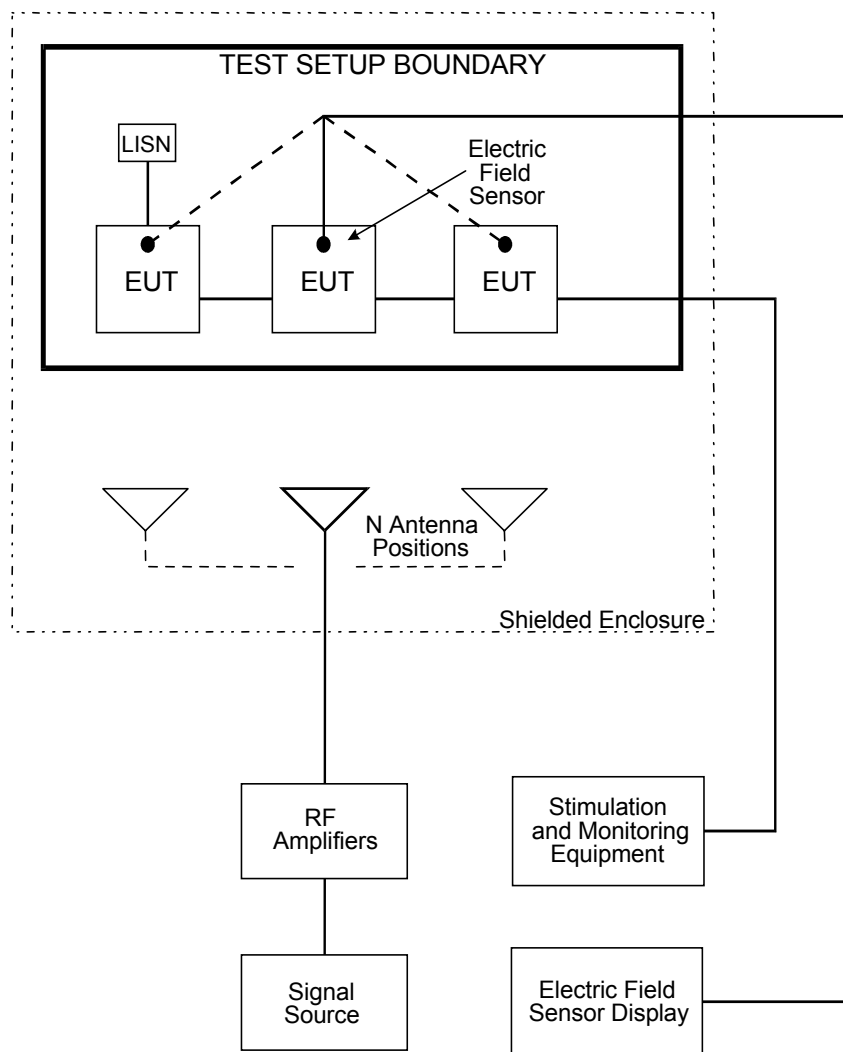
TABLE NRS02-1 Limits.

Frequency Range (MHz)	Tuner Positions
200 - 300	50
300 - 400	20
400 - 600	16
Above 600	12

**TABLE NRS02-2 Required number of tuner positions for a reverberation chamber.**



**FIGURE NRS02-1** Test equipment configuration.



**FIGURE NRS02-2 Multiple test antenna locations for frequency > 200 MHz.**

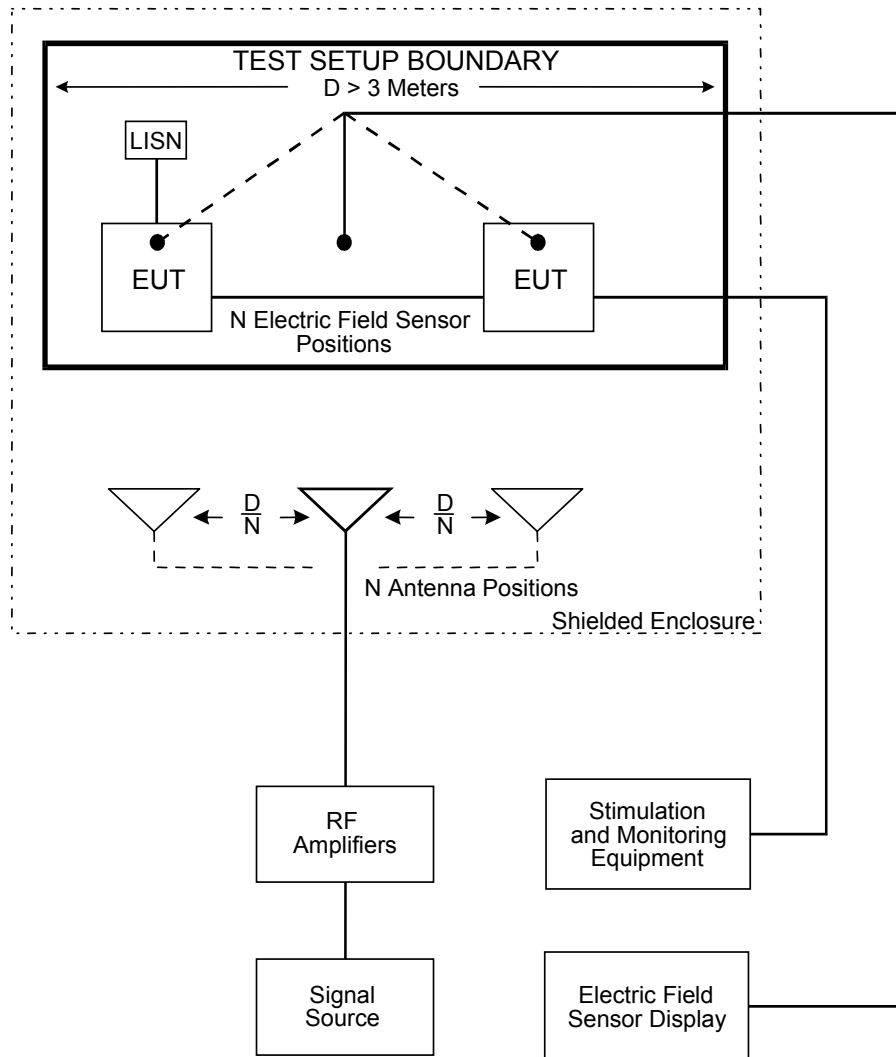


FIGURE NRS02-3 Multiple test antenna locations for N positions,  $D > 3$  metres.

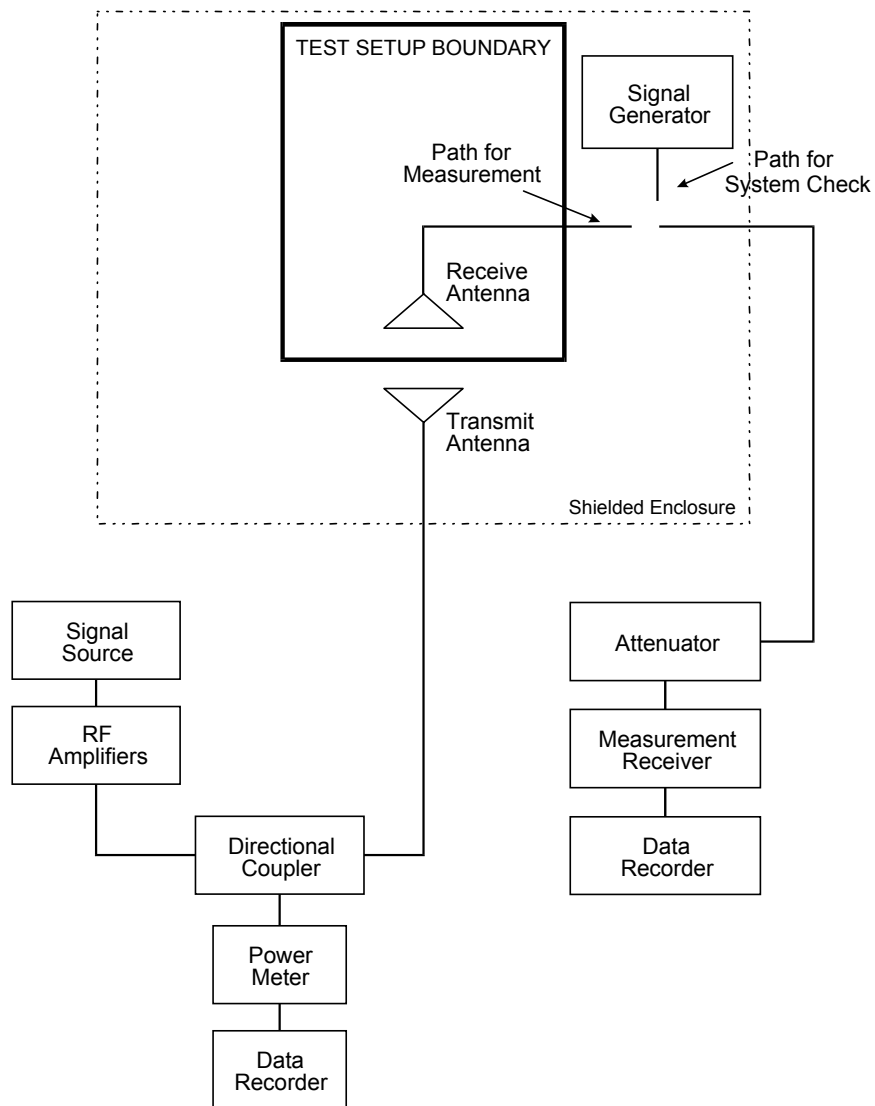
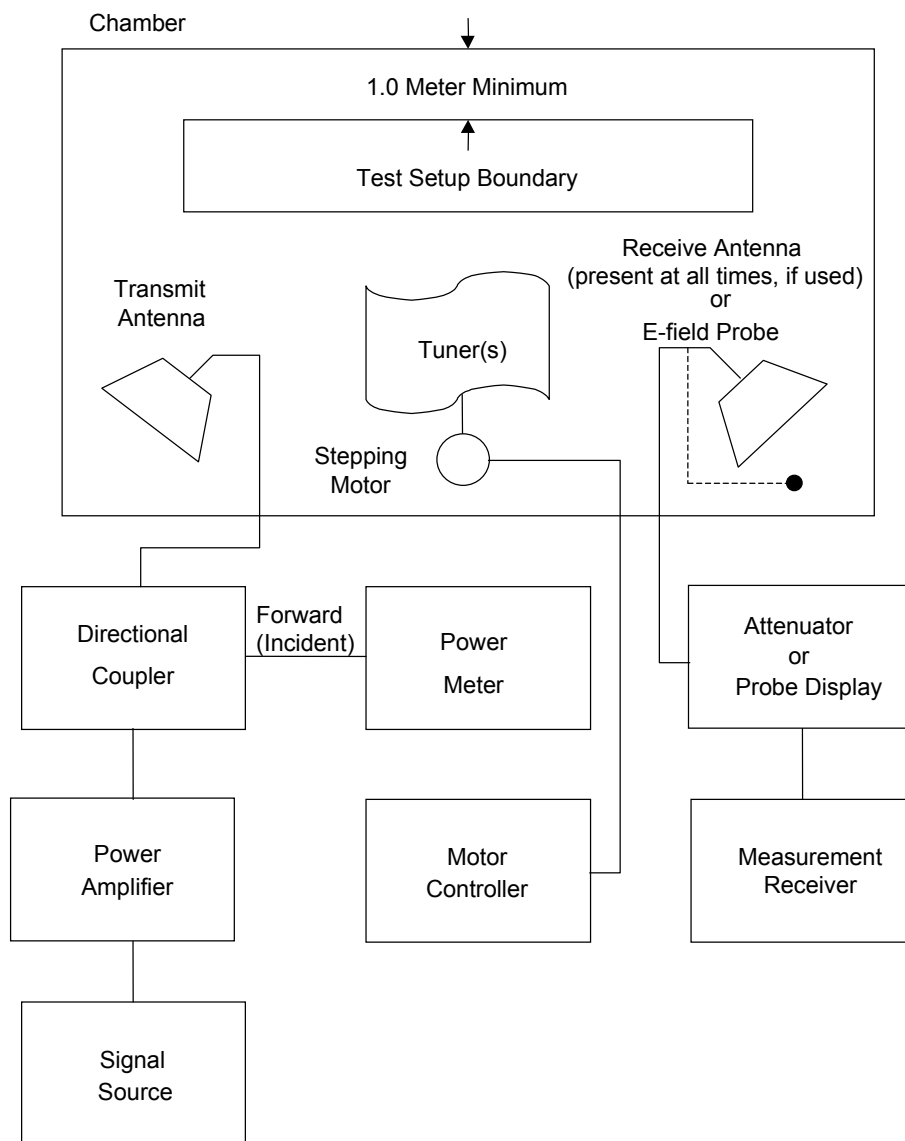
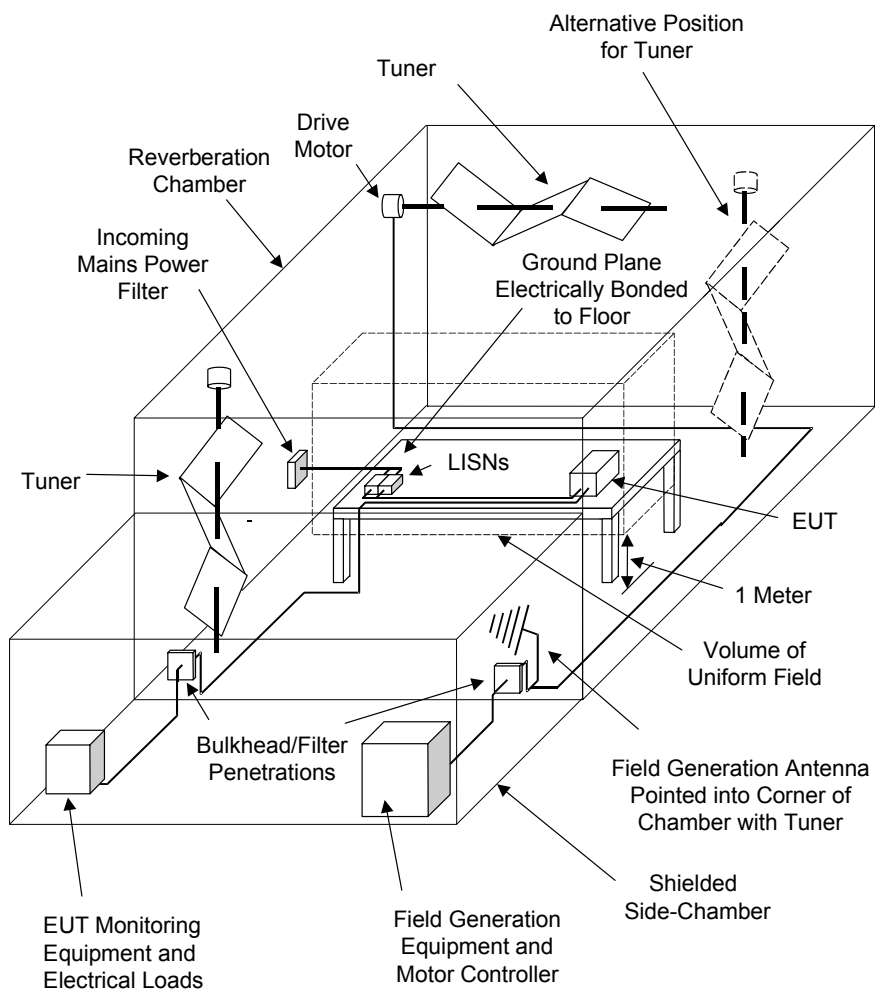


FIGURE NRS02-4 Receive antenna procedure (1 to 40 GHz).



**FIGURE NRS02-5 Reverberation chamber set-up.**



**FIGURE NRS02-6 Reverberation Chamber Overview.**

## **NRS03** **Radiated Susceptibility, Transient Electromagnetic Field**

### TABLE OF CONTENTS

<b>1.</b>	<b>NRS03 APPLICABILITY .....</b>	<b>NRS03-2</b>
<b>2.</b>	<b>NRS03 LIMITS .....</b>	<b>NRS03-2</b>
<b>3.</b>	<b>NRS03 TEST PROCEDURES.....</b>	<b>NRS03-2</b>
3.1	Purpose .....	NRS03-2
3.2	Test Equipment .....	NRS03-2
3.3	Setup .....	NRS03-2
3.4	Procedures .....	NRS03-3
3.5	Data Presentation.....	NRS03-4

## **NRS03**

### **Radiated Susceptibility, Transient Electromagnetic Field**

#### **1. NRS03 APPLICABILITY**

This requirement is applicable to equipment and subsystem enclosures when the equipment or subsystem is to be located external to a hardened (shielded) platform or facility. The requirement is applicable for equipment intended solely for use on non-metallic platforms when specified by the procuring activity. The requirement is applicable to Army aircraft for safety critical equipment and subsystems located in an external installation.

This test should only be performed as part of a qualification test program for equipment that is likely to encounter fast transient radiated electric fields as encountered during nuclear electromagnetic pulses.

Reference should also be made to paragraph 6.26 of Category 501.

#### **2. NRS03 LIMIT**

The EUT shall not exhibit any malfunction, degradation of performance, or deviation from specified indications, beyond the tolerances indicated in the individual equipment or subsystem specification, when subjected to a test signal having the waveform and amplitude shown on Figure NRS03-1. At least five pulses shall be applied at the rate of not more than one pulse per minute.

#### **3. NRS03 TEST PROCEDURES**

##### **3.1 Purpose**

This test procedure is used to verify the ability of the EUT enclosure to withstand a transient electromagnetic field.

##### **3.2 Test Equipment**

The test equipment shall be as follows:

- a. Transverse electromagnetic (TEM) cell, parallel plate transmission line or equivalent
- b. Transient pulse generator, monopulse output, plus and minus polarity
- c. Storage oscilloscope, 500 MHz, single-shot bandwidth (minimum), variable sampling rate up to 1gigasample per second (GS/s)
- d. Terminal protection devices
- e. High-voltage probe, 1 GHz bandwidth (minimum)
- f. B-dot sensor probe
- g. D-dot sensor probe
- h. 50  $\mu$ H LISNs
- i. Integrator, time constant ten times the overall pulse width

##### **3.3 Setup**

Set up the EUT as described below.

CAUTION: Exercise extreme care if an open radiator is used for this test.

- a. Calibration. Configure the test equipment in accordance with Figure NRS03-2.
  - (1) Before installing the EUT in the test volume, place the B-dot or D-dot sensor probe in the centre position of the five point grid in the vertical plane where the front face of the EUT will be located (see Figure NRS03-2).
  - (2) Place the high-voltage probe across the input to the radiation system at the output of the transient pulse generator. Connect the probe to a storage oscilloscope.
- b. EUT Testing. Configure the test equipment as shown in Figure NRS03-3.
  - (1) Place the EUT centreline on the centreline of the working volume of the radiation system in such a manner that it does not exceed the usable volume of the radiation system ( $h/3, B/2, A/2$ )/(x,y,z) as shown in Figure NRS03-3 (h is the maximum vertical separation of the plates). If the EUT is mounted on a ground plane in the actual installation, the EUT shall be placed on the radiating system ground plane. The EUT shall be bonded to the ground plane in a manner that duplicates the actual installation. Otherwise, the EUT shall be supported by dielectric material that produces a minimum distortion of the EM fields.
  - (2) The EUT orientation shall be such that the maximum coupling of electric and or magnetic fields is simulated. This may require more than one test orientation.
  - (3) Cables for EUT operation and monitoring shall be oriented to minimise induced currents and voltages on the cables. Cabling shall be oriented normal to the electric field vector and in a manner that minimises the loop area normal to the magnetic field vector. Cables extending out of the parallel plate working volume should remain normal to the electric field vector for a minimum distance equal to 2 times h.
  - (4) Bond the bottom plate of the radiation system to an earth reference.
  - (5) Keep the top plate of the radiation system at least 2 times h from the closest metallic ground, including ceiling, building structural beams, metallic air ducts, shielded room walls, and so forth.
  - (6) Place the EUT actual or simulated loads and signals for electrical interfaces in a shielded enclosure when an open radiator is used.
  - (7) Place transient protection devices (TPDs) in the EUT power lines near the power source to protect the power source.
  - (8) Connect the transient pulse generator to the radiation system.

### 3.4 Procedures

The test procedures shall be as follows:

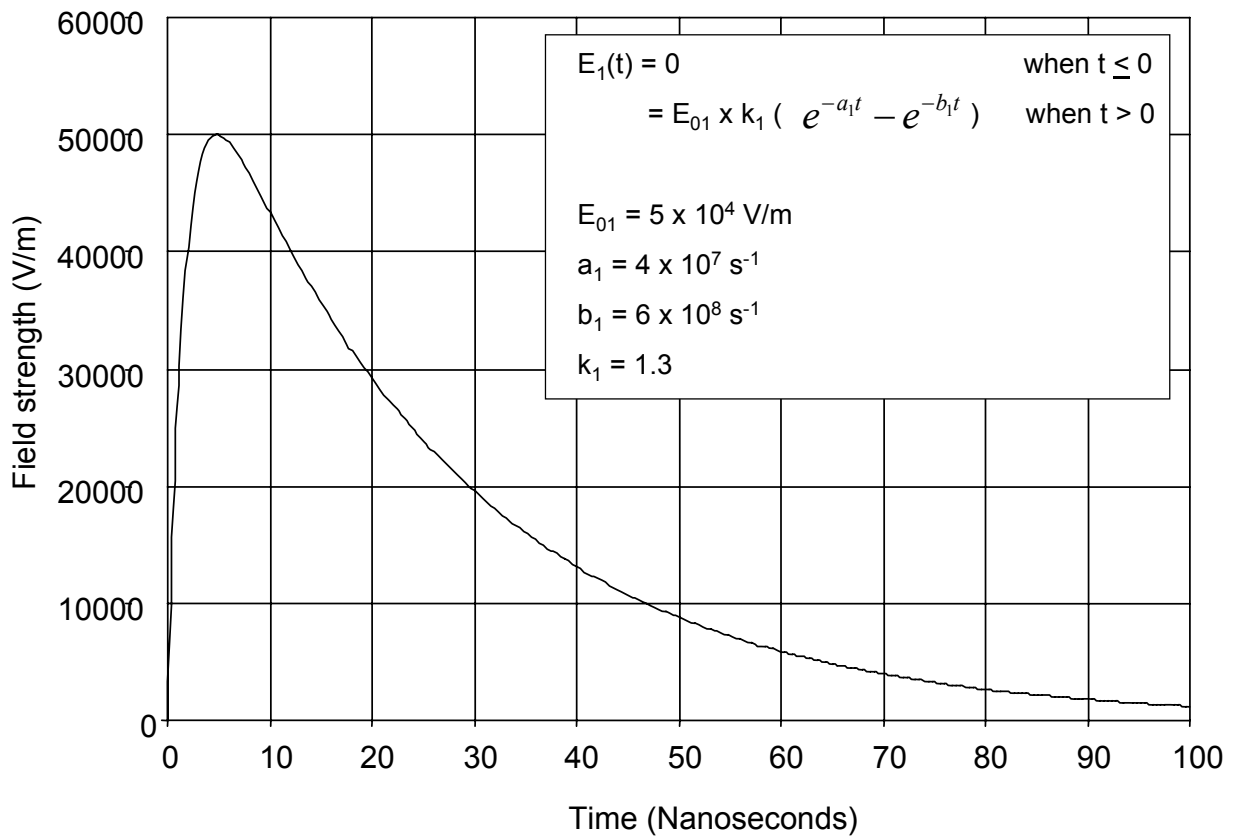
- a. Turn on the measurement equipment and allow a sufficient time for stabilisation.
- b. Calibration. Perform the following procedures using the calibration setup:
  - (1) Generate a pulse and adjust the pulse generator to produce a pulsed field, as measured with the B-dot or D-dot probes, which meets the peak amplitude, rise time, and pulse width requirements. CAUTION: High voltages are used which are potentially lethal. Record the drive pulse waveform as displayed on the oscilloscope.

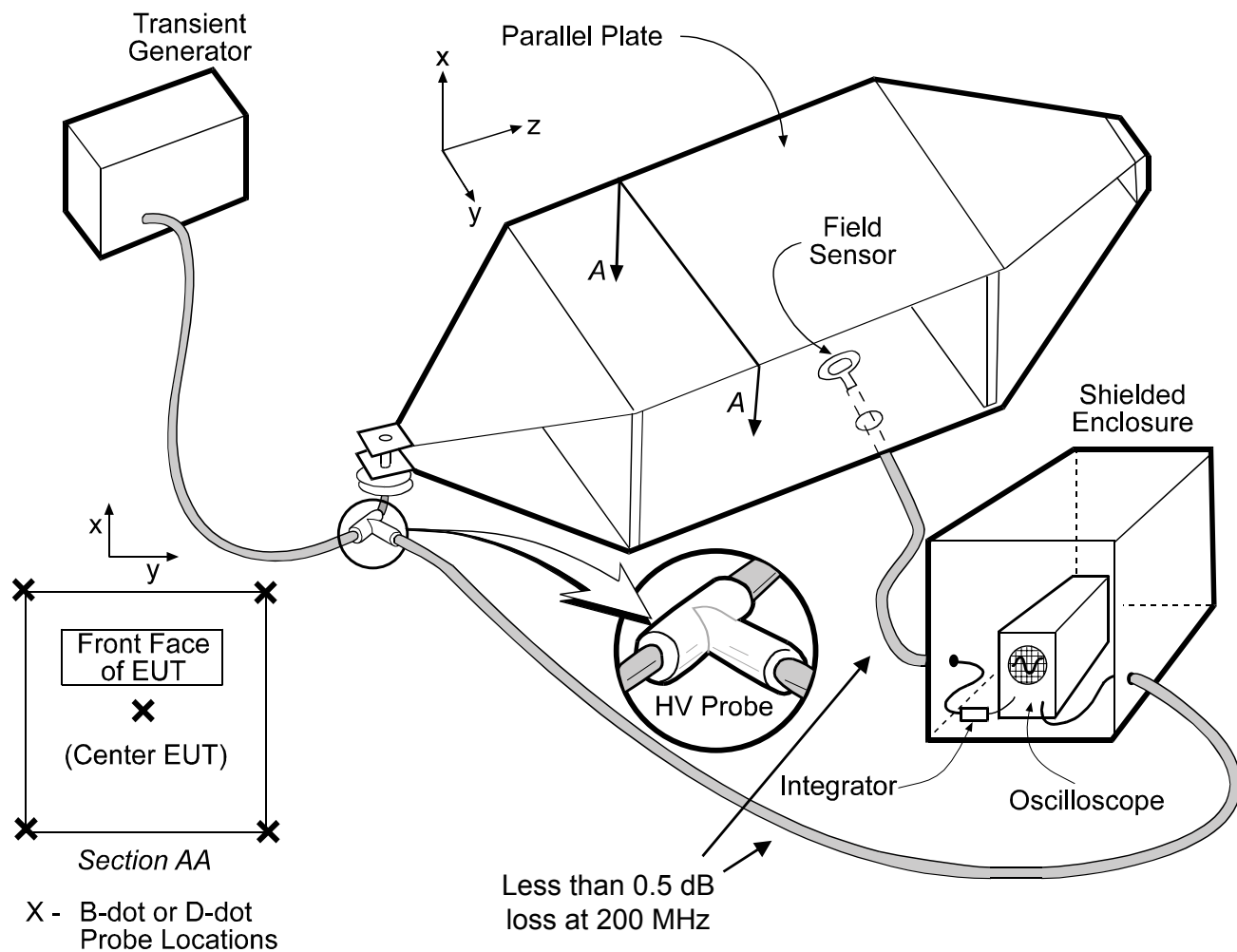
- (2) Tolerances and characteristics of the NRS105 limit shall be as follows:
    - Rise time (between 10% and 90% points) between 1.8 ns and 2.8 ns (electric field continuously increasing).
    - Full width half maximum (FWHM) pulse width equal to 23 ns  $\pm$  5 ns.
    - Peak value of the electric or magnetic field for each grid position:  
0 dB  $\leq$  magnitude  $\leq$  6 dB above limit.
  - (3) Repeat steps (1) and (2) above for the other four test points on Figure NRS03-2.
  - (4) Determine the pulse generator settings and associated pulse drive amplitude which simultaneously satisfies the field requirements for all five grid positions.
- c. EUT Testing. Perform the following procedures using the test setup:
- (1) Turn on the EUT and allow sufficient time for stabilisation.
  - (2) Test the EUT in its orthogonal orientations whenever possible.
  - (3) Apply the pulse starting at 10% of the pulse peak amplitude determined in 3.4b(4) with the specified waveshape where practical. Increase the pulse amplitude in step sizes of 2 or 3 until the required level is reached.
  - (4) Ensure that the drive pulse waveform characteristics at the required test level are consistent with those noted in 3.4b(2).
  - (5) Apply the required number of pulses at a rate of not more than 1 pulse per minute.
  - (6) Monitor the EUT during and after each pulse for signs of susceptibility or degradation of performance.
  - (7) If an EUT malfunction occurs at a level less than the specified peak level, terminate the test and record the level.
  - (8) If susceptibility is noted, determine the threshold level in accordance with paragraph 4.3.10.4.3 of test Category 501 and verify that it is above the limit.
- Note: Wherever practical all cables should remain connected to the EUT during applications of this test to simulate, as near as possible, the normal installation.

### 3.5 Data Presentation

Data presentation shall be as follows:

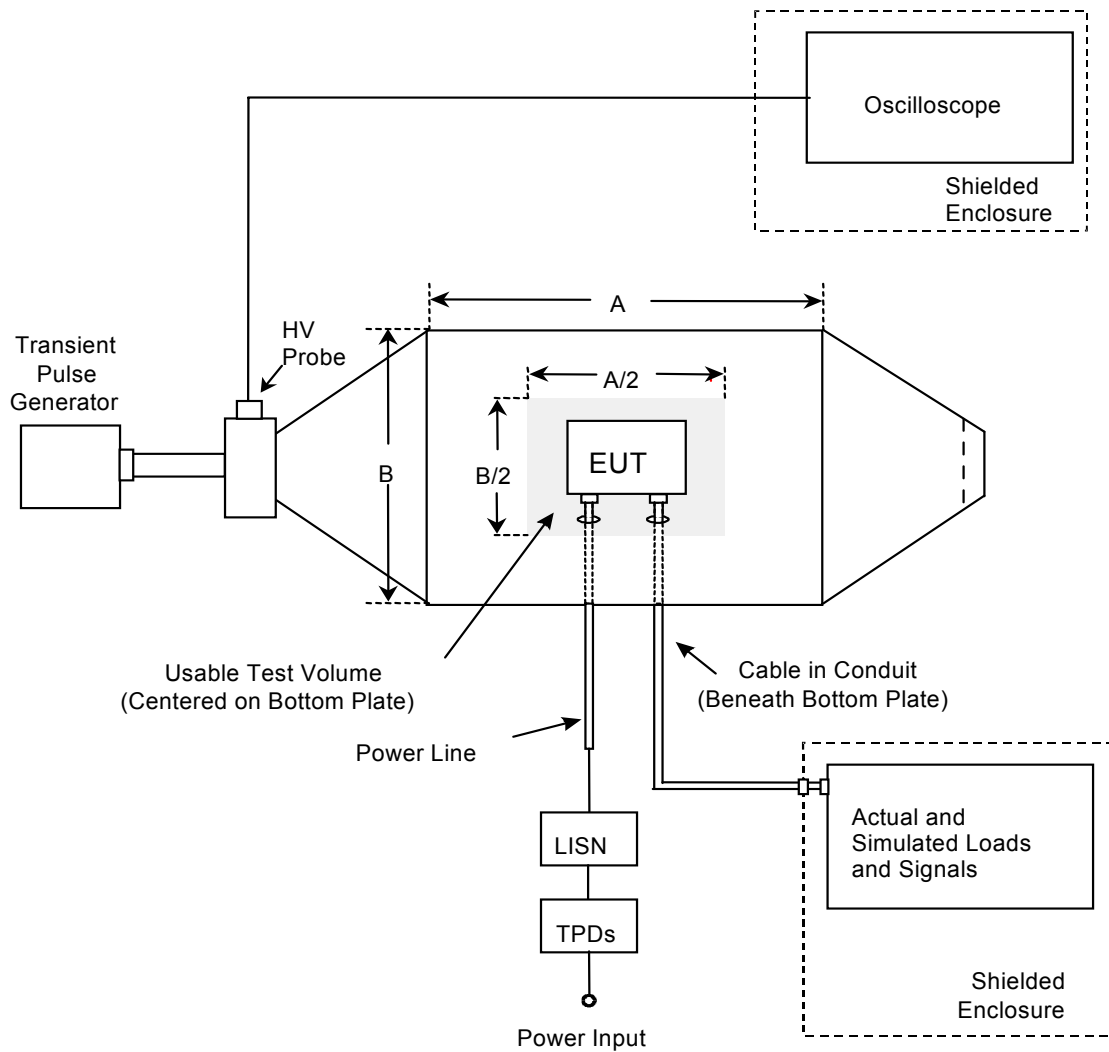
- a. Provide photographs of EUT orientation including cables.
- b. Provide a detailed written description of the EUT configuration.
- c. Provide oscilloscope recordings that show peak value, rise time, and pulse width of one applied pulse for each EUT orientation.
- d. Provide the pulse number, with the first pulse being Number 1, for each recorded waveshape.
- e. Record the time-to-recovery for each EUT failure, if applicable.

**FIGURE NRS03-1** Limit for all applications.



**FIGURE NRS03-2** Typical calibration set-up using parallel plate radiation system.

TOP VIEW



**FIGURE NRS03-3 Typical test set-up using parallel plate radiation system.**

AECTP 500  
Edition 2  
Category 501  
Test NRS03

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## **NRS04** **Radiated Susceptibility, Magnetic Field, Susceptibility (DC)**

### TABLE OF CONTENTS

<b>1</b>	<b>NRS04 APPLICABILITY.....</b>	<b>NRS04-2</b>
<b>2</b>	<b>NRS04 LIMITS.....</b>	<b>NRS04-2</b>
<b>3</b>	<b>NRS04 TEST PROCEDURE.....</b>	<b>NRS04-2</b>
	3.1 Purpose.....	NRS04-2
	3.2 Test equipment .....	NRS04-2
	3.3 Setup.....	NRS04-2
	3.4 Procedure for standard test method. ....	NRS04-3
	3.5 Procedure for localised test method. ....	NRS04-3
	3.6 Data presentation.....	NRS04-4

## **NRS04**

### **Radiated Susceptibility, Magnetic Field, (DC)**

#### **1 NRS04 APPLICABILITY**

The test method shall be primarily applied to equipment deployed aboard ships and submarines, although in some land based installation the procuring authority may require a tailored version of the test to be applied.

This test is applicable to all equipment containing components potentially sensitive to magnetic fields, e.g. cathode ray tubes, photo multipliers, sensitive Hall effect devices and moving coil meters. For an EUT comprising a number of units, each unit with potentially sensitive components shall be tested individually. The interconnecting cables do not have to be subjected to this test.

NOTE: Wherever possible the standard test method shall be applied.

Reference should be made to the Applicability Tables 6 and 7 and paragraph 6.27 in Category 501 before subjecting the EUT to this test method

#### **2 NRS04 LIMITS**

A test level of 800 A/m or higher (up to 4800 A/m for some submarine applications) shall be applied to simulate DC magnetic field effects. The test field shall be ramped continually up and down at a linear rate of 1600A/m/s to the required test level.

#### **3 NRS04 TEST PROCEDURE**

##### **3.1 Purpose**

The purpose of this test is to confirm that the magnetic field produced by degaussing coils aboard ships and submarines and the effect of deperming does not cause malfunction of the EUT.

##### **3.2 Test equipment**

The test equipment shall be as follows:

- a. Current meter
- b. Programmable DC power supply
- c. Helmholtz coil
- d. Oscilloscope

##### **3.3 Setup**

The test setup shall be as follows:

- a. Maintain a basic test setup for the EUT as shown and described in Category 501, Figures 3 through to 6 and paragraph 4.3.8.
- b. Calibration. Configure the test setup for the measurement system check as shown in Figure NRS04-1.
- c. EUT testing

- (1) Using the standard test method, position the EUT within the Helmholtz coil as shown in figure NRS04-2.
- (2) For larger equipment configurations the localised test method should be utilized and positioned as shown in Figure NRS04-3.

### 3.4 Procedure for standard test method.

The test procedures shall be as follows:

- a. Turn on the measurement equipment and allow a sufficient time for stabilization.
- b. Calibration. Evaluate the level of magnetic field being generated within the Helmholtz coil.
  - (1) Apply a DC current to the Helmholtz coil at the level necessary to produce the required field strength.
  - (2) Verify the current level, using the current meter and the current waveform using the oscilloscope.
  - (3) The level of DC current applied to the Helmholtz coil to produce the necessary field strength is dependent upon the constructional properties of the coil itself. The relationship between the coil's dimensions, the current flowing around it and the field strength generated is given by the following equation:

$$\text{Number of turns on each coil} = \frac{\text{Required field strength (A/m)} \times \text{Coil radius (m)}}{0.716 \times \text{Current (Amps)}}$$

- c. EUT testing. Determine if the EUT is susceptible to DC magnetic fields.
  - (1) Place the EUT within the centre of the Helmholtz coil, turn it on and allow sufficient time for stabilization.
  - (2) With one of the EUT's axis aligned with the direction that the field will be generated in apply the DC current to the coil. See Figure NRS04-2 for clarification.
  - (3) Monitor EUT for degradation or malfunction in performance and record result.
  - (4) If the EUT exhibits any degradation or malfunction during application of the field reduce the current level until it resumes normal operation, record threshold level.
  - (5) Change field polarity by reversing connections to the Helmholtz coil and repeat 3.4c(3) and 3.4c(4).
  - (6) Repeat 3.4c(3) to 3.4c(5) for each EUT axis.

### 3.5 Procedure for localised test method.

- a. The Helmholtz coil assembly is replaced by a single closely wound circular coil for the purpose of testing EUT greater than 1m<sup>3</sup> only.
- b. Turn on the measurement equipment and allow a sufficient time for stabilization.
- c. Calibration. Evaluate the level of magnetic field being generated within the single coil.
  - (1) Apply a DC current to the coil at the level necessary to produce the required field strength.
  - (2) Verify the current level, using the current meter and the current waveform using the oscilloscope.

- (3) Prior to application of the test field to the EUT, the DC current supplied to the coil to generate the required test level must be calculated. This is achieved using the following equation

$$\text{Current (Amps)} = \frac{2 \times \text{Required field strength (A/m)} \times \text{Coil radius (m)}}{0.716 \times \text{Number of turns on coil}}$$

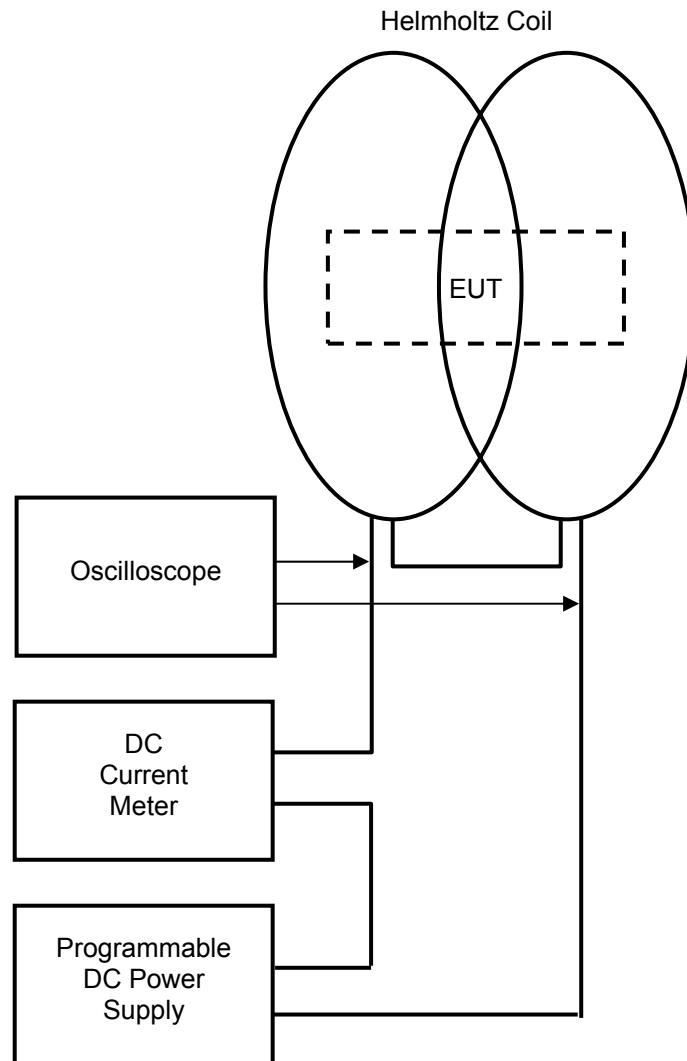
- d. EUT testing. Determine if the EUT is susceptible to DC magnetic fields.
- (1) Place the coil adjacent to the area of the EUT (or unit of the EUT system) to be assessed, turn it on and allow sufficient time for stabilization. See Figure NRS04-3 for clarification.
  - (2) The test shall be applied to each test position in turn with the coil energised first with a positive polarity and subsequently with the coil connections reversed to give a negative polarity. This reverses the direction of the magnetic field produced.
  - (3) Monitor EUT for degradation or malfunction in performance and record result.
  - (4) If the EUT exhibits any degradation or malfunction during application of the field reduce the current level until it resumes normal operation, record threshold level.

NOTE The test field shall be applied for long enough duration to comprehensively establish whether any malfunction, degradation in performance or damage has occurred to any part of the EUT. Additionally the EUT shall be checked for permanent magnetising effects after application of the test field.

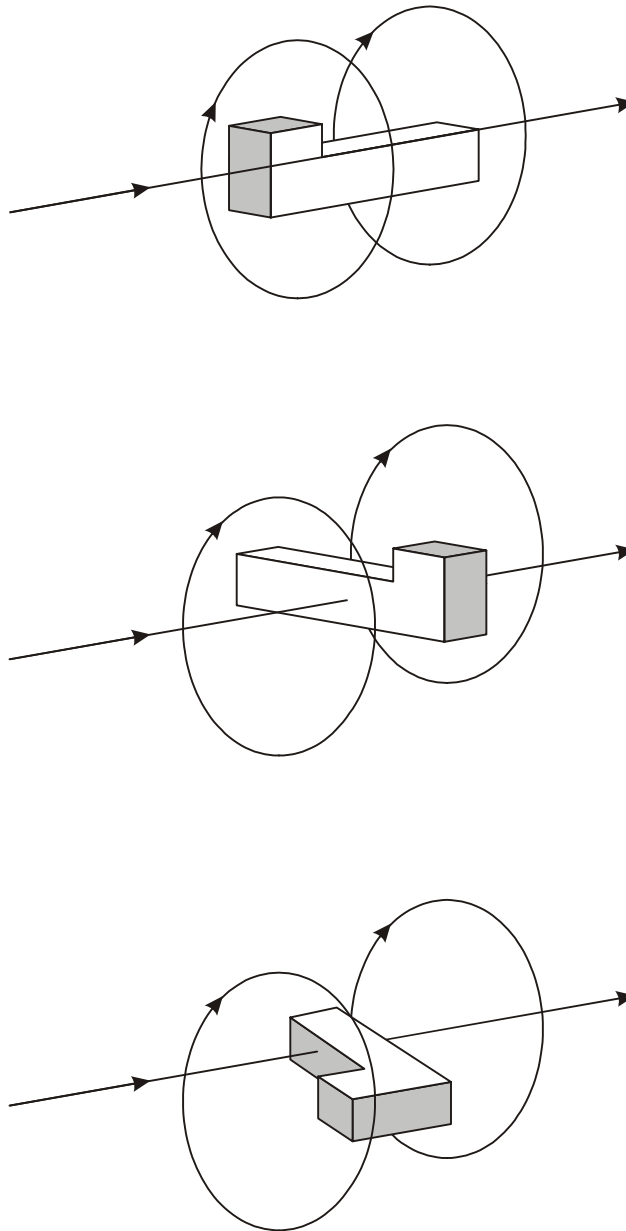
### 3.6 Data presentation.

Data presentation shall be as follows:

- a. Results shall be presented in table form with a statement of compliance given for each EUT orientation and field polarity applied to each system or sub-system tested.

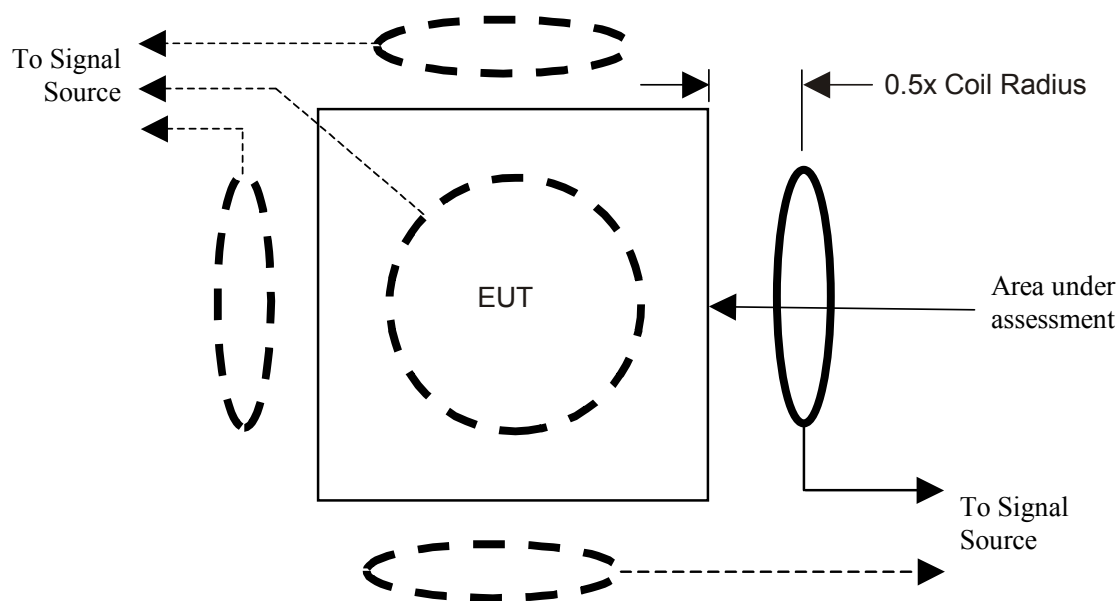


**FIGURE NRS04-1**      **Equipment Calibration Set-up.**



**FIGURE NRS04-2 Arrangement of EUT within Helmholtz Coil Assembly.**

Additional Coils shown  
for illustration purposes  
only



**FIGURE NRS04-3 Localised Test Method.**

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Category 501  
Test NRS04

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